Service Guide

E8361A Agilent Technologies PNA Series Microwave Network Analyzer



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Safety Notes

The following safety notes are used throughout this document. Familiarize yourself with each of these notes and its meaning before performing any of the procedures in this document.

| WARNING | Warning denotes a hazard. It calls attention to a procedure which, if not correctly performed or adhered to, could result in injury or loss of life. Do not proceed beyond a warning note until the indicated conditions are fully understood and met. |
|---------|--|
| CAUTION | Caution denotes a hazard. It calls attention to a procedure that, if not correctly performed or adhered to, could result in damage to or destruction of the instrument. Do not proceed beyond a caution sign until the indicated conditions are fully understood and met. |

Assistance

Product maintenance agreements and other customer assistance agreements are available for Agilent Technologies, Inc. products. For information about these agreements and for other assistance, contact Agilent. Refer to "Contacting Agilent" on page 2-11.

Safety and Regulatory Information

The safety and regulatory information pertaining to this product is located in Chapter 1, "Safety and Regulatory Information."

Safety Notes

The following safety notes are used throughout this manual. Familiarize yourself with each of the notes and its meaning before operating this instrument. All pertinent safety notes for using this product are located in Chapter 1, "Safety and Regulatory Information."

| WARNING | Warning denotes a hazard. It calls attention to a procedure which, if not correctly performed or adhered to, could result in injury or loss of life. Do not proceed beyond a warning note until the indicated conditions are fully understood and met. | |
|---------|--|--|
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Documentation Map



The online Help files are embedded in the analyzer, offering quick reference to programming and user documentation. From the Help drop-down menu, you can access the Help system in five different languages. Also, you can view the Analyzer Product Overview multimedia presentation and access the analyzer's Web page.



The *Installation and Quick Start Guide* helps you to quickly familiarize yourself with the analyzer. Procedures are provided for installing, configuring, and verifying the operation of the analyzer.

Printing Copies of Documentation from the Web

To print copies of documentation from the Web, download the PDF file from the Agilent web site:

- Go to www.agilent.com.
- Enter the product model number in the search function and click **Search**.
- Click on the Manuals hyperlink.
- Open the PDF of your choice and print the document.

1 Safety and Regulatory Information

| Information in This Chapter |
|---------------------------------------|
| Chapter One at-a-Glance |
| Safety Symbols |
| General Safety Considerations1-3 |
| Safety Earth Ground1-3 |
| Before Applying Power1-3 |
| Servicing |
| Electrostatic Discharge Protection1-6 |
| Regulatory Information1-7 |
| Instrument Markings1-7 |
| Lithium Battery Disposal1-8 |

2 General Product Information

| Information in This Chapter | |
|---|--|
| Chapter Two at-a-Glance | |
| Maintenance | |
| Physical Maintenance | |
| Electrical Maintenance | |
| Analyzer Options Available | |
| Options as Upgrades | |
| Option 010, Time Domain. | |
| Option 014, Configurable Test Set | |
| Option 016, Receiver Attenuators | |
| Option 080, Frequency Offset Mode. | |
| Option 081, External Reference Switch | |
| Option 083, Frequency Converter Measurement Application | |
| Option 099, Firmware Upgrade | |
| Option H08, Pulse Measurement Capability | |
| Option H11, IF Access. | |
| Option UNL, Source Attenuators and Bias Tees | |
| Option 1CP, Rack Mount Flange Kit for Instruments with Handles | |
| Option 1CM, Rack Mount Flange Kit for Instruments without Handles | |
| Analyzer Upgrades Available | |
| Analyzer Accessories Available | |
| CD-RW Drive. | |
| USB Hub | |
| Required Service Test Equipment | |
| Agilent Support, Services, and Assistance | |
| Service and Support Options | |
| Calibration Options. | |
| Contacting Agilent | |
| Shipping Your Analyzer to Agilent for Service or Repair | |
| | |

3 Tests and Adjustments

| Information in This Chapter | 3-2 |
|-----------------------------|-----|
| Chapter Three at-a-Glance | 3-2 |
| Before You Begin | 3-4 |

| | _ |
|--|--|
| Verify the Operating Environment | |
| Protect Against Electrostatic Discharge (ESD) | |
| Allow the Analyzer to Warm Up | |
| Review the Principles of Connector Care | |
| About System Verification and Performance Tests | |
| System Specifications | |
| Instrument Specifications | |
| System Verification Procedure. | |
| Performance Tests | |
| Certificate of Calibration | |
| ANSI/NCSL Z540–1–1994 Verification | . 3-8 |
| Non-ANSI/NCSL Z540–1–1994 Verification | . 3-9 |
| Preliminary Checks | 3-10 |
| The Operator's Check. | |
| The Test Port Cable Checks | 3-12 |
| System Verification | |
| What the System Verification Verifies | |
| Measurement Uncertainty. | |
| Measurement Traceability | |
| Performing System Verification. | |
| Option H11, IF Access, Operation Verification | |
| | |
| Performance Tests (Agilent N7840A Software Package). | 3-29 |
| Performance Tests (Agilent N7840A Software Package). | |
| Source Power Accuracy Test | 3-29 |
| Source Power Accuracy Test Source Maximum Power Output Test | 3-29 3-30 |
| Source Power Accuracy Test Source Maximum Power Output Test Source Power Linearity Test Source Power Linearity Test | 3-29 3-30 3-30 |
| Source Power Accuracy Test Source Maximum Power Output Test Source Power Linearity Test Frequency Accuracy Test | 3-29 3-30 3-30 3-31 |
| Source Power Accuracy Test Source Maximum Power Output Test Source Power Linearity Test Frequency Accuracy Test Trace Noise Test | 3-29 3-30 3-30 3-31 3-31 |
| Source Power Accuracy Test Source Maximum Power Output Test Source Power Linearity Test Frequency Accuracy Test Trace Noise Test Receiver Compression Test | 3-29 3-30 3-30 3-31 3-31 3-32 |
| Source Power Accuracy Test Source Maximum Power Output Test Source Power Linearity Test Frequency Accuracy Test Trace Noise Test Receiver Compression Test Noise Floor Test | 3-29 3-30 3-30 3-31 3-31 3-32 3-33 |
| Source Power Accuracy TestSource Maximum Power Output TestSource Power Linearity TestFrequency Accuracy TestTrace Noise TestReceiver Compression TestNoise Floor TestCalibration Coefficient Test | 3-29 3-30 3-31 3-31 3-32 3-33 3-33 3-34 |
| Source Power Accuracy TestSource Maximum Power Output TestSource Power Linearity TestFrequency Accuracy TestTrace Noise TestReceiver Compression TestNoise Floor TestCalibration Coefficient TestSystem Crosstalk Test | 3-29 3-30 3-31 3-31 3-32 3-33 3-33 3-34 3-35 |
| Source Power Accuracy TestSource Maximum Power Output TestSource Power Linearity TestFrequency Accuracy TestTrace Noise TestReceiver Compression TestNoise Floor TestCalibration Coefficient TestSystem Crosstalk TestDynamic Accuracy Test | 3-29 3-30 3-31 3-31 3-32 3-33 3-33 3-34 3-35 3-36 |
| Source Power Accuracy TestSource Maximum Power Output TestSource Power Linearity TestSource Power Linearity TestFrequency Accuracy TestTrace Noise TestReceiver Compression TestNoise Floor TestCalibration Coefficient TestSystem Crosstalk TestDynamic Accuracy TestPower Meter Accuracy Test | 3-29 3-30 3-31 3-31 3-32 3-33 3-33 3-34 3-35 3-36 3-38 |
| Source Power Accuracy TestSource Maximum Power Output TestSource Power Linearity TestFrequency Accuracy TestTrace Noise TestReceiver Compression TestNoise Floor TestCalibration Coefficient TestSystem Crosstalk TestDynamic Accuracy TestPower Meter Accuracy TestAdjustments | 3-29 3-30 3-31 3-31 3-32 3-33 3-33 3-34 3-35 3-36 3-38 3-43 |
| Source Power Accuracy TestSource Maximum Power Output TestSource Power Linearity TestFrequency Accuracy TestTrace Noise TestReceiver Compression TestNoise Floor TestCalibration Coefficient TestSystem Crosstalk TestDynamic Accuracy TestPower Meter Accuracy TestAdjustments10 MHz Frequency Reference Adjustment | 3-29 3-30 3-31 3-31 3-32 3-33 3-34 3-35 3-36 3-38 3-43 3-44 |
| Source Power Accuracy TestSource Maximum Power Output TestSource Power Linearity TestFrequency Accuracy TestTrace Noise TestReceiver Compression TestNoise Floor TestCalibration Coefficient TestSystem Crosstalk TestDynamic Accuracy TestPower Meter Accuracy TestAdjustments10 MHz Frequency Reference Adjustment3.8 GHz PMYO Frequency Adjustment | 3-29 3-30 3-31 3-31 3-32 3-33 3-34 3-35 3-36 3-38 3-43 3-44 3-45 |
| Source Power Accuracy Test . Source Maximum Power Output Test . Source Power Linearity Test . Frequency Accuracy Test . Trace Noise Test . Receiver Compression Test . Noise Floor Test . Calibration Coefficient Test . System Crosstalk Test . Dynamic Accuracy Test . Power Meter Accuracy Test . Adjustments . 10 MHz Frequency Reference Adjustment . 3.8 GHz PMYO Frequency Adjustment . LO Power Adjustment . | 3-29 3-30 3-31 3-31 3-32 3-33 3-34 3-35 3-36 3-38 3-43 3-44 3-45 3-46 |
| Source Power Accuracy Test . Source Maximum Power Output Test . Source Power Linearity Test . Frequency Accuracy Test . Trace Noise Test . Receiver Compression Test . Noise Floor Test . Calibration Coefficient Test . System Crosstalk Test . Dynamic Accuracy Test . Power Meter Accuracy Test . Adjustments . 10 MHz Frequency Reference Adjustment . 3.8 GHz PMYO Frequency Adjustment . LO Power Adjustment . LO Offset Adjustment . | 3-29 3-30 3-31 3-31 3-32 3-33 3-34 3-35 3-36 3-38 3-43 3-44 3-45 3-46 3-48 |
| Source Power Accuracy Test Source Maximum Power Output Test Source Power Linearity Test Frequency Accuracy Test Trace Noise Test Receiver Compression Test Noise Floor Test Calibration Coefficient Test System Crosstalk Test Dynamic Accuracy Test Power Meter Accuracy Test Adjustments 10 MHz Frequency Reference Adjustment 3.8 GHz PMYO Frequency Adjustment LO Power Adjustment LO Offset Adjustment Source Calibration Adjustment. | 3-29 3-30 3-30 3-31 3-32 3-32 3-33 3-34 3-35 3-36 3-38 3-38 3-43 3-44 3-45 3-46 3-48 3-50 |
| Source Power Accuracy TestSource Maximum Power Output TestSource Power Linearity TestFrequency Accuracy TestTrace Noise TestReceiver Compression TestNoise Floor TestCalibration Coefficient TestSystem Crosstalk TestDynamic Accuracy TestPower Meter Accuracy Test10 MHz Frequency Reference Adjustment3.8 GHz PMYO Frequency AdjustmentLO Offset AdjustmentLO Offset AdjustmentSource Calibration Adjustment | 3-29 3-30 3-30 3-31 3-32 3-32 3-32 3-34 3-35 3-36 3-38 3-36 3-38 3-44 3-45 3-46 3-48 3-50 3-52 |
| Source Power Accuracy Test Source Maximum Power Output Test Source Power Linearity Test Frequency Accuracy Test Trace Noise Test Receiver Compression Test Noise Floor Test Calibration Coefficient Test System Crosstalk Test Dynamic Accuracy Test Power Meter Accuracy Test Adjustments 10 MHz Frequency Reference Adjustment 3.8 GHz PMYO Frequency Adjustment LO Power Adjustment LO Offset Adjustment Source Calibration Adjustment. | 3-29 3-30 3-30 3-31 3-32 3-32 3-32 3-34 3-35 3-36 3-38 3-36 3-38 3-44 3-45 3-46 3-48 3-50 3-52 |

4 Troubleshooting

| Information in This Chapter | 4-2 |
|---|-----|
| Chapter Four at-a-Glance | 4-2 |
| Protect Against Electrostatic Discharge (ESD) | 4-3 |
| Assembly Replacement Sequence | 4-3 |
| Getting Started with Troubleshooting | 4-4 |
| Check the Basics. | 4-4 |

| Troubleshooting Organization | |
|---|--|
| Power Up Troubleshooting. | |
| Power Supply Check | |
| Troubleshooting LCD Display Problems | |
| Front Panel Troubleshooting | |
| A1 Front Panel Keypad and RPG Test. | |
| A2 Display Test | |
| A3 Front Panel Interface Board | |
| Rear Panel Troubleshooting. | |
| Checking the USB Ports | |
| Checking the SERIAL (RS-232), PARALLEL (1284-C), or VGA Port | |
| Checking the GPIB Port | |
| LAN Troubleshooting | |
| Measurement System Troubleshooting | |
| Before you begin—consider: Where do you see a problem? | |
| Verifying the A, B, R1, and R2 Traces (Standard S-Parameter Mode) | |
| Where to Begin Troubleshooting | |
| Checking the Source Group | |
| Checking the Signal Separation Group | |
| Checking the Receiver Group | |
| Checking the Frequency Offset Group (Options 080 and 081) | |
| E8361A Overall Block Diagram, No Options | |
| E8361A Overall Block Diagram, All Options | |
| | |

5 Theory of Operation

| Information in This Chapter | |
|--|--|
| Chapter Five at-a-Glance | |
| Network Analyzer System Operation | |
| Functional Groups of the Network Analyzer. | |
| Source Group Operation | |
| Band Modes | |
| A8 Fractional-N Synthesizer Board | |
| A17 L.O. Multiplier/Amplifier 12 (LOMA 12) | |
| A18 Multiplier/Amplifier 24 (MA 24) | |
| A19 Splitter | |
| A20 L.O. Distribution Assembly (LODA) | |
| A10 Frequency Reference Board | |
| A11 Phase Lock Board | |
| A12 Source 20 | |
| A21 Source Multiplier/Amplifier 50 (SOMA 50) | |
| A23 and A24 Source Multiplier/Amplifier 70 (SOMA 70) | |
| A16 Test Set Motherboard | |
| Signal Separation Group Operation | |
| A22 Switch. | |
| A23 and A24 Source Multiplier/Amplifier 70 (SOMA 70) | |
| A25 and A26 Test Port Couplers | |
| A36 and A37 50-dB Source Step Attenuators (Option UNL) | |
| A38 and A39 Bias Tees (Option UNL) | |
| A43 and A44 50-dB Receiver Step Attenuators (Option 016) | |
| | |

| Option 014 Configurable Test Set | 5-18 |
|--|------|
| Receiver Group Operation. | 5-21 |
| A27, A28, A29, and A30 Receiver First Converters (Mixers). | 5-21 |
| A49 IF Multiplexer Board | 5-21 |
| A31, A32, A33, and A34 Receiver Modules | |
| A6 SPAM Board (Analog Description). | |
| A35 Receiver Motherboard | |
| Frequency Offset Group Operation (Options 080 and 081). | 5-24 |
| A9 Fractional-N Synthesizer Board (Option 080) | |
| A13 Frequency Offset Receiver Assembly (Option 080) | |
| A45 Reference Transfer Switch (Option 081) | |
| IF Access Group (Option H11) | |
| A47 RF Path Coupler | |
| A48 LO Path Coupler | |
| A49 IF Multiplexer Board | |
| Rear-Panel Connections. | |
| Digital Processing and Digital Control Group Operation | 5-29 |
| Front Panel Subgroup | |
| Data Acquisition and Processing Subgroup | |
| Power Supply Group Operation | |

6 Replaceable Parts

| Information in This Chapter |
|---|
| Chapter Six at-a-Glance |
| Ordering Information |
| Assembly Replacement Sequence |
| Rebuilt-Exchange Assemblies |
| Replaceable Parts Listings |
| Front Panel Assembly, All Options |
| Top Assemblies, All Options |
| Top Cables—All, All Options |
| Bottom Assemblies, No Options |
| Bottom Semi-Rigid Cables, No Options |
| Bottom Assemblies, Option 014 and Options 014/0806-20 |
| Bottom Semi-Rigid Cables, Option 014 and Options 014/080 6-22 |
| Bottom Assemblies, Options 014/UNL |
| Bottom Semi-Rigid Cables, Options 014/UNL |
| Bottom Assemblies, Options 014/UNL/016 |
| Bottom Semi-Rigid Cables, Options 014/UNL/016 |
| Bottom Assemblies, Options 014/UNL/080/081 6-32 |
| Bottom Semi-Rigid Cables, Options 014/UNL/080/081 |
| Bottom Assemblies, Options 014/UNL/016/080/0816-36 |
| Bottom Semi-Rigid Cables, Options 014/UNL/016/080/0816-38 |
| Bottom Assemblies, Options 014/UNL/080/081/H116-40 |
| Bottom Semi-Rigid Cables, Options 014/UNL/080/081/H11 6-42 |
| Bottom Flexible RF Cables, All Options |
| Bottom Ribbon and Wrapped-Wire Cables, All Options |
| Top Hardware and Parts, All Options |
| Bottom Hardware and Parts, All Options |

| Internal Hardware and Parts, All Options | 6-52 |
|--|------|
| External Hardware and Parts, All Options | 6-54 |
| Rear Panel Assembly, All Options | 6-56 |
| Hard Disk Drive Assembly, All Options. | 6-58 |
| Miscellaneous Part Numbers | 6-59 |

7 Repair and Replacement Procedures

| Information in This Chapter | |
|---|--|
| Chapter Seven at-a-Glance. | |
| Before Starting the Removal and Replacement Procedures | |
| Personal Safety Warnings. | |
| Electrostatic Discharge (ESD) Protection | |
| Assembly Replacement Sequence | |
| Removal and Replacement Procedures | |
| Removing the Covers | |
| Raising and Removing the Receiver Deck | |
| Removing and Replacing the Front Panel Assembly | |
| Removing and Replacing Front Panel Subassemblies | |
| Removing and Replacing the Display Inverter Board and the Display Lamp | |
| Removing and Replacing the A4 Power Supply Assembly | |
| Removing and Replacing the A6, A8, A9, and A10 Boards | |
| Removing and Replacing the A11 Phase Lock Board | |
| Removing and Replacing the A12 Source 20 | |
| Removing and Replacing the A13 Frequency Offset Receiver Assembly | |
| Removing and Replacing the A14 System Motherboard | |
| Removing and Replacing the A15 CPU Board | |
| Removing and Replacing the A16 Test Set Motherboard | |
| Removing and Replacing the A17 LOMA 12 | |
| Removing and Replacing the A18 MA 24 | |
| Removing and Replacing the A19 Splitter | |
| Removing and Replacing the A20 LODA | |
| Removing and Replacing the A21 SOMA 50 | |
| Removing and Replacing the A22 Switch | |
| Removing and Replacing the A23 and A24 SOMA 70s | |
| Removing and Replacing the A25 and A26 Test Port Couplers | |
| Removing and Replacing the A27–A30 First Converters (Mixers) and Mixer Bias | |
| Removing and Replacing the A31–A34 Receiver Modules and A49 IF Multiplexer | |
| Removing and Replacing the A35 Receiver Motherboard | |
| Removing and Replacing the A36 and A37 50-dB Source Step Attenuators (Optio | |
| Removing and Replacing the A38 and A39 Bias Tees (Option UNL) | |
| Removing and Replacing the A40 Floppy Disk Drive | |
| Removing and Replacing the A41 Hard Disk Drive (HDD) | |
| Removing and Replacing the A43 and A44 50-dB Receiver Step Attenuators | |
| (Option 016) | |
| Removing and Replacing the A45 Reference Channel Transfer Switch (Option 08 | |
| Removing and Replacing the A47 and A48 Couplers (Option H11) | |
| Removing and Replacing the Midweb and the B1 Fan | |
| Removing and Replacing the USB Hub | |
| Post-Repair Procedures | |

| A | Error Terms |
|---|--|
| | Information in This Appendix |
| | Appendix A at-a-Glance |
| | Using Error Terms as a Diagnostic Tool |
| | Preventive Maintenance |
| | Troubleshooting |
| | Performing Measurement Calibration |
| | Using Flowgraphs to Identify Error Terms |
| | Accessing Error Terms |
| | Manual Access to Error Terms |
| | Programmatic Access to Error Terms |
| | If Error Terms Seem Worse than Expected |
| | Directivity (EDF and EDR) |
| | Source Match (ESF and ESR) |
| | Load Match (ELF and ELR) |
| | Reflection Tracking (ERF and ERR) |
| | Transmission Tracking (ETF and ETR) |
| | Isolation (EXF and EXR) |
| | |
| B | Option Enable Utility |
| | Information in This AppendixB-2 |
| | Appendix B at-a-Glance |
| | Accessing the Option Enable UtilityB-3 |
| | Enabling or Removing Options |
| | Repairing and Recovering Option DataB-5 |
| | Recovery of Data After RepairB-5 |
| | Recovery of Data if Option or Model Numbers are Incorrect |
| | Installing or Changing a Serial NumberB-6 |
| ~ | |
| С | Firmware Upgrades |
| | Information in This Appendix |
| | Appendix C at-a-Glance C-2 How to Check the Current Firmware Version C-2 |
| | Downloading from the Internet |
| | Downloading Using Option 099, Firmware UpgradeC-3 |
| | Installation Requirements |
| | Downloading from a USB CD Drive Connected to the Analyzer |
| | Downloading from a Shared CD Drive Over the LAN |
| | Downloading Over the LAN. |
| | |
| D | Operating System Recovery |
| | Information in This AppendixD-2 |
| | Appendix D at-a-GlanceD-2 |
| | Overview |
| | System Recovery Procedure |
| | If the Operating System Does Not Boot From the Hard Disk Drive |
| | If the Operating System Does Not Boot From the Floppy Disk DriveD-6 |

1 Safety and Regulatory Information

Information in This Chapter

This chapter provides safety information that will help protect you and your network analyzer. It also contains information that is required by various government regulatory agencies.

Chapter One at-a-Glance

| Section Title | Summary of Content | Start Page |
|---|--|------------|
| Safety Symbols | Descriptions of CAUTION and WARNING symbols used throughout this manual. | Page 1-3 |
| General Safety Considerations | A list of safety points to consider when servicing your network analyzer. | Page 1-3 |
| Electrostatic Discharge Protection | A discussion of electrostatic discharge (ESD) and related recommendations and requirements for ESD protection. | Page 1-6 |
| Regulatory InformationDefinitions of instrument markings.Instructions for disposing of the analyzer's lithium battery. | | Page 1-7 |

Safety Symbols

The following safety symbols are used throughout this manual. Familiarize yourself with each of the symbols and its meaning before operating this instrument.

| CAUTION | Caution denotes a hazard. It calls attention to a procedure that, if not correctly performed or adhered to, could result in damage to or destruction of the instrument. Do not proceed beyond a caution note until the indicated conditions are fully understood and met. |
|---------|---|
| | |

WARNING Warning denotes a hazard. It calls attention to a procedure which, if not correctly performed or adhered to, could result in injury or loss of life. Do not proceed beyond a warning note until the indicated conditions are fully understood and met.

General Safety Considerations

Safety Earth Ground

| WARNING | This is a Safety Class I product (provided with a protective earthing ground incorporated in the power cord). The mains plug shall only be inserted in a socket outlet provided with a protective earth contact. Any interruption of the protective conductor, inside or outside of the instrument, will make the instrument dangerous. Intentional interruption is prohibited. | | |
|----------|--|--|--|
| CAUTION | Always use the three-prong AC power cord supplied with this product. Failure to ensure adequate grounding by not using this cord may cause product damage. | | |
| Before A | Applying Power | | |
| WARNING | ING If this product is not used as specified, the protection provided by the equipment could be impaired. This product must be used in a normal condition (in which all means for protection are intact) only | | |
| WARNING | If an instrument handle is damaged, you should replace it immediately. Damaged handles can break while you are moving or lifting the instrument and cause personal injury or damage to the instrument. | | |

| CAUTION | This instrument has autoranging line voltage input. Be sure the supply voltage is within the specified range. | |
|----------|---|--|
| CAUTION | This product is designed for use in Installation Category II and Pollution Degree 2 per IEC 61010-1:2001 and 664 respectively. | |
| CAUTION | Ventilation Requirements: When installing the product in a cabinet, the convection into and out of the product must not be restricted. The ambient temperature (outside the cabinet) must be less than the maximum operating temperature of the instrument by 4 °C for every 100 watts dissipated in the cabinet. If the total power dissipated in the cabinet is greater than 800 watts, then forced convection must be used. | |
| CAUTION | The measuring terminals on this instrument are designed to be used with external signals described in Measurement Category I, but NOT with external signals described in Categories II, III, and IV. The input of this instrument cannot be connected to the mains. | |
| Servicir | ng | |
| WARNING | These servicing instructions are for use by qualified personnel only. To avoid electrical shock, do not perform any servicing unless you are qualified to do so. | |
| WARNING | Danger of explosion if battery is incorrectly replaced. Replace only with the same or equivalent type recommended. Discard used batteries according to local ordinances and/or manufacturer's instructions. | |
| WARNING | Procedures described in this document may be performed with power supplied to the product while protective covers are removed. Energy available at many points may, if contacted, result in personal injury. | |
| WARNING | No operator serviceable parts inside. Refer servicing to qualified personnel. To prevent electrical shock, do not remove covers. | |
| WARNING | The opening of covers or removal of parts may expose dangerous voltages. Disconnect the instrument from all voltage sources while it is being opened. | |

| WARNING | For continued protection against fire hazard, replace line fuse only with same type and rating. The use of other fuses or material is prohibited. | | |
|---------|---|--|--|
| WARNING | The detachable power cord is the instrument disconnecting device. It disconnects the mains circuits from the mains supply before other parts of the instrument. The front panel switch is only a standby switch and is not a LINE switch (disconnecting device). | | |

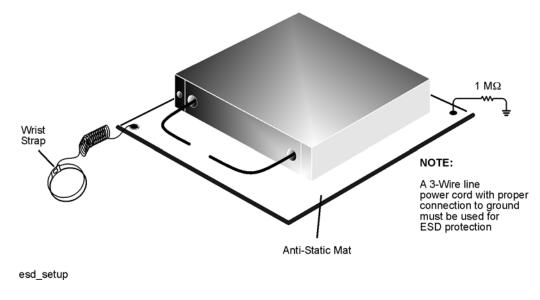
Electrostatic Discharge Protection

Protection against electrostatic discharge (ESD) is essential while removing assemblies from or connecting cables to the network analyzer. Static electricity can build up on your body and can easily damage sensitive internal circuit elements when discharged. Static discharges too small to be felt can cause permanent damage. To prevent damage to the instrument:

- always have a grounded, conductive table mat in front of your test equipment.
- *always* wear a grounded wrist strap, connected to a grounded conductive table mat, having a 1 M Ω resistor in series with it, when handling components and assemblies or when making connections.
- *always* wear a heel strap when working in an area with a conductive floor. If you are uncertain about the conductivity of your floor, wear a heel strap.
- *always* ground yourself before you clean, inspect, or make a connection to a static-sensitive device or test port. You can, for example, grasp the grounded outer shell of the test port or cable connector briefly.
- *always* ground the center conductor of a test cable before making a connection to the analyzer test port or other static-sensitive device. This can be done as follows:
 - 1. Connect a short (from your calibration kit) to one end of the cable to short the center conductor to the outer conductor.
 - 2. While wearing a grounded wrist strap, grasp the outer shell of the cable connector.
 - 3. Connect the other end of the cable to the test port and remove the short from the cable.

Figure 1-1 shows a typical ESD protection setup using a grounded mat and wrist strap. Refer to "ESD Supplies" on page 6-60 for part numbers.





Regulatory Information

This section contains information that is required by various government regulatory agencies.

Instrument Markings



The instruction documentation symbol. The product is marked with this symbol when it is necessary for the user to refer to the instructions in the documentation.



The CE mark is a registered trademark of the European Community. (If accompanied by a year, it is when the design was proven.)



The CSA mark is a registered trademark of the Canadian Standards Association.



This is a marking to indicate product compliance with the Canadian Interference-Causing Equipment Standard (ICES-001).



This is a symbol of an Industrial Scientific and Medical Group 1 Class A product.



This is a required mark signifying compliance with an EMC requirement. The C-Tick mark is a registered trademark of the Australian Spectrum Management Agency.



This product complies with the WEEE Directive (2002/96/EC) marking requirements. The affixed label indicates that you must not discard this electrical/ electronic product in domestic household waste.

Product Category: With reference to the equipment types in the WEEE Directive Annex I, this product is classed as a "Monitoring and Control instrumentation" product.

Do not dispose in domestic household waste.

To return unwanted products, contact your local Agilent office, or see http://www.agilent.com/environment/product/ for more information.

Lithium Battery Disposal

If the battery on the A15 CPU board assembly needs to be disposed of, dispose of it in accordance with your country's requirements. If required, you may return the battery to Agilent Technologies for disposal. Refer to "Contacting Agilent" on page 2-11 for assistance.



DO NOT THROW BATTERIES AWAY BUT COLLECT AS SMALL CHEMICAL WASTE.

2 General Product Information

Information in This Chapter

Chapter Two at-a-Glance

| Section Title | Summary of Content | | |
|---------------------------------|---|-----------|--|
| Maintenance | Cleaning instructions for the external surfaces of your analyzer. Information about electrical maintenance of your analyzer. | Page 2-3 | |
| Analyzer Options Available | A list of the options and upgrades available for the microwave network analyzers. | Page 2-3 | |
| Required Service Test Equipment | A list of service equipment that is required to perform system verification, performance tests, adjustments, and troubleshooting. | Page 2-7 | |
| | The Internet address (URL) for on-line assistance. | | |
| Agilent Support, Services, and | Telephone and fax numbers for contacting Agilent for assistance. | | |
| Assistance | Service and support options available. | Page 2-10 | |
| | Calibration options available. | | |
| | Important information about shipping your analyzer to Agilent for service or repair. | | |

Maintenance

WARNING To prevent electrical shock, disconnect the analyzer from the mains source before cleaning. Use a dry cloth or one slightly dampened with water to clean the external case parts. Do not attempt to clean internally.

Physical Maintenance

Clean the cabinet, including the front panel, using a dry or slightly damp cloth only.

Electrical Maintenance

Refer to "Contacting Agilent" on page 2-11 and to Chapter 3, "Tests and Adjustments."

Analyzer Options Available

Options as Upgrades

The options described in this section can be ordered as upgrades. Refer to "Analyzer Upgrades Available" on page 2-6.

Individual upgrade kits are also available and can be ordered by part number. Refer to "Upgrade Kits" on page 6-60 for a complete list of available kits.

Option 010, Time Domain

An Option 010 analyzer can display the time domain response of a network or test device by calculating the inverse Fourier transform of the frequency domain response. This calculation allows the Option 010 analyzer to show the response of a test device as a function of time or distance. In time domain, the magnitude and location of a discontinuity and the characteristics of individual transmission paths of a network or test device can be determined. Time domain operation retains all the accuracy of active error correction.

Option 014, Configurable Test Set

An Option 014 analyzer can be configured to measure high-power devices and devices for high dynamic range.

For a high-power measurement, external amplifiers and high power attenuators or isolators can be added to complete the test setup. Test port output power up to 1 Watt (+30 dBm) can be applied to the device under test (DUT). There is an external reference input that allows the external amplifier's frequency response and drift to be ratioed out.

For high dynamic range measurements, front panel jumpers are moved to reverse the signal path through one of the couplers, allowing for a 15 dB improvement in transmitted signal sensitivity in one direction only. Jumpers are installed on both ports allowing the user to choose a measurement in either the forward or reverse direction.

Option 016, Receiver Attenuators

This upgrade provides the a 50-dB step attenuator (in 10-dB steps) in the A and B channels.

Option 080, Frequency Offset Mode

This upgrade provides the additional hardware and software necessary to make frequency offset measurements.

Option 081, External Reference Switch

This upgrade adds a solid-state internal RF transfer switch in the R1 reference receiver path. The switch allows the instrument to easily switch between standard S-parameter (non-frequency offset) measurements and frequency offset measurements such as relative phase or absolute group delay that require an external reference mixer. The user can set the switch manually or remotely, but it is best used with the frequency-converter application (option 083), where it is controlled automatically during the vector-mixer calibration procedure.

Option 083, Frequency Converter Measurement Application

This option adds an intuitive and easy-to-use user interface, advanced calibration choices that provide exceptional amplitude and phase accuracy, and control of external signal sources for use as local oscillators (both fixed and swept-LO measurements are supported). A graphical set-up dialog box lets you quickly set up the instrument for single or dual conversion devices. This set-up screen also helps you calculate and choose where mixing and image products will fall. This option requires that Option 081 also be installed.

Option 099, Firmware Upgrade

This upgrade provides the latest revision of firmware for the PNA series network analyzers on CD-ROM. This firmware is user installable. The installation requires a USB CD-ROM drive (see "CD-RW Drive") or an external computer connected to a Local Area Network (LAN).

This firmware is also available on the Internet at the Agilent website: http://www.agilent.com/find/pna. (Select your analyzer's model number in this website to view available upgrades.)

Option H08, Pulse Measurement Capability

This option enables additional firmware and hardware within the analyzer to allow you to perform pulse measurements with you PNA. This option requires that Option H11 also be installed.

Option H11, IF Access

This option adds additional hardware to your PNA that allows for external connection to the internal IF path of the PNA. This option requires that Options 014, 080, 081, and UNL also be installed.

Option UNL, Source Attenuators and Bias Tees

This option adds a 50-dB step attenuator (in 10-dB steps) and a bias tee between the port switch and each of the ports. The step attenuators are used to adjust the power level to the device under test (DUT) without changing the power in the reference path. The bias tees provide a means of biasing active devices under test. DC bias for the bias tees is provided through two rear-panel BNC connectors. These inputs are fused for protection.

Option 1CP, Rack Mount Flange Kit for Instruments with Handles

Option 1CP provides a rack mount kit that contains a pair of flanges (cut to adapt to handles), rack mount rails, and the necessary hardware to mount the analyzer in an equipment rack with 482.6 mm (19 inches) horizontal spacing.

Additional kits may be ordered from Agilent. Refer to "Rack Mount Kits and Handle Kits" on page 6-61 for the part numbers.

Option 1CM, Rack Mount Flange Kit for Instruments without Handles

Option 1CM provides a rack mount kit that contains a pair of flanges, rack mount rails, and the necessary hardware to mount the analyzer in an equipment rack with 482.6 mm (19 inches) horizontal spacing.

Additional kits may be ordered from Agilent. Refer to "Rack Mount Kits and Handle Kits" on page 6-61 for the part numbers.

Analyzer Upgrades Available

The options described in this section can be ordered as upgrades. To order an upgrade for your microwave PNA, order the analyzer's model number, followed by a "U", then indicate the option to be added:

- Your analyzer's current model number followed by a "U". For example, E8361AU.
 - The number of the desired option from the available list. For example, Time Domain option would be E8361AU-010.

Individual upgrade kits are also available and can be ordered by part number. Refer to "Upgrade Kits" on page 6-60 for a complete list of available kits.

The following table lists the upgrades that are available for your PNA. Refer to the previous section, "Analyzer Options Available" on page 2-3, for a complete description of each option upgrade.

| Upgrade | Order Number |
|--|--------------|
| Time domain (Option 010) | E8361AU-010 |
| Configurable test set (Option 014) | E8361AU-014 |
| Receiver attenuators (Option 016) | E8361AU-016 |
| Frequency offset mode (Option 080) | E8361AU-080 |
| External reference switch (Option 081) | E8361AU-081 |
| Frequency converter measurement application (Option 083) | E8361AU-083 |
| Firmware upgrade on CD-ROM (Option 099) | E8361AU-099 |
| Pulse measurement capability (Option H08) | E8361AU-H08 |
| IF access (Option H11) | E8361AU-H11 |
| Source attenuators and bias tees (Option UNL) | E8361AU-UNL |

Table 2-1Analyzer Upgrades Available

Analyzer Accessories Available

CD-RW Drive

This accessory is an external read/write CD drive with a USB cable. This accessory can be ordered as model number N4688A.

USB Hub

This accessory is a 4-port USB hub for connecting additional USB peripheral devices. This accessory can be ordered as model number N4689A.

Required Service Test Equipment

| Equipment | Critical Specifications | Recommended Model or Part Number | Alternate Model or Part Number | Use ^a |
|--|---|---|---|------------------|
| | Test Instruments an | nd Software | | |
| Frequency counter | Freq: 10 MHz to 24 GHz Accuracy : ±0.5 ppm | 53151A Opt 001 | None | Р, А,Т |
| Spectrum analyzer | Min Freq: 1 MHz Max Freq: > 4 GHz Resolution BW: 300 Hz | 8565E | 856xE | A,T |
| Power meter | Accuracy: ±0.0068 dB | E4418B/19B Opt G12 or H12 ^b | E4418A/19A ^c | Р, А,Т |
| Power sensor | Freq: 10 MHz to 4.2 GHz Range: –30 to +20 dBm | 8482A | None | Р, А,Т |
| Power sensor | Freq: 4.2 GHz to 50 GHz Range: –30 to +20 dBm | 8487A | None | Р, А,Т |
| Power sensor ^d | Freq: 50 GHz to 67 GHz Range: –30 to +20 dBm | V8486A | None | P, A, T |
| Adapter ^d (WR-15 to 1.85 mm) | Return Loss: ≥ 22 dB | V281A | None | P, A, T |
| Dynamic accuracy test set | None specified | Z5623A Opt H01 | None | Р |
| Digital voltmeter | Resolution: 10 mV | Any | Any | Т |
| Printer | N/A | Any printer with Microsoft® Windows® 2000 driver | | Р |
| Test software ^e | N/A | N7840A | None | Р |

a. P = Performance tests, A = Adjustments, T = Troubleshooting, V = System verification

b. The accuracy of a standard E4418B or E4419B of ± 0.02 dB is adequate for all tests except "Dynamic Accuracy Test." This test requires a power meter with Option G12 or H12 that has been certified to a higher accuracy specification. If an Option G12 or H12 power meter is not available, a test is provided on page 3-38 to verify the accuracy of a standard power meter.

c. If an accurate measurement of the dynamic accuracy specification is not required, the E4418A or E4419A can be used.

- d. This sensor and adapter must be calibrated together by the Agilent factory. The data supplied is only valid as long as the sensor and adapter remain connected.
- e. The recommended model or part number for all equipment listed with a "P" in the Use column is required for proper operation of this test software.

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| Equipment ^a | Critical Specifications | Recommended Model or Part Number | Alternate Model or Part Number | Use ^b |
|--|-----------------------------------|--|---|------------------|
| | Calibration and Verifica | ation Kits | | |
| 1.85 mm calibration kit | Freq: 10 MHz to 67 GHz | 85058B | 85058E | P,T |
| 1.85 mm verification kit | Freq: 10 MHz to 67 GHz | 85058V | None | V |
| ECal module | Freq: 10 MHz to 67 GHz | N4694A | None | Р,А, Т |
| | Cables | | | |
| BNC cable (2 required) | 50Ω , length ≥ 60 cm | 8120-1839 | None | Α |
| 1.85 mm RF cable (Qty 2) | 50Ω , length ≥ 60 cm | N4697F | Equivalent | P,A,V |
| GPIB cable | N/A | 10833A/B/C/D | None | P,A |
| | Adapters | | | |
| WR-15 to 1.85 mm (m) | Return Loss: $\geq 22 \text{ dB}$ | V281B | None | P,A,T |
| 1.85 mm (f) to 1.85 mm (f) | Return Loss: $\geq 22 \text{ dB}$ | 85058-60114 ^{c, d} | None | P,A,T |
| 2.4 mm (f) to 2.4 mm (f) | Return Loss: ≥ 26 dB | 11900B | 85056-60007 | P,A,T |
| Adapter, 3.5 mm (m) to 2.4 mm (f) | Return Loss: ≥ 32 dB | 11901D | E4413A ^e | P,A,T |
| $2.4 \text{ mm} (f) \text{ to Type-N} (f)^{f}$ | Return Loss: ≥ 28 dB | 11903B | None | P,A,T |
| Adapter, SMA (m) to SMA (f), right angle | Return Loss: ≥ 20 dB | 1250-1249 | Equivalent | А |
| Attenuators | | | | |
| 1.85 mm, 10-dB fixed attenuator, (m,f) | Freq: 10 MHz to 67 GHz | Anritsu 41V-10 | None | Р |
| 1.85 mm, 20-dB fixed attenuator, (m,f) | Freq: 10 MHz to 67 GHz | Anritsu 41V-20 | None | Р |

a. Unless specified otherwise, equipment listed is required for all analyzer models.

b. P = Performance tests, A = Adjustments, T = Troubleshooting, R = Repair, V = System verification c. Included in the 85058B/E calibration kits.

d. This adapter is included in the calibration kit 85058B, and is only required when using the ECal module—model N4694A—is used to perform the calibration.

e. The E4413A 3.5 mm power sensor may be used instead of the 8487A power sensor and 11901D adapter.

f. The 1.85 mm connector has the same ruggedness and is compatible with the 2.4 mm connectors. 1.85 mm and 2.4 mm adapters may be used interchangeably.

| Equipment ^a | Critical Specifications | Recommended Model or Part Number | Alternate Model Number | Use ^b |
|---|--|--|------------------------------|------------------|
| | Tools | | | |
| Extender board | N/A | E8356-60021 | None | Т |
| T-8 TORX driver | 0.6 N-m (5 in-lb) setting | N/A | N/A | R |
| T-10 TORX driver | 0.5, 0.8, and 1.0 N-m (4, 7, and 9 in-lb) settings | N/A | N/A | T,R |
| T-20 TORX driver | 2.4 N-m (21 in-lb) setting | N/A | N/A | T,R |
| 1/4 inch and 5/16 inch open-end wrench | Thin profile | 8710-0510 | N/A | A,R |
| 5/16 inch, open-end torque wrench (metric equivalent is 8 mm) | 1.1 and 2.4 N-m (10 and 21 in-lb) settings (for semi-rigid cables) | N/A | N/A | T,R |
| 1 inch, open-end torque wrench (metric equivalent is 26 mm) | 8.1 N-m (72 in-lb) setting (for Port 1 and Port 2 connector nuts) | N/A | N/A | R |
| 20 mm, open-end torque wrench | 0.9 N-m (8 in-lb) setting (for Port 1 and Port 2 measurement connections) | 8710-1764 | N/A | P,A,T |
| | Static Safety Parts | 5 | | |
| Adjustable antistatic wrist strap | N/A | 9300-1367 | None | P,A,T |
| Antistatic wrist strap grounding cord (5 foot) | N/A | 9300-0980 | None | P,A,T |
| Static control table mat and earth ground wire | N/A | 9300-0797 | None | P,A,T |
| Floppy disks | 3.5 inch | Any | None | A |
| Miscellaneous | | | | |
| Floppy disks | 3.5 inch | Any | None | A |

a. Unless specified otherwise, equipment listed is required for all analyzer models.

b. P = Performance tests, A = Adjustments, T = Troubleshooting, R = Repair, V = System verification

Agilent Support, Services, and Assistance

Information on the following topics is included in this section.

- "Service and Support Options"
- "Calibration Options"
- "Contacting Agilent"
- "Shipping Your Analyzer to Agilent for Service or Repair"

Service and Support Options

The analyzer's standard warranty is a *one-year return to Agilent Technologies* service warranty.

NOTE There are many other repair and calibration options available from the Agilent Technologies support organization. These options cover a range of service agreements with varying response times. Contact Agilent for additional information on available service agreements for this product. Refer to "Contacting Agilent" on page 2-11.

Calibration Options

Option R-50C-001, Commercial Calibration with Data

This option adds a calibration label, a calibration certificate, and the corresponding calibration data on a 3.5-in floppy disk. This calibration conforms to ISO 9001.

This certificate and data can be obtained by sending your analyzer to Agilent for calibration along with an order for R-50C-001. Refer to "Shipping Your Analyzer to Agilent for Service or Repair".

Option R-50C-002, Standards Compliant Calibration

This option adds calibration label, a calibration certificate, and the corresponding calibration data, measurement uncertainties, and guardbands on all customer specifications on a CD-ROM. This calibration conforms to ISO 17025 and ISO 9001.

This certificate and data can be obtained by sending your analyzer to Agilent for calibration along with an order for R-50C-002. Refer to "Shipping Your Analyzer to Agilent for Service or Repair".

Contacting Agilent

Assistance with test and measurements needs and information on finding a local Agilent office are available on the Web at:

http://www.agilent.com/find/assist

If you do not have access to the Internet, please contact your Agilent field engineer.

NOTE In any correspondence or telephone conversation, refer to the Agilent product by its model number and full serial number. With this information, the Agilent representative can determine whether your product is still within its warranty period.

Shipping Your Analyzer to Agilent for Service or Repair

IMPORTANT Agilent Technologies reserves the right to reformat or replace the internal hard disk drive in your analyzer as part of its repair. This will erase all user information stored on the hard disk. It is imperative, therefore, that you make a backup copy of your critical test data located on the analyzer's hard disk before shipping it to Agilent for repair.

If you wish to send your network analyzer to Agilent Technologies for service or repair:

- Include a complete description of the service requested or of the failure and a description of any failed test and any error message.
- Ship the analyzer using the original or comparable antistatic packaging materials.
- Contact Agilent for instructions on where to ship your analyzer. Refer to "Contacting Agilent" on page 2-11.

3 Tests and Adjustments

Information in This Chapter

This chapter contains procedures to help you check, verify, and adjust your PNA series network analyzer.

- The checks verify the operation of the assemblies in your analyzer.
- The verification compares the operation of your analyzer to a gold standard.
- The adjustments allow you to tune your analyzer for maximum response.

Chapter Three at-a-Glance

| Section Title | Summary of Content | Start Page |
|---|--|------------|
| Before You Begin | Items to consider or procedures to perform before testing is begun: • Verify the Operating Environment • Protect Against Electrostatic Discharge (ESD) • Allow the Analyzer to Warm Up | Page 3-4 |
| | Review the Principles of Connector Care Descriptions of: | |
| About System Verification and Performance Tests | System Specifications Instrument Specifications System Verification Procedure Performance Tests Certificate of Calibration | Page 3-6 |
| ANSI/NCSL Z540–1–1994 Verification | The ANSI/NCSL Z540-1-1994 process of verifying your analyzer. | Page 3-8 |
| Non-ANSI/NCSL Z540–1–1994 Verification | The non-ANSI/NCSL Z540-1-1994 process of verifying your analyzer. | Page 3-9 |

NOTE A description of the performance tests in the Agilent N7840A software package is included in this chapter. The Agilent N7840A software package must be purchased separately.

| Section Title | Summary of Content | Start Page |
|--|---|------------|
| Preliminary Checks | Performing the operator's check. | |
| | Checking your test cables. | Page 3-10 |
| | Perform these checks before performing system verification. | |
| System Verification | What the system verification does. | |
| | How to perform the verification test. | Page 3-19 |
| | How to interpret the results. | |
| Option H11, IF Access, Operation Verification | How to verify the operation of Option H11, IF access. | Page 3-28 |
| Performance Tests (Agilent N7840A Software Package) ^a | A brief summary of each performance test in the Agilent N7840A software package: | Page 3-29 |
| | Source Power Accuracy Test | |
| | Source Power Linearity Test | |
| | Frequency Accuracy Test | |
| | Trace Noise Test | |
| | Receiver Compression Test | |
| | Noise Floor Test | |
| | Calibration Coefficient Test | |
| | System Crosstalk Test | |
| | Dynamic Accuracy Test | |
| Adjustments | Setups and procedures for adjusting your analyzer: | Page 3-43 |
| | • 10 MHz Frequency Reference Adjustment | |
| | LO Power Adjustment | |
| | LO Offset Adjustment | |
| | 3.8 GHz PMYO Frequency Adjustment | |
| | Source Calibration Adjustment | |
| | Receiver Calibration Adjustment | |

a. The Agilent N7840A software package must be purchased separately.

Before You Begin

Before checking, verifying, or adjusting the analyzer, refer to the following paragraphs to:

- make sure the operating environment is within its requirements
- make sure that proper electrostatic discharge (ESD) protection is provided
- make sure the analyzer has warmed up properly to achieve system stability
- review the principles of connector care

Verify the Operating Environment

Due to their operating specifications, the verification and calibration kit devices determine your operating environment conditions. Open the calibration and verification kits and place all the devices on top of the foam inserts so they will reach room temperature. As the device dimensions change with temperature, their electrical characteristics change as well. It is necessary to keep the environmental levels within the limits stated in the *PNA Series Installation and Quick Start Guide*, Chapter 3, located online at: http://cp.literature.agilent.com/litweb/pdf/E8356-90001.pdf

Protect Against Electrostatic Discharge (ESD)

This is important. If not properly protected against, electrostatic discharge can seriously damage your analyzer, resulting in costly repair.

CAUTION To reduce the chance of electrostatic discharge, follow all of the recommendations outlined in "Electrostatic Discharge Protection" on page 1-6, for all of the procedures in this chapter.

Allow the Analyzer to Warm Up

NOTE To achieve the maximum system stability, allow the analyzer to warm up for at least 90 minutes.

Review the Principles of Connector Care

Proper connector care and connection techniques are critical for accurate and repeatable measurements. Refer to Table 3-1 for tips on connector care.

Prior to making connections to your analyzer, carefully review the information about inspecting, cleaning, and gaging connectors. Refer to the calibration kit documentation for detailed connector care information.

For course numbers about additional connector care instruction, contact Agilent Technologies. Refer to "Contacting Agilent" on page 2-11.

| Handling and Storage | | | | | |
|----------------------|--|-----------|---|--|--|
| Do | • Keep connectors clean | Do Not | Touch mating-plane surfaces | | |
| | • Extend sleeve or connector nut | | • Set connectors contact-end down | | |
| | • Use plastic end-caps during storage | | • Store connectors or adapters loose | | |
| | Visual I | nspection | | | |
| Do | • Inspect all connectors carefully | Do Not | • Use a damaged connector - ever | | |
| | • Look for metal particles, scratches, and dents | | | | |
| | Connector Cleaning | | | | |
| Do | • Try compressed air first | Do Not | • Use any abrasives | | |
| | • Use isopropyl alcohol ^a | | • Get liquid into plastic support | | |
| | • Clean connector threads | | beads | | |
| | Gaging C | onnector | s | | |
| Do | • Clean and zero the gage before use | Do Not | • Use an out-of-specification | | |
| | • Use the correct gage type | | connector | | |
| | • Use correct end of calibration block | | | | |
| | • Gage all connectors before first use | | | | |
| Making Connections | | | | | |
| Do | • Align connectors carefully | Do Not | • Apply bending force to connection | | |
| | • Make preliminary connection contact lightly | | • Over tighten preliminary connection | | |
| | • Turn only the connector nut | | • Twist or screw any connection | | |
| | • Use a torque wrench for final connection | | • Tighten past torque wrench "break" point | | |

Table 3-1 Connector Care Quick Reference Guide

a. Cleaning connectors with alcohol shall only be done with the instrument's power cord removed, and in a well-ventilated area. Allow all residual alcohol moisture to evaporate, and the fumes to dissipate prior to energizing the instrument.

About System Verification and Performance Tests

The performance of the network analyzer is specified in two ways: system specifications, and instrument specifications. It is the end user's responsibility to determine which set of specifications is applicable to their use of the PNA.

A network analyzer measurement "system" includes the analyzer, calibration kit, test cables, and any necessary adapters. **The system verification software in the PNA is used to verify the system's conformance to the "system" specifications.** A "pass" result demonstrates that the analyzer, test cables, and adapters, perform correctly as a system. It DOES NOT demonstrate that any one component performs according to its individual specifications. A change to any part of this measurement system requires a re-verification of the system.

Instrument specifications specify the network analyzer's uncorrected measurement port characteristics and its output and input behavior. The PNA performance tests are used to verify the analyzer's conformance to "instrument" specifications.

System Specifications

System specifications specify warranted performance of the measurement system when making error-corrected measurements using the same calibration kit and test cables used during the system verification routine. System specifications are applicable only when the measurement system is used to make error-corrected measurements.

The analyzer's system specifications are described in the *Agilent PNA Series Network Analyzer Technical Specifications* and also in the analyzer's on-line help system in the section titled "Corrected System Performance".

System specifications are expressed in two ways:

- residual errors of the measurement system shown as tabular specification values
- graphs of measurement uncertainty versus reflection and transmission coefficients

System specifications are verified in one of the following ways:

- Complete the system verification procedure using a certified verification kit and certified calibration kit that will be used for future measurements, or
- Complete all of the performance tests using a certified calibration kit that will be used for future measurements. This alternative verifies both the system specifications and the instrument specifications for the analyzer.

Instrument Specifications

The analyzer's instrument specifications are described in the *Agilent PNA Series Network Analyzer Technical Specifications* and also in the analyzer's on-line help system in the sections titled "Uncorrected System Performance", "Test Port Output", and "Test Port Input".

These specifications apply when the analyzer is used to make either raw or error-corrected measurements.

System Verification Procedure

The system verification procedure tests the network analyzer measurement "system", as defined previously, against the system specifications. If confirmation is successful, the measurement system is capable of making measurements to the accuracy specified by the graphs of measurement uncertainty.

An illustrated outline of the system verification procedure:

- for ANSI/NCSL Z540-1-1994 verification, is shown in Figure 3-1 on page 3-8.
- for non-ANSI/NCSL Z540-1-1994 verification, is shown in Figure 3-2 on page 3-9.

Performance Tests

Performance tests are used to confirm analyzer performance against the "instrument" specifications. If confirmation is successful, the analyzer meets the instrument specifications.

Performance tests are contained in the N7840A Software Package and are described at "Performance Tests (Agilent N7840A Software Package)" on page 3-29.

Certificate of Calibration

Agilent Technologies will issue a certificate of calibration upon successful completion of system verification or completion of the performance tests. The certificate of calibration will apply to the "system" (analyzer, calibration kit, test cables, and any necessary adapters) if the system verification procedure is used to confirm the system specifications. If the performance tests are used to confirm instrument specifications, the certificate of calibration will apply to the PNA as an independent instrument. The equipment and measurement standards used for the tests must be certified and must be traceable to recognized standards.

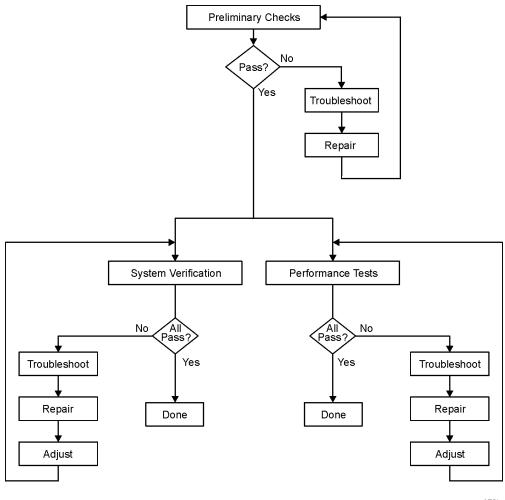
NOTE If you have a measurement application that does not use all of the measurement capabilities of the analyzer, you may ask your local Agilent Technologies service office to verify only a subset of the specifications. However, this "limited calibration" creates the possibility of making inaccurate measurements if you then use the analyzer in an application requiring additional capabilities.

NOTE Calibration kits are different from verification kits. Calibration kits are used to determine the systematic errors of a network analyzer measurement system. Verification kits are used to confirm system specifications and are not used to generate error correction.

ANSI/NCSL Z540–1–1994 Verification

To meet the criteria for ANSI/NCSL Z540-1-1994, perform the preliminary checks and either system verification or performance tests *without stopping to repair or adjust*¹. Refer to Figure 3-1 for test flow. Print data at the completion of all the tests, even if you are aware that the analyzer did not pass. If there is a failure, complete the verification before you troubleshoot, repair, and adjust. After the failure has been corrected, repeat the entire system verification or performance tests and generate a new set of data.

Figure 3-1 ANSI/NCSL Z540–1–1994 Test Path Verification Flowchart



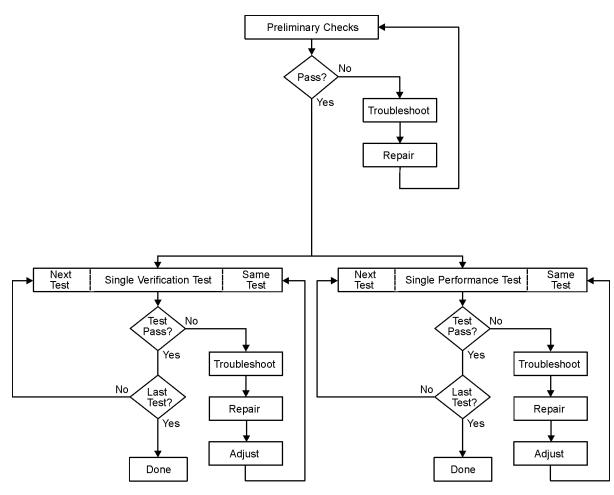
sc870b

^{1.} Stop only in case of a catastrophic failure or cable connector damage

Non-ANSI/NCSL Z540–1–1994 Verification

For non-ANSI/NCSL Z540-1-1994, perform the preliminary checks and either the system verification or performance tests while *stopping to troubleshoot*. Refer to Figure 3-2 for test flow. Troubleshoot and repair the first problem encountered without continuing to other tests. After you troubleshoot, repair, and adjust, repeat the *last failed* portion and generate a new set of data. Print out the system verification results or complete the performance test record as the analyzer passes each test.

Figure 3-2 Non-ANSI/NCSL Z540-1-1994 Test Path Verification Flowchart



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Preliminary Checks

Preliminary checks include the following:

• "The Operator's Check" on page 3-10

The operator's check tests the network analyzer's basic functionality of the source, switch, and receivers.

• "The Test Port Cable Checks" on page 3-12

The test port cable checks are not required, but are recommended to verify the performance of the test port cables before performing the verification test.

The Operator's Check

NOTE To achieve the maximum system stability, allow the analyzer to warm up for at least 90 minutes before performing the Operator's Check.

The operator's check is a software driven test that checks the basic operation of the assemblies in the Port 1 and Port 2 signal paths. By performing the operator's check, the following are determined:

- repeatability of the RF test port switch
- attenuation ranges of all installed attenuators
- calibration of the receivers
- frequency response of the receivers
- phase lock and leveling
- noise floor and trace noise

Accessories Used in the Operator's Check

| Equipment Type | Part Number |
|-----------------------|---|
| Female short, 1.85 mm | (any short from the 85058B calibration kit) |
| Female open, 1.85 mm | (any open from the 85058B calibration kit) |

Performing the Operator's Check

- 1. From the System menu, point to Service, and then click Operator's Check.
- 2. In the **PNA Operator's Check** dialog box (refer to Figure 3-3), under **Configure**, select either **Prompt for attachment of Short/Open**, to pause at each step in the process to allow moving the short/open to the appropriate port, or **Shorts/Opens are attached to ALL ports**, to run through the test without stopping. Shorts and opens can be mixed on the test ports.
- 3. Click Begin.
- 4. If shorts and opens are not connected to all ports, you will be prompted to connect them as they are needed.

5. The result of the operator's check will be shown as a PASS or FAIL next to each test (refer to Figure 3-3). The PNA Operator's Check dialog box will look different for different PNA model numbers and installed options. Some of the tests are performed only if the appropriate options are installed in the PNA.

🗹 Operator's Check - 🗆 X <u>H</u>elp <u>A</u>bout PNA Operator's Check Results Phase Lock Configure Prompt for attachment of Short/Open Agilent Leveling C Shorts/Opens are attached to ALL ports Revr Cal PNA-Model: E8364B Serial: US42060008 Rev: A.04.85 **Receivers** Options: 010,080,083,UNL,016,014,081,H11 Src Atten Connect either a Short or an Open to Port 1. To speed testing, and if available, you can connect a Short/Open to ALL ports now and select the proper configuration above. Rovr Atten Make sure the external loop jumpers are connected! Noise Floor Select 'Begin' when ready. Trace Noise <u>B</u>egin E<u>x</u>it X Fail -< \square Legend: Not Tested Pending Pass Pass

Figure 3-3 Operator's Check Dialog Box

If the Operator's Check Fails

- 1. Clean the test ports, shorts, and adapters. Torque connections to specification. Repeat the check.
- 2. If the check still fails, suspect a faulty component. Refer to "Measurement System Troubleshooting" on page 4-28 to begin troubleshooting to determine the faulty component.

The Test Port Cable Checks

A faulty test port cable can cause a failure in the verification test. The following checks are not required, but are recommended to verify the performance of the test port cable.

- "Cable Return Loss Check" on page 3-13
- "Cable Insertion Loss Check" on page 3-14
- "Cable Magnitude and Phase Stability Check" on page 3-15
- "Cable Connector Repeatability Check" on page 3-17

Accessories Used in the Test Port Cable Checks

| Equipment Type | Model or Part Number | Alternate Model or Part Number |
|--|-------------------------|-----------------------------------|
| Calibration kit, 1.85 mm | 85058B | 85058E |
| Test cable, 1.85 mm (f) to 1.85 mm (f) | N4697E | N4697-60200 |

Cable Return Loss Check

- 1. Press Preset.
- 2. Perform a one-port calibration on Port 1, **1-Port Reflection**. Refer to the embedded help in the analyzer if necessary.
- 3. Connect the test port cable to Port 1. Connect a broadband load to the other end of the cable. Tighten to the specified torque for the connector type.

The analyzer now displays the return loss of the cable.

- 4. From the Marker menu, click Marker Search. In the Marker Search dialog box, in the Search Type box, make sure Maximum is selected. Click Execute, and then click OK.
- 5. The marker annotation on the screen indicates the worst case return loss. Refer to the cable manual to see if it meets the return loss specification. For an example of a typical return loss measurement, see Figure 3-4.

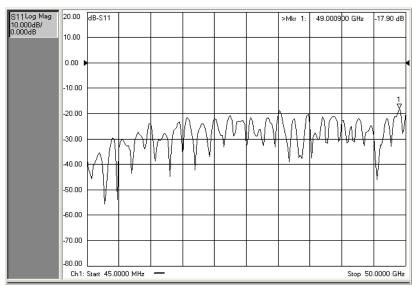


Figure 3-4 Typical Cable Return Loss Response

If the Cable Return Loss Check Fails

- 1. Clean the cable and devices and torque to specification. Repeat the check.
- 2. If the check still fails, the cable should be repaired or replaced.

Cable Insertion Loss Check

- 1. With the test port cable still connected to Port 1, connect a short to the other end of the cable.
- 2. From the Marker menu, click Marker Search. In the Marker Search dialog box, in the Search Type box, select Minimum. Click Execute, and then click OK.
- 3. The displayed response is twice the actual loss. To get the actual worst case insertion loss, divide the value at the marker annotation by two. Refer to the cable manual to see if it meets the insertion loss specification. For an example of a typical insertion loss measurement, see Figure 3-5.

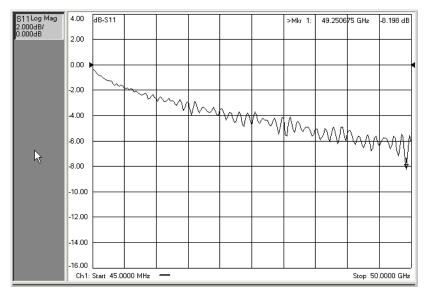


Figure 3-5 Typical Cable Insertion Loss Response

If the Cable Insertion Loss Check Fails

- 1. Clean the cable and devices and torque to specification. Repeat the check.
- 2. If the check still fails, the cable should be repaired or replaced.

Cable Magnitude and Phase Stability Check

- 1. With the test port cable still connected to Port 1, connect a short to the other end of the cable.
- 2. Press Preset.
- 3. On the **Trace** menu, click **New Trace**. In the **New Trace** dialog box, click the **S11** box, and then click **OK**.
- 4. On the **Trace** menu, click **Format**. In the **Format** dialog box, click **Phase**, and then click **OK**.
- 5. On the **Channel** menu, click **Average**. In the **Average** dialog box, click the **Average ON** check box. In the **Average Factor** box, type 50 or click the arrows to select 50, and then click **OK**.
- 6. To provide a good reference, hold the test cable in a straight line perpendicular to the front panel of the network analyzer.
- 7. On the **Channel** menu, click **Restart Avg**.
- 8. Wait for the analyzer to average the measurement 50 times (approximately two seconds).
- 9. To normalize the data trace:
 - a. On the **Trace** menu, click **Math/Memory**.
 - b. In the Math/Memory dialog box, click the Data->Memory button.
 - c. In the Data Math list, select Data/Memory.
 - d. Under Trace View Options, make sure Data Trace is selected.
 - e. Click $\boldsymbol{\mathsf{OK}}$
- 10. Slowly make a 180 degree bend in the middle of the cable and hold it in that position.
- 11. For each trace: On the **Scale** menu, set the **Scale Per Division** for optimum viewing as shown in Figure 3-6.
- 12. Place a marker on the largest deflection that goes above the reference line and is within the cable's specified frequency range. For a typical response of cable magnitude and phase stability, see Figure 3-6.
- 13. Place a marker on the largest deflection that goes below the reference line and is within the cable's specified frequency range.

In this S_{11} measurement, the displayed trace results from energy being propagated down the cable and reflected back from the short. Therefore, the measured deflection value must be divided in half to reach the correct value.

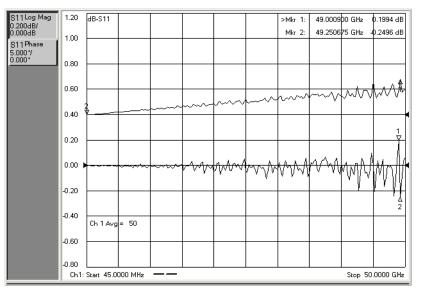


Figure 3-6 Typical Cable Magnitude and Phase Stability Response

If the Cable Magnitude and Phase Stability Check Fails

- 1. Clean the cable and devices and torque to specification. Repeat the check.
- 2. If the check still fails, the cable should be repaired or replaced.

Cable Connector Repeatability Check

| NOTE | The connector repeatability measurement should be done at the test port as |
|------|--|
| | well as at the end of the test port cable. |

- 1. With the test port cable still connected to Port 1, connect a broadband load to the other end of the cable.
- 2. Press Preset.
- 3. On the **Channel** menu, click **Average**. In the **Average** dialog box, click the **Average ON** check box. In the **Average Factor** box, type 100 or click the arrows to select 100. Click **OK**.
- 4. Wait for the analyzer to average the measurement 100 times (approximately five seconds).
- 5. To normalize the data trace:
 - a. On the Trace menu, click Math/Memory.
 - b. In the Math/Memory dialog box, click the Data->Memory button.
 - c. In the Data Math list, select Data/Memory.
 - d. Under Trace View Options, make sure Data Trace is selected.
 - e. Click $\boldsymbol{\mathsf{OK}}$
- 6. To adjust the display scale:
 - a. On the Scale menu, click Scale.
 - b. In the Scale Per Division box, click the arrow to select 0.5 dB.
 - c. In the **Level** box under **Reference** click the arrow to select 0 dB.
 - d. Click **OK**.
- 7. Disconnect and then reconnect the cable to the test port. Tighten the connection to the specified torque for the connector type.
- 8. On the Channel menu, click Restart Avg.
- 9. Look at the trace for spikes or modes.
- 10. To re-normalize the data trace of the reconnected cable:
 - a. On the Trace menu, click Math/Memory.
 - b. In the Math/Memory dialog box, click the Data->Memory button.
 - c. Click **OK**.
- 11. Repeat steps 7 through 9 at least three times to look for modes. Modes appear when a harmonic of the source fundamental frequency is able to propagate through the cable or connector. It is helpful to print a plot of the trace each time to compare several connections. If any mode appears each time the cable is connected and reconnected, measurement integrity will be affected.

For a typical response of cable connector repeatability, see Figure 3-7.

12. For the Port 2 Check, connect the cable (with the load attached) to Port 2 and repeat steps 2 through 11.

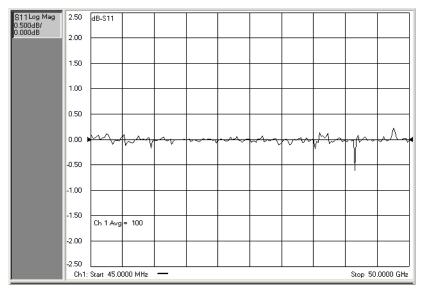


Figure 3-7 Typical Cable Connector Repeatability Response

If the Cable Connector Repeatability Check Fails

- 1. Clean the cable and devices, and torque to specification. Repeat the check.
- 2. If the check still fails, the cable should be repaired or replaced.

System Verification

System verification is used to verify system-level, error-corrected uncertainty limits for network analyzer measurements. The verification procedure is automated and is contained in the firmware of the analyzer.

The device data provided with the verification kit has a traceable path to a national standard. The difference between the supplied traceable data and the measured data must fall within the total uncertainty limits at all frequencies for the system verification to pass.

The total measurement uncertainty limits for the system verification are the sum of the factory measurement uncertainties for the verification devices and the uncertainties associated with the system being verified. You can determine your system measurement uncertainty limits by referring to the analyzer embedded on-line help.

IMPORTANT Passing this system verification does not guarantee that the analyzer meets all of its performance specifications. However, it does show that the network analyzer being verified measures the same devices with the same results as a factory system which has had all of its specifications verified and its total measurement uncertainty minimized.

What the System Verification Verifies

The system verification procedure verifies proper operation of the:

- network analyzer
- calibration kit
- test port cables

together as a "system". It DOES NOT verify that any of these components pass their specifications independently. The user is responsible for independently calibrating and verifying the proper operation of the calibration kit and test port cables prior to performing the system verification.

NOTE Additional equipment or accessories used with the above system are not verified by system verification.

Measurement Uncertainty

Measurement uncertainty is defined as the sum of:

- the residual systematic (repeatable) errors, and
- the random (non-repeatable) errors

in the measurement system after calibration.

The systematic errors are:

- directivity,
- source match,
- load match,
- reflection and transmission frequency tracking, and
- isolation (crosstalk).

The random errors include:

- noise,
- drift,
- connector repeatability, and
- test cable stability.

A complete description of system errors and how they affect measurements is provided in the analyzer's on-line embedded help.

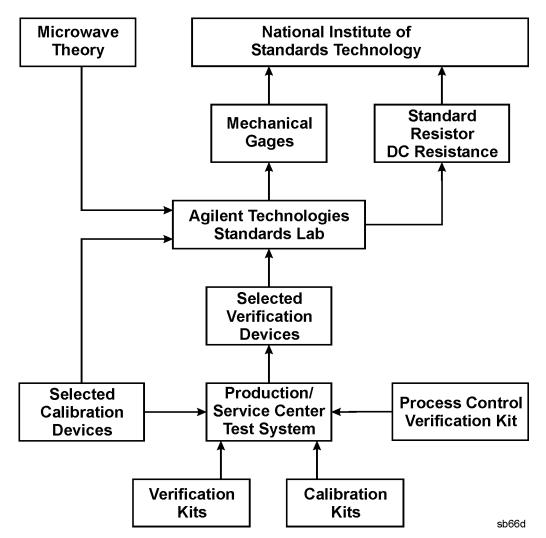
Any measurement result is the vector sum of the actual test device response plus all error terms. The precise effect of each error term depends on its magnitude and phase relationship to the actual test device response. When the phase of an error response is not known, phase is assumed to be worst-case (-180° to $+180^{\circ}$). Random errors such as noise and connector repeatability are generally combined in a root-sum-of-the-squares (RSS) manner.

Measurement Traceability

To establish a measurement traceability path to a national standard for a network analyzer system, the overall system performance is verified through the measurement of devices that have a traceable path. This is accomplished by measuring the devices in an Agilent verification kit.

The measurement of the devices in the verification kit has a traceable path because the factory system that measured the devices is calibrated and verified by measuring standards that have a traceable path to the National Institute of Standards and Technology (NIST) (see Figure 3-8). This chain of measurements defines how the verification process brings traceability to the network analyzer system.

Figure 3-8 NIST Traceability Path for Calibration and Verification Standard



Performing System Verification

The following verification procedure is automated by the analyzer firmware. For each verification device, the analyzer reads a file from the verification disk and sequentially measures the magnitude and phase for all four S-parameters.

| IMPORTANT | For system verification to perform correctly, it is NECESSARY that the verification devices be measured with their female connectors connected to Port 1 and their male connectors connected to Port 2. |
|-----------|--|
| NOTE | The following procedure, and the connection prompts given, assumes only one female-to-female cable connected to Port 2. However, this procedure can also be performed with the addition of a female-to-male cable connected to Port 1. |
| NOTE | Although the performance for all four S-parameters are measured, the S_{11} and S_{22} phase uncertainties for the attenuators and airlines are less important for verifying system performance. Therefore, the limit lines will not appear on the printout. |

Equipment Used in the System Verification Procedure

| Equipment Type | Model or Part Number | Alternate Model or Part Number |
|--|-------------------------|-----------------------------------|
| Calibration kit, 1.85 mm | 85058B | 85058E |
| Verification kit, 1.85 mm | E8058V | None |
| Test cable, $1.85 \text{ mm} (f)$ to $1.85 \text{ mm} (f)$ | N4697E | N4697-60200 |

Cable Substitution

The test port cables specified for the network analyzer system have been characterized for connector repeatability, magnitude and phase stability with flexing, return loss, insertion loss, and aging rate. Since test port cable performance is a significant contributor to the system performance, cables of lower performance will increase the uncertainty of your measurement. Refer to the plots in the cable tests (earlier in this chapter) that show the performance of good cables. It is highly recommended that the test port cables to be regularly tested.

If the system verification is performed with a non-Agilent cable, ensure that the cable meets or exceeds the specifications for the test cable specified in the above table, "Equipment Used in the System Verification Procedure." Refer to the cable's user's guide for specifications.

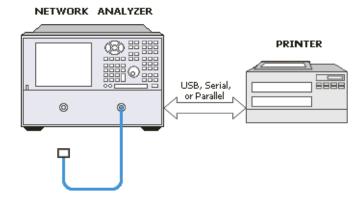
Kit Substitution

Non-Agilent calibration kits and verification kits are not recommended nor supported.

System Verification Procedure

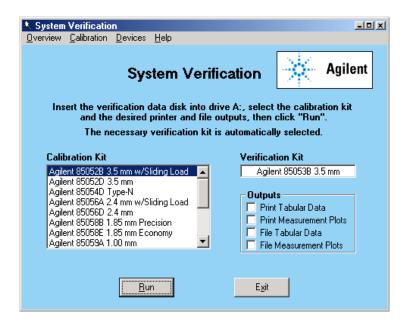
1. Connect a cable to the analyzer as shown in Figure 3-9. If you desire printed test outputs, connect a printer to the analyzer. For the printer, ensure that the correct driver is loaded and the printer is defined as the default printer. Refer to the embedded help in the analyzer for printer setup. Let the analyzer warm up for at least 90 minutes.

Figure 3-9 System Verification Test Setup



- 2. Insert the verification kit disk into the analyzer disk drive.
- 3. On the System menu, point to Service, and then click System Verification. The System Verification dialog box is displayed; refer to Figure 3-10.

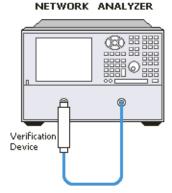
Figure 3-10 System Verification Dialog Box



- 4. In the **Calibration Kit** box, select the calibration kit that is being used by clicking on it. The corresponding verification kit to use is selected for you and displayed in the **Verification Kit** box. Refer to Figure 3-10.
- 5. Under Printer Output, click one of the following options. Refer to Figure 3-10.
 - None: No printout of results.
 - **Tabular Data**: Prints the verification data in tabular form which includes measured data and uncertainty limits. For an example, refer to Figure 3-13 on page 3-26.
 - **Measurement Plots**: Prints the verification data in graphical form. The graphical form includes the measured data trace, factory supplied data trace, and uncertainty limits. For an example, refer to Figure 3-14 on page 3-27.
 - **Both**: Prints the verification data in both formats.
- NOTEFor printed output, it is assumed that the printer has been tested and the
Windows 2000 driver is installed for the printer that is being used. The
system verification test prints to the printer that has been designated as the
default printer. (On the Windows Desktop display, click on My Computer,
Control Panel, and then Printers to verify the printer setup.)
- 6. Click Run.
- 7. Follow the instructions on the analyzer for performing a full 2-port calibration.
- 8. After completion of the full 2-port calibration, follow the instructions on the analyzer for performing the system verification.

For the system verification, insert the devices as shown in Figure 3-11.

Figure 3-11 System Verification Device Connections

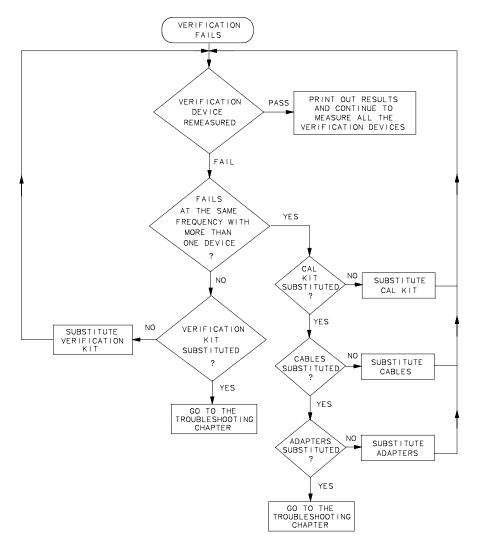


If the System Fails the Verification Test

IMPORTANT Inspect all connections. *Do not* remove the cable from the analyzer test port. This *will invalidate* the calibration that you performed earlier.

- 1. Disconnect and clean the device that failed the verification test.
- 2. Reconnect the device making sure that all connections are torqued to the proper specifications.
- 3. Measure the device again.
- 4. If the analyzer still fails the test, check the measurement calibration by viewing the error terms as described in "Accessing Error Terms" on page A-6.
- 5. Refer to Figure 3-12 for additional troubleshooting steps.

Figure 3-12 System Verification Failure Flowchart



sb69d

Interpreting the Verification Results

Figure 3-13 shows an example of typical verification results with **Tabular Data** selected in the **Printer Output** area of the **System Verification** dialog box.

At the top of the printed output is the name of the device, the serial number of the device, and the date tested.

Each S-parameter measurement result is printed with frequency tested, lower and upper limit lines, the measured data, and the result of the test.

Figure 3-13 Example of Printed Tabular Verification Results

Sys Ver -- 20 dB attenuator magnitude results, Serial #00810 -- 6 Sep 2000

| S11 Results | | | | |
|-------------|--------------|---------------|--------------|--------|
| Frequency | Lower Limit | Measured Data | Upper Limit | Result |
| 0.3 MHz | 0.0048 Units | 0.0090 Units | 0.0139 Units | PASS |
| 100 | 0.0046 | 0.0091 | 0.0137 | PASS |
| 200 | 0.0042 | 0.0092 | 0.0134 | PASS |
| 300 | 0.0040 | 0.0091 | 0.0133 | PASS |
| 400 | 0.0038 | 0.0089 | 0.0131 | PASS |
| 500 | 0.0036 | 0.0087 | 0.0129 | PASS |
| 600 | 0.0034 | 0.0085 | 0.0127 | PASS |
| 700 | 0.0031 | 0.0082 | 0.0125 | PASS |
| 800 | 0.0029 | 0.0080 | 0.0122 | PASS |
| 900 | 0.0026 | 0.0079 | 0.0119 | PASS |
| 1000 | 0.0023 | 0.0075 | 0.0117 | PASS |
| 1100 | 0.0020 | 0.0072 | 0.0114 | PASS |
| 1200 | 0.0017 | 0.0068 | 0.0111 | PASS |
| 1300 | 0.0013 | 0.0064 | 0.0107 | PASS |
| 1400 | -0.0006 | 0.0059 | 0.0118 | PASS |
| 1500 | -0.0011 | 0.0052 | 0.0113 | PASS |
| 1600 | -0.0015 | 0.0044 | 0.0108 | PASS |
| 1700 | -0.0020 | 0.0038 | 0.0103 | PASS |
| 1800 | -0.0026 | 0.0032 | 0.0097 | PASS |
| 1900 | -0.0031 | 0.0024 | 0.0091 | PASS |
| 2000 | -0.0036 | 0.0019 | 0.0085 | PASS |
| 2100 | -0.0045 | 0.0016 | 0.0082 | PASS |
| 2200 | -0.0050 | 0.0018 | 0.0077 | PASS |
| 2300 | -0.0054 | 0.0023 | 0.0073 | PASS |
| 2400 | -0.0052 | 0.0031 | 0.0075 | PASS |
| 2500 | -0.0048 | 0.0039 | 0.0080 | PASS |
| 2600 | -0.0040 | 0.0050 | 0.0087 | PASS |
| 2700 | -0.0032 | 0.0060 | 0.0094 | PASS |
| 2800 | -0.0024 | 0.0071 | 0.0103 | PASS |
| 2900 | -0.0014 | 0.0082 | 0.0113 | PASS |
| 3000 | -0.0004 | 0.0095 | 0.0124 | PASS |

Overall PASS/FAIL result for entire frequency range = PASS

Figure 3-14 shows an example of typical verification results with **Measurement Plots** selected in the **Printer Output** area of the **System Verification** windows. The printed graphical results show the following:

- the name of the device measured
- the serial number of the device
- the parameters measured
- Results of the measurements. Labeled as A in Figure 3-14.
- Data measured at the factory from the verification kit. Labeled as B in Figure 3-14.
- Upper and lower limit points as defined by the total system uncertainty system. Labeled as C in Figure 3-14.

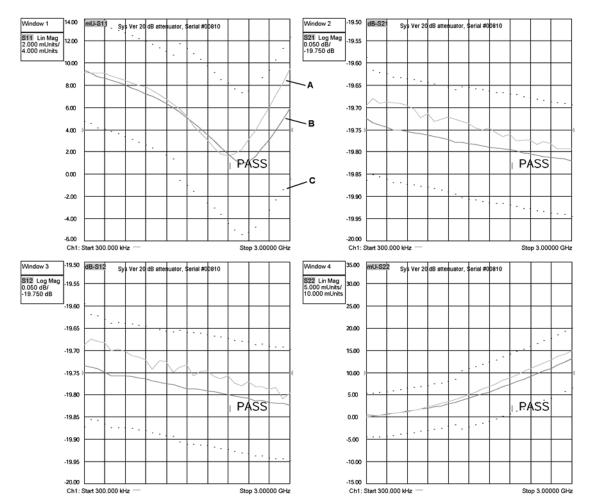


Figure 3-14 Example of Printed Graphical Verification Results

Option H11, IF Access, Operation Verification

To verify that the Option H11, IF Access, is functioning properly:

- 1. Download and install the verification program from the Web:
 - a. Go to website: http://na.tm.agilent.com/pna/support/.
 - b. Download file: H11VerifyInstall.exe to the C:\ drive on the PNA.
 - c. After the file has finished loading, double click on the filename. At this point the file will self-extract and load into its default file location. Allow this process to complete, uninterrupted.
- 2. Create (if necessary) a macro for the verification program:
 - a. On the analyzer's **System** menu, point to **Macro**. If a macro named **H11Verify** is present in the list, proceed to step 3. If not, continue here to create the macro.
 - b. Click Macro Setup.
 - c. In the **Macro Setup** window, click on the first blank line in the list (the next line after the last entry). Click **Edit**.
 - d. In the Edit Macro Setup window, enter H11Verify as the Macro Title.
 - e. Click Browse.
 - f. In the Open window, navigate to Network Analyzer/Service/H11Verify.exe. Click Open. This places the H11Verify.exe filename in the Macro Executable box in the Macro Setup window.
 - g. In the Macro Setup window, click OK.
 - h. The macro should now be entered in the list in the Macro Setup window.
 - i. Click **OK**.
- 3. Run the H11Verify macro:
 - a. On the analyzer's System, Macro menu, click H11Verify.

Performance Tests (Agilent N7840A Software Package)

The Agilent N7840A software package verifies the electrical performance of your E8361A PNA series microwave network analyzer. The software automatically configures your analyzer to execute the performance tests. The N7840A software package is not included with the analyzer; it must be ordered separately. The model numbers of the equipment used are specified under "Required Service Test Equipment" on page 2-7.

There are nine tests in the software package:

- Source Power Accuracy Test
- Source Maximum Power Output Test
- Source Power Linearity Test
- Frequency Accuracy Test
- Trace Noise Test
- Receiver Compression Test
- Noise Floor Test
- Calibration Coefficient Test
- System Crosstalk Test
- Dynamic Accuracy Test

IMPORTANT The descriptions of these tests are provided here as a convenience only. These tests are subject to change at any time. As a result of such change, the descriptions provided here may no longer be accurate. Refer to the N7840A product itself for the latest, most accurate descriptions of the tests.

Source Power Accuracy Test

Function of the Test: To confirm the accuracy of the source output power of your network analyzer over its full frequency range.

Specification Tested: Test Port Output-Power Level Accuracy

Equipment Used: A power meter, power sensors, and adapters.

Description of the Test:

- 1. The analyzer's output power level is set to 0 dBm.
- 2. A power sensor is connected to Port 1.
- 3. The output power is measured at hundreds of CW frequencies across the analyzer's frequency range and the values compared to the setting of 0 dBm.

- Perform the "Source Calibration Adjustment" on page 3-50 and repeat this test.
- If the analyzer still fails this test, replace the source assembly and repeat this test. Refer to "Removing and Replacing the A12 Source 20" on page 7-22.

Source Maximum Power Output Test

Function of the Test: To confirm the maximum source output power of your network analyzer over its full frequency range.

Specification Tested: Test Port Output-Maximum Leveled Power

Equipment Used: A power meter, power sensors, and adapters.

Description of the Test:

- 1. A power sensor is connected to Port 1.
- 2. The analyzer's output is set to hundreds of CW frequencies and, at each frequency, the output power is increased until an "UNLEVELED" error is detected.
- 3. The power level at this point is measured and compared to the maximum output power specification.

If the Analyzer Fails this Test:

• Go to "Checking the Signal through the Signal Separation Path" on page 4-48 for troubleshooting information to determine the faulty assembly.

Source Power Linearity Test

Function of the Test: To verify that the power level is linear over the analyzer's frequency range and to check the linearity of the automatic leveling control (ALC).

Specification Tested: Power Sweep Range and Power Level Linearity

Equipment Used: A test cable. (And a 20 dB attenuator if the analyzer does not have an internal step attenuator.)

Description of the Test:

- 1. The Port 2 receiver is used to test Port 1. The receiver linearity is the standard against which the source linearity is checked.
- 2. A test cable is connected between Port 1 and Port 2 with 20 dB of attenuation in series with the cable. This can be done with an internal step attenuator or an external 20 dB attenuator. This attenuation ensures that the receiver remains in its linear range.
- 3. The analyzer is set to 25 different points across its frequency range.
- 4. At each frequency point, the output power level on Port 2 is set to 0.000 dBm and the power is measured to establish a reference, P_{reference}.
- 5. The source setting is then stepped from -15 to +10 dBm in 1 dB steps and the power is measured, $P_{measured}$, at each setting.
- 6. The non-linearity in dB at each frequency point is calculated as:

(P_{measured} – P_{reference}) – (source setting)

- Perform the "Source Calibration Adjustment" on page 3-50 and repeat this test.
- If the analyzer still fails this test, replace the source assembly and repeat this test. Refer to "Removing and Replacing the A12 Source 20" on page 7-22.

Frequency Accuracy Test

Function of the Test: To verify the frequency accuracy and range of the analyzer's source output.

Specification Tested: Test Port Output-CW Accuracy

Equipment Used: A frequency counter, a test cable, and adapters.

Description of the Test:

- 1. Port 1 is connected to a frequency counter.
- 2. A series of frequencies across the band are checked.

If the Analyzer Fails this Test:

- Verify the accuracy of the 10 MHz OCXO by connecting a frequency counter to the rear-panel 10 MHz REF OUT.
- If the 10 MHz reference is off by more than 10 Hz, perform the "10 MHz Frequency Reference Adjustment" on page 3-44 and also the "3.8 GHz PMYO Frequency Adjustment" on page 3-45 and repeat this test.

Trace Noise Test

Function of the Test: To measure the stability of a signal in the internal source and receiver system of your analyzer.

Specification Tested: Test Port Input–Trace Noise Magnitude and Trace Noise Phase

Equipment Used: A test cable.

Description of the Test:

- 1. Port 1 and Port 2 are connected with a test cable.
- 2. The analyzer is set to a series of CW frequencies across its frequency range.
- 3. Magnitude and phase are measured at each frequency at a 1 kHz IF bandwidth, in both directions.
- 4. All measurements are made at a nominal power level of 0 dBm and with 201 points per sweep.

- Repeat this test. It is unlikely for the analyzer to fail this test without a complete failure of the network analyzer system.
- If the analyzer still fails this test, perform the "Receiver Calibration Adjustment" on page 3-53 and repeat this test.

Receiver Compression Test

Function of the Test: To measure the compression at the analyzer's specified maximum power level for the receivers.

Specification Tested: Test Port Input–Maximum Test Port Input Level

Equipment Used: The compression test set (Z5623A Option K01), a power meter, power sensors, two test cables, and a calibration kit. (And 10-dB and 20-dB pads if the analyzer does not have an internal step attenuator.)

Description of the Test:

- 1. All measurements are made with a 1 kHz IF bandwidth and 201 points per sweep.
- 2. The measurements are made separately on each port.
- 3. The analyzer is set to various CW frequencies across the range of the analyzer.
- 4. A power sensor is connected to the "signal source point" to be used to test the port. The "signal source point" may be either the port connector itself, when a short is used, or the end of the test cable, when the compression test set is used to source the test signal.
- 5. The analyzer source output level is adjusted to create the maximum power level specified for the receiver.
- 6. The power sensor is disconnected and the "signal source point" is connected to the port to be tested.
- 7. The absolute log magnitude value (dBm) for the reference channel on the port is read.
- 8. The log magnitude ratioed measurement using the receiver under test is read: (P_a) .
- 9. The source output level is adjusted to decrease the output by 15 dB.
- 10. The log magnitude ratioed measurement using the receiver under test is read: (P_b) .
- 11. Attenuation of 20 dB is introduced between the source and receiver. This can be done with an internal step attenuator, an external 10 dB pad (if a short is being used to reflect the signal back into the port), or an external 20 dB pad (if the signal source is the compression test set).
- 12. The log magnitude ratioed measurement using the receiver under test is read: (P_c) .
- 13. The source output level is adjusted to produce a reading of Pref (within ± 0.03 dBm) for the reference channel on the source port.
- 14. The log magnitude ratioed measurement using the receiver under test is read: (P_d) .
- 15. The compression in $dB = (P_a P_b) (P_d P_c)$.

- Repeat this test. There are no adjustments that can be made.
- Since all four receivers are identical, the suspect failed receiver can be swapped with one of the other receivers to verify that it is faulty. Swap the suspect receiver and repeat this test. Refer to "Removing and Replacing the A31–A34 Receiver Modules and A49 IF Multiplexer Board" on page 7-50.
- If the faulty channel "follows" the receiver, replace the receiver. If the same channel (now with a different receiver) is still faulty, suspect the associated cabling.

Noise Floor Test

Function of the Test: To measure the absolute power level of the noise floor for the analyzer's receivers.

Specification Tested: Test Port Input-Test Port Noise Floor

Equipment Used: A power meter, power sensor, a calibration kit, and a test cable.

Description of the Test:

- 1. The analyzer is set to various CW frequencies across its frequency range at an IF bandwidth of 1 kHz and 801 points per sweep.
- 2. A test cable is connected to the driving port for the measurement and a power sensor is connected to the other end of the cable.
- 3. The power level at the end of the cable is set to -5.00 dBm.
- 4. The power sensor is disconnected and the cable is connected to the port to be tested.
- 5. The absolute power level in dBm (log magnitude) is read: (P_{log}) .
- 6. The test cable is removed and loads are connected to both ports.
- 7. The analyzer's trace is set to represent the absolute power level (linear magnitude) for the receiver under test and a sweep is taken.
- 8. The mean of the points on the trace, in watts, is read: (P_{lin}) .
- 9. Average power in dBm is calculated: $P_{dBm}=10*Log10(P_{lin}*1000)$.
- 10. Corrected noise floor in dBm for a 10 Hz IF bandwidth = P_{dBm} -19.96 dB-(5.00- P_{log}).

- A failure of this test indicates a failure of one or more of the following assemblies.
 - A31 channel A receiver
 - A34 channel B receiver
 - A6 SPAM board
- Since all four receivers are identical, the channel A and channel B receivers can be swapped with the channel R1 and channel R2 receivers to determine if they are the cause of the failure. Refer to "Removing and Replacing the A31–A34 Receiver Modules and A49 IF Multiplexer Board" on page 7-50. After swapping the receivers, repeat this test.
- If the analyzer still fails this test, replace the A6 SPAM board and repeat this test. Refer to "Removing and Replacing the A6, A8, A9, and A10 Boards" on page 7-18.

Calibration Coefficient Test

Function of the Test: To verify the uncorrected calibration coefficients of your analyzer. The calibration coefficients are measured in forward and reverse direction. Refer to Appendix A, "Error Terms," for error term information relating to the calibration coefficients measured.

Specification Tested: Uncorrected System Performance

Equipment Used: A calibration kit and a test cable.

Description of the Test:

- 1. A series of 2-port calibrations are performed. Two full SOLT 2-port calibrations are performed on each port. Isolation is turned off during each 2-port calibration.
- 2. A test cable is attached to the first port, and a calibration is performed at the end of the cable and at the second port. The cable is moved to the second port and another calibration is performed. Using two calibrations helps to eliminate the unknown characteristics of the through cable.
- 3. Each calibration produces 12 error terms.
- 4. The error terms are used to determine the following characteristics: directivity, source match, load match, reflection tracking, and transmission tracking.

- If the analyzer fails tracking error terms only, perform "Receiver Calibration Adjustment" on page 3-53 and repeat this test.
- Failure of any other error terms indicate a hardware failure. Refer to the appropriate error term discussion in Appendix A, "Error Terms," for a typical cause of failure. Refer to Chapter 7, "Repair and Replacement Procedures," for instructions on replacing the suspected faulty component or assembly.

System Crosstalk Test

Function of the Test: To measure the signal leakage between the analyzer's test ports.

Specification Tested: Test Port Input–Crosstalk

Equipment Used: A calibration kit and a test cable.

Description of the Test:

- 1. The analyzer is tested in both directions at various frequency segments.
- 2. The analyzer sweep is set for the desired frequency and number of points at a 10 Hz IF bandwidth. The power level is set to the lesser of either the maximum specified power level for the driving port or the maximum input power level for the receiving port.
- 3. A test cable is connected between the driving and receiving ports.
- 4. The analyzer is set for a ratioed through measurement (S21 for example) with log magnitude display and a sweep is taken and stored to memory (MEM).
- 5. The trace is set to data divided by memory (DATA/MEM).
- 6. The test cable is removed and shorts are placed on both ports.
- 7. The average of 16 sweeps is taken.
- 8. The resultant log magnitude trace represents the system crosstalk in dB for the frequency range or segment tested.

- A failure of this test usually indicates one of the following:
 - a loose cable connection
 - degradation of signal isolation in the receivers
 - degradation of signal isolation on the A35 receiver motherboard
- Remove the covers from the analyzer and tighten all test cable connections and tighten all screws on the receivers and repeat this test. Refer to "Removing and Replacing the A31–A34 Receiver Modules and A49 IF Multiplexer Board" on page 7-50 for instructions on how to remove the covers and for illustrations of the cable and screw locations.
- If the analyzer still fails this test, replace the receiver associated with the port that is failing and repeat this test. Refer to "Removing and Replacing the A31–A34 Receiver Modules and A49 IF Multiplexer Board" on page 7-50.
- If the analyzer still fails this test, replace the A35 receiver motherboard and repeat this test. Refer to "Removing and Replacing the A35 Receiver Motherboard" on page 7-52.

Dynamic Accuracy Test

Function of the Test: To measure the relative power linearity of the analyzer's receivers.

Specification Tested: Test Port Input–Dynamic Accuracy

Equipment Used: The dynamic accuracy test set (Z5623A Option H01), a power meter (E4418B or E4419B Option G12 or Option H12)¹, power sensors, and two test cables.

Description of the Test:

- 1. The analyzer's test ports are tested separately at a specific CW frequency and a reference power level of -20 dBm.
- 2. The analyzer's driving port is connected to the dynamic accuracy test set's source port and the analyzer's receiving port is connected to the dynamic accuracy test set's receiver port. A power sensor is connected to the dynamic accuracy test set's power meter port.
- 3. The dynamic accuracy test set is used to input a signal from the driving port on the analyzer. The input signal is routed through step attenuators to both the analyzer and a power sensor.
- 4. The analyzer source and the dynamic accuracy test set create power levels that are "deltas" from the reference power level of -20 dBm. Each delta is measured two ways: by the power sensor and by the analyzer's receiver under test.
- 5. The analyzer's power level into the port under test is set to the -20 dBm reference level.
- 6. The power level is measured with the power sensor: (P_{mr}) .
- 7. The power level is measured using the analyzer's receiver under test: (P_{pr}).
- 8. The power level into the analyzer's port under test is stepped, in 5 dB steps, over the range of 0 to −120 dBm. Each power level represents a "delta" from the reference power level.
- 9. At each step, the power level is measured using the power meter: (P_{md}) .
- 10. At each step, the power level is measured using the receiver under test: (P_{pd}) .
- 11. The power error in $dB = (P_{mr}-P_{md})-(P_{pr}-P_{pd})$.

This test requires a higher accuracy power meter than standard. Refer to "Required Service Test Equipment" on page 2-7 for specifications. If an Option G12 or H12 power meter is not available, refer to the "Power Meter Accuracy Test" on page 3-38 to verify the accuracy of a standard power meter.

- A failure of this test indicates a failure of one or more of the following assemblies.
 - A31 channel A receiver
 - A34 channel B receiver
 - A6 SPAM board
- Since all four receivers are identical, the channel A and channel B receivers can be swapped with the channel R1 and channel R2 receivers to determine if they are the cause of the failure. Refer to "Removing and Replacing the A31–A34 Receiver Modules and A49 IF Multiplexer Board" on page 7-50. After swapping the receivers, repeat this test.
- If the analyzer still fails this test, replace the A6 SPAM board and repeat this test. Refer to "Removing and Replacing the A6, A8, A9, and A10 Boards" on page 7-18.

Power Meter Accuracy Test

This test is intended for power meters used in testing the PNA series network analyzers. The "Dynamic Accuracy Test" requires the use of a power meter that has been calibrated to a higher accuracy than the standard power meter.

Power meters with options G12 and H12 specify an improved instrumentation accuracy over a limited power range. (These power meters do not contain unique hardware.) A power meter may be returned to the factory to have one of these options added to an existing power meter or to renew the calibration for one of these options.

This test procedure is an alternative to returning the power meter to the factory. When a power meter passes this test, it is considered to be *calibrated* for the G12 or H12 option even though it has not been returned to the factory.

This test procedure is available on the Internet as a separate document, Agilent Part Number E8356-90051. The on-line document may have a more recent print date. Refer to "Contacting Agilent" on page 2-11 for the Internet address (URL).

EPM Series Power Meters That Can Be Tested Using This Procedure

This procedure assumes that the recommended model number power meter is being tested. The alternate model numbers can be tested but the necessary procedural steps may differ.

| Recommended Model Number | | Alternate Model Numbers |
|---|--|---|
| E4419B | | E4418A/B, E4419A, EPM-441A, EPM-442A |
| NOTE It is recommended that the revision number for the power meter "Ma Firmware" be Ax.03.00 or higher. This applies to all power meter more numbers listed above (both recommended and alternate). | | e" be Ax.03.00 or higher. This applies to all power meter model |

Equipment Used for the Power Meter Accuracy Test

| Equipment Type | Recommended Model or Part Number | Alternate Model or Part Number |
|--|-------------------------------------|--|
| Range calibrator | 11683A | None |
| Precision digital voltmeter | 3458A | Any with the required accuracy and resolution ^a |
| Power sensor cable | 8120-8319, 11730A | Any equivalent |
| Cable, BNC, 50Ω | Any | Any |
| Adapter for connecting BNC cable to DVM inputs | Any | Any |

a. Required accuracy and resolution at the following voltage levels:

| 14 mV input: | 0.0100% accuracy | 10 nV resolution |
|----------------|------------------|-------------------|
| 0.140 V input: | 0.0050% accuracy | 100 nV resolution |
| 0.450 V input: | 0.003% accuracy | 100 nV resolution |

Description of the Test

The power meter accuracy is verified for various power inputs and the actual readings are recorded in a test record. A range calibrator is used to provide the reference inputs.

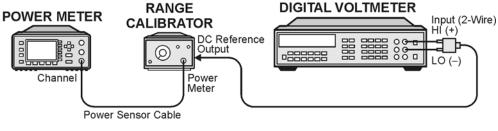
| NOTE | It is recommended that a copy of the test record on page 3-42 be made, and |
|------|--|
| | the values be recorded on the copy, thus preserving the original for future use. |

Test Procedure

| NOTE | This procedure assumes the use of the recommended equipment model |
|------|---|
| | numbers. The actual steps required, therefore, may differ for other model |
| | numbers of equipment used. |

- 1. Setup the equipment as shown in Figure 3-15:
 - a. Connect the DC REFERENCE OUTPUT connector on the rear panel of the range calibrator to the DVM voltage input.
 - b. Connect the POWER METER output of the range calibrator to the input of the power meter being tested.
 - c. Switch on the power to the power meter, the range calibrator, and the digital voltmeter.

Figure 3-15 Setup for the Power Meter Accuracy Test



- st410a
- 2. Preset the power meter: Press [Preset/Local], then Confirm.
- 3. Perform the following steps for each channel on the power meter:
 - a. Set to read in dBm: Press [dBm/W], then dBm.
 - b. Set the ref cal factor to 100%: Press [Zero/Cal], Cal, A/B Ref CF, then set to 100.0, if necessary.
 - c. Set the cal factor to 100%: Press [Frequency/Cal Fac], A/B Cal Fac, then set to 100.0, if necessary.
 - d. Set readout to 0.001 dBm: Press **[Meas Setup]**, then **Resolution 1 2 3 4**, to highlight **4**.
 - e. Set filter step detect on and filter length to 512: Press **[System/Inputs]**, channel **A** or **B Input Settings**, **[More]**, **Ch A/B Filter**, **Step Det On**, **Filter On**, **Mode MAN**, **Length**, then set the filter length to **512**.

- 4. Setup the digital voltmeter (DVM) as follows:
 - a. Reset the DVM: Press the **blue key** followed by **Reset**.
 - b. Set the sample period to a value greater than one second: Press **NPLC**, **5**, **0**, then **Enter**.
- 5. Set the range calibrator controls as follows:

| POLARITY | NORMAL |
|----------|-----------|
| RANGE | 1 mW |
| FUNCTION | CALIBRATE |

- 6. Allow the equipment to warm up for approximately 30 minutes. Do not change any connections or control settings during this time.
- 7. Zero and calibrate the power meter channel to which the range calibrator is connected:
 - a. The range calibrator's RANGE switch should be set to 1 mW.
 - b. Set the range calibrator's FUNCTION switch to STANDBY.
 - c. Press **[Zero/Cal]**, then **Zero A** or **Zero B** (as appropriate). Wait for the operation to complete.
 - d. Set the range calibrator's FUNCTION switch to CALIBRATE.
 - e. Press **[Zero/Cal]**, **Cal**, then **Cal A** or **Cal B** (as appropriate). Wait for the operation to complete.
- 8. Monitor the drift rate of the power meter reading: Five minutes following calibration, the meter must read 0.001, 0.000, or -0.001 dBm. If the power meter reading is not one of these values, allow additional warm up time, then check the drift rate again. The range calibrator must remain connected to the power meter during this warm up time.
- 9. Zero and calibrate the power meter channel to which the range calibrator is connected:

NOTE After a channel on the power meter is calibrated, do not allow more than 5 minutes to elapse before completing the remaining measurement steps for that channel.

- a. The range calibrator's RANGE switch should be set to 1 mW.
- b. Set the range calibrator's FUNCTION switch to STANDBY.
- c. Press **[Zero/Cal]**, then **Zero A** or **Zero B** (as appropriate). Wait for the operation to complete.
- d. Set the range calibrator's FUNCTION switch to CALIBRATE.
- e. Press **[Zero/Cal]**, **Cal**, then **Cal A** or **Cal B** (as appropriate). Wait for the operation to complete.

10. Record the DVM voltage reading as value A in the test record on page 3-42.

| NOTE | All DVM readings in this procedure should be recorded showing five |
|------|--|
| | significant digits. |

11. The reading on the power meter should be 0.000 \pm 0.001 dBm.

- 12. Switch the range calibrator RANGE to 300 μ W.
- 13. Record the DVM voltage reading as value B in the test record.
- 14. Wait for the power meter reading to settle (no settling drift within 20 seconds).
- 15. Record the power meter reading as value C in the test record.
- 16. Switch the range calibrator RANGE to 100 $\mu W\!.$
- 17. Record the DVM voltage reading as value D in the test record.
- 18. Wait for the power meter reading to settle (no settling drift within 20 seconds).
- 19. Record the power meter reading as value E in the test record.
- 20. If testing a dual-channel power meter, perform steps 7 through 19 for the other channel.
- 21. Perform the pass/fail calculations indicated on the test record.
- **NOTE** If a channel of the power meter does not pass this test, the power meter cannot be used in applications that require Option G12 or H12. There are no adjustments that can be performed to improve the performance of the power meter. Typically, replacing the A6 measurement assembly associated with the failed channel will correct the problem.

| TEST RECORD FOR POWER METER ACCURACY TEST | | | | |
|---|----------------------|------------------------------|----------------------|------------------------------|
| Power Meter Tested: Model No.: | | Serial No: | | |
| Date: | | Tested by: | | |
| | ſ | Fest Equipment | Used | |
| Range Calib | rator: Model No.: | 11683A | Serial No.: | |
| Digital Voltn | neter: Model No.: | | Serial No.: | |
| | | Test Results | s | |
| Range | Chan | nel A | Chan | nel B |
| Calibrator Setting | DVM Reading (Vdc) | Power Meter Reading (dBm) | DVM Reading (Vdc) | Power Meter Reading (dBm) |
| $1 \mathrm{mW}$ | A = | 0.000 ± 0.001 | A = | 0.000 ± 0.001 |
| 300 μW | B = | C = | B = | C = |
| 100 μW | D = | E = | D = | E = |
| | Ι | Pass/Fail Calcula | ations | |
| | R = B/A = | | R = B/A = | |
| | $S = 10^{(C/10)} =$ | | $S = 10^{(C/10)} =$ | |
| 300 μW | % ERROR = ((R-S)/R | 2) × 100 = % | % ERROR = $((R-S)/R$ | 2) × 100 = % |
| | Limits: ±0.13% | | Limits: ±0.13% | |
| | Pass | Fail | Pass | Fail 🗌 |
| | T = D/A = | | T = D/A = | |
| | $U = 10^{(E/10)} =$ | | $U = 10^{(E/10)} =$ | |
| 100 µW | % ERROR = ((T-U)/T | ") × 100 = % | % ERROR = ((T-U)/T | ") × 100 = % |
| | Limits: ±0.10% | | Limits: ±0.10% | |
| | Pass | Fail 🗌 | Pass | Fail |

Adjustments

These adjustments are firmware-driven tests that are used to fine-tune your analyzer for optimum response.

If multiple adjustments are to be performed, perform them in the order listed.

- "10 MHz Frequency Reference Adjustment" on page 3-44
- "3.8 GHz PMYO Frequency Adjustment" on page 3-45
- "LO Power Adjustment" on page 3-46
- "LO Offset Adjustment" on page 3-48
- "Source Calibration Adjustment" on page 3-50
- "Phase Lock IF Gain Adjustment" on page 3-52
- "Receiver Calibration Adjustment" on page 3-53

10 MHz Frequency Reference Adjustment

The 10 MHz frequency adjustment is used to adjust the frequency accuracy of the network analyzer's 10 MHz frequency reference on the A10 frequency reference board assembly.

Equipment Used for the Frequency Adjustment at 10 MHz

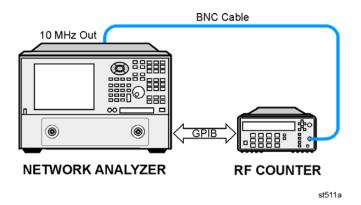
| Equipment Type | Model or Part Number | Alternate Model or Part Number |
|--------------------------|-------------------------|-----------------------------------|
| Cable, BNC, 50Ω, 24 inch | 8120-1839 | Any |
| Frequency counter | 53151A, Option 001 | Any ^a |

a. Must be capable of measuring a signal at 10 MHz.

Procedure

- **NOTE** The specification of frequency accuracy is ± 1 ppm. However, this test typically adjusts to ± 0.01 ppm.
- 1. Connect the equipment as shown in Figure 3-16. Connect a GPIB cable between the network analyzer and the frequency counter.

Figure 3-16 Setup for Adjustment of the 10 MHz Frequency Reference



- 2. On the System menu, point to Service, Adjustments, and then click 10 MHz Freq Adjust.
- 3. Ensure the GPIB settings are correct.
- 4. Click **Begin Adj**, and then follow the instructions as they are displayed.

3.8 GHz PMYO Frequency Adjustment

The 3.8 GHz adjustment is used to adjust the frequency accuracy of the network analyzer's 3.8 GHz permanent-magnet YIG oscillator (PMYO) on the A12 source 20.

| Equipment used for the Freque | ency Adjustment at 3.8 GHz |
|--------------------------------------|----------------------------|
|--------------------------------------|----------------------------|

| Equipment Type | Model or Part Number | Alternate Model or Part Number |
|---|-------------------------|-----------------------------------|
| Spectrum analyzer | 8565E | 856xE ^a |
| Test cable, 1.85 mm (f) to 1.85 mm (f) | N4697E | N4697-60200 |
| Adapter, Type-N (m) to 2.4 mm $(m)^b$ | 11903A | None |

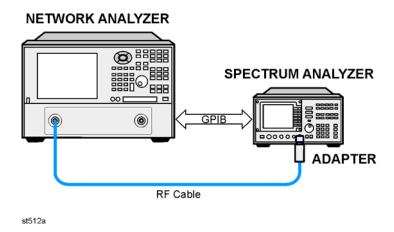
a. Must be capable of measuring a signal at 3.8 GHz.

b. The 1.85 mm connector has the same ruggedness and is compatible with the 2.4 mm connectors. 1.85 mm and 2.4 mm adapters are interchangeable.

Procedure

1. Connect the equipment as shown in Figure 3-17. Connect a GPIB cable between the network analyzer and the spectrum analyzer.

Figure 3-17 Setup for Adjustment of the 3.8 GHz PMYO



On the System menu, point to Service, Adjustments, and then click
 3.8 GHz Freq Adjust.

- 3. Ensure the GPIB settings are correct.
- 4. Click **Begin Adj**, and then follow the instructions as they are displayed.

LO Power Adjustment

The LO power adjustment is used to adjust the power level of the LO signals from the A20 LO distribution assembly. This adjustment is done for only one LO output. The differences between each LO output is negligible; therefore, separate adjustments are not required.

| Equipment used for th | e LO Power Adjustment |
|-----------------------|-----------------------|
|-----------------------|-----------------------|

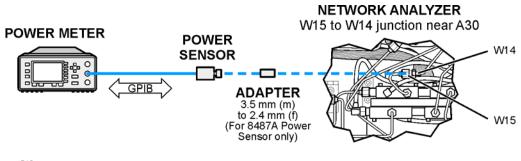
| Equipment Type | Model or Part Number | Alternate Model or Part Number |
|--|-------------------------|-----------------------------------|
| Power meter | E4418B/E4419B | E4418A/E4419A |
| Power sensor, 2.4 mm | 8487A | E4413A ^a |
| Adapter, 3.5 mm (m) to 2.4 mm (f) | 11901D | 1111011 |
| 5/16 inch, open-end torque wrench (set to 10 in-lbs) | 8710-1765 | N/A |
| 1/4 inch, open-end wrench, thin profile | 8710-0510 | N/A |

a. The E4413A 3.5 mm power sensor may be used instead of the 8487A power sensor and 11901D adapter.

Procedure

- 1. Turn off the network analyzer and remove the power cable and other external cables from the rear panel.
- 2. Remove the outer cover. Refer to "Removing the Covers" on page 7-6.
- 3. Place the analyzer on its side to allow access to the bottom of the analyzer.
- 4. Connect the equipment as shown in Figure 3-18. Connect a GPIB cable between the analyzer and the power meter.
- 5. With a 5/16 inch open-end wrench, loosen W15 at the first converter (mixer).
- 6. At the junction of W15 and W14, place a 5/16 inch wrench on the W15 connector and a 1/4 inch wrench on the W14 connector. While holding the 1/4-in wrench to prevent W14 from rotating, disconnect W15 from W14 and move W15 aside.
- 7. Connect the power sensor to the end of W14, as shown in Figure 3-18.

Figure 3-18 Setup for the LO Power Adjustment



st510a

- 8. Reconnect the power and USB cables. Turn on the analyzer.
- 9. On the System menu, point to Service, Adjustments, and then click LO Power Adjust.
- 10. Ensure the GPIB settings are correct.
- 11. Click **Begin Adj**, and then follow the instructions as they are displayed.
- 12. Turn off the analyzer, disconnect the power cable, reconnect the semi-rigid cables, and replace the covers.

LO Offset Adjustment

The LO power adjustment is used to adjust the power level of the LO signals from the A20 LO distribution assembly. This adjustment is done for only one LO output. The differences between each LO output is negligible; therefore, separate adjustments are not required.

| Equipment used for the L | LO Offset Adjustment |
|--------------------------|----------------------|
|--------------------------|----------------------|

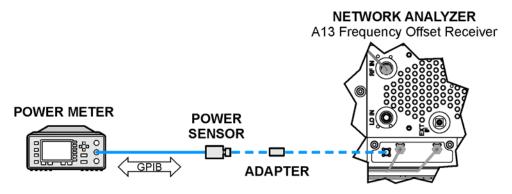
| Equipment Type | Model or Part Number | Alternate Model or Part Number |
|---|-------------------------|-----------------------------------|
| Power meter | E4418B/E4419B | E4418A/E4419A |
| Power sensor, 2.4 mm | 8487A | E4413A ^a |
| Adapter, 3.5 mm (m) to 2.4 mm (f) | 11901D | Lillon |
| Adapter, SMA (m) to SMA (f), right angle | 1250-1249 | Equivalent |
| 5/16 inch, open-end torque wrench (set to 10 in-lbs) | 8710-1765 | N/A |

a. The E4413A 3.5 mm power sensor may be used instead of the 8487A power sensor and 11901D adapter.

Procedure

- 1. Turn off the network analyzer and remove the power cable and other external cables from the rear panel.
- 2. Remove the outer cover. Refer to "Removing the Covers" on page 7-6.
- 3. Connect a GPIB cable between the analyzer and the power meter.
- 4. Remove the semi-rigid cable connected to J3 LO OUT and the RECEIVER LO IN on the A13 frequency offset receiver assembly.
- 5. Connect the right angle adapter to A13 LO OUT connector.

Figure 3-19 Setup for the LO Offset Adjustment



st510b

- 6. Connect the power sensor 8487A and the 11901D adapter or the E4413A power sensor to the end of the right angle adapter as shown in Figure 3-18 on page 3-46.
- 7. Reconnect the power and USB cables. Turn on the analyzer.
- 8. On the System menu, point to Service, Adjustments, and then click LO Power Adjust.
- 9. Ensure the GPIB settings are correct.
- 10. Click **Begin Adj**, and then follow the instructions as they are displayed.
- 11. Turn off the analyzer, disconnect the power cable, reconnect the semi-rigid cables, and replace the covers.

Source Calibration Adjustment

The source calibration is used to adjust your network analyzer for a flat source power across its full frequency range. There are differences between Port 1 and Port 2; therefore, a Port 2 adjustment is required.

| Equipment Type | Model or Part Number | Alternate Model or Part Number |
|---|-------------------------|-----------------------------------|
| Power meter | E4418B/E4419B | E4418A/E4419A |
| Power sensor, Type-N | 8482A | None |
| Power sensor, 2.4 mm | 8487A | None |
| Power sensor, V-Band ^a | V8486A | None |
| Adapter ^a , WR-15 to 1.85 mm (m) | V281B | None |
| Adapter, 1.85 mm (f) to 1.85 mm (f) | 85058-60114 | None |
| Adapter, 2.4 mm (f) to 2.4 mm (f) | 11900B | 85056-60007 |
| Adapter, Type-N (f) to 2.4 mm $(f)^b$ | 11903B | None |

Equipment Used for the Source Calibration Adjustment

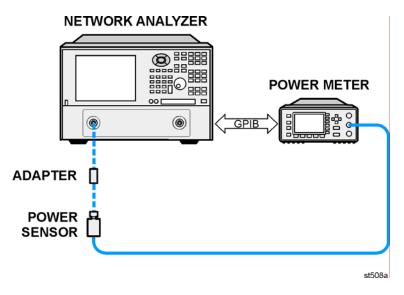
a. This sensor and adapter must be calibrated together by the Agilent factory. The data supplied is only valid as long as the sensor and adapter remain connected.

b. The 1.85 mm connector has the same ruggedness and is compatible with the 2.4 mm connectors. 1.85 mm and 2.4 mm adapters are interchangeable.

Procedure

1. Connect the equipment as shown in Figure 3-20. Connect a GPIB cable between the network analyzer and the power meter.

Figure 3-20 Setup for the Source Calibration Adjustment



- 2. On the System menu, point to Service, Adjustments, and then click Source Calibration.
- 3. Ensure the GPIB settings are correct.
- 4. Click **Calibrate**, and then follow the instructions as they are displayed.

Phase Lock IF Gain Adjustment

The phase lock IF gain adjustment is used to adjust the phase-lock loop IF signal amplitude to a constant level across the analyzer's full frequency range:

- 1. No additional equipment is required for this adjustment.
- 2. No connections to the test ports are required for this adjustment.

Procedure

- 1. On the System menu, point to Service, Adjustments, and then click IF Gain Adjustment.
- 2. If appropriate, select any special test options installed. Otherwise, leave this selection at **None**. The **Advanced** screen is for factory use only.
- 3. Click Begin Adj.
- 4. The adjustment takes approximately one minute to complete.

Receiver Calibration Adjustment

The receiver calibration is used to adjust the network analyzer receivers for a flat response across its full frequency range:

- 1. A power meter/sensor is connected to Port 1, as shown in Figure 3-21, to establish a reference for flatness.
- 2. A cable is inserted between the power sensor and the test port, as shown in Figure 3-22, to establish a reference for the cable.
- 3. The same cable is connected between the two test ports, as shown in Figure 3-23, and a signal from Port 1 is used to adjust the "B" receiver at Port 2.

The adjustment is repeated using a signal from Port 2 to adjust the "A" receiver at Port 1.

Data obtained during this adjustment are stored in the mxcalfile_pxx files on the hard disk drive (where xx is a 1 or 2 digit number). The data are used in subsequent measurements.

If the hard disk drive is replaced, these mxcalfile_pxx files will be lost. Therefore, they should be backed up (saved on a floppy disk) so that they can be restored. If using multiple disk drives (e.g. classified and general usage), then these files must be replaced on each individual disk drive.

These files can be recreated by performing another receiver calibration adjustment.

| Equipment Type | Model or Part Number | Alternate Model Part Number |
|--|-------------------------|--------------------------------|
| Power meter | E4418B/E4419B | E4418A/E4419A |
| Power sensor, Type-N | 8482A | None |
| Power sensor, 2.4 mm | 8487A | None |
| Power sensor, V-Band ^a | V8486A | None |
| Adapter ^a WR-15 to 1.85 mm (m) | V281B | None |
| Adapter, 2.4 mm (f) to 2.4 mm (f) | 11900B | 85056-60007 |
| Adapter, Type-N (f) to 2.4 mm (f) ^b | 11903B | None |
| Adapter, 1.85 mm (f) to 1.85 mm (f) | 85058-60114 | None |
| Test cable, 2.4 mm (f) to 2.4 mm (f) | 85133C | 85133E |
| Test cable 1.85 mm (f) to 1.85 mm (f) | N4697E | N4697-60200 |

Equipment Used for the Receiver Calibration Adjustment

a. This sensor and adapter must be calibrated together by the Agilent factory. The data supplied is only valid as long as the sensor and adapter remain connected.

b. The 1.85 mm connector has the same ruggedness and is compatible with the 2.4 mm connectors. 1.85 mm and 2.4 mm adapters are interchangeable.

Service Guide E8361-90001

Procedure

1. Connect the equipment as shown in Figure 3-21. Connect a GPIB cable between the network analyzer and the power meter.

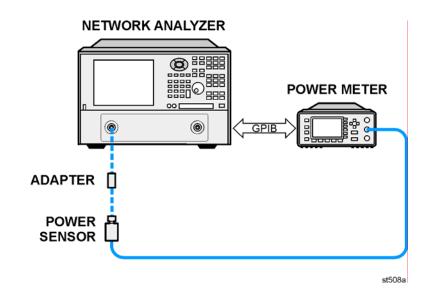


Figure 3-21 Setup 1 for the Receiver Calibration Adjustment

- 2. On the System menu, point to Service, Adjustments, and then click Receiver Calibration.
- 3. Ensure the GPIB settings are correct.
- 4. Click **Calibrate**, and then follow the instructions as they are displayed.

Figure 3-22 Setup 2 for the Receiver Calibration Adjustment

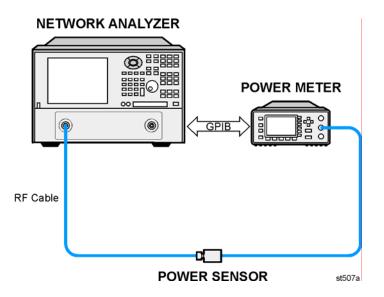
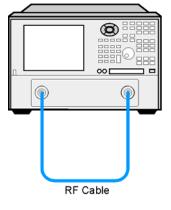


Figure 3-23 Setup 3 for the Receiver Calibration Adjustment

NETWORK ANALYZER



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4 Troubleshooting

Information in This Chapter

The information in this chapter helps you:

- Identify the portion of the analyzer at fault.
- Locate the specific troubleshooting procedure to identify the assembly or peripheral at fault.

The sections in this chapter are arranged in a logical troubleshooting order. The following table lists the sections and a brief summary of what to look for in that section.

Chapter Four at-a-Glance

| Section Title | Summary of Content | Start Page |
|---|---|------------|
| 'Getting Started with Troubleshooting' | A starting point to begin troubleshooting. | Page 4-4 |
| 'Power Up Troubleshooting' | Power-up problems: Power supply problems LCD problems Bootup for the network analyzer interface | Page 4-6 |
| 'Front Panel Troubleshooting' | Problems occurring after the network analyzer interface is loaded: Does the display color appear correct? Do the front panel keys function properly? Does the front panel USB connector function properly? | Page 4-17 |
| 'Rear Panel Troubleshooting' | Problems associated with the rear panel interconnects. The data found at these rear panel interconnects can be used to troubleshoot the CPU board. | Page 4-21 |
| 'Measurement System Troubleshooting' | Problems with the measurement portion of the analyzer. Checking the A, B, R1, and R2 signals. Checking the source group. Checking the receiver group. Checking the signal separation group. Checking the frequency offset group (options 080 and 081). | Page 4-28 |
| Instrument Block Diagrams | Block diagrams for the analyzer including all options. | Page 4-59 |

Protect Against Electrostatic Discharge (ESD)

This is important. If not properly protected against, electrostatic discharge can seriously damage your analyzer, resulting in costly repair.

CAUTION To reduce the chance of electrostatic discharge, follow all of the recommendations outlined in "Electrostatic Discharge Protection" on page 1-6, for all of the procedures in this chapter.

Assembly Replacement Sequence

After identifying the problem requiring an assembly to be replaced, follow these steps:

- Step 1. Order a replacement assembly. Refer to Chapter 6, "Replaceable Parts."
- **Step 2.** Replace the faulty assembly and determine what adjustments are necessary. Refer to Chapter 7, "Repair and Replacement Procedures."
- Step 3. Perform the necessary adjustments. Refer to Chapter 3, "Tests and Adjustments."
- **Step 4.** Perform the necessary performance tests. Refer to Chapter 3, "Tests and Adjustments."

Getting Started with Troubleshooting

Where you begin troubleshooting depends upon the symptoms of the failure. Start by checking the basics as outlined in the following section. Also review the flowchart in Figure 4-1 on page 4-5. You should then be able to determine where in the troubleshooting procedure to begin, to locate the failed assembly.

Check the Basics

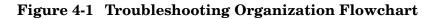
A problem can often be solved by repeating the procedure you were following when the problem occurred. Before calling Agilent Technologies or returning the instrument for service, please perform the following checks:

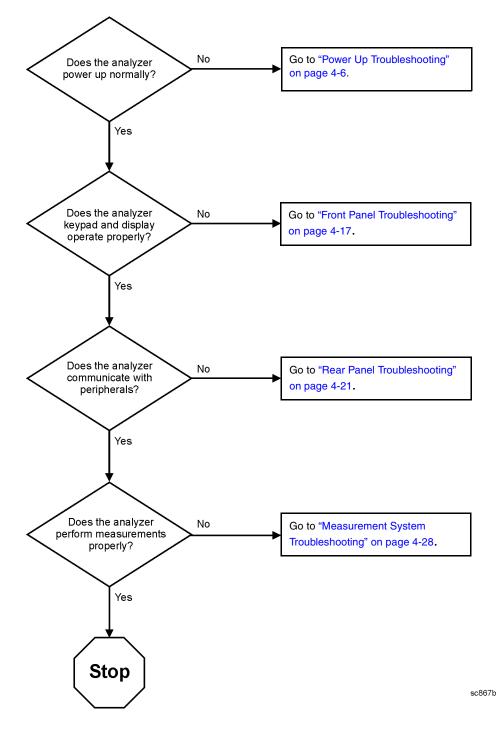
- 1. Is there power at the mains receptacle? If not, correct this situation and proceed.
- 2. Is the instrument turned on? Check to see if the front panel line switch glows. This indicates the power supply is on. If the front panel line switch is on but the power supply does not appear to be on, go to "Power Up Troubleshooting" on page 4-6.
- 3. Is the Windows® operating system running? If not, refer to Appendix D, "Operating System Recovery," for instructions.
- 4. If other equipment, cables, and connectors are being used with the instrument, make sure they are clean, connected properly and operating correctly.
- 5. Review the procedure for the measurement being performed when the problem appeared. Are all the settings correct? If not, correct them.
- 6. If the instrument is not functioning as expected, return the unit to a known state by pressing the **Preset** key.
- 7. Is the measurement being performed, and the results that are expected, within the specifications and capabilities of the instrument? Refer to the embedded help in the analyzer for instrument specifications.
- 8. If the problem is thought to be due to firmware, check to see if the instrument has the latest firmware before starting the troubleshooting procedure. Refer to Appendix C, "Firmware Upgrades," for instructions.
- 9. If the necessary test equipment is available, perform the operator's check and system verification in Chapter 3, "Tests and Adjustments."

Windows® is a U.S. registered trademark of Microsoft Corporation.

Troubleshooting Organization

Follow the flowgraph in Figure 4-1 to help direct you to the correct section for troubleshooting the analyzer.





Power Up Troubleshooting

WARNING Immediately unplug the instrument from the ac power line if the unit shows any of the following symptoms:

- Smoke, arcing, or unusual noise from inside the analyzer.
- A circuit breaker or fuse on the main ac power line opens.

Check your network analyzer for evidence that it is powering up correctly. Perform the following steps and make sure that the analyzer is displaying correct behavior as noted in the following steps.

- **Step 1.** Disconnect all peripherals and plug in the network analyzer. Before the analyzer is powered on, the line switch should glow yellow and no other lights should be on.
- **Step 2.** Turn on the network analyzer.
 - The line switch should glow green.
 - The fans should be audible.
 - The display should flash and then show the hardware boot-up sequence. This process checks the RAM and communication with the hard disk drive. These checks return an error message if a problem is detected.
 - The Windows 2000 operating system should start.
 - The network analyzer measurement interface should open with an S_{11} measurement displayed.
- **Step 3.** If the analyzer powers up correctly, continue troubleshooting with "Front Panel Troubleshooting" on page 4-17.
- **Step 4.** If the analyzer does not power up correctly, follow these troubleshooting steps:
 - If the line switch does not glow or the fans are not operating (audible), go to "Power Supply Check" on page 4-7.
 - If you cannot hear the fans operating, go to "If the Fans Are Not Operating" on page 4-12.
 - If the line switch glows green and the fans are operating (audible), but the display remains dark, go to "Troubleshooting LCD Display Problems" on page 4-13.
 - If the instrument appears to abort the network analyzer measurement interface process, contact Agilent. Refer to "Contacting Agilent" on page 2-11.

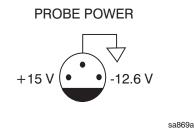
Power Supply Check

NOTE There are no fuses to replace within the power supply. If you determine that the power supply is the failed assembly, replace the power supply.

A catastrophic failure in the power supply can be determined by observing the line switch, and by measuring the probe power at the front-panel Probe Power connectors:

- 1. Ensure that the instrument is plugged in with the power switch in the standby position (power not switched on). Verify that the line switch glows yellow. A line switch that glows yellow indicates that the +15 VDC line (P15 STB) is providing enough voltage to light the LED. (The actual voltage may not be +15 VDC.)
- 2. Turn on the instrument power and verify that the line switch glows yellow. When the line switch glows, it is an indication that the power supply has received an "ON" command and that the +5.2 VDC supply can supply enough current to light, at least, these lamps.
- 3. The front-panel probe power-connector can be used to check the +15 VDC and -12.5 VDC (-15 VDC) supplies. The -12.5 VDC is produced by post regulating the -15 VDC supply. Refer to Figure 4-2 for a diagram of the probe power connector.

Figure 4-2 Probe Power Connector



If all of these supply voltages are missing, it is likely that the problem is either a defective A4 power supply, or another assembly is loading down the A4 power supply. Continue with "If All Supply Voltages Are Missing" on page 4-10, to determine the cause of the problem.

If the line switch is lit correctly, and the probe power voltages measure within the specifications listed in Table 4-1 on page 4-9, the power supply has not suffered a catastrophic failure; however, the power supply could still be at fault. Continue with the next section to measure the individual voltage supplies.

Measure the Individual Voltage Supplies

WARNING The instrument contains potentially hazardous voltages. Refer to the safety symbols provided on the instrument and in "General Safety Considerations" on page 1-3 before operating the unit with the cover removed. Make sure that the safety instructions are strictly followed. Failure to do so can result in personal injury or loss of life.

To measure the power supply voltages, it is necessary to remove the instrument's outer and inner covers. Refer to "Removing the Covers" on page 7-6 for removal procedures. Use the E8356-60021 extender board to measure the individual power supply voltages. Insert the extender board into an empty slot next to the A6 signal processing ADC module (SPAM) board.

NOTE If any one individual voltage supply from the A4 power supply develops an over-voltage or over-current problem, all supplies are affected. The supply goes into a "burp" mode characterized by the supplies cycling on and off at a low voltage level. The cause of the over-voltage or over-current condition can be the A4 power supply itself, or any assembly to which the A4 power supply provides voltage. To isolate the cause of "burp" mode, continue to the assembly removal process as described in the section titled "If All Supply Voltages Are Missing" on page 4-10.

On the extender board, measure the power supply voltages using a digital voltmeter. Refer to Figure 4-3 for the power supply test points on the extender board. Use the point marked "GND" for the ground connection. Refer to Table 4-1 on page 4-9 for the correct voltages.

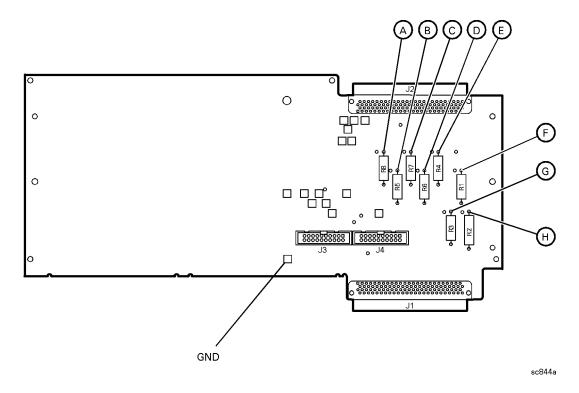


Figure 4-3 E8356-60021 Synthesizer/Reference Extender Measurement Points

 Table 4-1
 Extender Board Measurement Points

| Measurement Location | Signal Description | Test Equipment Used ^a | Expected Level (Vdc) |
|-------------------------|--------------------|----------------------------------|-------------------------|
| Α | power supply | DVM | +5.0 |
| В | power supply | DVM | -15.0 |
| С | power supply | DVM | -5.0 |
| D | power supply | DVM | +9 |
| Е | power supply | DVM | +15 |
| F | power supply | DVM | +15 |
| G | power supply | DVM | +22 |
| Н | power supply | DVM | +32 |

a. DVM = Digital volt meter

If All Supply Voltages are Present

If all of the supplies have measured within tolerances, and the instrument still is not functioning properly, refer to "Rear Panel Troubleshooting" on page 4-21.

If All Supply Voltages Are Missing

WARNING Disconnect the line-power cord before removing any assembly. Procedures described in this document may be performed with power supplied to the product while protective covers are removed. Energy available at many points may, if contacted, result in personal injury or loss of life.

It is necessary to sequentially remove all of the assemblies, taking care to disconnect the line-power cord before each removal, and then to measure the supply voltages after each removal.

If the missing supply voltages return to a "power on" condition after removal of an assembly, suspect that assembly as being defective.

Remove the network analyzer assemblies in the order specified in the following steps (refer to Chapter 7 for removal instructions).

- 1. Unplug the test set motherboard cable from the A16 test set motherboard (refer to "Removing and Replacing the A16 Test Set Motherboard" on page 7-30).
- 2. Unplug the front panel interface cable from the A3 front panel interface board (refer to "Removing the A3 Front Panel Interface Board" on page 7-12).
- 3. Remove the A6 SPAM board (refer to "Removing and Replacing the A6, A8, A9, and A10 Boards" on page 7-18).
- 4. Remove the A8 fractional-N synthesizer board (refer to "Removing and Replacing the A6, A8, A9, and A10 Boards" on page 7-18).
- 5. Remove the A9 fractional-N synthesizer board (option 080) (refer to "Removing and Replacing the A6, A8, A9, and A10 Boards" on page 7-18)
- 6. Remove the A10 frequency reference board (refer to "Removing and Replacing the A6, A8, A9, and A10 Boards" on page 7-18).
- 7. Remove the A11 phase lock board (refer to "Removing and Replacing the A11 Phase Lock Board" on page 7-20).
- 8. Unplug the A30 floppy disk drive from the A14 system motherboard (refer to "Removing and Replacing the A27–A30 First Converters (Mixers) and Mixer Bias Board" on page 7-48).
- 9. Unplug the A31 hard disk drive from the A15 CPU board (refer to "Removing and Replacing the A31–A34 Receiver Modules and A49 IF Multiplexer Board" on page 7-50).

The minimum required assemblies to power up the analyzer are:

- A4 power supply
- A14 system motherboard
- A15 CPU board

To further isolate the failure in the three remaining assemblies, measure the resistance on the extender board (with the power turned off) from the power supply test points to "GND". Refer to Figure 4-3 on page 4-9. The voltages should be as shown in Table 4-2.

| NOTE | Make sure that the only assemblies plugged in are the three minimum |
|------|---|
| | required assemblies listed above. |

Check for shorts (zero Ω) or very low resistance (approximately 1 Ω). If a short or low resistance is measured, isolate each of the remaining three boards in the following order, and recheck the shorted test point after each board is removed. Note that the resistance may be different from that listed in the table, but you should be able to determine if the shorted condition has changed.

Isolate the remaining three assemblies:

- remove the A15 CPU board
- remove the A4 power supply
- This leaves only the A14 system motherboard installed. If the measurements are still incorrect, this is the suspected faulty assembly.

| Measurement Location | Supply (Vdc) | Approximate Resistance (Ω) | | |
|-------------------------|-----------------|--|--|--|
| А | +5.0 | 285 | | |
| В | -15.0 | 12.7 k | | |
| С | -5.0 | 7.2 k | | |
| D | +9 | 4.0 k | | |
| E | +15 | 3.0 k | | |
| F | +22 | 2.8 k | | |
| G | +22 | 890 | | |
| Н | +32 | 2.6 k | | |

 Table 4-2
 Power Supply Voltages and Resistances

If the Fans Are Not Operating

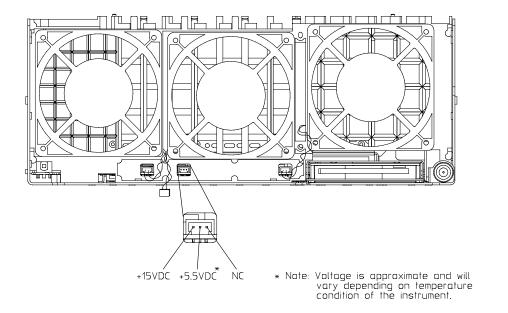
CAUTION The power supply may be in thermal shutdown if the instrument has been operating without the fans running. Allow the instrument to cool down before troubleshooting.

If all three fans are not operating, suspect a power supply problem or a defective A14 system motherboard. Refer to "Power Supply Check" on page 4-7 to check the individual supplies. If the supplies are within specifications, the most probable cause is a defective A14 system motherboard. Refer to "Removing and Replacing the A14 System Motherboard" on page 7-26.

If only one or two fans are not functioning, and the power supplies are within specifications, suspect the A14 system motherboard or a defective fan. Perform the following procedure.

- 1. Remove the front panel assembly from the instrument. Refer to "Removing and Replacing the Front Panel Assembly" on page 7-10.
- 2. Refer to Figure 4-4. Measure the fan voltages at J1, J3, and J4 on the A14 system motherboard.

Figure 4-4 Fan Voltages



sa867a

3. If the correct voltage is present and the fan connector is in good mechanical condition, suspect a defective fan. Refer to "Removing and Replacing the Midweb and the B1 Fan" on page 7-72.

If the voltage is not present, suspect a defective A14 system motherboard. Refer to "Removing and Replacing the A14 System Motherboard" on page 7-26.

Troubleshooting LCD Display Problems

This procedure is intended to isolate the faulty assembly when the display is dark. If the display is lit, but the color mix is faulty, refer to "A2 Display Test" on page 4-19.

| NOTE There are no front panel adjustments for intensity and contrast of the LCD |
|--|
|--|

1. If the display is dim, the backlight assembly is defective. Refer to "Removing and Replacing the Front Panel Assembly" on page 7-10.

If the display is dark (not visible), connect an external VGA monitor to the rear panel VGA output connector on the instrument. Be aware that some multisync monitors might not be able to lock to a 60 Hz sync pulse. If the video information is not present on the external VGA monitor, the most probable cause is the A15 CPU board. Refer to "Removing and Replacing the A15 CPU Board" on page 7-28.

- 2. If the external VGA monitor is functioning, verify that the front panel interface ribbon cable is properly plugged into the motherboard connector.
- 3. If the front panel interface ribbon cable is properly connected, suspect that one or more of the following is defective:
 - inverter board (mounted on the display assembly)
 - display lamp assembly
 - A3 front panel interface board
 - A2 display assembly

Refer to the following paragraphs to determine which of the above listed assemblies is defective.

Creating the Test Setup

For easy access to measure the voltages on the inverter board and on the A3 front panel interface board, it is best to disassemble the front panel and remove these two boards to set in front of you for testing. Use the ribbon cables that come with the boards and the analyzer as the supply source. Follow this procedure:

- 1. Turn off the analyzer.
- 2. Remove the front panel. Refer to "Removing and Replacing the Front Panel Assembly" on page 7-10.
- 3. After the front panel is removed from the analyzer, isolate the inverter board by first removing the display assembly. Refer to "Removing the A2 Display Assembly" on page 7-12. Put the A2 display assembly and its ribbon cables aside.
- 4. Remove the A3 board by referring to "Removing the A3 Front Panel Interface Board" on page 7-12. Put the A3 board aside.
- 5. Duplicate the board connections on your ESD safe test desk top by laying the A2 and A3 in front of the open-faced analyzer. Lay the A2 and A3 boards component-side down, the A2 to the left of the A3, with the top of the boards towards you.

- 6. Connect the display ribbon cable and display lamp cable from A2 to A3. Connect the front panel interface ribbon cable coming from the analyzer to the A3 board.
- 7. Turn the analyzer on and refer to "Verifying the Inverter Board" on page 4-14 and "Verifying the A3 Front Panel Interface Board" on page 4-16 to test and troubleshoot the boards.

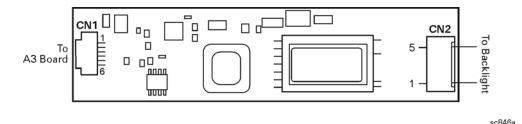
Verifying the Inverter Board

| WARNING | High voltage is present on the inverter board and the A3 front panel interface board. Be careful when measuring signals and voltages on these boards. |
|---------|---|
| | |

NOTE To access the front panel boards for measurements, it is necessary to remove the front panel assembly. Refer to "Removing and Replacing the Front Panel Assembly" on page 7-10.

Using Figure 4-5 as a reference, measure the signals and voltages indicated in Table 4-3 on page 4-14. If the signals and voltages measure good, the inverter board is functioning correctly.

Figure 4-5 Inverter Board Test Point Locations



| Table 4-3 | Inverter Board, Ve | oltages and Signals |
|-----------|--------------------|---------------------|
|-----------|--------------------|---------------------|

| Test Point | Signal or Voltage | Test Point | Signal or Voltage |
|------------|-------------------|------------|-------------------------------------|
| CN1 pin 1 | +5.1 Vdc | CN1 pin 5 | 0 V (ground) |
| CN1 pin 2 | +5.1 Vdc | CN1 pin 6 | +2.54 V |
| CN1 pin 3 | 39 mV | CN2 pin 1 | +400 V peak sinewave @ 38 kHz |
| CN1 pin 4 | 0 V (ground) | CN2 pin 5 | ac neutral (referenced to pin 1) |

After measuring the points CN1 and CN2, match the results and perform the rework as indicated in the action column in Table 4-4.

| Input (CN1) | Output (CN2) | Action |
|----------------|-----------------|--|
| Good | Good | Replace the display lamp. Refer to "Removing and Replacing the Display Inverter Board and the Display Lamp" on page 7-14. |
| Good | Bad | Replace the inverter. Refer to "Removing and Replacing the Display Inverter Board and the Display Lamp" on page 7-14. |
| Bad | Bad | Refer to "Verifying the A3 Front Panel Interface Board" on page 4-16. |

Table 4-4Inverter Board Troubleshooting Steps

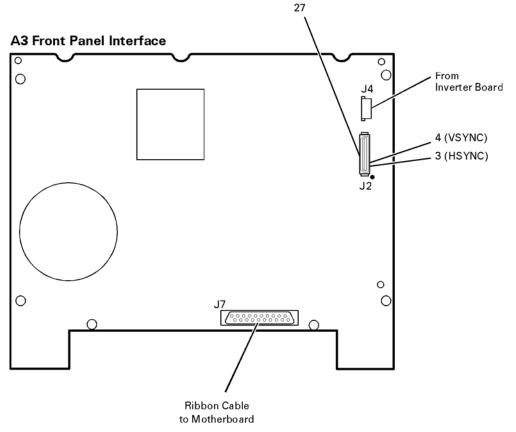
Verifying the A3 Front Panel Interface Board

To verify that the HSYNC (horizontal sync), VSYNC (vertical sync), and LCD clock are functioning correctly, measure the signals listed in Table 4-5 and illustrated in Figure 4-6 on page 4-16. If all of these signals measure correctly, suspect a defective backlight or LCD. The backlight is the most probable cause.

CAUTION Be careful not to short connector pins together when measuring these signals.

| Signal Type | Test Point | Voltage | Signal | |
|-------------|------------|----------------------|----------------------|--|
| HSYNC | J2 pin 3 | 0 to +3 V | 30.8 kHz square wave | |
| VSYNC | J2 pin 4 | 0 to +3 V | 60 Hz square wave | |
| CLOCK | J2 pin 27 | 0 to +3.4 V pk-to-pk | 25 MHz sine wave | |





If any of the three signal types is incorrect, replace the A3 front panel interface board. Refer to "Removing the A3 Front Panel Interface Board" on page 7-12.

If all of the signal types are correct, replace the A2 display assembly. Refer to "Removing the A2 Display Assembly" on page 7-12.

Front Panel Troubleshooting

The front panel assembly consists of the A1 keypad, A2 display, and the A3 front panel interface. The following tests verify the operation of the front panel assembly when the analyzer is in the measurement mode. If the instrument fails to power up correctly, or it is difficult to verify due to a faulty display, refer to "Power Up Troubleshooting" on page 4-6.

Refer to the following sections to verify the operation of the noted assemblies.

- "A1 Front Panel Keypad and RPG Test" below
- "A2 Display Test" on page 4-19
- "A3 Front Panel Interface Board" on page 4-20
 - USB
 - Speaker
 - Probe Power

If all assemblies are working correctly, continue troubleshooting with "Rear Panel Troubleshooting" on page 4-21.

A1 Front Panel Keypad and RPG Test

Test the front panel keypad by running the front panel test. To run the front panel test, perform the following:

On the System menu, point to Service and click Front Panel Test.

A Front Panel Service Test dialog box will be displayed, as shown in Figure 4-7.

Figure 4-7 Front Panel Service Test Dialog Box

| 🕅 Front Panel Service Test | | × |
|--|------------------------|--------|
| RPG Ticks Velocity | Keys Value Count | Cancel |
| Press Macro (extreme lower right) k Be sure to close program when dor | - | exit. |

Checking the Front Panel Keys

To check the front panel keys, push each key and compare the decimal value in the Value box under Keys to the key values in Table 4-6.

- If all the key values are correct, then the A1 front panel keypad is working. If some of the keys are not working, suspect a faulty A1 keypad. To replace the A1 keypad, refer to "Removing the A1 Keypad Assembly" on page 7-12.
- If none of the keys are working correctly, suspect a faulty A3 front panel interface board. To replace the A3 front panel interface board, refer to "Removing the A3 Front Panel Interface Board" on page 7-12.

| Key Value | Front Panel Key | Key Value | Front Panel Key | Key Value | Front Panel Key | Key Value | Front Panel Key |
|--------------|--|--------------|--------------------|--------------|--------------------|--------------|------------------------|
| 50 | Tab ← | 66 | Measure Setups | 82 | 7 | 98 | 1 |
| 51 | Up ↑ | 67 | F2 | 83 | 8 | 99 | 2 |
| 52 | $\begin{array}{c} \text{Tab} \\ \rightarrow \end{array}$ | 68 | F3 | 84 | 6 | 100 | +/- ⇐ |
| 53 | Window | 69 | F4 | 85 | M/u | 101 | Not Applicable |
| 54 | OK | 70 | Help | 86 | Cancel | 102 | Not Applicable |
| 55 | Start/ Center | 71 | Trigger | 87 | Marker | 103 | Save |
| 56 | Stop/ Span | 72 | Average | 88 | Marker Table | 104 | Maximum Window Icon |
| 57 | Power | 73 | Calibrate | 89 | Limit Table | 105 | Preset |
| 58 | Down ↓ | 74 | F1 | 90 | 4 | 106 | 0 |
| 59 | Click | 75 | Not Applicable | 91 | 5 | 107 | • |
| 60 | Trace | 76 | 9 | 92 | 3 | 108 | Not Applicable |
| 61 | Display Configure Icon | 77 | G/n | 93 | Enter | 109 | Not Applicable |
| 62 | Not Applicable | 78 | Menu Dialog | 94 | Not Applicable | 110 | Not Applicable |
| 63 | Sweep Setup | 79 | Measure | 95 | Marker Search | 111 | Recall |
| 64 | Channel | 80 | Format | 96 | Marker Function | 112 | Print Icon |
| 65 | Sweep Type | 81 | Scale | 97 | Math/ Memory | 113 | Macro |

Table 4-6Keyboard Key Numbers

Checking the RPG (Front Panel Knob)

To check the RPG knob, rotate the knob and check for a fluid movement of numbers in the **Velocity** box.

• If the movement of numbers in the **Velocity** box is not smooth or no numbers appear at all, suspect a faulty A3 front panel interface board. To replace the A3 front panel interface board, refer to "Removing the A3 Front Panel Interface Board" on page 7-12.

A2 Display Test

The display should be bright with all annotations and text readable. The display test allows you to check for non-functioning pixels and other problems.

NOTE If the display is dim or dark, refer to "Troubleshooting LCD Display Problems" on page 4-13.

What Is a Damaged Pixel?

A pixel is a picture element that combines to create the image on the display. They are about the size of a small pin point. Damaged pixels can be either "stuck on" or "dark."

- A "stuck on" pixel is red, green, or blue and is always displayed regardless of the display setting. It will be visible on a dark background.
- A "dark" pixel is always dark and will be displayed against a background of its own color.

How to Run the Display Test

To run the display test, perform the following:

On the System menu, point to Service, and then click Display Test.

A multi-color screen is displayed. Be prepared to look for the symptoms described in "How to Identify a Faulty Display," and then click the **Start Test** button. To continue to the next test, click the moving **Next Test** button. The button moves to allow you to see all of the display. After the test is completed, the display defaults to the network analyzer screen.

How to Identify a Faulty Display

One or more of the following symptoms indicate a faulty A2 display assembly:

- a complete row or column of "stuck on" or "dark" pixels
- more than six "stuck on" pixels (but not more than three green)
- more than twelve "dark" pixels (but not more than seven of the same color)
- two or more consecutive "stuck on" pixels or three or more consecutive "dark" pixels (but no more than one set of two consecutive dark pixels)
- "stuck on" or "dark" pixels less than 6.5 mm apart (excluding consecutive pixels)

If any of these symptoms occur, replace the A2 display assembly. Refer to "Removing the A2 Display Assembly" on page 7-12.

A3 Front Panel Interface Board

This assembly performs the following functions:

- It routes USB signals between the front-panel USB connector and the A15 CPU board.
- The speaker produces the audio output from signals supplied by the A15 CPU board.
- It supplies power to the two front-panel probe power connectors.
- It routes key pad commands from the A1 keypad to the A15 CPU board.
- It routes display signals from the A15 CPU board to the A2 display assembly.

Checking the USB Port

To verify proper operation of the USB port:

- Connect a known good USB device, such as a USB mouse.
- Wait 15 seconds for the analyzer to verify the device connection, and then check the operation of the USB device.
- If the device performs correctly, the USB port is functioning properly.
- If the device does not perform correctly, the USB port is faulty. Refer to "Removing the A3 Front Panel Interface Board" on page 7-12.

Checking the Speaker

If no audio is heard:

- Verify that the volume is set correctly and the proper sound driver is loaded; do the following:
 - On the System menu, point to Configure, and then click Control Panel.
 - Click the Sounds and Multimedia icon. Follow the normal Windows procedure to check the sound drivers and volume. If the audio is still not heard, suspect a faulty speaker. Refer to "Removing the A3 Front Panel Interface Board" on page 7-12.

Checking the Probe Power Connectors

To verify the probe power operation, refer to "Power Supply Check" on page 4-7.

Checking the Operation of the Key Pad Commands

To verify the key pad functionality, refer to "A1 Front Panel Keypad and RPG Test" on page 4-17.

Checking the Display

To verify the display functionality, refer to "A2 Display Test" on page 4-19.

Rear Panel Troubleshooting

Each rear panel connector is associated with a hardware group in the analyzer. You can use the data at these rear panel connectors to help troubleshoot these hardware groups in addition to testing the connectors.

The connectors discussed in this section are:

- USB
- SERIAL (RS-232)
- PARALLEL (1284-C)
- VGA
- GPIB
- LAN

Checking the USB Ports

NOTE The rear panel contains five USB ports; one "stand-alone USB port" on the CPU board and a "group-of-four" connected to a separate hub.

To verify proper operation of any USB port:

- Connect a known good USB device, such as a USB mouse.
- Wait 15 seconds for the analyzer to verify the device connection, and then check the operation of the USB device.
- If the device performs correctly, the USB port is functioning properly.
- If the device does not perform correctly, remove the non-working USB device, wait 15 seconds, and then reconnect the device to the USB port.
- If the device still does not perform correctly, remove the USB device and connect it to the front panel USB.

| NOTE | If the front panel USB port does not work, refer to "A3 Front Panel Interface |
|------|---|
| | Board" on page 4-20. |

- If the USB device has been verified to work on the front panel but *not* on the stand-alone USB port:
 - Then the A15 CPU board is faulty. Refer to "Removing and Replacing the A15 CPU Board" on page 7-28.
- If the USB device has been verified to work on the front panel but not on one of the "group-of-four" USB ports:
 - Then the rear panel hub is faulty. Refer to "Removing and Replacing the USB Hub" on page 7-75 for replacing the rear panel hub board (part number E8356-60202).

Checking the SERIAL (RS-232), PARALLEL (1284-C), or VGA Port

To verify the proper operation of the SERIAL, PARALLEL, or VGA port:

- Connect a known good serial, parallel, or VGA peripheral device.
- Wait 15 seconds for the analyzer to verify the device connection, and then check the operation of the peripheral device.
- If the peripheral device performs correctly, the port is functioning properly.
- If the peripheral device does not function properly, the A15 CPU board is faulty. Refer to "Removing and Replacing the A15 CPU Board" on page 7-28.

Checking the GPIB Port

The network analyzer uses a National Instruments 488.2 GPIB controller and associated driver software. This software includes a test utility that scans the GPIB bus and returns the status of all the connected peripherals.

To run the test utility software and check the GPIB status:

- 1. Connect a known good peripheral to the analyzer using a known good GPIB cable.
- 2. On the **System** menu, point to **Configure**, and then click **SCPI/GPIB**. A **SCPI/GPIB** dialog box is displayed.
- 3. In the **GPIB** block, click **System Controller** to establish the analyzer as a controller. Wait for the analyzer to configure, and then click **OK**.
- 4. On the System menu, click Windows Taskbar to open the Start Menu window.
- 5. On the Start Menu window, point to Programs, National Instruments NI-488.2, and then click Explore GPIB to open the Measurement & Automation window.
- 6. On the left side of the Measurement & Automation window under folders:
 - a. Click the plus sign to expand the Measurement & Automation folder.
 - b. Click the plus sign to expand the **Devices and Interfaces** folder.
 - c. Right click GPIB0 (AT-GPIB/TNT) to open a submenu.
- 7. On the submenu, click **Scan for Instruments** to run the test.
- 8. The state of all the peripherals found on the bus is returned.
- 9. If problems are detected, check the connections of all GPIB cables, and check all the GPIB addresses of the instruments on the bus.

NOTE Address Information

- Each device must have its own unique address.
- The network analyzer's default GPIB address in the controller mode is 21.
- The address set on each device must match the one recognized by the analyzer (and displayed).
- Refer to the manual of the peripheral to read or change its address.

Troubleshooting Systems with Controllers

Passing the preceding test indicates that the analyzer's peripheral functions are operating normally. Therefore, if the analyzer has not been operating properly with an external controller, check the following:

- The GPIB interface hardware is incorrectly installed or not operational. (Refer to the embedded help in your analyzer.)
- The programming syntax is incorrect. (Refer to the embedded help in your analyzer.)

LAN Troubleshooting

Problems with the Local Area Network (LAN) can be difficult to solve. Software and protocol problems can make it difficult to determine whether the analyzer's hardware is working properly, or if there is a problem with the LAN or cabling.

The purpose of this section is to determine if the analyzer's hardware is functioning properly. While the turn-on self-test verifies some LAN hardware functionality, it is limited to internal testing only. Incorrect IP addresses will prevent proper operation. Improper subnet masks may allow only one-way communication, while improper gateway addresses may exclude outside LAN access.

Ping Command

The analyzer has the built-in capability of performing a "ping" operation. Ping will request the analyzer to send a few bytes of information to a specific LAN device. That device will then signal the analyzer that it has received the information. The analyzer computes the approximate round trip time of the communication cycle and displays it. For a full test of two-way communications, a ping test should be performed in two directions.

- **First**: you should ping from the analyzer to the local area network.
- **Second**: you should ping from the local area network to the analyzer.

| NOTE | In the second case, any other network device capable of sending a ping |
|------|---|
| | command could be used, assuming it is connected to the same network. This |
| | could be a computer or even another analyzer. |

How to Ping from the Analyzer to the Local Area Network (LAN)

Follow the steps below to verify proper LAN operation (assuming you have a functioning LAN). If no network LAN is available, see "Testing Between Two Analyzers" on page 4-26.

- 1. Make sure the IP address on the analyzer is set properly and that it is unique. If unsure how to check the IP address, refer to the embedded help in the analyzer.
- 2. Make sure the subnet mask is 0.0.0.0. If not, note the current setting (to allow setting it back later) and then set it to 0.0.0.0.
- 3. Find and note the IP address of another working LAN device on the same network. Make sure this device is turned on, connected, and is functioning properly.
- 4. To ping the network device:
 - a. On the System menu, click Windows Taskbar.
 - b. On the Windows Taskbar menu, point to Programs, Accessories, and then click Command Prompt.
 - c. The command prompt window is displayed.
 - d. At the prompt, type ping xxx.xxx.xxx¹ and press **Enter** on the front panel or keyboard. Refer to Step 5 for the results of a successful ping.

^{1.} The letters x represent the IP address of the other device on the network.

- 5. The analyzer attempts four cycles of communications with the indicated LAN device.
 - It displays the time it took to complete each cycle.
 - Each cycle times-out after one second if no communication is established and the message, Request timed out, is displayed.
 - It is common for the first of the four cycles to time-out even though subsequent cycles pass.
 - See below for an example output of a successful ping.

```
C:>ping 141.121.69.162
Pinging 141.121.69.162 with 32 bytes of data:
Reply from 141.121.69.162: bytes=32 time<10ms TTL=127
Ping statistics for 141.121.69.162:
    Packets: Sent = 4, Received = 4, lost = 0 <0% loss>.
Approximate round trip times in milli-seconds:
    Minimum = 0ms, Maximum = 0ms, Average = 0ms
```

- 6. The above message verifies that one way communication from the analyzer to the network has been established
- 7. If the subnet mask was changed in step 2, set it back at this time.

How to Ping from the Local Area Network (LAN) to the Analyzer

Reverse communication should also be verified. Determining this, though, is dependent upon your network setup and software. Generally, you need to issue a ping command using the IP address of the analyzer to be tested. For example, using Windows 95, 98, 2000 and while at a DOS prompt, type in ping xxx.xxx.xxx¹. Then press **Enter** on the front panel or keyboard. If full communication can be established, then the computer display shows the cycle time for each of four cycle attempts (similar to that in step 5). Other software may behave somewhat differently, but basically the same.

If the analyzer can talk to the network, but the network can not talk to the analyzer, then the computer or device used from the network may have a subnet mask that excludes communication with the IP address chosen for the analyzer. Any subnet mask other than 0.0.0.0 will exclude operation from some addresses. Changing the subnet mask of a computer or other device should only be attempted by a qualified network administrator. Failure to communicate due to a subnet mask incompatibility does not indicate any failure of the analyzer.

If the analyzer fails to ping in either direction, and assuming the subnet masks are set properly, then the fault must be isolated to the analyzer or to the network. Contact a qualified network administrator.

^{1.} The letters x represent the IP address of the analyzer.

Testing Between Two Analyzers

The ability of the analyzer's LAN to function can be easily tested by connecting two analyzers together using a "crossover cable" (a short length of cable with an RJ-45 connector on each end).

Some network hubs have the capability to make a crossover connection using two normal, or straight-through, cables. If this capability is not available and a crossover cable is not available, a crossover cable can be made by following the directions in "Constructing a Crossover Cable" on page 4-26.

Set the IP addresses on two analyzers. The addresses can be set to anything, but they must be different. Make sure the subnet mask and gateway addresses are set to 0.0.0.0 and that the LAN is active on both analyzers. Connect the two analyzers together using either a crossover cable or a crossover hub.

Now follow the steps in "How to Ping from the Analyzer to the Local Area Network (LAN)" on page 4-24 to have the first analyzer ping the second analyzer. When done, repeat the procedure having the second analyzer ping the first. If both procedures function properly, the LAN circuitry on both analyzers is verified.

If neither function properly:

- One or both IP addresses could be wrong.
- One or both LAN states could be set to off.
- The crossover cable could be miswired.
- One or both analyzers could be defective.

If possible, eliminate the possibility of a defective analyzer by substitution of a known working unit. Once the analyzer has been proven to be working properly, concentration can be placed on the network itself to determine the cause of the failure.

Constructing a Crossover Cable

A crossover cable can be made from a standard LAN cable by connecting pin 1 from each connector to pin 3 of the other connector, and pin 2 from each connector to pin 6 of the other connector.

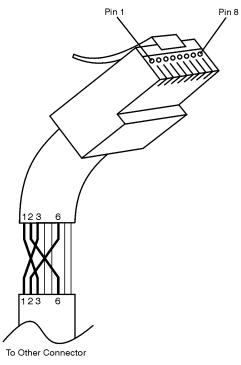
- 1. Strip away a few inches of the outside jacket insulation from the middle of a standard LAN cable that has an RJ-45 connector on each end.
- **NOTE** Pins 1, 2, 3, and 6 of the connectors must be located to determine which wires to cut in the following steps. Most, but not all, LAN cables use the color coding listed in Table 4-7. If your cable does not use this color scheme, you will have to determine the locations of the appropriate wires before proceeding with this procedure.

| Pin Number | Color | Pin Number | Color |
|----------------|--------------|---------------|-------------|
| 1 (transmit +) | White/orange | 5 | White/blue |
| 2 (transmit –) | Orange | 6 (receive –) | Green |
| 3 (receive +) | White/green | 7 | White/brown |
| 4 | Blue | 8 | Brown |

 Table 4-7
 LAN Pin Definitions and Wire Color Codes

- 2. Cut the wires going to pins 1, 2, 3, and 6. Strip away a small amount of insulation from each of the eight cut ends.
 - a. Connect the wire from pin 1 on one end of the cable to the wire from pin 3 on the other end of the cable.
 - b. Connect the wire from pin 3 on one end of the cable to the wire from pin 1 on the other end of the cable.
 - c. Connect the wire from pin 2 on one end of the cable to the wire from pin 6 on the other end of the cable.
 - d. Connect the wire from pin 6 on one end of the cable to the wire from pin 2 on the other end of the cable.
- 3. Insulate all exposed wires so that they cannot short together.
- 4. Label this as a crossover cable so that it cannot be confused with a standard cable.

Figure 4-8 Construction of a Crossover Cable



sd623c

Measurement System Troubleshooting

This section provides troubleshooting procedures for the measurement portion of the PNA series network analyzer. In this section, the analyzer is used as a tool to help isolate the suspected faulty functional group. Once the faulty functional group is determined, troubleshooting steps are provided to help you isolate the faulty assembly or part.

This section is divided into two major sections for troubleshooting. The first section *mainly* covers the standard S-parameter measurement troubleshooting (pages 4-30 thru page 4-51). However, some parts are applicable for the frequency offset section. The second section is for troubleshooting the frequency offset section, option 080 (refer to pages 4-53 thru pages 4-56). The "Checking the Frequency Offset Group (Options 080 and 081)" on page 4-53 section will also reference portions of the S-parameter troubleshooting section in its troubleshooting process.

Before you begin—consider: Where do you see a problem?

If you are seeing a problem at **Preset**, perform the standard S-parameter test set troubleshooting procedure, starting with: "Verifying the A, B, R1, and R2 Traces (Standard S-Parameter Mode)" on page 4-30.

You should also consider the problem indications that are observed and whether the observed condition is a soft failure or a hard failure.

Soft Failure

With a *soft* failure, the network analyzer's performance has degraded to an unacceptable level, yet it continues to operate and displays no error messages. For this type of failure, performance tests must be conducted to isolate the problem. Begin with viewing the error terms as described in Appendix A, "Error Terms." This will help to isolate most problems. If additional tests are required, refer to "Performance Tests (Agilent N7840A Software Package)" on page 3-29.

Hard Failure

With a *hard* failure, the PNA does not perform well and displays one or more error messages. To diagnose and repair a hard failure:

- Check "Help About" to verify that the model number and options listed match the actual analyzer model and options.
- Check "EEPROM Headers" to verify that the data there is correct.
- Check error messages. Refer to "Error Messages" and follow the suggestions outlined there for each applicable error message.

Help About

Go to the Help About screen by selecting **Help**, **About Network Analyzer** in the network analyzer application. Verify that the information displayed in this screen is correct for your analyzer. If any of the information is incorrect, contact Agilent Technologies. Refer to "Contacting Agilent" on page 2-11.

EEPROM Headers

The network analyzer application uses the firmware revision information stored in the pc board header EEPROM. If the information stored in any EEPROM is incorrect, the network analyzer may not operate properly.

The following table lists the pc boards in your network analyzer that contain EEPROM headers. The pc boards are listed by name and part number and the correct firmware revision code is given for each.

| PC Board Name | PC Board Part Number | Memory ID | Hardware ID | Firmware Revision |
|------------------------------------|-------------------------|--------------|----------------|----------------------|
| A5 SPAM | E8356-60006 | 3 | 6 | А |
| A8 and A9 fractional-N synthesizer | E8364-60099 | 3 | 8 | С |
| A10 frequency reference | E8364-60136 | 3 | 10 | В |
| A11 phase lock | E8364-60137 | 3 | 11 | С |
| ALC source (P/O A12 source 20) | E8362-60001 | 3 | 12 | В |
| A13 frequency offset receiver | E8364-60097 | 3 | 13 | А |
| A16 test set motherboard | E8364-60138 | 3 | 16 | С |

To view this EEPROM header information on the network analyzer display, select **System**, **Service**, **Utilities**, **View EEPROM Headers** in the network analyzer application.

If the information is incorrect for any of the pc boards, contact Agilent Technologies. Refer to "Contacting Agilent" on page 2-11.

Error Messages

PHASE LOCK LOST: The level of the signal from at least one of the reference receivers, and sensed by the A11 phase lock board, is too low to be accurately captured. This could be due to a problem in the source group, signal separation group, or receiver group (refer to "Checking the Source Group" on page 4-34, "Checking the Signal Separation Group" on page 4-47, and "Checking the Receiver Group" on page 4-51).

SOURCE UNLEVELED: The source ALC circuits on the A12 source or the A16 test set motherboard is running open-loop. Check the cable connections for W38 and W39 from the A23 and A24 SOMA 70s to the A16 test set motherboard, and for W40 from A16 to the A21 SOMA 50. If the problem is associated with one port and not the other, replace the SOMA 70 associated with the problem port. If the problem affects both ports, replace the A16 test set motherboard.

Verifying the A, B, R1, and R2 Traces (Standard S-Parameter Mode)

NOTE There is no way to view the frequency offset receiver response (Option 080). However, some standard S-parameter receiver trace information is helpful in troubleshooting the frequency offset section of the PNA. It is therefore recommended that you run this test even if you *only* suspect the frequency offset section of malfunctioning.

The first step is to verify that the A, B, R1, and R2 traces are present and that they are approximately level:

- On the System menu, point to Service, Utilities, and then click Receiver Display.
- Traces A, B, R1, and R2 are displayed in four separate data windows as shown in Figure 4-9. Identifying discrepancies of the traces in these windows can help you to isolate the faulty assembly.

| <u>F</u> ile | ⊻iew | <u>C</u> hannel | Sw <u>e</u> ep | Calibration | <u>T</u> race | <u>S</u> cale | M <u>a</u> rker | System | <u>W</u> indow | <u>H</u> elp | | | | |
|--------------|--------------------------|---|----------------|-------------|---------------|---------------|-----------------|---------------------------|---|--------------|--------|------|-------|--------|
| St | imulus | | | Start 4 | 5.00000 | 0 MHz | ÷ | Start | S | top | Center | | Sp | ban |
| 10.0 | ig Mag 000dB/ 00dB | 50.00 40.00 20.00 10.00 -10.00 -20.01 -30.01 -40.01 -50.01 Ch1 | | | Stop 5 | 50.0000 G | 10 0.0 | og Mag 000dB/ 00dB | 50.00 d 40.00 - 20.00 - 10.00 - -10.00 - -20.00 - -30.00 - 40.00 - 50.00 - Ch1: Si | B-B | | Stop | 50.00 | |
| 10.0 | Log Ma 000dB/ 00dB | 40.00 30.00 20.00 10.00 -10.00 -20.00 -30.00 -40.00 -50.0 | | 000 MHz - | Stop 5 | 50.0000 G | | Log Mag 000dB/ 00dB | 50.00 d 40.00 - 20.00 - 10.00 - -10.00 - -20.00 - -30.00 - 40.00 - 50.00 - Ch1: S | B-R2 | MHz - | Stop | 50.00 | 00 GH2 |

Figure 4-9 Typical Four Channel Display

• If all traces are present and are similar to the traces in Figure 4-9, then there are no major problems with the analyzer's measurement system. There may, however, be a minor failure in the analyzer.

To test further:

- Go to Chapter 3, "Tests and Adjustments" and perform all the tests in that section.

— If a problem still exists, contact Agilent. Refer to "Contacting Agilent" on page 2-11.

• If any of the traces are not present, are noisy or distorted, or are at an incorrect level, then there is a problem with the analyzer's measurement system. Proceed to "Where to Begin Troubleshooting."

Where to Begin Troubleshooting

For the purposes of troubleshooting, the analyzer block diagram is divided into the following functional groups:

the source group

- A8 fractional-N synthesizer
- A10 frequency reference
- A11 phase lock
- A12 source 20
- A16 test set motherboard
- A17 LOMA 12
- $-\operatorname{A18}\operatorname{MA}24$
- A19 splitter
- A20 LODA
- $-\operatorname{A21}\operatorname{SOMA}50$
- A23 and A24 SOMA 70s

• the signal separation group

- A22 switch
- A36 and A37 50-dB step attenuators (Option UNL only)
- A38 and A39 bias tees (Option UNL only)
- A25 and A26 test port couplers
- Port 1, Port 2 and A, B, R1, and R2 ports

the receiver group

- A43 and A44 50-dB step attenuators (Option 016 only)
- A27, A28, A29, and A30 first converters
- A31 receiver A
- A32 receiver R1
- A33 receiver R2
- A34 receiver B
- A35 receiver motherboard
- A6 SPAM board

• the frequency offset group (Options 080 and 081 only)

- A9 fractional-N synthesizer (Option 080 only)
- A10 frequency reference
- A12 source 20
- A13 frequency offset receiver (Option 080 only)
- A45 transfer switch (Option 081 only)

Use the list on the following pages to help you determine in which analyzer functional group to begin troubleshooting.

This is by no means an exhaustive list of possible symptoms nor possible failures. It is recommended that you view the system block diagram, at the end of this chapter, as you review the entries in this list and perform any of the troubleshooting procedures listed.

Good judgement and established logical troubleshooting techniques must be used to complement the procedures contained in this section.

Refer to Table 4-8 on page 4-46 for a list of the frequencies associated with each of the network analyzer's 27 bands.

All Traces

- *If all traces are missing in all bands*, the problem is most likely in the source group. However, a missing or disabled DSP driver may exhibit the same or similar symptoms. To verify that this DSP driver is present and enabled:
 - 1. Click My Computer, Properties, Hardware tab, Device Manager. Expand Network Adapters. The following entry should be listed: Agilent Technologies DSP Driver #2 and should be enabled.
 - 2. If the icon to the left of the name is a yellow box containing an exclamation mark (!), use Windows Explorer to verify the presence of the following file: C:\WINNT\system32\drivers\spampnp.sys.
 - 3. If you have verified that the DSP driver is present and enabled, but all traces are still missing in all bands, go to "Checking the Source Group" on page 4-34.
- If the trace faults are band-related, the problem is in the source group. Using Table 4-8 on page 4-46, note the frequency bands in which problems are seen. Go to "Source Group Tests" on page 4-40 and perform the band-specific tests that correspond to the bands in which the problems are seen.

R1 and A Traces

If both traces are affected, the problem is in the R1 phase lock loop.

- *If both traces are missing in all bands*, the problem is in the A16 test set motherboard, the A28 R1 first converter, the A32 R1 receiver, or the A22 switch. To determine which is at fault:
- 1. Bypass the A22 switch using a flexible RF cable connected between the input cable W2 and the R1 output cable W4.
- 2. If the R1 trace is now present, replace the A22 switch. If the R1 trace is still missing, reconnect the cables to the A22 switch.

- 3. Swap the A32 R1 receiver with the A33 R2 receiver. (Each of the four receivers is identical.)
- 4. If the missing trace is now R2 (still associated with the same A32 R1 receiver), replace the A32 R1 receiver. If the R1 trace is still missing, replace the A16 test set motherboard.
- *If the trace faults are band-related*, especially above 50 GHz, the problem is in the A23 SOMA 70. Swap the A23 and A24 SOMA 70 assemblies. If the fault is now in the R2 and B traces, replace the A23 SOMA 70 assembly.

R2 and B Traces

If both traces are affected, the problem is in the R2 phase lock loop.

- *If both traces are missing in all bands*, the problem is in the A16 test set motherboard, the A29 R2 first converter, the A33 R2 receiver, or the A22 switch. To determine which is at fault:
- 1. Bypass the A22 switch using a flexible RF cable connected between the input cable W2 and the R2 output cable W5.
- 2. If the R2 trace is now present, replace the A22 switch. If the R2 trace is still missing, reconnect the cables to the A22 switch.
- 3. Swap the A33 R2 receiver with the A32 R1 receiver. (Each of the four receivers is identical.)
- 4. If the missing trace is now R1 (still associated with the same A33 R2 receiver), replace the A33 channel R2 receiver. If the R2 trace is still missing, replace the A16 test set motherboard.
- *If the trace faults are band-related*, especially above 50 GHz, the problem is in the A24 SOMA 70. Swap the A24 and A23 SOMA 70 assemblies. If the fault is now in the R1 and A traces, replace the A24 SOMA 70 assembly.

R1 Trace Only

A problem that affects only the R1 trace is isolated to the A28 R1 first converter, the A32 R1 receiver, or the A6 SPAM board. Go to "Checking the Receiver Group" on page 4-51.

R2 Trace Only

A problem that affects only the R2 trace is isolated to the A29 R2 first converter, the A33 R2 receiver, or the A6 SPAM board. Go to "Checking the Receiver Group" on page 4-51.

A Trace Only

If the trace is missing in all bands, go to "Checking the Signal Separation Group" on page 4-47.

B Trace Only

If the trace is missing in all bands, go to "Checking the Signal Separation Group" on page 4-47.

Checking the Source Group

Serial Bus Test

Before performing tests on specific assemblies in the source group, it is recommended that you perform the serial bus test. This may help to isolate the failure to a specific assembly.

Through the front panel, the serial bus test allows you to check signal and voltage levels at 32 points (nodes) distributed across four of the printed circuit board assemblies in the analyzer. With this test you can isolate problem board assemblies in the analyzer. The board assemblies tested and their associated node numbers are as follows:

NOTE This test is written for a PNA series network analyzer as it was originally shipped from the factory. Due to changes in board production, this test may not show accurate pass/fail results if the A8, A9, A10, A11, A12, or A16 board have been replaced with newer board assemblies.

| Board Assembly ^a | Node Numbers |
|---|--------------|
| A12 source 20 | 111 to 118 |
| A10 frequency reference | 211 to 218 |
| A11 phase lock | 311 to 318 |
| A8 fractional-N synthesizer | 411 to 418 |
| A16 test set motherboard, MA 20 | 511 to 518 |
| A16 test set motherboard, SOMA 50 | 611 to 618 |
| A16 test set motherboard, AUX 1 | 711 to 718 |
| A16 test set motherboard, AUX 2 | 811 to 818 |
| A9 fractional-N synthesizer (Option 080 only) | 911 to 918 |

a. Board assembly A9 troubleshooting is discussed further in the "Checking the Frequency Offset Group (Options 080 and 081)" on page 4-53.

Descriptions of each board assembly and node is included in this section. Location of the nodes is indicated with a \blacklozenge symbol on the block diagrams located at the end of this chapter.

Performing the Serial Bus Test

First, this test sequentially checks all 48 nodes at 45 MHz. Next, the test checks all nodes that change values with frequency, at 49 different frequency points. For each node, measured values are copied to an ASCII text file in the service directory on the hard disk drive. Any measured values that exceed the tolerances are highlighted in the application and the data file.

To run the serial bus test:

- On the System menu, point to Service, and then click Serial Bus Test.
- The dialog box in Figure 4-10 on page 4-35 is displayed. Click **Begin** to start the test.

Figure 4-10 Serial Bus Test Dialog Box

| 😎 Serial Bus To | est | | | _ 🗆 × |
|-----------------------------|-----------|-------------|-------------|--------------|
| <u>A</u> bout <u>H</u> elp | | | | |
| Current Test Freq. (MHz) | Assembly | Node | Power (dBm) | Begin |
| | Descrip | otion | | ⊻iew Results |
| | 🗖 Pause o | n Failure | | <u> </u> |
| Minimum V. | Result | 8 | Maximum V. | Failures |
| None | | | | |
| | | Failure Sum | nmary | |

Node Descriptions, A12 Source 20

- **Node 111 ALC integrator** Node 111 senses the output of the ALC integrator. The output of the ALC integrator is the combined voltage output of all compensation circuits in the ALC. The voltage level varies with frequency and output power.
- **Node 112** *Level Output* Node 112 senses the output of the detector log amp in the ALC.
- **Node 113** *Detector Level* Node 113 senses the power level of the internal detector signal from the output of the A12 source 20.
- **Node 114** –*1V/GHz Compensation* Node 114 senses the inverse of the –1V/GHz signal that comes from the A11 phase lock board. The –1V/GHz compensates for first-order power changes of the YIG oscillator with respect to frequency.
- **Node 115** *Temperature Compensation* Node 115 senses the output of thermistor circuity that compensates for changes in operating temperature of the YIG oscillator.
- **Node 116** *Power DAC* Node 116 senses the output voltage of the power DAC. This output is summed with other compensation signals to control the source output level. The power DAC has the most influence of the compensation signals.
- **Node 117** *Power Amplifier Compensation* Node 117 senses the voltage compensation for the source output power amplifiers. This compensation is set for each source band.
- **Node 118** *Permanent Magnet YIG Oscillator (PMYO) DAC* Node 118 senses the output voltage of the DAC that sets the frequency of the 3.8 GHz PMYO.

Node Descriptions, A10 Frequency Reference Board

- Node 211100 MHz TuneNode 211 senses the tune voltage that phase locks the
100 MHz VCO. The tune voltage is set by referencing the 100 MHz VCO to
the internal 10 MHz OCXO or to the 10 MHz EXT REF.
- **Node 212** *100 MHz Level* Node 212 senses the average voltage output level of the 100 MHz VCO phase locked reference signal.
- Node 21399.50 MHz TuneNode 213 senses the tune voltage that phase locks the
99.50 MHz VCO. The tune voltage is set by referencing the 100 MHz VCO.
- **Node 214 99.50** *MHz Level* Node 214 senses the average voltage output level of the 99.50 MHz reference VCO.
- **Node 215** *External Reference Detect* Node 215 senses a TTL signal that is used to set the reference frequency switch. The node registers a low TTL voltage when the internal 10 MHz OCXO signal is used or a high TTL voltage when the external 10 MHz EXT REF is used.
- **Node 216** *Phase Lock Average Voltage* Node 216 senses the average voltage of the 8.333 MHz phase lock reference signal that is routed to the A11 phase lock board. This voltage is constant through all bands.
- **Node 217 500** *kHz Level* Node 217 senses the average voltage of the 500 kHz phase lock reference signal.
- Node 21833.1667 MHz 2nd LO Average VoltageNode 218 senses the averagevoltage of the 33.1667 MHz 2nd LO signal that is routed to the A35 receiver
motherboard. This voltage is constant through all bands.

Node Descriptions, A11 Phase Lock Board

- Node 311 NC Node 311 is not used in this product.
- **Node 312** *100 kHz Phase Detector* Node 312 senses the average voltage of the phase comparator at the output of a 700 kHz low-pass filter.
- **Node 313** *NC* Node 313 is not used in this product.
- **Node 314 100 kHz Phase Detector Integrator** Node 314 senses the tune voltage that phase locks the source. The integrator that supplies this signal receives its input from the 700 kHz phase detector (Node 312).
- **Node 315** *1V/GHz YTO Drive Voltage* Node 315 senses the YIG-tuned oscillator drive voltage that sweeps at 1V/GHz.
- **Node 316** *YTO Drive Current* Node 316 senses the YIG-tuned oscillator drive current.
- **Node 317** *YTO Tune Compensation* Node 317 senses the voltage output of the YTO tune compensation summation node.
- **Node 318** *Ground* Node 318 is connected to digital ground to serve as a measurement reference.

Node Descriptions, A8 Fractional-N Synthesizer Board

- **Node 411** +5 *Vdc Supply Voltage* Node 411 senses the 5 Vdc supply voltage that serves as a measurement reference.
- **Node 412** *1.5 to 3.0 GHz VCO Compensation* Node 412 senses the average voltage output level of the 1.5 to 3.0 GHz VCO.
- **Node 413 1.5 to 3.0 GHz VCO Tune Voltage** Node 413 senses the average voltage input level of the 1.5 to 3.0 GHz VCO.
- **Node 414** *Heterodyne Band ALC Level* Node 414 senses the ALC output voltage that is used to level the heterodyne circuit output for band 1.
- Node 415**2.250 GHz VCO Tune Voltage**Node 415 senses the average voltage input
level of the 2.250 GHz VCO.
- **Node 416** *Fundamental and Divide-by-2 Band ALC Level* Node 416 senses the ALC output voltage that is used to level the heterodyne circuit output for bands 2-25.
- **Node 417** 2.250 GHz VCO Compensation Node 417 senses the average voltage output level of the 2.250 GHz VCO.
- **Node 418** *ALC Level Adjust* Node 418 senses the voltage that is used to set the offset on the heterodyne band ALC.

Node Descriptions, A16 Test Set Motherboard, MA 20

- **Node 511** *ALC Output* Node 511 senses the output of the ALC integrator. The output of the integrator is the combined voltage output of the compensation circuits in the ALC.
- **Node 512** *Power DAC* Node 512 senses the output voltage of the power DAC. This output is summed with other compensation signals to control the SOMA 50 output level. The power DAC has the most influence of the compensation signals.
- **Node 513** *ALC Output* Node 513 senses the output of the ALC summing junction. The output of the ALC summing junction is the combined voltage output of all compensation circuits in the ALC. The voltage level varies with frequency and output power.
- **Node 514** *1V/GHz Compensation* Node 514 senses the output voltage of the 1V/GHz compensation amplifier for the LO ALC.
- **Node 515** Slope Compensation Node 515 senses the slope compensation.
- **Node 516** –15 V Reference Node 516 senses the –15 Vdc supply voltage that serves as a measurement reference.
- **Node 517** +9 V Reference Node 517 senses the +9 Vdc supply voltage that serves as a measurement reference.
- **Node 518** +15 V Reference Node 518 senses the +15 Vdc supply voltage that serves as a measurement reference.

Node Descriptions, A16 Test Set Motherboard, SOMA 50

- **Node 611** *Detector Level* Node 611 senses the power level of the internal detector signal from the A22 switch or the power level from the external detector from the rear panel.
- **Node 612** *Level Output* Node 612 senses the output of the detector log amp in the ALC.
- **Node 613** *ALC Output* Node 613 senses the output of the ALC integrator. The output of the ALC integrator is the combined voltage output of all compensation circuits in the ALC. The voltage level varies with frequency and output power.
- **Node 614** *1V/GHz Compensation* Node 614 senses the inverse of the -1V/GHz signal that comes from the A11 phase lock board. The -1V/GHz compensates for first-order power changes of the YIG oscillator with respect to frequency.
- **Node 615** *Temperature Compensation* Node 615 senses the input voltage applied to the temperature compensation amplifier for the source ALC.
- **Node 616** Slope Compensation Node 616 senses the slope compensation.
- **Node 617** Log Amp Collector Voltage Node 617 senses the collector voltage of the source ALC log amp.
- **Node 618** *Power DAC* Node 618 senses the output voltage of the power DAC. This output is summed with other compensation signals to control the source output level. The power DAC has the most influence of the compensation signals.

Node Descriptions, A16 Test Set Motherboard, AUX 1

- **Node 711** *Log Amp Breakpoint 1 Voltage* Node 711 senses the breakpoint voltage for stage 1 of the source ALC log amp.
- **Node 712** Log Amp Breakpoint 2 Voltage Node 712 senses the breakpoint voltage for stage 2 of the source ALC log amp.
- **Node 713** *1V/GHz Compensation* Node 713 senses the input voltage applied to the 1V/GHz compensation amplifier for the LO ALC.
- Node 714Log Amp Offset VoltageNode 714 senses the offset voltage for the source
ALC log amp.
- **Node 715** +10 V Reference Node 715 senses the +10 V supply voltage that serves as a measurement reference.
- **Node 716** Log Amp Emitter Voltage Node 716 senses the emitter voltage of the source ALC log amp.
- **Node 717** *Temperature Compensation* Node 717 senses the output voltage of the temperature compensation amplifier for the source ALC.
- **Node 718 SOMA 50 Prelevel DAC** Node 718 senses the prelevel DAC voltage applied to the output of the source ALC circuitry upon analyzer startup to preset the output level of the SOMA 50.

Node Descriptions, A16 Test Set Motherboard, AUX 2

- **Node 811** –*10 V Reference* Node 811 senses the –10 V supply voltage that serves as a measurement reference.
- **Node 812** +1.78 V Bias Reference Node 812 senses the +1.78 V bias supply voltage that serves as a measurement reference.
- Node 813Phase Lock IF DetectorNode 813 senses the voltage input to the phase
lock IF detector.
- **Node 814** +10 V Reference Node 814 senses the +10 V supply voltage that serves as a measurement reference.
- **Node 815** –1.25 V Bias Reference Node 815 senses the –1.25 V bias supply voltage that serves as a measurement reference.
- **Node 816** +5 *V Reference* Node 816 senses the +5 V supply voltage that serves as a measurement reference.
- **Node 817** *Logger Drive Voltage Output* Node 817 senses the drive voltage applied to the source ALC log amp.
- Node 818Detector Voltage OutputNode 818 senses the output voltage of the
phase lock IF detector.

Node Descriptions, A9 Fractional-N Synthesizer Board (Option 080 Only)

- **Node 911** +5 *Vdc Supply Voltage* Node 911 senses the 5 Vdc supply voltage that serves as a measurement reference.
- **Node 912 1.5 to 3.0 GHz VCO Compensation** Node 912 senses the average voltage output level of the 1.5 to 3.0 GHz VCO.
- **Node 913 1.5 to 3.0 GHz VCO Tune Voltage** Node 913 senses the average voltage input level of the 1.5 to 3.0 GHz VCO.
- **Node 914** *Heterodyne Band ALC Level* Node 914 senses the ALC output voltage that is used to level the heterodyne circuit output for band 1.
- Node 915**2.250 GHz VCO Tune Voltage**Node 915 senses the average voltage input
level of the 2.250 GHz VCO.
- **Node 916** *Fundamental and Divide-by-2 Band ALC Level* Node 916 senses the ALC output voltage that is used to level the heterodyne circuit output for bands 2-25.
- Node 9172.250 GHz VCO CompensationNode 917 senses the average voltage
output level of the 2.250 GHz VCO.
- **Node 918** *ALC Level Adjust* Node 918 senses the voltage that is used to set the offset on the heterodyne band ALC.

Source Group Tests

| NOTE | A defective A22 switch can exhibit the same symptom as a faulty source. |
|------|---|
| | Therefore, if it is determined that the source is functioning properly, you are |
| | directed to "Checking the Signal Separation Group" on page 4-47. |

Equipment Used for These Tests

| Equipment Type | Model or Part Number | Alternate Model or Part Number |
|--|-------------------------|-----------------------------------|
| Spectrum analyzer | 8565E | None |
| Power meter | E4418B/19B | E4418A/19A |
| Power sensor, 1.85 mm | V8486A | None |
| RF cable, SMA (f) to SMA (f) | Any | Any |
| $SMB\left(m\right) to \ SMA\left(f\right) \ adapter$ | 1250-0674 | Any |
| $SMA\left(m ight)$ to $SMA\left(m ight)$ adapter | 1250-1159 | Any |
| Power sensor, 2.4 mm | 8487A | None |
| RF cable, 2.4 mm (f) to 2.4 mm (f) | 85133C | Any |

Getting Ready to Test

Before checking the assemblies, you must open the analyzer.

CAUTION Use an antistatic work surface and wrist strap to reduce the chance of electrostatic discharge for all of the procedures in this chapter.

- 1. Turn off the analyzer power.
- 2. Unplug the power to the analyzer and disconnect all rear panel connections.
- 3. Remove the covers from the analyzer. Refer to "Removing the Covers" on page 7-6.
- 4. With the covers off, plug in the analyzer and turn on the power.

Single vs. Broadband Failure

There are two main types of failures that are related to the source group. The failures are classified as:

- broadband
- single band

Single band failures are indicated by all four channel traces having partial dropouts across the frequency range or intermittent phase lock problems. Troubleshooting information is provided under "If the traces faults are band-related," under "All Traces" on page 4-32.

Broadband failures are indicated by all four channel traces being in the noise floor. Most often this is due to problems in the phase lock signal path and will be characterized by a "PHASE LOCK LOST" error message on the display.

A phase lock problem is due to either:

- faulty RF signal generation (caused by the A12 source 20, A21 SOMA 50, A23 and A24 SOMA 70)
- faulty LO signal generation (caused by the A8, A10, A11, A17 or A18 board)

RF Signal Troubleshooting

To isolate a broadband RF signal generation failure, check the test port output power:

- 1. Connect a power meter and power sensor to Port 1 of the analyzer.
- 2. On the analyzer, press **Preset**, set the **Center Frequency** to **2 GHz**, and the **Frequency Span** to **0 Hz**. Note the power reading displayed on the power meter.

- 3. Connect the power sensor to Port 2 and set trace to measure S_{22} . Note the power reading displayed on the power meter.
- If the power level is low on both ports the problem is either A12 or A21, confirm the failure with the following checks for the A12 board and A21 assembly on page 4-41.
- If the power level is low on only one of the ports the problem is either A23 (Port 1) or A24 (Port 2), confirm the failure with the following checks for A23 or A24 on page 4-42 (as required for your port's failure).
- If the output power is high on both test ports the problem is LO signal related (continue with "LO Signal Troubleshooting").

LO Signal Troubleshooting

To isolate a broadband LO signal, refer to the data obtained from the "Serial Bus Test" on page 4-34:

- If the data obtained for the A10 frequency reference board is out of tolerance, confirm the failure with the following checks for the A10 board starting on page 4-42.
- If the data obtained for the A10 frequency reference board is correct but the data for the A8 fractional-N synthesizer board is out of tolerance, confirm the failure with the following checks for the A8 board on starting on page 4-43.
- If the data obtained for the A8 fractional-N synthesizer board is correct—and the RF has been checked—but there is still a phase lock problem, confirm the failure with the following checks for the A17, A18, and A20 boards starting on page 4-44.

Checking the A12 Output, All Bands

- 1. Disconnect W1 from A12.
- 2. Connect a cable to A12 and measure the output power. A power level of -17 dBm ± 5 dB indicates the A12 assembly is functioning normally.
- 3. If the output power level is at or below the minimum power level for the power sensor, replace the A12 assembly.

NOTE In the unlocked state, the analyzer will "search" for the reference signal. The output power, as indicated on the power meter, should be approximately -15 dBm ±5 dB.

4. If the signal is present, reconnect cable W1 to A12 and then continue with "Checking the A21 Output, All Bands" on page 4-42.

Checking the A21 Output, All Bands

- 1. Disconnect W2 from A21.
- 2. Connect a cable to A21 and measure the output power. A power level of $-7 \text{ dBm} \pm 5 \text{ dB}$ indicates the A21 assembly is functioning normally.
- 3. If the output power level, is at or below the minimum power level for the power sensor, replace the A21 assembly.
- 4. If the signal is present, reconnect cable W2 to A21 and then continue with "Checking the A23 and A24 Outputs, All Bands" on page 4-42.

Checking the A23 and A24 Outputs, All Bands

- Perform this procedure if the test port output power is low on one port and not on the other.
- 1. Disconnect the three semi-rigid cables, one flex cable, and one ribbon cable from each of the A23 and A24 SOMA 70 assemblies.
- 2. Swap the A23 and A24 assemblies.
- 3. Reconnect all cables.
- 4. Measure the test port power again.
- 5. If the problem follows the SOMA 70, replace the faulty assembly.
- 6. If the problem does not follow the SOMA 70, recheck all cable connections and the A25 and A26 coupler assemblies associated with the SOMA 70 assemblies (refer to "Checking the Signal Separation Group" on page 4-47).

Checking the A10 5 MHz Reference Output, All Bands

- 1. Refer to the block diagram at the end of this chapter and to "Top Cables—All, All Options" on page 6-14. Locate flexible cable W43, at the A10 frequency reference board.
- 2. Disconnect W43 from A10J10.
- 3. Connect the spectrum analyzer to A10J10.
- 4. The spectrum analyzer should measure a signal at 5 MHz.
- 5. If no 5 MHz signal is present, replace the A10 frequency reference board. Refer to "Removing and Replacing the A6, A8, A9, and A10 Boards" on page 7-18.
- 6. If the 5 MHz signal is present, reconnect cable W43, and then continue with "Checking the A10 Phase Lock Reference Output, All Bands" on page 4-43.

Checking the A10 Phase Lock Reference Output, All Bands

- 1. Refer to the block diagram at the end of this chapter and "Top Cables—All, All Options" on page 6-14. Locate flexible cable W44 at the A10 frequency reference board.
- 2. Disconnect W44 from A10J5.
- 3. Connect the spectrum analyzer to A10J5.
- 4. Verify the presence of the 8.333 MHz phase lock reference output signal.
- 5. If the signal is not present, replace the A10 frequency reference board. Refer to "Removing and Replacing the A6, A8, A9, and A10 Boards" on page 7-18.
- 6. If the signal is present, reconnect cable W44, and then continue with "Checking the 2nd LO at the A10 Frequency Reference, All Bands" on page 4-43.

Checking the 2nd LO at the A10 Frequency Reference, All Bands

Perform this procedure if a problem is in one of the receiver channels and appears to be a band related problem.

- 1. Refer to the block diagram at the end of this chapter and to "Top Cables—All, All Options" on page 6-14. Locate the flexible cable W35 at the A10 frequency reference board.
- 2. Disconnect the flexible cable W35 at A10J4.
- 3. Connect the spectrum analyzer to A10J4.
- 4. Verify the presence of the 33.1667 MHz signal at A10J4.
- 5. If the signal is not present, replace the A10 frequency reference board. Refer to "Removing and Replacing the A6, A8, A9, and A10 Boards" on page 7-18.
- 6. If the signal is present, reconnect cable W35, and then go to "Checking the A31 through A34 Receiver Outputs" on page 4-52.

Checking the A8 Fractional-N Synthesizer Output, Bands 0 and 1

- 1. Refer to the block diagram at the end of this chapter and to "Top Cables—All, All Options" on page 6-14. Locate the flexible cable W21, at the A8 fractional-N synthesizer board.
- 2. Disconnect W21 from A8J101.
- 3. Connect the spectrum analyzer to A8J101.
- 4. Set the network analyzer for a 500 MHz CW frequency and observe the spectrum analyzer measurement.
 - The spectrum analyzer should measure a signal at 508.33 MHz.
- 5. If the 508.33 MHz signal is not present and the 5 MHz reference signal is present from "Checking the A10 5 MHz Reference Output, All Bands," replace the A8 fractional-N synthesizer board. Refer to "Removing and Replacing the A6, A8, A9, and A10 Boards" on page 7-18.

6. If the signal is present, reconnect cable W21, and then continue with "Checking the A8 Fractional-N Synthesizer Output, Band 2" on page 4-44.

Checking the A8 Fractional-N Synthesizer Output, Band 2

Perform this procedure if you observe a problem in band 2 in all receivers.

1. Refer to the block diagram at the back of this chapter and to "Top Cables—All, All Options" on page 6-14. Locate semirigid cable W20, at the A8 fractional-N synthesizer board.

| CAUTION | Be careful not to damage the center pins of the semirigid cable. Some flexing |
|---------|---|
| | of the cables is necessary to measure the output. |

- 2. Using a 5/16 inch torque wrench, disconnect W20 at A8J106.
- 3. Connect the spectrum analyzer to A8J106.
- 4. Set the network analyzer to a CW frequency of 1 GHz.
 - The spectrum analyzer should measure a signal at 1.008 GHz.
- 5. If this signal is not present, replace the A8 fractional-N synthesizer board. Refer to "Removing and Replacing the A6, A8, A9, and A10 Boards" on page 7-18.
- 6. If the signal is present, leave the spectrum analyzer connected to A8J106 and continue with "Checking the A8 Fractional-N Synthesizer Output, Bands 3 through 26" on page 4-44.

Checking the A8 Fractional-N Synthesizer Output, Bands 3 through 26

Perform this procedure if you observe a problem in bands 3 through 26 in all receivers.

- 1. Set the network analyzer to a CW frequency of 2 GHz.
 - The spectrum analyzer should measure a signal at 2.008 GHz.
- 2. If the signal is not present, replace the A8 fractional-N synthesizer board. Refer to "Removing and Replacing the A6, A8, A9, and A10 Boards" on page 7-18.
- 3. If the signal is present, reconnect cable W20, and then continue with "Checking the A17 LOMA 12, All Bands (With All A8 Signals Present)" on page 4-44.

Checking the A17 LOMA 12, All Bands (With All A8 Signals Present)

Perform this procedure if you observe a problem in any band and all signals from the A8 fractional-N synthesizer are present.

1. Refer to the block diagram at the back of this chapter and to "Bottom Semi-Rigid Cables, No Options" on page 6-19. Locate semirigid cable W19, at the A17 LOMA 12.

| CAUTION | Be careful not to damage the center pins of the semirigid cable. Some flexing |
|---------|---|
| | of the cables is necessary to measure the output. |

- 2. Using a 5/16 inch torque wrench, disconnect W19 at the A17 LOMA 12.
- 3. Connect the spectrum analyzer to the open A17 connector.

- 4. For each frequency band in which problems were seen: Set the network analyzer to each of the frequencies indicated in the "Network Analyzer Source Frequency Setting (GHz)" column in Table 4-8 on page 4-46.
- 5. Set the spectrum analyzer to measure each of the corresponding frequencies in the column labeled: "Expected A17 Output Frequency (GHz)" in Table 4-8 on page 4-46.
- 6. If the signals are <-30 dBm or not present, replace the A17 LOMA 12. Refer to "Removing and Replacing the A17 LOMA 12" on page 7-32.
- 7. If the signals are present, reconnect cable W19, and then continue with "Checking the A18 MA 24 Output" on page 4-45.

Checking the A18 MA 24 Output

Perform this procedure if you observe a problem in any band and all signals from the A8 fractional-N synthesizer are present.

1. Refer to the block diagram at the back of this chapter and to "Bottom Semi-Rigid Cables, No Options" on page 6-19. Locate semirigid cable W18, at the A18 MA 24.

| CAUTION | Be careful not to damage the center pins of the semirigid cable. Some flexing |
|---------|---|
| | of the cables is necessary to measure the output. |

- 2. Using a 5/16 inch torque wrench, disconnect W18 at the A18 MA24.
- 3. Connect the spectrum analyzer to the open A18 connector.
- 4. For each frequency band in which problems were seen: Set the network analyzer to each of the frequencies indicated in the "Network Analyzer Source Frequency Setting (GHz)" column in Table 4-8 on page 4-46.
- 5. Set the spectrum analyzer to measure each of the corresponding frequencies in the column labeled: "Expected A18 Output Frequency (GHz)" in Table 4-8 on page 4-46.
- 6. If the signals are <-30 dBm or not present, replace the A18 MA 24. Refer to "Removing and Replacing the A18 MA 24" on page 7-34.
- 7. If the signals are present, reconnect cable W18, and then continue with "Checking the A20 LODA Output" on page 4-45.

Checking the A20 LODA Output

Perform this test if you observe a problem in all bands on a single channel.

- 1. Refer to the block diagram at the end of this chapter and to "Bottom Semi-Rigid Cables, No Options" on page 6-19. Locate cables W11, W12, W13, and W14, at the A20 LODA.
- 2. Using a 5/16 inch torque wrench, disconnect the cable associated with the faulty channel (W11, W12, W13, or W14) and connect the spectrum analyzer to the A20 LODA connector.
- 3. Set the network analyzer to any one of the frequencies listed in Table 4-8 on page 4-46.
- 4. Set the spectrum analyzer to measure the corresponding A18 output frequency listed in Table 4-8.

- 5. If the signal is not present, replace the A20 LODA. Refer to "Removing and Replacing the A20 LODA" on page 7-38.
- 6. If the signal is present, reconnect the cable, and then go to "Checking the Receiver Group" on page 4-51.

Table 4-8LO Path Frequencies

| Band | Network Analyzer Frequency Band of Problem (GHz) | Network Analyzer Source Frequency Setting (GHz) | Expected A17 Output Frequency (GHz) | Expected A18 Output Frequency (GHz) |
|------|--|---|--|--|
| 0 | 0.010 to 0.045 | 0.025 | 0.026 | 0.026 |
| 1 | 0.045 to 0.748 | 0.500 | 0.508 | 0.508 |
| 2 | 0.748 to 1.500 | 1.000 | 1.008 | 1.008 |
| 3 | 1.50 to 3.00 | 2.200 | 2.208 | 2.208 |
| 4 | 3.00 to 4.00 | 3.400 | 3.408 | 3.408 |
| 5 | 4.00 to 4.50 | 4.200 | 4.208 | 4.208 |
| 6 | 4.50 to 5.00 | 4.600 | 4.608 | 4.608 |
| 7 | 5.00 to 6.00 | 5.400 | 5.408 | 5.408 |
| 8 | 6.00 to 7.70 | 6.900 | 6.908 | 6.908 |
| 9 | 7.70 to 10.00 | 8.900 | 8.908 | 8.908 |
| 10 | 10.00 to 12.00 | 11.000 | 11.008 | 11.008 |
| 11 | 12.00 to 12.80 | 12.400 | 6.204 | 12.408 |
| 12 | 12.80 to 15.40 | 14.100 | 7.054 | 14.108 |
| 13 | 15.40 to 16.00 | 15.700 | 7.854 | 15.708 |
| 14 | 16.00 to 20.00 | 18.000 | 9.004 | 18.008 |
| 15 | 20.00 to 24.00 | 22.000 | 11.004 | 22.008 |
| 16 | 24.00 to 25.60 | 24.800 | 8.269 | 8.269 |
| 17 | 25.60 to 30.00 | 27.800 | 9.269 | 9.269 |
| 18 | 30.00 to 32.00 | 31.000 | 10.336 | 10.336 |
| 19 | 32.00 to 36.00 | 34.000 | 11.336 | 11.336 |
| 20 | 36.00 to 40.00 | 38.000 | 6.335 | 12.669 |
| 21 | 40.00 to 44.70 | 42.400 | 7.068 | 14.136 |
| 22 | 44.70 to 46.20 | 45.500 | 7.585 | 15.169 |
| 23 | 46.20 to 51.20 | 48.700 | 8.118 | 16.236 |
| 24 | 51.20 to 60.00 | 55.600 | 9.268 | 18.536 |
| 25 | 60.00 to 64.00 | 62.000 | 10.335 | 20.669 |
| 26 | 64.00 to 70.00 ^a | 65.500 | 10.918 | 21.836 |

a. Performance from 67 to 70 GHz is typical and not warranted by Agilent.

Checking the Signal Separation Group

Before checking the signal separation group, perform the following procedures:

• "Getting Ready to Test" on page 4-40

Checking the Output Power of the A and B Signals

Using a power meter, you can measure the outputs of the A and B signals from the front panel. The measurement results will help you isolate a faulty assembly. The outputs of the R1 and R2 channels cannot be measured because it would necessitate breaking the phase lock loop, causing all of the signals to be lost.

| Equipment Type | Model or Part Number | Alternate Model or Part Number |
|-----------------------------------|-------------------------|-----------------------------------|
| Power meter | E4418B/E441B | E4418A/E4419A |
| Power sensor, 1.85 mm | V8486A | None |
| Adapter, 3.5 mm (f) to 3.5 mm (f) | 83059B | 85052-60012 |
| Power sensor, 2.4 mm | 8487A | None |
| Adapter, 2.4 mm (f) to 2.4 mm (f) | 11900B | 85056-60007 |

Equipment Used for These Tests

Equipment Setup

- 1. Before starting these checks, zero and calibrate the power meter. (See the power meter user's guide for instructions on setting the calibration factor.)
- 2. If the **Receiver Display** (Figure 4-9) is not on the analyzer screen, perform the following: On the **System** menu, point to **Service**, **Utilities**, and then click **Receiver Display**.
- 3. Set the sweep speed for a 10 second sweep: On the Sweep menu, click Sweep Time and set the time to 10.000 seconds in the Sweep Time box.

Checking Port 1 Power (A Signal)

The object of this check is to verify the power of the A signal across the entire frequency range. Perform this test if there is an observed problem only with the channel A trace. The ten second sweep is slow enough to allow you to observe the output power on the power meter as the sweep occurs.

- 1. Connect the power sensor to Port 1.
- 2. Observe the power reading on the power meter as the sweep occurs on the analyzer.
- 3. The measured output power on the power meter should be within -15 dBm ± 4 dB for all E8361A PNAs, over the entire frequency range.
 - If the measured power is correct, go to "Checking the Receiver Group" on page 4-51.
 - If the measured power is not correct, go to "Checking the Signal through the Signal Separation Path" on page 4-48.

Checking Port 2 Power (B Signal)

The object of this check is to verify the power of the B signal across the entire frequency range. Perform this test if there is an observed problem only with the channel B trace. The ten second sweep is slow enough to allow you to observe the output power on the power meter as the sweep occurs.

- 1. Connect the power sensor to Port 2.
- 2. Observe the power reading on the power meter as the sweep occurs on the analyzer.
- 3. The measured output power on the power meter should be within -15 dBm ± 4 dB for all E8361A PNAs, over the entire frequency range.

Checking the Signal through the Signal Separation Path

For all of the following checks, refer to the block diagrams at the end of this chapter and to:

- "Bottom Assemblies, No Options" on page 6-17
- 1. "Bottom Semi-Rigid Cables, No Options" on page 6-19

Port 1 trace loss in the signal separation group is due to one or more of the following assemblies being defective:

- A22 switch
- A25 test port 1 coupler

Port 2 trace loss in the signal separation group is due to one or more of the following assemblies being defective:

- A22 switch
- A26 test port 2 coupler

Equipment Used for These Tests

| Equipment Type | Model or Part Number | Alternate Model or Part Number |
|-------------------|-------------------------|-----------------------------------|
| Spectrum analyzer | 8565E | 856xE ^a |

a. Must be capable of measuring a signal at 1 GHz.

To determine which assembly is defective, check the signal at each available measurement point in the signal path from the A22 switch to the test port coupler.

For Port 1 measurements, set the network analyzer for an S_{11} measurement with a CW frequency of 1 GHz.

For Port 2 measurements, set the network analyzer for an S_{22} measurement with a CW frequency of 1 GHz.

Perform the following checks in the order presented.

Checking the A22 Switch

1. Locate the following semirigid cable at the A22 switch:

| All analyzer options | W3 for Port 1 |
|-----------------------|---------------|
| All analyzers options | W4 for Port 2 |

- 2. Using a 5/16 inch torque wrench, disconnect the semirigid cable at the A22 switch.
- 3. Connect the spectrum analyzer to the connector. Set the spectrum analyzer to measure a signal at 1 GHz.
- 4. If the 1 GHz signal is not present, replace the A22 switch. Refer to "Removing and Replacing the A22 Switch" on page 7-42.
- 5. If the 1 GHz signal is present, replace the cable and then continue with "Checking the A23 and A24 SOMA 70s and the A25 and A26 Test Port Couplers" on page 4-49.

Checking the A23 and A24 SOMA 70s and the A25 and A26 Test Port Couplers

| 1. | Locate the following semirigid cable at the SOMA 70: | |
|----|--|----------------|
| | A23 SOMA 70 (analyzers with no options) | W5 for Port 1 |
| | A23 SOMA 70 (analyzers with option 014) | W61 for Port 1 |
| | A24 SOMA 70 (analyzers with no options) | W6 for Port 2 |
| | A24 SOMA 70 (analyzers with option 014) | W62 for Port 1 |
| | | |

- 2. Using a 5/16 inch torque wrench, disconnect the semirigid cable at the SOMA 70 (as required).
- 3. Connect the spectrum analyzer to the connector. Set the spectrum analyzer to measure a signal at 1 GHz.
- 4. If the 1 GHz signal is not present, replace the SOMA 70 (as required). Refer to "Removing and Replacing the A23 and A24 SOMA 70s" on page 7-44.
- 5. If the 1 GHz signal is present, replace the test port coupler (as required). Refer to "Removing and Replacing the A25 and A26 Test Port Couplers" on page 7-46.

Checking the A36 and A37 50-dB Step Attenuators (Option UNL)

1. Locate the following semirigid cable at the appropriate step attenuator:

- 2. Using a 5/16-inch torque wrench, disconnect the semirigid cable at the step attenuator.
- 3. Connect the spectrum analyzer to the step attenuator connector. Set the spectrum analyzer to measure a signal at 1 GHz.
- 4. If the 1 GHz signal is not present, replace the appropriate step attenuator. Refer to "Removing and Replacing the A36 and A37 50-dB Source Step Attenuators (Option UNL)" on page 7-54.
- 5. If the 1 GHz signal is present, reconnect the semirigid cable and go to "Checking the A38 and A39 Bias Tees (Option UNL)" on page 4-50.

Checking the A38 and A39 Bias Tees (Option UNL)

- 1. Locate the following semirigid cable at the appropriate bias tee:
 - Options UNL and UNL/014 $\ldots \ldots \ldots$. W55 for Port 1 or W56 for Port 2
- 2. Using a 5/16-inch torque wrench, disconnect the semirigid cable at the bias tee.
- 3. Connect the spectrum analyzer to the step attenuator connector. Set the spectrum analyzer to measure a signal at 1 GHz.
- 4. If the 1 GHz signal is not present, replace the appropriate bias tee. Refer to "Removing and Replacing the A38 and A39 Bias Tees (Option UNL)" on page 7-56.
- 5. If the 1 GHz signal is present, replace the appropriate test port coupler. Refer to "Removing and Replacing the A25 and A26 Test Port Couplers" on page 7-46.

Checking the Receiver Group

Equipment Used for These Tests

| Equipment Type | Model or Part Number | Alternate Model or Part Number |
|-------------------|-------------------------|-----------------------------------|
| Spectrum analyzer | 8565E | 856xE ^a |

a. Must be capable of measuring signals at 8.333 MHz and 41.667 MHz.

Getting Ready to Test

Before checking the assemblies, you must open the analyzer.

CAUTION Use an antistatic work surface and wrist strap to reduce the chance of electrostatic discharge for all of the procedures in this chapter.

- 1. Turn off the analyzer power.
- 2. Unplug the power to the analyzer and disconnect all rear panel connections.
- 3. Remove the covers from the analyzer. Refer to "Removing the Covers" on page 7-6.
- 4. With the covers off, plug in the analyzer and turn on the power.
- 5. For Port 1 measurements, set the network analyzer for an S_{11} measurement with a CW frequency of 1 GHz.

For Port 2 measurements, set the network analyzer for an S_{22} measurement with a CW frequency of 1 GHz.

Checking the A27 through A30 First Converter Outputs

Perform this procedure if you observe a problem in all bands on a single channel.

- 1. Refer to the block diagram at the end of this chapter and to "Bottom Semi-Rigid Cables, No Options" on page 6-18. Locate the cables W23, W24, W25, and W26 at the first converters, A27, A28, A29, and A30, respectively.
- 2. Using a 5/16 inch torque wrench, disconnect the semirigid cable associated with the faulty channel, from the first converter.
- 3. Connect the spectrum analyzer to the connector to which this cable was connected.
- 4. The measured signal on the spectrum analyzer should be at 8.333 MHz.
- 5. If the signal is not present, replace the faulty first converter. Refer to "Removing and Replacing the A27–A30 First Converters (Mixers) and Mixer Bias Board" on page 7-48.
- 6. If the signal is present, reconnect the cable and continue with "Checking the A49 IF Multiplexer Board Outputs" on page 4-52.

Checking the A49 IF Multiplexer Board Outputs

Perform this procedure if a problem appears to be in one of the receiver channels.

- 1. Refer to the block diagram at the end of this chapter and to "Bottom Semi-Rigid Cables, No Options" on page 6-18. Locate the flexible cables W27, W28, W29 and W30.
- 2. Disconnect the flexible cable for the suspect channel at the A49 IF multiplexer board.
- 3. Connect the spectrum analyzer to the suspect open A49 IF multiplexer board connector.
- 4. The measured signal on the spectrum analyzer should be at 8.333 MHz.
- 5. If the measured signal is present, replace cable and then continue with "Checking the A31 through A34 Receiver Outputs" on page 4-52.
- 6. If the measured signal is not present, replace the A49 IF multiplexer board. Refer to "Removing and Replacing the A31–A34 Receiver Modules and A49 IF Multiplexer Board" on page 7-50

Checking the A31 through A34 Receiver Outputs

Perform this procedure if a problem appears to be in one of the receiver channels.

- 1. Refer to the block diagram at the end of this chapter and to "Bottom Semi-Rigid Cables, No Options" on page 6-18. Locate the flexible cables W31, W32, W33 and W34 at each receiver IF output.
- 2. Disconnect the flexible cable at the suspect receiver.
- 3. Connect the spectrum analyzer to the suspect receiver connector.
- 4. The measured signal on the spectrum analyzer should be at 41.667 kHz.
 - If the measured signal is present, replace the A6 SPAM board. Refer to "Removing and Replacing the A6, A8, A9, and A10 Boards" on page 7-18.
- 5. If the measured signal is not present, verify the receiver operation:
 - a. Replace the suspect receiver with a known good receiver. You can use a known good receiver from the same analyzer.
 - b. If the error still occurs, replace the A35 receiver motherboard. Refer to "Removing and Replacing the A35 Receiver Motherboard" on page 7-52.
 - c. If the replacement receiver functions properly, replace the suspect receiver. Refer to "Removing and Replacing the A31–A34 Receiver Modules and A49 IF Multiplexer Board" on page 7-50.

Checking the Frequency Offset Group (Options 080 and 081)

CAUTION This section troubleshoots only those circuits specifically related to the frequency offset group (option 080). Please refer to "Where to Begin Troubleshooting" on page 4-31 and refer to the appropriate standard S-parameter test—with frequency offset mode off—before proceeding with this section.

Frequency Offset Group Tests

NOTE A defective A22 switch can exhibit the same symptom as a faulty source. Therefore, if it is determined that the source is functioning properly, you are directed to "Checking the Signal Separation Group" on page 4-47.

Equipment Used for These Tests

| Equipment Type | Model or Part Number | Alternate Model or Part Number |
|------------------------------------|-------------------------|-----------------------------------|
| Spectrum analyzer | 8565E | 856xE ^a |
| RF cable, 3.5 mm (f) to 3.5 mm (f) | 85131C | Any |
| RF cable, 2.4 mm (f) to 2.4 mm (f) | 85133C | Any |
| Adapter, 3.5 mm (f) to 3.5 mm (f) | 83059B | 85052-60012 |
| Adapter, 2.4 mm (f) to 2.4 mm (f) | 11900B | 85056-60007 |

a. Must be capable of measuring signals at 1.04 MHz, 5.00 MHz, 508.33 MHz, 1.008 GHz, and 2.008 GHz.

Getting Ready to Test

Before checking the assemblies, you must open the analyzer.

CAUTION Use an antistatic work surface and wrist strap to reduce the chance of electrostatic discharge for all of the procedures in this chapter.

- 1. Turn off the analyzer power.
- 2. Unplug the power to the analyzer and disconnect all rear panel connections.
- 3. Remove the covers from the analyzer. Refer to "Removing the Covers" on page 7-6.
- 4. With the covers off, plug in the analyzer and turn on the power.
- 5. From Channel, click Frequency Offset. In the Frequency Offset dialog box, click in the Frequency Offset on/off box to select. Click OK.

Checking the A10 5 MHz Reference Output

1. Refer to the block diagram at the end of this chapter and to "Top Cables—All, All Options" on page 6-15. Locate flexible cable W94, at the A10 frequency reference board, A10J11.

- 2. Disconnect W94 from A10J11.
- 3. Connect the spectrum analyzer to A10J11.
- 4. The spectrum analyzer should measure a signal at 5 MHz.
- 5. If no 5 MHz signal is present, replace the A10 frequency reference board. Refer to "Removing and Replacing the A6, A8, A9, and A10 Boards" on page 7-18.
- 6. If the 5 MHz signal is present, reconnect cable W94, and then continue with "Checking the A9 Fractional-N Synthesizer Output, Bands 0 and 1" on page 4-54.

Checking the A9 Fractional-N Synthesizer Output, Bands 0 and 1

Perform this procedure if you observe a problem in band 1 of the frequency offset receiver.

1. Refer to the block diagram at the back of this chapter and to "Top Cables—All, All Options" on page 6-15. Locate semi-rigid cable W92, at the A9 fractional-N synthesizer board.

CAUTION Be careful not to damage the center pins of the semi-rigid cable. Some flexing of the cables is necessary to measure the output.

- 2. Disconnect W92 from A9J101.
- 3. Connect the spectrum analyzer to A9J101.
- 4. Set the network analyzer for a 500 MHz CW frequency and observe the spectrum analyzer measurement.
 - The spectrum analyzer should measure a signal at 508.33 MHz.
- 5. If the 508.33 MHz signal is not present and the 5 MHz reference signal is present from "Checking the A10 5 MHz Reference Output, All Bands," replace the A9 fractional-N synthesizer board. Refer to "Removing and Replacing the A6, A8, A9, and A10 Boards" on page 7-18.
- 6. If the signal is present, reconnect cable W92, and then continue with "Checking the A9 Fractional-N Synthesizer Output, Band 2" on page 4-54.

Checking the A9 Fractional-N Synthesizer Output, Band 2

Perform this procedure if you observe a problem in band 2 of the frequency offset receiver.

1. Refer to the block diagram at the back of this chapter and to "Top Cables—All, All Options" on page 6-15. Locate semi-rigid cable W91, at the A9 fractional-N synthesizer board.

| CAUTION | Be careful not to damage the center pins of the semi-rigid cable. Some flexing |
|---------|--|
| | of the cables is necessary to measure the output. |

- 2. Using a 5/16 inch torque wrench, disconnect W91 at A9J106.
- 3. Connect the spectrum analyzer to A9J106.
- 4. Set the network analyzer to a CW frequency of 1 GHz.
 - The spectrum analyzer should measure a signal at 1.008 GHz.

- 5. If this signal is not present, replace the A9 fractional-N synthesizer board. Refer to "Removing and Replacing the A6, A8, A9, and A10 Boards" on page 7-18.
- 6. If the signal is present, leave the spectrum analyzer connected to A9J106 and continue with "Checking the A9 Fractional-N Synthesizer Output, Bands 3 through 26" on page 4-55.

Checking the A9 Fractional-N Synthesizer Output, Bands 3 through 26

Perform this procedure if you observe a problem in bands 3 through 26 in all receivers.

- 1. Set the network analyzer to a CW frequency of 2 GHz.
 - The spectrum analyzer should measure a signal at 2.008 GHz.
- 2. If the signal is not present, replace the A9 fractional-N synthesizer board. Refer to "Removing and Replacing the A6, A8, A9, and A10 Boards" on page 7-18.
- 3. If the signal is present, reconnect cable W91, and then continue with "Checking the A12 Source 20 Output" on page 4-55.

Checking the A12 Source 20 Output

Perform this procedure if you observe a problem in any band and all signals from the A9 fractional-N synthesizer are present.

1. Refer to the block diagram at the end of this chapter and to "Top Cables—All, All Options" on page 6-15. Locate the semirigid cables W93 at the A12 source 10 output.

| CAUTION | Be careful not to damage the center pins of the semirigid cable. Some flexing |
|---------|---|
| | of the cables is necessary to measure the output. |

- 2. Using a 5/16 inch torque wrench, disconnect W93 at the output of the A12 source 20 board.
- 3. Connect the spectrum analyzer to the A12 source 20 board, where the W93 cable normally would connect to.
- 4. Set the network analyzer to a CW frequency of 1 GHz.
 - The spectrum analyzer should measure a signal at 1 GHz.
- 5. If the signal is not present, replace the A12 source 20 board. Refer to "Removing and Replacing the A12 Source 20" on page 7-22.
- 6. If the signal is present, reconnect cable W93, and then continue with "Checking the A13 Frequency Offset Receiver Output, Band 0" on page 4-56.

Checking the A13 Frequency Offset Receiver Output, Band 0

Perform this procedure if you observe a problem in band 0 and all signals from the A12 source 20 output are present.

1. Refer to the block diagram at the end of this chapter and to "Top Cables—All, All Options" on page 6-15. Locate the flexible cable W95 at the frequency offset receiver output.

| CAUTION | Be careful not to damage the center pins of the semirigid cable. Some flexing |
|---------|---|
| | of the cables is necessary to measure the output. |

- 2. Disconnect the flexible cable at the frequency offset receiver.
- 3. Connect the spectrum analyzer to the frequency offset receiver connector J6.
- 4. Set the network analyzer to a CW frequency of 25 MHz.
 - The spectrum analyzer should measure a signal at 1.04 MHz.
- 5. If the measured signal is not present, Replace the A13 receiver. Refer to "Removing and Replacing the A13 Frequency Offset Receiver Assembly" on page 7-24.
- 6. If the signal is present the frequency offset group is confirmed to be operational.

Checking the A45 Transfer Switch (Option 081 Only)

| NOTE | Before continuing, perform the Operator's check "The Operator's Check" on |
|------|--|
| | page 3-10. If the instrument passes the operator's check then the A45 |
| | transfer switch is ok. |
| | If you are still experiencing problems, and your instrument has passed all |
| | troubleshooting tests to this point, then contact Agilent (refer to "Contacting" |
| | Agilent" on page 2-11). |

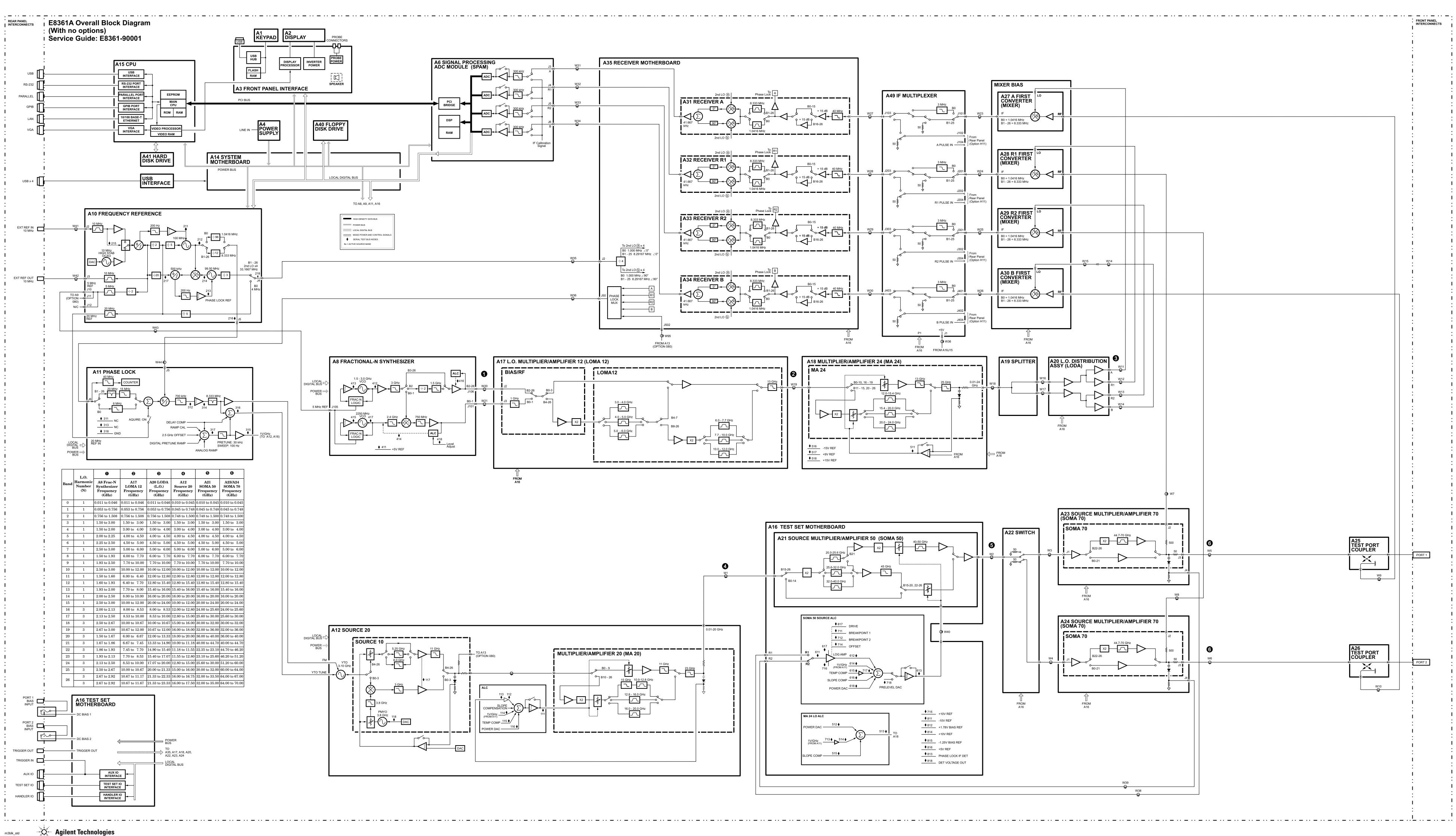
Perform this procedure if the instrument has passed all the frequency offset receiver tests but fails the operator's check and the problem appears to be at the A45 switch.

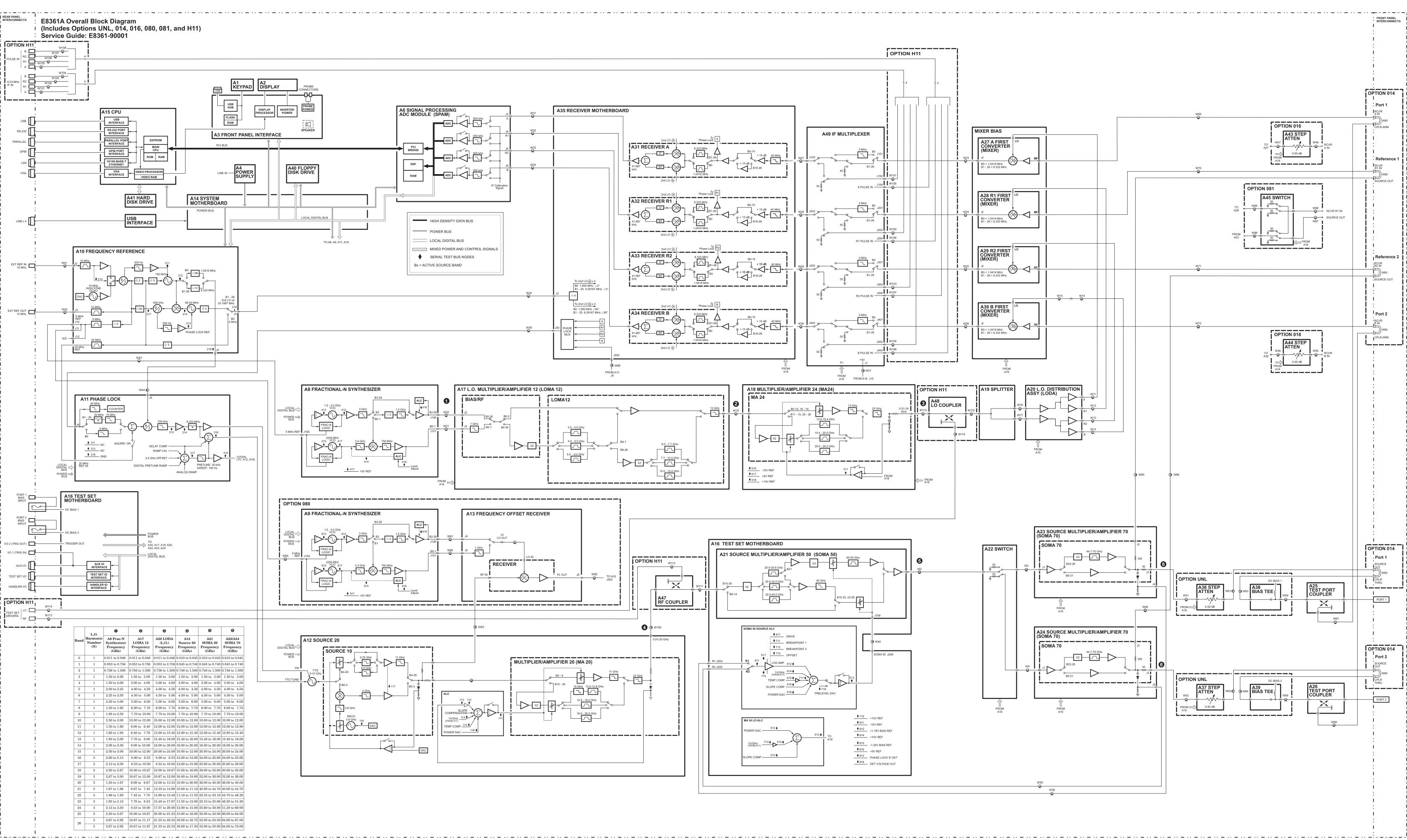
• Refer to the block diagram at the end of this chapter, to "Bottom Assemblies, Options 014/UNL/080/081/H11" on page 6-40, and to "Bottom Flexible RF Cables, All Options" on page 6-44. Locate the semirigid cable W99 at the A45 switch output.

CAUTION Be careful not to damage the center pins of the semirigid cable. Some flexing of the cables is necessary to measure the output.

- 1. Disconnect the W99 semirigid cable at the A45 transfer switch.
- 2. Connect the spectrum analyzer to the switch output (where W99 was connected).
- 3. From the Channel menu, click Test Set. In the Test Set dialog box, click External: flow through R1 loop. Click OK.
- 4. Make sure the front panel jumper is connected between **REFERENCE 1 SOURCE OUT** and **RCVR R1 IN**.
- 5. Set the network analyzer to a CW frequency of 1 GHz.
 - The spectrum analyzer should measure a signal at 1 GHz.

- 6. If the expected signal is present, the A45 transfer switch is functioning properly. Disconnect the spectrum analyzer and reconnect cable W99.
- 7. If the expected signal is not present, the problem could be either the switch or the associated cabling.
- 8. From the Channel menu, click Test Set. In the Test Set dialog box, click Internal: bypass R1 loop. Click OK.
- 9. If the expected signal is still not present, replace the A45 transfer switch. Refer to "Removing and Replacing the A45 Reference Channel Transfer Switch (Option 081)" on page 7-68.
- 10. If the expected signal is present then check the associated cabling:
 - From the Channel menu, click Test Set. In the Test Set dialog box, click External: flow through R1 loop. Click OK
 - Disconnect the front panel jumper and connect the spectrum analyzer to the **REFERENCE 1 SOURCE OUT** connector. If the signal is not present, replace cable W97. If the signal is present, replace cable W98.
 - Reconnect all cables and front panel jumpers.
- 11. If the instrument passes all the tests to this point but you still have a problem with your PNA, contact Agilent Technologies. Refer to "Contacting Agilent" on page 2-11.





Agilent Technologies

m3blk_h11 15 July 2005

5 Theory of Operation

Information in This Chapter

This chapter provides a general description of the operating theory of the E8361A PNA series microwave network analyzer.

- Theory of operation is explained to the assembly level only.
- Component-level circuit theory is not provided.
- Simplified block diagrams are included for each functional group.
- More detailed block diagrams are located at the end of Chapter 4, "Troubleshooting."

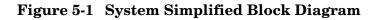
| Section Title | Summary of Content | Start Page |
|--|--|------------|
| Network Analyzer System Operation | A summary of the theory of operation for the analyzer. | Page 5-3 |
| | A summary of the operation of the six functional groups of the analyzer. | |
| Source Group Operation | Operation of the assemblies associated with the source group. | Page 5-6 |
| Signal Separation Group Operation | Operation of the assemblies associated with signal separation, including the operation of Option 014, configurable test set. | Page 5-16 |
| Receiver Group Operation | Operation of the assemblies associated with the receiver group. | Page 5-21 |
| Frequency Offset Group Operation (Options 080 and 081) | Operation of the assemblies associated with frequency offset mode of operation. | Page 5-24 |
| IF Access Group (Option H11) | Operation of the assemblies associated with Option H11, IF access. | Page 5-26 |
| Digital Processing and Digital Control Group Operation | Operation of the assemblies associated with digital processing and control. | Page 5-29 |
| Power Supply Group Operation | Operation of the power supply assembly group. | Page 5-34 |

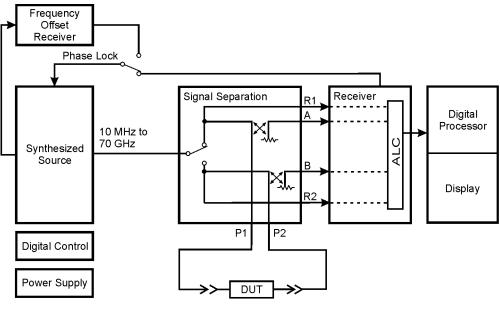
Chapter Five at-a-Glance

IMPORTANT Although simplified block diagrams are included within the description of each functional group, it is recommended that the more detailed block diagrams, located at the end of Chapter 4, be unfolded and available for reference, as you read the information in this chapter.

Network Analyzer System Operation

The PNA series network analyzer generates a phase-locked incident signal from the internal synthesized source. By means of signal separation, the incident signal is divided into a reference signal and a test signal. The reference signal is applied to the receiver group, while the test signal is applied to the device under test (DUT) and then to the receiver group. The signals are downconverted and are next sampled and digitally processed. Figure 5-1 is a simplified block diagram of the network analyzer system.





8361_001_501

Functional Groups of the Network Analyzer

The operation of the network analyzer can be separated into six functional groups. Each group consists of several major assemblies that perform a distinct function in the instrument. Some of the assemblies are related to more than one group, and all the groups, to some extent, are interrelated and affect each other's performance. The six major functional groups are:

- Synthesized Source Group
- Signal Separation Group
- Receiver Group
- Frequency Offset Group
- IF Access Group
- Digital Processor and Digital Control Group
- Power Supply Group

Synthesized Source Group

The built-in synthesized source generates a swept, stepped, or continuous wave (CW) signal in the frequency ranges as listed in Table 5-1. The source output power is leveled by an internal automatic leveling control (ALC) circuit. In the standard analyzer, a portion of the source signal is routed to one of the reference receivers (R1 or R2), and fed back to the source for phase lock. In the Option 080 (frequency offset mode) analyzer, a portion of the source signal is routed to a frequency offset receiver to provide the phase lock signal. The maximum output power level of the network analyzer at the test ports is shown in Table 5-1.

The operation of the source functional group is described in "Source Group Operation" on page 5-6.

| | Frequency Range | | | | | | | | |
|---|-------------------------------------|-------------------------|-------------------------|------------------------|------------------------|------------------------|------------------------|------------------------|-------------------------------------|
| Parameter | 10 MHz to 45 MHz ^a | 45 MHz to 0.5 GHz | 0.5 GHz to 10 GHz | 10 GHz to 30 GHz | 30 GHz to 40 GHz | 40 GHz to 45 GHz | 45 GHz to 50 GHz | 50 GHz to 60 GHz | 60 GHz to 70 GHz ^a |
| Max. Pwr. Out (Standard) (Option 014) | –7 dBm –7 dBm | −3 dBm −3 dBm | 0 dBm 0 dBm | +1 dBm 0 dBm | −1 dBm −2 dBm | –5 dBm –6 dBm | −1 dBm −2 dBm | –3 dBm –4 dBm | –5 dBm –7 dBm |

 Table 5-1
 Frequency Range and Maximum Output Power Level

a. Values for 10 MHz to 45 MHz and 67 GHz to 70 GHz are typical.

Signal Separation Group

The source signal is separated into a reference path and a test path. The reference signal is transmitted to the receiver group. The test signal is transmitted through—and reflected from—the DUT and then is transmitted to the receiver group.

The signal separation group also provides:

- RF path switching to allow forward and reverse measurements
- external connections for the DUT (Option 014)

Refer to "Signal Separation Group Operation" on page 5-16.

Receiver Group

The receiver converts the test signal to a 41 kHz intermediate frequency (IF) for signal processing, retaining both magnitude and phase characteristics. The IF signal is converted to a digital signal by the digital processing group.

Refer to "Receiver Group Operation" on page 5-21.

Frequency Offset Group

This group provides the phase lock needed for frequency offset mode (Option 080), where the source and receivers are tuned to different frequencies.

Refer to "Frequency Offset Group Operation (Options 080 and 081)" on page 5-24.

IF Access Group

This group provides the circuitry needed for the IF access (Option H11) capability.

Option H11 is also necessary for the operation of the pulse measurement capability, Option H08.

Refer to "IF Access Group (Option H11)" on page 5-26.

Digital Processor and Digital Control Group

The digital processor and digital control group are divided into a front panel group and a data acquisition and processing group. The front panel group provides communication to the network analyzer. The data acquisition and processing group provides signal processing and analyzer control, and output to the display.

Refer to "Digital Processing and Digital Control Group Operation" on page 5-29.

Power Supply Group

The power supply functional group provides power for the other assemblies in the instrument.

Refer to "Power Supply Group Operation" on page 5-34.

Source Group Operation

The source group produces a stable output signal by phase locking a yttrium-iron-garnet (YIG) oscillator to a synthesized voltage-controlled oscillator (VCO). Refer to Table 5-2 on page 5-8 for the full frequency range of the source. The outputs at the front panel test ports are swept, stepped or CW signals. Maximum leveled output powers are listed in Table 5-1 on page 5-4. For a simple block diagram of the source group, refer to Figure 5-2.

In this section the following are described:

- Band Modes
- A8 Fractional-N Synthesizer Board
- A17 L.O. Multiplier/Amplifier 12 (LOMA 12)
- A18 Multiplier/Amplifier 24 (MA 24)
- A19 Splitter
- A20 L.O. Distribution Assembly (LODA)
- A10 Frequency Reference Board (including rear-panel interconnects)
- A11 Phase Lock Board
- A12 Source 20
- A21 Source Multiplier/Amplifier 50 (SOMA 50)
- A16 Test Set Motherboard (including rear-panel interconnects)

Band Modes

Table 5-2 on page 5-8 lists the L.O. harmonic number, the synthesizer frequency, the source frequency, and the frequencies at various other locations within the analyzer for each band. This table is referred to throughout this chapter and also appears on the overall block diagram at the end of Chapter 4, "Troubleshooting."

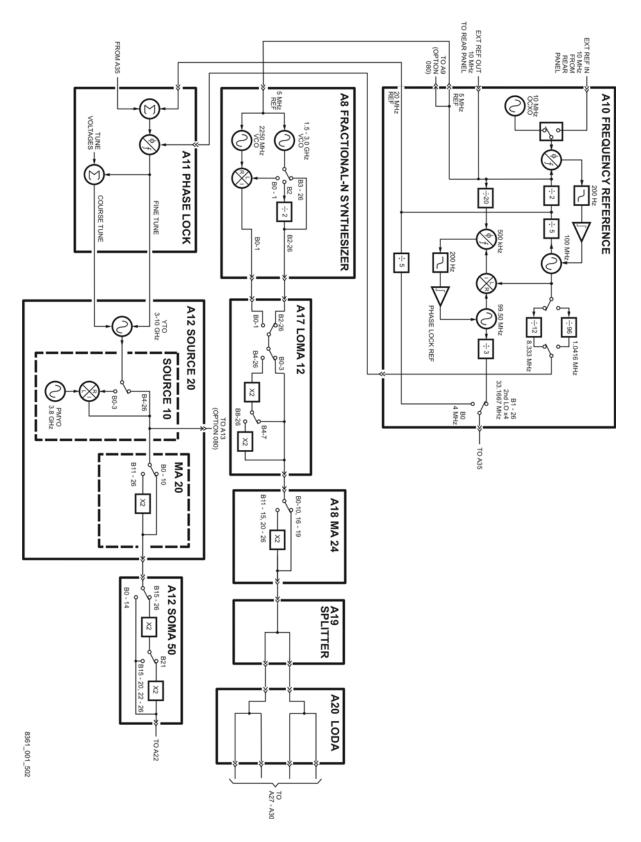
The A10 frequency reference board produces a constant phase locked reference signal of 8.333 MHz (1.0416 MHz for band 0) which is sent to the A11 phase lock board.

The A8 fractional-N synthesizer board produces an LO signal which is sent through the A17–A20 LO distribution path to the A27–A30 first converters. The frequency is synthesized such that the mixing product of this LO signal with the main source output is a constant 8.333 MHz. In the A31–A34 receiver modules, this 1st IF signal is mixed with the 2nd LO signals to produce a constant 2nd IF signal at 41.667 kHz.

A portion of the 1st IF signal is passed through the phase lock multiplexer on the A16 test set motherboard back to the A11 phase lock board to complete the phase lock loop. For Option 080 (frequency offset mode), this phase lock signal comes from the A13 frequency offset receiver. Refer to "Frequency Offset Group Operation (Options 080 and 081)" on page 5-24.

The A10 frequency reference board also produces a constant 33.1667 MHz signal (4 MHz for band 0) which is passed to the A35 receiver motherboard where the frequency is divided by four to produce a constant 2nd LO signal of 8.29167 MHz (1 MHz for band 0). It is then divided into two signals, the 2nd LO (a) and the 2nd LO (b). The 2nd LO (b) signal is phase shifted +90° relative to 2nd LO (a). Both of these signals are then distributed to each of the four receiver modules.

Figure 5-2 Source Group



| | | - | - | | | | |
|---------|-----------------------------|--|--------------------------------------|--|--|--------------------------------------|--|
| Band | L.O. Harmonic Number (N) | A8 Frac-N Synthesizer Frequency (GHz) | A17 LOMA 12 Frequency (GHz) | A20 LODA (L.O.) Frequency (GHz) | A12 Source 20 Frequency (GHz) | A21 SOMA 50 Frequency (GHz) | A23/A24 SOMA 70 Frequency (GHz) |
| 0^{a} | 1 | 0.011 to 0.046 | 0.011 to 0.046 | 0.011 to 0.046 | 0.010 to 0.045 | 0.010 to 0.045 | 0.010 to 0.045 |
| 1 | 1 | 0.053 to 0.756 | 0.053 to 0.756 | 0.053 to 0.756 | 0.045 to 0.748 | 0.045 to 0.748 | 0.045 to 0.748 |
| 2 | 1 | 0.756 to 1.508 | 0.756 to 1.508 | 0.756 to 1.508 | 0.748 to 1.500 | 0.748 to 1.500 | 0.748 to 1.500 |
| 3 | 1 | 1.50 to 3.00 | 1.50 to 3.00 | 1.50 to 3.00 | 1.50 to 3.00 | 1.50 to 3.00 | 1.50 to 3.00 |
| 4 | 1 | 1.50 to 2.00 | 3.00 to 4.00 | 3.00 to 4.00 | 3.00 to 4.00 | 3.00 to 4.00 | 3.00 to 4.00 |
| 5 | 1 | 2.00 to 2.25 | 4.00 to 4.50 | 4.00 to 4.50 | 4.00 to 4.50 | 4.00 to 4.50 | 4.00 to 4.50 |
| 6 | 1 | 2.25 to 2.50 | 4.50 to 5.00 | 4.50 to 5.00 | 4.50 to 5.00 | 4.50 to 5.00 | 4.50 to 5.00 |
| 7 | 1 | 2.50 to 3.00 | 5.00 to 6.00 | 5.00 to 6.00 | 5.00 to 6.00 | 5.00 to 6.00 | 5.00 to 6.00 |
| 8 | 1 | 1.50 to 1.93 | 6.00 to 7.70 | 6.00 to 7.70 | 6.00 to 7.70 | 6.00 to 7.70 | 6.00 to 7.70 |
| 9 | 1 | 1.93 to 2.50 | 7.70 to 10.00 | 7.70 to 10.00 | 7.70 to 10.00 | 7.70 to 10.00 | 7.70 to 10.00 |
| 10 | 1 | 2.50 to 3.00 | 10.00 to 12.00 | 10.00 to 12.00 | 10.00 to 12.00 | 10.00 to 12.00 | 10.00 to 12.00 |
| 11 | 1 | 1.50 to 1.60 | 6.00 to 6.40 | 12.00 to 12.80 | 12.00 to 12.80 | 12.00 to 12.80 | 12.00 to 12.80 |
| 12 | 1 | 1.60 to 1.93 | 6.40 to 7.70 | 12.80 to 15.40 | 12.80 to 15.40 | 12.80 to 15.40 | 12.80 to 15.40 |
| 13 | 1 | 1.93 to 2.00 | 7.70 to 8.00 | 15.40 to 16.00 | 15.40 to 16.00 | 15.40 to 16.00 | 15.40 to 16.00 |
| 14 | 1 | 2.00 to 2.50 | 8.00 to 10.00 | 16.00 to 20.00 | 16.00 to 20.00 | 16.00 to 20.00 | 16.00 to 20.00 |
| 15 | 1 | 2.50 to 3.00 | 10.00 to 12.00 | 20.00 to 24.00 | 10.00 to 12.00 | 20.00 to 24.00 | 20.00 to 24.00 |
| 16 | 3 | 2.00 to 2.13 | 8.00 to 8.53 | 8.00 to 8.53 | 12.00 to 12.80 | 24.00 to 25.60 | 24.00 to 25.60 |
| 17 | 3 | 2.13 to 2.50 | 8.53 to 10.00 | 8.53 to 10.00 | 12.80 to 15.00 | 25.60 to 30.00 | 25.60 to 30.00 |
| 18 | 3 | 2.50 to 2.67 | 10.00 to 10.67 | 10.00 to 10.67 | 15.00 to 16.00 | 30.00 to 32.00 | 30.00 to 32.00 |
| 19 | 3 | 2.67 to 3.00 | 10.67 to 12.00 | 10.67 to 12.00 | 16.00 to 18.00 | 32.00 to 36.00 | 32.00 to 36.00 |
| 20 | 3 | 1.50 to 1.67 | 6.00 to 6.67 | 12.00 to 13.33 | 18.00 to 20.00 | 36.00 to 40.00 | 36.00 to 40.00 |
| 21 | 3 | 1.67 to 1.86 | 6.67 to 7.45 | 13.33 to 14.90 | 10.00 to 11.18 | 40.00 to 44.70 | 40.00 to 44.70 |
| 22 | 3 | 1.86 to 1.93 | 7.45 to 7.70 | 14.90 to 15.40 | 11.18 to 11.55 | 22.35 to 23.10 | 44.70 to 46.20 |
| 23 | 3 | 1.93 to 2.13 | 7.70 to 8.53 | 15.40 to 17.07 | 11.55 to 12.80 | 23.10 to 25.60 | 46.20 to 51.20 |
| 24 | 3 | 2.13 to 2.50 | 8.53 to 10.00 | 17.07 to 20.00 | 12.80 to 15.00 | 25.60 to 30.00 | 51.20 to 60.00 |
| 25 | 3 | 2.50 to 2.67 | 10.00 to 10.67 | 20.00 to 21.33 | 15.00 to 16.00 | 30.00 to 32.00 | 60.00 to 64.00 |
| 26 | 3 | 2.67 to 2.92 | 10.67 to 11.67 | 21.33 to 23.33 | 16.00 to 17.50 | 32.00 to 35.00 | 64.00 to 70.00 ^a |

a. The analyzer presets to 45 MHz to 67 GHz. Frequencies below or above this must be entered directly.

A8 Fractional-N Synthesizer Board

The A8 fractional-N synthesizer board uses the 5 MHz reference signal from the A10 frequency reference board to tune two VCO circuits: one that sweeps from 1500 to 3010 MHz and one that is set to a CW frequency of 2250 MHz.

In bands 0–1, these signals are mixed to produce the output frequencies listed in Table 5-2.

In band 2, the output of the swept VCO is passed through a divide-by-2 circuit to produce the output frequencies listed in Table 5-2. In all other bands, the swept VCO signal is sent directly to the synthesizer output.

At the output, an ALC circuit maintains the power level at $-5 \text{ dBm} \pm 2 \text{ dB}$ for bands 0–2 or $-1.5 \text{ dBm} \pm 1.5 \text{ dB}$ for bands 3–26. In all bands, the output is sent to the A17–A20 LO distribution path and on to the A27–A30 first converters, as the 1st LO signal.

A17 L.O. Multiplier/Amplifier 12 (LOMA 12)

In bands 0–3, the input signal from the A8 fractional-N synthesizer board is passed through the A17 LOMA 12 unchanged. For all other bands, the signals are doubled, filtered, and amplified. In bands 8–26, the signals are again doubled, filtered, and amplified. Together, all of these signal paths create the full output frequency range of 11 MHz to 12 GHz.

A18 Multiplier/Amplifier 24 (MA 24)

In bands 0-10 and 16-19, the 11 MHz to 12 GHz input frequencies are filtered, amplified, and passed through the A18 MA 24. In bands 11-15, and 20-26, the signals are doubled, filtered, and amplified.

Together, these signal paths create the full output frequency range of 11 MHz to 24 GHz that is sent to the A19 splitter.

A19 Splitter

The A19 splitter receives the 11 MHz to 24 GHz LO signal from the A8, A17, and A18 LO generation chain and divides it into two signals which are routed to the A20 L.O. distribution assembly (LODA). This splitter configuration provides the highest level of balance and control of the LO signal.

A20 L.O. Distribution Assembly (LODA)

In the A20 LODA, the LO signal is amplified and split to provide balanced LO signals to each of the A27–A30 receiver first converters.

A10 Frequency Reference Board

This assembly provides stable reference frequencies to the rest of the instrument. A high stability 10 MHz oven-controlled crystal oscillator (OCXO) normally provides the frequency standard. However, if a 10 MHz external reference signal is detected at the 10 MHz EXT REF IN port on the rear panel, it is used as the frequency reference instead.

The 10 MHz reference signal is used to phase lock a 100 MHz VCO. This VCO is then used to phase lock a second VCO at 99.5 MHz. It is also used to provide the 10 MHz EXT REF OUT rear panel signal, a 20 MHz reference for the A11 phase lock board, and a 5 MHz reference for the A6 signal processing ADC module (SPAM) board, the A8 fractional-N synthesizer board, and the A9 fractional-N synthesizer board (Option 080 only).

The 95.5 MHz reference signal is sent through a divide-by-3 circuit to produce the fourth multiple of the 8.29167 MHz 2nd LO signal (33.1667 MHz) for bands 1-26 which is sent to the A35 receiver motherboard.

The 20 MHz reference is sent through a divide-by-5 circuit to produce the 4 MHz signal sent to the A35 receiver motherboard to produce the 1 MHz 2nd LO signal for band 0.

The 100 MHz reference signal is sent through either a:

- divide-by-12 circuit to produce the 8.3333 MHz phase lock reference signal for bands 1-26, or a
- divide-by-96 circuit to produce the 1.0416 MHz phase lock reference signal for band 0.

One of these is selected to be sent to the A11 phase lock board.

| 10 MHz REF. INPUT | A BNC connector that allows an external frequency reference signal to be used to phase lock the analyzer for increased frequency accuracy. | |
|--------------------|--|--|
| | The analyzer automatically enables the external frequency reference feature when a signal is connected to this input. When the signal is removed, the analyzer automatically switches back to its internal frequency reference. | |
| 10 MHz REF. OUTPUT | A BNC connector that allows a 10 MHz reference signal, produced by the A10 frequency reference board, to be output for use in phase locking external test equipment. | |

Rear-Panel Interconnects

A11 Phase Lock Board

The A11 phase lock board compares the phase lock IF signal from the A35 receiver motherboard with the phase lock reference signal from the A10 frequency reference board to generate the tuning voltage for the A12 source 20 YIG-tuned oscillator (YTO). In addition, various digital-to-analog converters (DACs) on this assembly are set by the A6 SPAM board to inject offset and delay voltages for the various source bands and measurement sweep rates.

A12 Source 20

The A12 source 20 consists of:

- Source 10
- Multiplier/Amplifier 20 (MA 20)
- ALC Circuitry

Source 10

The A12 source 20 contains a 3–10 GHz YIG-tuned oscillator (YTO) and a fixed frequency 3.8 GHz permanent-magnet YIG oscillator (PMYO).

The YTO has a main coil and an FM coil. These are analogous to the woofer and the tweeter in a stereo speaker: the woofer reproduces low frequencies and the tweeter reproduces high frequencies. Similarly in the YTO, the main coil allows large, slow changes in frequency but cannot respond to high frequency deviations, which are sent to the faster-acting FM coil.

The tune current from the A11 phase lock board splits into two paths. One path is low-pass filtered, removing high frequency components, and goes to the YTO main coil; the other path is highpass filtered, removing low frequency components, and goes to the YTO FM coil. The filters are matched in stop-band response, such that one picks up where the other leaves off.

The frequency of the PMYO is set by a voltage from a DAC set by the A6 SPAM board.

In bands 0–3, the 3.810 to 6.8 GHz output of the YTO and the 3.8 GHz output of the PMYO are mixed to produce the 10 MHz to 3.0 GHz output frequency that is sent to the multiplier/amplifier 20 (MA 20). In bands 4–26, the 3 to 10 GHz output of the YTO is filtered and sent directly to the MA 20.

An additional signal is split off from the output signal and routed to the A13 Frequency Offset Receiver Assembly (Option 080) where it is used to create the phase lock signal for the frequency offset mode of operation (Option 080). Refer to Frequency Offset Group Operation (Options 080 and 081).

Multiplier/Amplifier 20 (MA 20)

The MA 20 filters, amplifies, and passes through, the 10 MHz to 10 GHz output frequencies in bands 0–10. The signals for bands 11–26 are doubled, filtered, and amplified. Together, these two paths produce an output frequency range of 10 MHz to 20 GHz.

This signal is sent to the A21 source multiplier/amplifier 50 (SOMA 50).

A portion of this output signal is split off and combined with other inputs in the ALC circuitry to control the output power level.

ALC Circuitry

The following inputs are combined in the ALC circuitry to produce a signal that is sent to the MA20 to control its output power level:

- output of the MA 20 (within the A12 source)
- temperature compensation
- slope compensation
- power level DAC
- 1V/GHz signal from the A11 phase lock board

A21 Source Multiplier/Amplifier 50 (SOMA 50)

The A21 SOMA 50 consists of three signal paths:

- In the first path, the 10 MHz to 20 GHz source signals for bands 0–14 are leveled, amplified, and passed through to the A22 switch.
- In the second path, the 10 to 20 GHz signals for bands 15–20, and 11.8 to 17.5 GHz signals for bands 22–26, are doubled, filtered, and amplified to produce 20 to 40 GHz and 22.35 to 35 GHz outputs respectively. (The band 22–26 signals are again doubled in the SOMA 70 to provide the 44.7 to 70 GHz outputs.)

• In the third path, a portion of the second-path signal is doubled to produce the 40.0 to 44.7 GHz output for band 21.

The source ALC circuitry (located on the A16 test set motherboard) provides feedback to the SOMA 50 to control the output power level.

A23 and A24 Source Multiplier/Amplifier 70 (SOMA 70)

Refer to "A23 and A24 Source Multiplier/Amplifier 70 (SOMA 70)" on page 5-17.

A16 Test Set Motherboard

The A16 test set motherboard serves these functions:

- to act as an interface between the A15 CPU board and the auxiliary rear panel interconnects.
- to provide ALC signals to the A21 SOMA 50 and to the A18 multiplier/amplifier.
- to route control signals to the signal separation group. Refer to "Signal Separation Group Operation" on page 5-16 for more information.

Rear Panel Interconnects

The A16 test set motherboard includes the following rear panel interconnects.

| TEST SET I/O | A DB-25 female connector that is used to control external test sets. The external test set bus consists of 13 multiplexed address and data lines, three control lines, and an open-collector interrupt line. Pin assignments are listed in Table 5-3 on page 5-13. | | | |
|------------------|--|--|--|--|
| | Up to 16 test sets may be "daisy-chained" on the bus at one time. | | | |
| | The Test Set I/O is not compatible with 8753 network analyzer test sets. | | | |
| HANDLER I/O | A rectangular 36-pin, female connector providing four independent parallel input/output ports, nine control signal lines, one ground, and a power supply line. This connector has Type 2 output pin assignments as listed in Table 5-4 on page 5-14. | | | |
| | All signals are TTL-compatible. Data input/output ports consist of two 8-bit output ports (Port A and Port B) and two 4-bit bidirectional ports (Port C and Port D). | | | |
| | Connector settings can be changed using SCPI and COM commands. The settings are not accessible from the front panel. | | | |
| AUX I/O | A DB-25 male connector that provides a variety of both analog and digital input and output signals as described in Table 5-5 on page 5-15. | | | |
| I/O 1 (TRIG IN) | A BNC connector for input of an external trigger. The analyzer can be triggered by an external device using this input. This is the same signal that appears on AUX I/O pin 19 as described in Table 5-5 on page 5-15. | | | |
| I/O 2 (TRIG OUT) | A BNC connector for output of a trigger signal. This trigger signal can be used to trigger external devices used in the measurement setup, such as signal generators. | | | |

| Image: Connector Image: Connector Image: Connector Image: Connector | | | |
|---|------------------|--|--|
| Pin Numbers Name Function | | Function | |
| 1 | SEL0 | TTL out, test set select bit 0, tied to 0 V | |
| 2 | Sweep Holdoff In | TTL in, low level holds off sweep | |
| 3–6 | AD12–AD8 | TTL I/O, address and latched data | |
| 7 | GND | 0 V, ground reference | |
| 8 | LAS | TTL out, active low address strobe (1 μ s min) | |
| 9–11 | AD4–AD2 | TTL I/O, address and latched data | |
| 12 | GND | 0 V, ground reference | |
| 13 | Interrupt In | TTL in, low level (10 μs min) aborts sweep | |
| 14 | +22 V | +22 Vdc, 100 mA max. | |
| 15–16 | SEL1-2 | TTL out, test set select bits 1-2, tied to 0 V | |
| 17 | AD11 | TTL I/O, address and latched data | |
| 18 | SEL3 | TTL out, test set select bit 3, tied to 0 V | |
| 19–21 | AD7–5 | TTL I/O, address and latched data | |
| 22–23 | AD0-1 | TTL I/O, address and latched data | |
| 24 | LDS | TTL out, active low data strobe (1 µs min) | |
| 25 | RLW | TTL out, high = read, low = write | |

Table 5-3 TEST SET I/O Connector Pin Assignments

| () 123456789101112131415161718 sz348a Rectangular 36-Pin Female Connector | | | |
|--|-------------------------------|---|--|
| Pin Numbers | Name | Function | |
| 1 | GND | 0 V, ground reference | |
| 2 | INPUT1 | TTL in, negative pulse (1 μ s min) latches OUTPUT1-2 | |
| 3-4 | OUTPUT1–2 | TTL out, latched | |
| 5-12 | Port A0–7 Out | TTL out, latched | |
| 13–20 | Port B0–7 Out | TTL out, latched | |
| 21–24 | Port C I/O | TTL I/O, latched | |
| 25-28 | Port D I/O | TTL I/O, latched | |
| 29 | Port C Status | TTL out, low = input mode, high = output mode | |
| 30 | Port D Status | TTL out, low = input mode, high = output mode | |
| 31 | Output Strobe Write Strobe | TTL out, active low data write strobe (1 μs min) | |
| 32 | No connect | Not used | |
| 33 | Pass Fail | TTL out, latched, indicates pass fail (programmable polarity) | |
| 34 | +5 V | +5 Vdc, 100 mA max. | |
| 35 | Sweep End | TTL out, active low (10 μs min) indicates sweep done | |
| 36 | Pass/Fail Write Strobe | TTL out, active low pass/fail write strobe (1 μ s min) | |

 Table 5-4
 HANDLER I/O Connector Key Pin Assignments

1

| $\bigcirc \qquad (\bigcirc \ (\bigcirc \ (\bigcirc \ (\bigcirc \ () \ () \ () \ () \$ | | | | | |
|---|-----------------------------|---|--|--|--|
| | DB-25 Male Connector | | | | |
| Pin Numbers | Name Function | | | | |
| 1 | ACOM | 0 V, ground reference for analog signals | | | |
| 2–3 | Analog Out 2–1 | -10 to $+10$ Vdc output, 10 mA max, Ro = 100Ω | | | |
| 4 | No connect | For future enhancements | | | |
| 5 | DCOM | 0 V, ground reference for digital signals | | | |
| 6–8 | Pulse Out 3–1 | TTL out, programmable pulse (for future use) | | | |
| 9 | +5 V | +5 Vdc output, 100 mA max. | | | |
| 10 | Pass/Fail Write Strobe | TTL out, active low (1 μs min) indicates pass/fail line is valid | | | |
| 11 | Sweep End | TTL out, active low (10 μs min) indicates sweep is done | | | |
| 12 | Pass/Fail | TTL out, latched, indicates pass or fail (programmable polarity) | | | |
| 13 | Output Port Write Strobe | TTL out, active low (10 μs min) writes I/O port data | | | |
| 14 | Analog In | -10 to $+10$ Vdc input, Ri = 100k Ω | | | |
| 15 | ACOM | 0 V, ground reference for analog signals | | | |
| 16 | Power Button In | Open-collector input, active low replicates a power button press | | | |
| 17 | DCOM | 0 V, ground reference for digital signals | | | |
| 18 | Ready for Trigger | TTL out, low indicates ready for external trigger | | | |
| 19 | External Trigger In | TTL in, level trigger (width >1 µs), programmable polarity | | | |
| 20 | Footswitch In | TTL in, active low (width >1 µs), triggers a programmable event | | | |
| 21 | +22 V | +22 Vdc output, 100 mA max. | | | |
| 22-25 | In/Out Port C0–3 | TTL I/O, general purpose | | | |

Table 5-5 AUX I/O Connector Pin Assignments

Signal Separation Group Operation

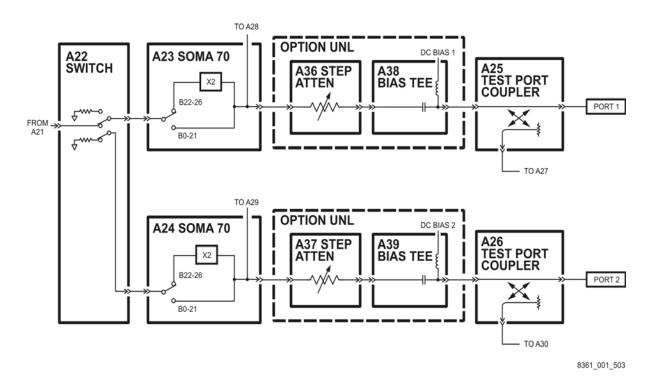
The signal separation group divides the source signal into a reference path and a test path. Refer to Figure 5-3 on page 5-16.

- The reference signal is transmitted to the receiver group.
- The test signal is transmitted through—and reflected from—the device under test (DUT) and then is transmitted to the receiver group.
- Control lines to this group are routed from the A16 test set motherboard.

In this section, the following assemblies are described:

- A22 Switch
- A23 and A24 Source Multiplier/Amplifier 70 (SOMA 70)
- A25 and A26 Test Port Couplers
- A36 and A37 50-dB Source Step Attenuators (Option UNL)
- A38 and A39 Bias Tees (Option UNL)
- A43 and A44 50-dB Receiver Step Attenuators (Option 016)
- Front Panel Jumpers (Option 014 Configurable Test Set)

Figure 5-3 Signal Separation Group, Analyzer without Option 014



A22 Switch

The output of the A21 SOMA 50 is routed to the A22 switch. The A22 switch is a solid-state switch that switches the signal between the A23 SOMA 70 (Port 1 measurement path) and A24 SOMA 70 (Port 2 measurement path), automatically enabling alternate forward and reverse measurements. The A22 switch provides an internal termination for the measurement port that is inactive.

A23 and A24 Source Multiplier/Amplifier 70 (SOMA 70)

The A23 and A24 SOMA 70 each consist of two signal paths:

- In the first path, the 10 MHz to 44.7 GHz source signals for bands 0–21 are amplified and passed through to the test port coupler.
- In the second path, the 22.35 GHz to 35 GHz signals for bands 22–26 are doubled, filtered, and amplified to produce the 44.7 to 70 GHz output.

A portion of each of the SOMA 70 output signals is split off to provide reference signals for the R1 and R2 channels.

A25 and A26 Test Port Couplers

The test port signal goes into the through-line arm of the couplers, and from there to the test ports and the DUT. The coupled arm of the couplers carries the signal reflected from or transmitted through the DUT, to the receiver (through a front panel jumper for Option 014) for measurement. The coupling coefficient of the directional couplers is nominally 15 dB over the full frequency range.

A36 and A37 50-dB Source Step Attenuators (Option UNL)

The 50-dB step attenuators provide coarse power control for the test port signals. They are electro-mechanical step attenuators that provide 0 to 50 dB of attenuation in 10-dB steps. These attenuators are controlled by the A15 CPU board. They adjust the power level to the DUT without changing the level of the incident power in the reference path.

A38 and A39 Bias Tees (Option UNL)

The A38 and A39 bias tees provide a means of biasing active devices with an external dc voltage connected to the rear-panel DC BIAS CONNECT ports. The dc voltage is applied directly to the center conductor of the test port connectors. A blocking capacitor ensures that the dc bias current goes only to the DUT, and not back into the source. Similarly, an inductor in the bias path prevents RF from being imposed on the external dc supply.

A43 and A44 50-dB Receiver Step Attenuators (Option 016)

These 50-dB step attenuators provide coarse power control for amplified input. They are electro-mechanical step attenuators that provide 0 to 50 dB of attenuation in 10-dB steps. These attenuators are controlled by the A15 CPU board.

Option 014 Configurable Test Set

The Option 014 analyzer allows you to measure devices with higher power and higher dynamic range limits than the standard analyzer. The theory of operation is the same as for the standard analyzer except that there are six front panel SMA jumpers.

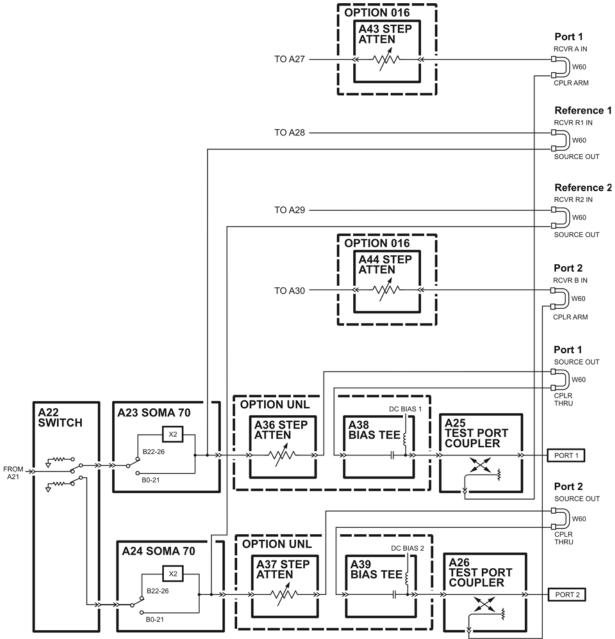
As shown in Figure 5-4 on page 5-19, these jumpers allow access to the test port and reference signals between:

- the A23 SOMA 70 and the A25 test port 1 coupler
- the A24 SOMA 70 and the A26 test port 2 coupler
- the A25 test port 1 coupler and the A27 receiver A first converter
- the A26 test port 2 coupler and the A30 receiver B first converter
- the A23 SOMA 70 and the A28 receiver R1 first converter
- the A24 SOMA 70 and the A29 receiver R2 first converter

Normal Option 014 Configuration

The normal configuration for the Option 014 is shown in Figure 5-4. With this configuration and inclusion of an external amplifier and accessories, you can calibrate the analyzer and test devices at power levels up to +30 dBm. You can make measurements in the forward, reverse or both directions and still achieve these high power levels. For more information on higher power measurements, search for "Option 014" in the embedded help index in the analyzer.

Figure 5-4 Signal Separation Group, Option 014 Analyzer



8361_001_504

High Dynamic Range Configuration

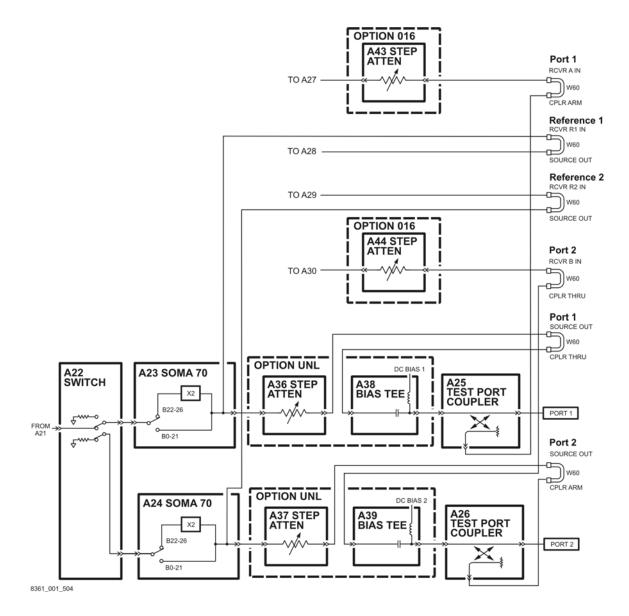
With a few jumper changes, you can configure the Option 014 for higher dynamic range measurements. By swapping the front panel jumpers for one port, signal flow through the corresponding coupler is reversed, increasing the test signal sensitivity by 15 dB.

In the forward direction, as shown in Figure 5-5, the signal flow through the test port coupler (A26) is reversed by arranging the front panel jumpers such that RCVR B IN connects to CPLR THRU and CPLR ARM connects to SOURCE OUT.

In the reverse direction, not shown, the signal flow through the test port coupler (A25) is reversed by arranging the front panel jumpers such that RCVR A IN connects to CPLR THRU and CPLR ARM connects to SOURCE OUT.

For more information on high dynamic range measurements and configurations, search for "Option 014" in the embedded help index in the analyzer.

Figure 5-5 High Dynamic Range Configuration in the Forward Direction



Receiver Group Operation

The receiver group measures and processes the input signals into digital information for processing and eventual display. Figure 5-6 on page 5-22 is a simplified block diagram of the receiver functional group.

In this section the following assemblies are described:

- A27, A28, A29, and A30 Receiver First Converters (Mixers)
- A49 IF Multiplexer Board
- A31, A32, A33, and A34 Receiver Modules
- A6 SPAM Board (Analog Description)
- A35 Receiver Motherboard
- A16 Test Set Motherboard

A27, A28, A29, and A30 Receiver First Converters (Mixers)

The four receiver first converters (mixers) function identically and are completely interchangeable.

Each first converter receives the RF reference or test signal and mixes it with the 1st LO signal from the A20 LODA to create the 1st IF signal at a constant 8.333 MHz for bands 1–26 or 1.0416 MHz for band 0. This 1st IF signal is sent to the A49 IF multiplexer board.

A49 IF Multiplexer Board

In each of the four channels, a 3 MHz lowpass filter is switched into the signal path for band 0, to allow only the 1st IF signal of 1.0416 MHz to pass but higher frequencies to be blocked. See "IF Access Group (Option H11)" on page 5-26 also.

A31, A32, A33, and A34 Receiver Modules

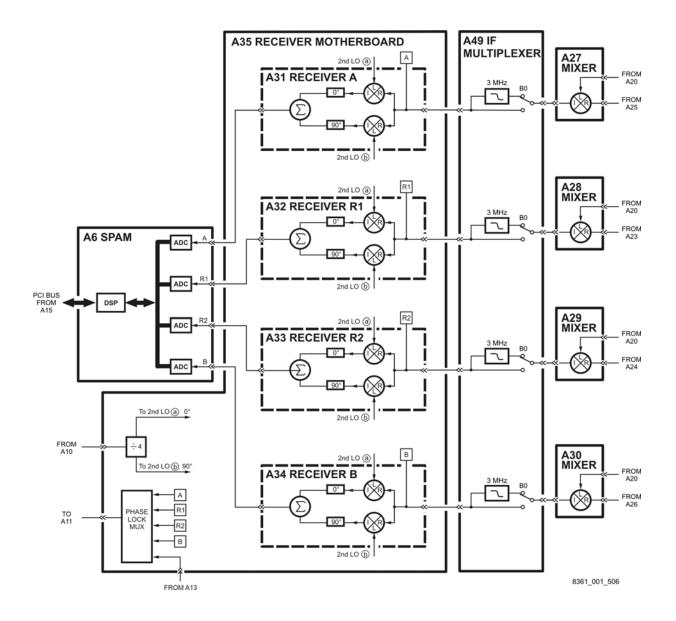
The four receiver modules function identically and are completely interchangeable.

The 8.333 MHz 1st IF signal is filtered and amplified. For bands 16–26, additional amplification is applied to overcome conversion loss of the A27–A30 first converters in their third-order conversion mode.

A portion of the 8.333 MHz 1st IF signal is sent to a multiplexer on the A35 receiver motherboard, the output of which is routed to the A11 phase lock board to complete the phase lock loop. The 8.333 MHz 1st IF signal is also filtered, amplified, and routed to the 2nd converter.

The 2nd converter divides the 8.333 MHz signal into two paths and mixes each with a separate LO signal, designated 2nd LO (a) and 2nd LO (b). These 2nd LO signals are 8.29167 MHz for bands 1–26 and 1 MHz for band 0. The 2nd LO (b) signal is phase shifted +90° relative to the 2nd LO (a) signal. The two generated 2nd IF (a) and 2nd IF (b) signals are a constant 41.667 kHz and are phase shifted –45 degrees and +45 degrees, respectively. These signals are summed together and routed to the A6 signal processing and ADC module (SPAM) board.

Figure 5-6 Receiver Group



A6 SPAM Board (Analog Description)

The A6 SPAM board contains digital and analog circuitry. For digital descriptions, refer to "A6 SPAM Board (Digital Description)" on page 5-32.

In this assembly, the 2nd IF signals from the A, B, R1, and R2 second converters go through a gain stage where signals less than -40 dBm are amplified by 34 dB to ensure that they can be detected by the analog-to-digital converter (ADC).

All four signals are sampled simultaneously by the ADCs, where they are converted to digital form. The ADC conversions are triggered by timing signals from the digital signal processor (DSP) in response to commands from the central processing unit (CPU). The digitized data is processed into magnitude and phase data by the DSP and sent to the CPU random access memory (RAM) by way of the peripheral component interconnect (PCI) bus.

The processed and formatted data is finally routed to the display, and to the general-purpose interface bus (GPIB) for remote operation. Refer to "Digital Processing and Digital Control Group Operation" on page 5-29 for more information on signal processing.

A35 Receiver Motherboard

The A35 receiver motherboard:

- supplies power and signal leveling control to the A31, A32, A33, and A34 receiver modules
- selects a phase lock signal and routes it to the A11 phase lock board
- receives the 2nd LO signal from the A10 frequency reference board

Power and Signal Leveling Control

Power and signal leveling control signals are received from the A16 test set motherboard and routed to each of the receiver modules.

Phase Lock Control

A portion of the 8.333 MHz 1st IF signal from each of the receiver modules is routed to a multiplexing circuit. For Option 080 (frequency offset mode), an additional signal is input to the multiplexer from the A13 Frequency Offset Receiver Assembly (Option 080). With control from the A15 CPU board, one of these five signals is selected for routing to the A11 phase lock board to complete the phase lock loop.

2nd LO Control

The 33.1667 MHz signal from the A10 frequency reference board is divided by four, and then divided into two paths, designated 2nd LO (a) and 2nd LO (b). The 2nd LO (b) signal is phase shifted $+90^{\circ}$ relative to the 2nd LO (a) signal.

Frequency Offset Group Operation (Options 080 and 081)

The frequency offset group provides the circuitry necessary to phase lock the analyzer while the source and receiver are tuned to different frequencies. Figure 5-7 on page 5-25 is a simplified block diagram of the frequency offset functional group.

In this section the following assemblies are described:

- A9 Fractional-N Synthesizer Board (Option 080)
- A13 Frequency Offset Receiver Assembly (Option 080)
- A45 Reference Transfer Switch (Option 081)

A9 Fractional-N Synthesizer Board (Option 080)

The A9 fractional-N synthesizer is identical to the A8 fractional-N synthesizer. Therefore, the values listed in Table 5-2 on page 5-8 for the A8, apply to both the A8 and A9.

The A9 fractional-N synthesizer board uses the 5 MHz reference signal from the A10 frequency reference board to tune two VCO circuits: one that sweeps from 1500 to 3010 MHz and one that is set to a CW frequency of 2250 MHz. In bands 0–1, these two signals are heterodyned to produce the output frequencies listed in Table 5-2 on page 5-8. In band 2, the output of the swept VCO is passed through a divide-by-2 circuit to produce the output frequencies listed in Table 5-2. In all other bands, the swept VCO signal is sent directly to the synthesizer output.

At the output, an ALC circuit maintains the power level at $-5 \text{ dBm} \pm 2 \text{ dB}$ for bands $0-2 \text{ or} -1.5 \text{ dBm} \pm 1.5 \text{ dB}$ for bands 3-26. In all bands, the output is sent to the A13 frequency offset receiver assembly.

A13 Frequency Offset Receiver Assembly (Option 080)

The A13 frequency offset receiver assembly consists of a frequency offset receiver board and a separate receiver module.

The output of the A9 fractional-N synthesizer board is directed to the receiver module where it is mixed with a signal from the A12 source assembly to produce a phase lock output signal.

This phase lock signal is sent to a multiplexer on the A35 receiver motherboard, the output of which is routed to the A11 phase lock board to complete the phase lock loop. Refer to "Phase Lock Control" on page 5-23.

A45 Reference Transfer Switch (Option 081)

The A45 reference transfer switch are used to direct the reference signal to either an external reference mixer or directly to the A28 channel R1 first converter (mixer). Refer to "A27, A28, A29, and A30 Receiver First Converters (Mixers)" on page 5-21.

This allows an external reference mixer to be switched in or out of the measurement setup without the need to manually disconnect and reconnect cables.

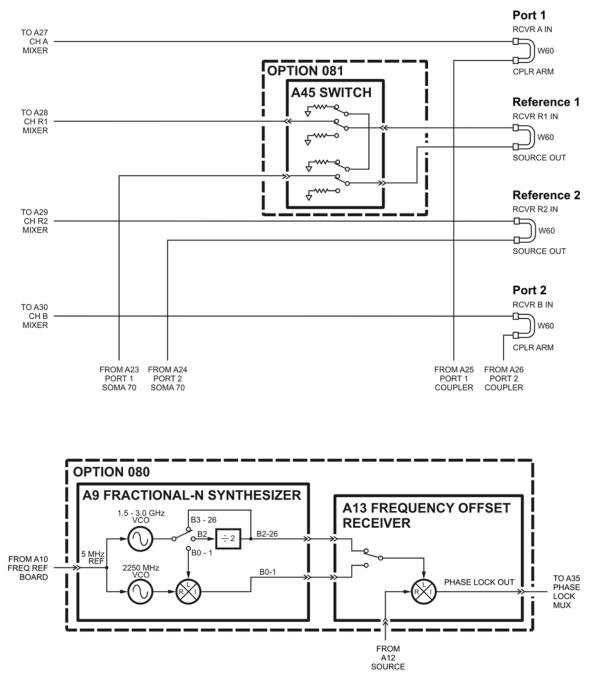


Figure 5-7 Frequency Offset Group (Options 080 and 081)

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IF Access Group (Option H11)

The IF access group is additional hardware included in the PNA that allows for external connection to the internal IF path of the analyzer.

The following assemblies and components are included in the IF access group:

- A47 RF Path Coupler
- A48 LO Path Coupler
- A49 IF Multiplexer Board
- Rear-Panel Connections
 - TEST SET DRIVERS
 - PULSE IN
 - 8.33 MHz IF IN

A47 RF Path Coupler

The A47 RF path coupler is located in the RF path of the PNA between the A12 source and either the A21 SOMA 50 (for E8363/4B) or the A22 switch (for E8362B). A portion of the RF signal is coupled off and delivered to the rear-panel TEST SET DRIVERS RF connector.

A48 LO Path Coupler

The A48 LO path coupler is located in the LO path of the PNA between the A18 MA24 and the A19 splitter. A portion of the LO signal is coupled off and delivered to the rear-panel TEST SET DRIVERS LO connector.

A49 IF Multiplexer Board

The A49 IF multiplexer board provides the circuitry to allow the external pulse and IF signals to be input.

Rear-Panel Connections

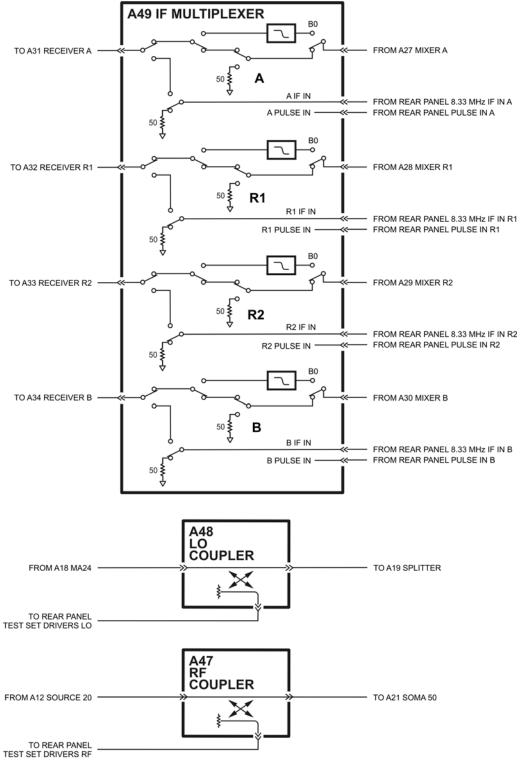
TEST SET DRIVERS: A portion of the RF path signal and the LO path signal is coupled off and routed to the rear panel TEST SET DRIVERS RF and LO connectors. These connectors provide access to the RF and LO signals for use by an external test set.

PULSE IN: An RF pulse input connection is provided for each of the four receiver channels (A, R1, R2, and B) via four rear-panel connectors. These signals are routed to the A49 IF multiplexer board where they can be switched into the signal path of each of the four measurement channels.

8.33 MHz IF IN: An 8.33 MHz IF input connection is provided for each of the four receiver channels (A, R1, R2, and B) via four rear-panel connectors. These signals are routed to the A49 IF multiplexer board where they can be switched into the signal path of each of the

four measurement channels.

Figure 5-8 IF Access Group



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Digital Processing and Digital Control Group Operation

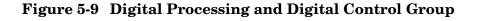
The digital processor and control group provides digital control for the entire analyzer. It provides:

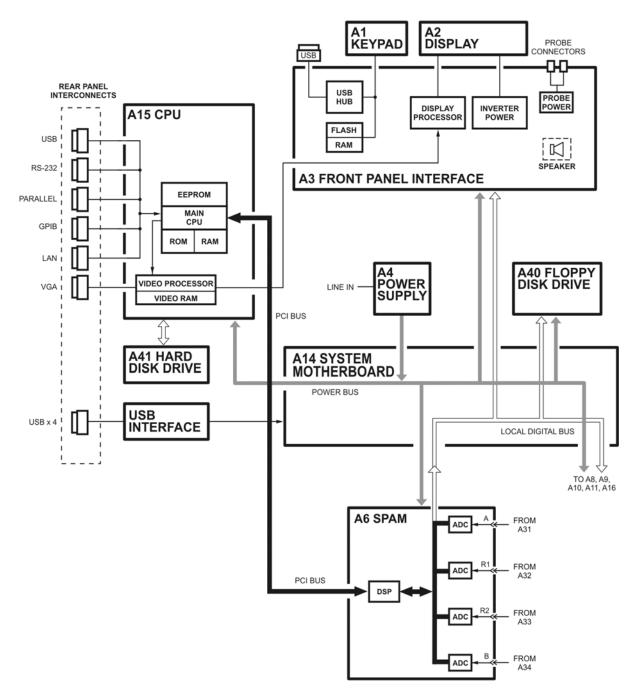
- front panel operation,
- output to the display,
- math processing functions, and
- communications between the analyzer and an external controller or peripherals.

A block diagram of the digital control functional group is shown in Figure 5-9 on page 5-30.

The digital control functional group consists of two subgroups:

- Front Panel Subgroup
 - A1 Keypad Assembly
 - A2 Display Assembly
 - A3 Front Panel Interface Board
 - A14 system motherboard
- Data Acquisition and Processing Subgroup
 - A6 SPAM Board (Digital Description)
 - A15 CPU Board
 - A40 Floppy Disk Drive
 - A41 Hard Disk Drive
 - USB Hub





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Front Panel Subgroup

The front panel subgroup contains the following assemblies:

- A1 Keypad Assembly
- A2 Display Assembly
- A3 Front Panel Interface Board

A1 Keypad Assembly

The A1 keypad assembly provides user interface to the analyzer. The front panel rotary pulse generator (RPG) knob is not electrically connected to the keypad, but rather provides user inputs directly to the front panel processor.

A2 Display Assembly

The A2 display assembly contains an 8.4 inch LCD with associated drive circuitry and backlight inverter. Two cables between the A2 display assembly and the A3 front panel interface board provide all necessary power and data for normal operation. The two cables are:

- 1. A cable to the inverter that supplies buffered power.
- 2. A cable to the display circuitry that supplies decoded data from the video processor on the A15 CPU board and the necessary drive circuit power. The video data received from the A15 CPU board includes the following:
 - digital TTL horizontal sync digital TTL blue video
 - digital TTL vertical sync blanking
 - digital TTL red video data clock
 - digital TTL green video

A3 Front Panel Interface Board

The A3 front panel interface board detects and decodes user inputs from the A1 keypad assembly and front panel knob, and transmits them to the A15 CPU board by way of the A14 system motherboard. It also decodes video data from the video processor on the A15 CPU board and supplies this to the A2 display assembly. Power from the power bus on the A14 system motherboard is buffered and routed to the A1 keypad assembly and the A2 display assembly. All data and power signals are routed through a single cable connector to the A14 system motherboard.

| USB | A universal serial bus (USB) jack (an industry standard 4-pin connector). |
|-------------|--|
| Probe Power | Two identical connectors (fused inside the instrument) that supply power to an active probe for in-circuit measurements of ac circuits. |
| Speaker | A speaker that emits the audio signals received from the A15 CPU board. |

The A3 front panel interface board also includes the following items:

Data Acquisition and Processing Subgroup

The data acquisition and processing subgroup contain the following assemblies. See Figure 5-9 on page 5-30.

- A6 SPAM Board (Digital Description)
- A15 CPU Board (including rear-panel interconnects)
- A40 Floppy Disk Drive
- A41 Hard Disk Drive
- USB Hub

A6 SPAM Board (Digital Description)

The A6 SPAM board contains digital and analog circuitry. For analog descriptions, refer to "A6 SPAM Board (Analog Description)" on page 5-23.

The digital signal processor (DSP) receives digitized data from the digital circuitry of the A6 SPAM board. It computes discrete Fourier transforms to extract the complex phase and magnitude data from the 41.667 kHz IF signal. The resulting raw data is written into the main random access memory (RAM). The data taking sequence is triggered either externally from the rear panel or by firmware on the A15 CPU board.

A15 CPU Board

The A15 CPU board contains the circuitry to control the operation of the analyzer. Some of the components include the central processing unit (CPU), memory (EEPROM, ROM, RAM), bus lines to other board assemblies, and connections to the rear panel. Some of the main components are described next:

- CPU
- Main RAM
- Rear Panel Interconnects

CPU The central processing unit (CPU) is a microprocessor that maintains digital control over the entire instrument through the instrument bus. The CPU receives external control information from the keypad, any USB device, LAN or GPIB, and performs processing and formatting operations on the raw data in the main RAM. It controls the DSP, the video processor, and the interconnect port interfaces. In addition, when the analyzer is in the system controller mode, the CPU controls peripheral devices through the peripheral port interfaces.

Front panel settings are stored in SRAM, with a battery providing at least five years of backup storage when external power is off.

Main RAM The main random access memory (RAM) is shared memory for the CPU and the DSP. It stores the raw data received from the DSP while additional calculations are performed on it by the CPU. The CPU reads the resulting formatted data from the main RAM, converts it to a user-definable display format, and writes this to the video processor for display.

| USB | A universal serial bus (USB) jack (an industry standard 4-pin connector). | | | |
|---------------|---|--|--|--|
| GPIB | A 24-pin, female, type D-24 connector that meets IEEE-488 standards. | | | |
| Serial | A 9-pin, male, RS-232 compatible, D-sub connector. | | | |
| Parallel | A 36-pin, mini-D, 1284-C connector that provides connection to printers or any other parallel port peripheral. | | | |
| LAN | A standard 8-pin, 10/100BaseT, Ethernet connection. It auto selects between the two data rates. | | | |
| Display (VGA) | A 15-pin, female, D-sub connector that provides a video output of the analyzer display that can be viewed on an external VGA monitor. | | | |

Rear Panel Interconnects The rear panel includes the following interfaces:

A40 Floppy Disk Drive

The A40 floppy disk drive allows you to store and recall instrument states and measurement results on a 3.5 inch, 1.44 MB floppy disk. This assembly is connected directly to the A14 system motherboard.

A41 Hard Disk Drive

The hard disk drive assembly (HDDA) is an integrated development environment (IDE) data storage device which is connected directly to the A15 CPU board. The full operating system and firmware for the network analyzer is stored on the A41 hard disk drive.

USB Hub

The rear-panel mounted, internal USB hub provides four additional USB ports for connection of external USB compatible devices.

Power Supply Group Operation

The A4 power supply assembly is a switching power supply operating at 103 kHz switching frequency. The input power ranges for the power supply are 90 to 132 Vac or 195 to 250 Vac. The power supply automatically senses the input voltage and switches between these two ranges.

The dc output voltages are:

- +5.2 V
- -5.2 V
- +9 V
- +15 V
- +15 V standby (always on)
- -15 V
- +22 V
- VCC (5.2 V for the A15 CPU board)
- VDL (3.3 V to the A15 CPU board)

The +15 V standby line remains on continuously whenever the power supply is plugged in. This line is used to provide power to front panel LEDs and CPU components when the analyzer is turned off.

An additional +32 V supply line is generated on the A14 system motherboard from the +22 V supply line.

NOTE If the power supply senses an over-voltage or over-current condition on any of the supply lines, the power supply will cycle on and off at a low voltage level (burp mode).

6 Replaceable Parts

Information in This Chapter

This chapter:

- identifies the replaceable parts for the Agilent PNA series microwave network analyzer.
- includes several tables and illustrations to assist you in identifying the correct part for your analyzer.
- contains ordering information for new assemblies and rebuilt-exchange assemblies.

Chapter Six at-a-Glance

| Section Title | Summary of Content | Start Page |
|----------------------------------|---|------------|
| Ordering Information | How to order a replaceable part from Agilent Technologies. | Page 6-3 |
| Assembly Replacement Sequence | The correct sequence for replacing a defective assembly. | Page 6-4 |
| Rebuilt-Exchange Assemblies | The definition of a rebuilt-exchange assembly. The procedure for replacing and returning a defective assembly to Agilent Technologies. | Page 6-5 |
| Replaceable Parts Listings | A table that lists the assemblies by reference designator. Lists and provides the location of the replaceable parts in your analyzer: Assemblies (front panel, top, and bottom) Options (parts included with options) Cables (top and bottom) Hardware (internal, hard disk drive, rear panel, and external) | Page 6-6 |
| | Miscellaneous replaceable parts | |

Ordering Information

To order a part listed in the replaceable parts lists:

- include the part number
- indicate the quantity required
- Contact Agilent Technologies for instructions on where to send the order. Refer to "Contacting Agilent" on page 2-11.

To order a part that is not listed in the replaceable parts lists:

- include the instrument model number and complete instrument serial number
- include the description and function of the part
- indicate the quantity required
- Contact Agilent Technologies for instructions on where to send the order. Refer to "Contacting Agilent" on page 2-11.

Assembly Replacement Sequence

The following steps describe how to replace an assembly in the network analyzer.

- **Step 1.** Identify the faulty group. Begin with Chapter 4, "Troubleshooting." Follow up with the appropriate troubleshooting chapter that identifies the faulty assembly.
- Step 2. Order a replacement assembly. Refer to this chapter.
- **Step 3.** Replace the faulty assembly and determine what adjustments are necessary. Refer to Chapter 7, "Repair and Replacement Procedures."
- Step 4. Perform the necessary adjustments. Refer to Chapter 3, "Tests and Adjustments."
- **Step 5.** Perform the necessary performance tests. Refer to Chapter 3, "Tests and Adjustments."

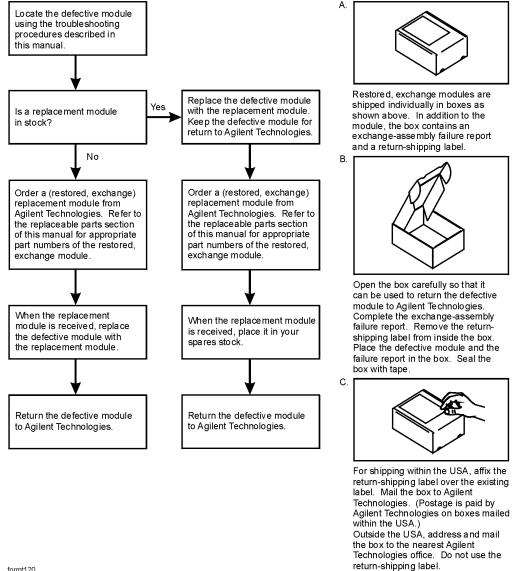
Rebuilt-Exchange Assemblies

Under the rebuilt-exchange assembly program:

- Certain factory-repaired and tested assemblies are available on a trade-in basis.
- Exchange assemblies are offered for lower cost than a new assembly, but meet all • factory specifications required of a new assembly.
- The defective assembly must be returned for credit under the terms of the rebuilt-exchange assembly program.
- Spare assembly stock desired should be ordered using the new assembly part number.

Figure 6-1 Module Exchange Procedure

The module exchange program described here is a fast, efficient, economical method of keeping your instrument in service.



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Replaceable Parts Listings

This section contains the replacement part numbers and their descriptions for your Agilent PNA series microwave network analyzer. You can find the locations of replaceable parts in this section:

- listed by reference designator in Table 6-1, or
- listed by the type of part in Table 6-2.

 Table 6-1
 Location by Reference Designator

| Reference Designator | Description | Location | | |
|-------------------------|--|---|--|--|
| A1 | Keypad assembly | | | |
| A2 | Display assembly | "Front Panel Assembly, All Options" on page 6-10. | | |
| A3 | Front panel interface board | have a rot | | |
| A4 | Power supply assembly | | | |
| A6 | Signal processing ADC module (SPAM) board | | | |
| A8 | Fractional-N synthesizer board | | | |
| A9 | Fractional-N synthesizer board (Option 080) | | | |
| A10 | Frequency reference board | "Ten Assembling All Ordings" on | | |
| A11 | Phase lock board | "Top Assemblies, All Options" on page 6-12. | | |
| A12 | Source 20 assembly | | | |
| A13 | Frequency offset receiver assembly (Option 080) | | | |
| A14 | System motherboard | | | |
| A15 | CPU board | | | |
| A16 | Test set motherboard | | | |
| A17 | Local oscillator multiplier/amplifier 12 (LOMA 12) | | | |
| A18 | Multiplier/amplifier (MA 24) | | | |
| A19 | Splitter | | | |
| A20 | Local oscillator distribution assembly (LODA) | | | |
| A21 | Source multiplier/amplifier 50 (SOMA 50) | "Bottom Assemblies, No Options" on page 6-16. | | |
| A22 | Switch | page o ro. | | |
| A23 | Source multiplier/amplifier 70 (SOMA 70) | | | |
| A24 | Source multiplier/amplifier 70 (SOMA 70) | | | |
| A25 | Test port 1 coupler | | | |
| A26 | Test port 2 coupler | | | |

| Reference Designator | Description | Location | |
|-------------------------|--|---|--|
| A27 | Channel A first converter (mixer) | | |
| A28 | Channel R1 first converter (mixer) | | |
| A29 | Channel R2 first converter (mixer) | | |
| A30 | Channel B first converter (mixer) | | |
| A31 | Channel A receiver module | "Bottom Assemblies, No Options" on page 6-16. | |
| A32 | Channel R1 receiver module | Page o to: | |
| A33 | Channel R2 receiver module | | |
| A34 | Channel B receiver module | | |
| A35 | Receiver motherboard | | |
| A36 | Port 1 60-dB step attenuator (Option UNL) | | |
| A37 | Port 2 60-dB step attenuator (Option UNL) | "Bottom Assemblies, Options 014/UNL" on page 6-24. | |
| A38 | Port 1 bias tee (Option UNL) | | |
| A39 | Port 2 bias tee (Option UNL) | | |
| A40 | Floppy disk drive | "Internal Hardware and Parts, All Options" on page 6-52. | |
| A41 | Hard disk drive assembly | "Hard Disk Drive Assembly, All Options" on page 6-58. | |
| A43 | Channel A 35-dB step attenuator (Option 016) | "Bottom Assemblies, Options | |
| A44 | Channel B 35-dB step attenuator (Option 016) | 014/UNL/016" on page 6-28. | |
| A45 | 70 GHz switch (Option 081) | "Bottom Assemblies, Options | |
| A46 | 70 GHz switch (Option 081) | 014/UNL/080/081" on page 6-32. | |
| A47 | RF path coupler (Option H11) | "Bottom Assemblies, Options | |
| A48 | LO path coupler (Option H11) | 014/UNL/080/081/H11" on page 6-40. | |
| A49 | IF multiplexer board | "Bottom Assemblies, No Options" on page 6-16. | |

 Table 6-1
 Location by Reference Designator (Continued)

| Type of Part | Location |
|--------------|---|
| Assemblies | "Front Panel Assembly, All Options" on page 6-10. "Top Assemblies, All Options" on page 6-12. "Bottom Assemblies, No Options" on page 6-16. "Bottom Assemblies, Option 014 and Options 014/080" on page 6-20. "Bottom Assemblies, Options 014/UNL" on page 6-24. "Bottom Assemblies, Options 014/UNL/016" on page 6-28. "Bottom Assemblies, Options 014/UNL/016" on page 6-32. "Bottom Assemblies, Options 014/UNL/080/081" on page 6-36. "Hard Disk Drive Assembly, All Options" on page 6-56. |
| Cables | "Top Cables—All, All Options" on page 6-14. "Bottom Semi-Rigid Cables, No Options" on page 6-18. "Bottom Semi-Rigid Cables, Option 014 and Options 014/080" on page 6-22. "Bottom Semi-Rigid Cables, Options 014/UNL" on page 6-26. "Bottom Semi-Rigid Cables, Options 014/UNL/016" on page 6-30. "Bottom Semi-Rigid Cables, Options 014/UNL/016" on page 6-34. "Bottom Semi-Rigid Cables, Options 014/UNL/016/080/081" on page 6-38. "Bottom Flexible RF Cables, All Options" on page 6-44. "Bottom Ribbon and Wrapped-Wire Cables, All Options" on page 6-46. |
| Hardware | "Top Hardware and Parts, All Options" on page 6-48. "Bottom Hardware and Parts, All Options" on page 6-50. "Internal Hardware and Parts, All Options" on page 6-52. "External Hardware and Parts, All Options" on page 6-54. "Hard Disk Drive Assembly, All Options" on page 6-58. "Rear Panel Assembly, All Options" on page 6-56. |

Table 6-2Part Number Location by Type of Part

| Type of Part | Location | | | | | | |
|---------------|--|--|--|--|--|--|--|
| Miscellaneous | Service Tools on page 6-59. Documentation on page 6-59. Protective Caps for Connectors on page 6-59. GPIB Cables/GPIB Adapter on page 6-59. Fuses on page 6-59. ESD Supplies on page 6-60. EMI/RFI Shielding Accessories on page 6-60. Memory Modules on page 6-59. Upgrade Kits on page 6-60. Touch-up Paint on page 6-60. USB Accessories on page 6-60. Rack Mount Kits and Handle Kits on page 6-61. | | | | | | |

Table 6-2 Part Number Location by Type of Part (Continued)

| Reference Designator | Part Number | Qty | Description |
|-------------------------|-------------|-----|--|
| A1 | E8356-60001 | 1 | Keypad assembly |
| A2 ^a | E8356-60002 | 1 | Display assembly |
| | 0950-3379 | 1 | Inverter board (included in A2 ^b) |
| | 2090-0386 | 1 | Display lamp for LCD (included in A2 ^b) |
| | 1000-1161 | 1 | Display glass (included in A2 ^b) |
| A3 | E8361-60061 | 1 | Front panel interface board |
| RPG | E8356-40006 | 1 | Front knob |
| (1) | 5041-9183 | 2 | With handles—front handle side trim |
| | 5041-9174 | 2 | Without handles—trim strip, filler |
| (2)c | 5063-9205 | 2 | Front handle |
| 3 | E8361-80002 | 1 | Front panel overlay, no options |
| 3 | E8361-80004 | 1 | Front panel overlay, any option combination that includes Option 014 |
| 4 | E8361-80001 | 1 | Nameplate |
| (5)d | E8364-60015 | 1 | Front frame assembly |
| 6 | 0515-0375 | 4 | Machine screw, M3.0 x 14 pan head |
| 7 | 0515-0372 | 10 | Machine screw, M3.0 x 8 pan head |
| 8 | E8364-00020 | 1 | Display cable retaining bracket |

Front Panel Assembly, All Options

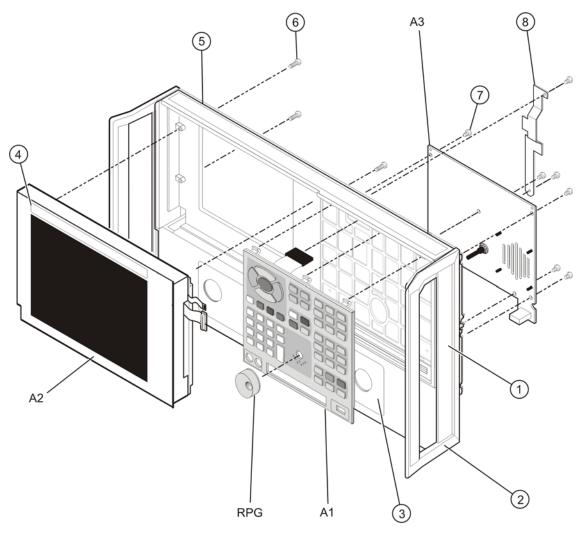
a. When ordering a replacement A2 display assembly, you must also order item (4).

b. Although included in the A2 display assembly, each of these parts is also available separately. If one of these parts should have to be replaced, it is not necessary to replace the entire A2 display assembly. For any other parts failures within the display, replace the entire A2 display assembly.

c. For part numbers of complete rack mount kits and handle kits, refer to "Rack Mount Kits and Handle Kits" on page 6-61.

d. When ordering a replacement front frame assembly, you must also order item \Im .





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| Reference Designator | Part Number ^a | Qty | Description |
|-------------------------|----------------------------|-----|---|
| A4 | 0950-4599 | 1 | Power supply assembly |
| A6 | E8356-60006 | 1 | Signal processing ADC module (SPAM) board |
| A8 | E8364-60099 | 1 | Fractional-N synthesizer board |
| A9 | E8364-60099 | 1 | Fractional-N synthesizer board (Option 080 only) |
| A10 | E8364-60136 | 1 | Frequency reference board |
| A11 | E8364-60137 | 1 | Phase lock board |
| A12 | E8361-60002 E8361-69002 | 1 | Source 20 assembly |
| | E8364-60097 | 1 | Frequency offset receiver board |
| A13 | E8356-60018 | 1 | Frequency offset receiver module |
| (Option 080 | N3381-20032 | 1 | Gasket |
| only) | E8364-20142 | 1 | RF cable, receiver module to receiver board |
| | 0515-1349 | 3 | Machine screw, for attaching receiver module to receiver board |
| A14 | E8364-60100 | 1 | System motherboard |
| A15 | E8364-60025 | 1 | CPU board; 500 MHz, 512 MB RAM |
| A40 | Floppy disk drive | | Refer to "Internal Hardware and Parts, All Options" on page 6-52. |
| B1 | Fans | | |
| 1 | USB hub board | | Refer to "Top Hardware and Parts, All Options" on page 6-48. |

Top Assemblies, All Options

a. Part numbers in *italic* typeface are for rebuilt exchange assemblies. Refer to "Rebuilt-Exchange Assemblies" on page 6-5.

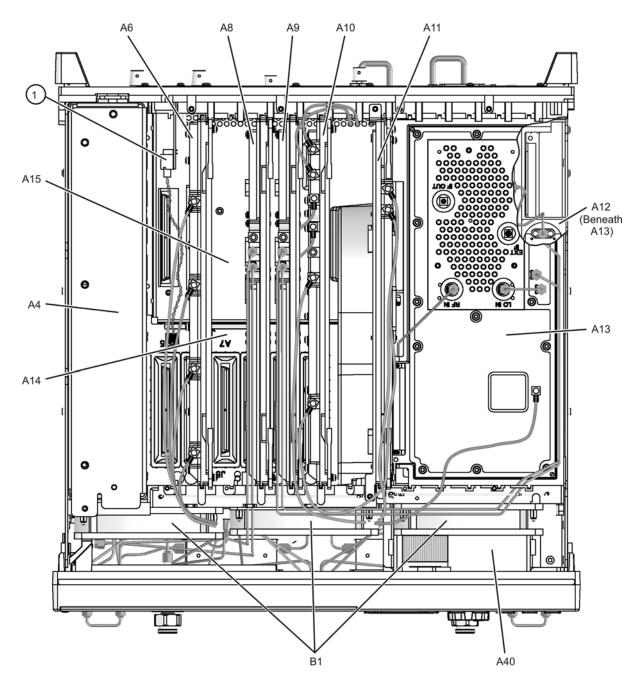


Figure 6-3 Top Assemblies, All Options

| Reference | | | | |
|------------|-------------------|-------------|-----|--|
| Designator | Type ^a | Part Number | Qty | Description |
| W20 | SR | E8361-20046 | 1 | A8 fractional-N synthesizer board J106 to A17 LOMA 12 J2 |
| W21 | SR | E8361-20045 | 1 | A8 fractional-N synthesizer board J101 to A17 LOMA 12 J3 |
| W31 | F | E8364-60126 | 1 | A6 SPAM board J3 to A31 receiver A J400 |
| W32 | F | E8364-60127 | 1 | A6 SPAM board J4 to A32 receiver R1 J400 |
| W33 | F | E8364-60128 | 1 | A6 SPAM board J5 to A33 receiver R2 J400 |
| W34 | F | E8364-60129 | 1 | A6 SPAM board J6 to A34 receiver B J400 |
| W35 | F | E8364-60124 | 1 | A10 frequency reference board J4 to A35 receiver motherboard J2 |
| W36 | F | E8364-60125 | 1 | A11 phase lock board J6 to A35 receiver motherboard J50 |
| W41 | Б | 8120 5055 | 1 | A10 frequency reference board J2 to rear-panel 10 MHz REF. IN |
| W42 | F | 8120-5055 | 1 | A10 frequency reference board J3 to rear-panel 10 MHz REF. OUT |
| W43 | F | E8356-60052 | 1 | A10 frequency reference board J10 to A8 fractional-N synthesizer board J105 |
| W44 | F | E8356-60043 | 1 | A10 frequency reference board J5 to A11 phase lock board J5 |
| W91 | SR | E8364-20140 | 1 | A9 fractional-N synthesizer board J106 to A13 frequency offset receiver assembly J4 |
| W92 | SR | E8364-20141 | 1 | A9 fractional-N synthesizer board J101 to A13 frequency offset receiver assembly J2 |
| W93 | SR | E8364-20143 | 1 | A13 frequency offset receiver assembly RF IN to A12 source 20 assembly |
| W94 | F | E8364-60018 | 1 | A10 frequency reference board J11 to A9 fractional-N synthesizer board J105 |
| W95 | F | E8364-60017 | 1 | A13 frequency offset receiver assembly J6 to A35 receiver motherboard J502 (Option 080) |
| 1 | 40R | 8121-0116 | 1 | A3 front panel interface board to A14 system motherboard |
| 2 | 6W | 8121-0932 | 1 | USB hub board to A14 system motherboard |
| 3 | 50R | 8121-0817 | 1 | A41 hard disk drive assembly to A15 CPU board |
| 4 | SR | E8364-20142 | 1 | A13 frequency offset receiver assembly J3 to receiver module LO IN (included with A13) |

Top Cables—All, All Options

a. SR = semirigid coaxial cable; F = flexible coaxial cable; nR = n wires in a ribbon (flat) cable;

nW = n wires in a wrapped cable

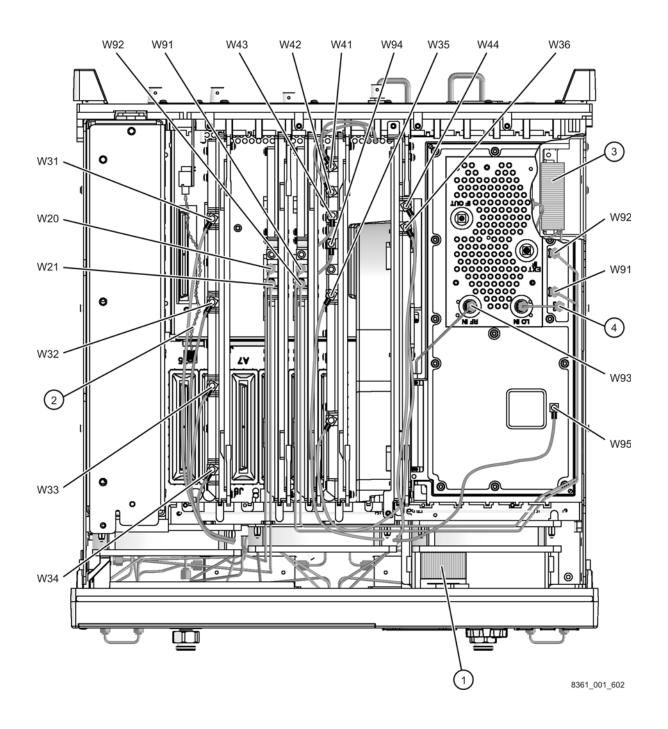


Figure 6-4 Top Cables—All, All Options

| Reference Designator | Part Number ^a | Qty | Description | |
|--------------------------|--|-----|--|--|
| A16 | E8364-60138 | 1 | Test set motherboard | |
| A17 | 5087-7247 5087-6247 | 1 | LOMA 12 | |
| A18 | 5087-7248 5087-6248 | 1 | MA 24 | |
| A19 | 5087-7139 | 1 | Splitter | |
| A20 | 5087-7129 5087-6129 | 1 | LODA | |
| A21 | 5087-7130 5087-6130 | 1 | SOMA 50 | |
| A22 | 5087-7238 5087-6238 | 1 | Switch | |
| A23 A24 | 5087-7249 | 2 | SOMA 70 | |
| A25 A26 | 5087-7225 | 2 | Test port 1 coupler Test port 2 coupler | |
| A27 A28 A29 A30 | 5087-7258 5087-6258 | 4 | Channel A first converter (mixer) Channel R1 first converter (mixer) Channel R2 first converter (mixer) Channel B first converter (mixer) | |
| A31 A32 A33 A34 | E8364-60134 E8364-69134 | 4 | Channel A receiver module Channel R1 receiver module Channel R2 receiver module Channel B receiver module | |
| A35 | E8364-60135 | 1 | Receiver motherboard | |
| A41 | Hard disk drive assembly. Refer to "Hard Disk Drive Assembly, All Options" on page 6-58. | | | |
| A49 | E8361-60043 | 1 | IF multiplexer board | |

Bottom Assemblies, No Options

a. Part numbers in *italic* typeface are for rebuilt exchange assemblies. Refer to "Rebuilt-Exchange Assemblies" on page 6-5.

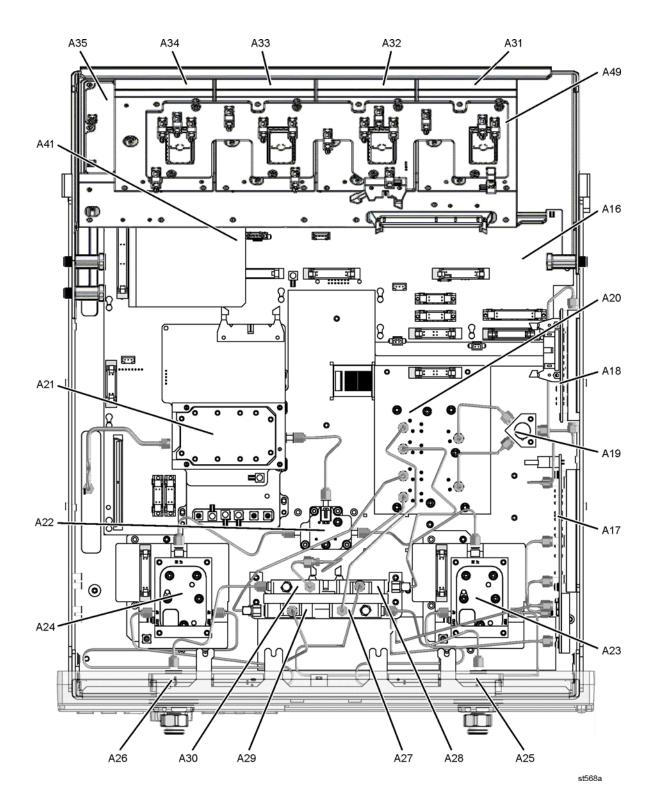


Figure 6-5 Bottom Assemblies, No Options

| Reference | | | | |
|------------|--|-----|--|--|
| Designator | Part Number | Qty | Description | |
| W1 | E8364-20036 | 1 | A21 SOMA 50 to A12 source 20 assembly | |
| W2 | E8361-20002 | 1 | A21 SOMA 50 to A22 switch | |
| W3 | E8361-20003 | 1 | A22 switch to A23 SOMA 70 | |
| W4 | E8361-20004 | 1 | A22 switch to A24 SOMA 70 | |
| W5 | E8361-20005 | 1 | A23 SOMA 70 to A25 test port 1 coupler | |
| W6 | E8361-20006 | 1 | A24 SOMA 70 to A26 test port 2 coupler | |
| W7 | E8361-20009 | 1 | A23 SOMA 70 to A28 channel R1 mixer | |
| W8 | E8361-20010 | 1 | A24 SOMA 70 to A29 channel R2 mixer | |
| W9 | E8361-20007 | 1 | A25 test port 1 coupler to A27 channel A mixer | |
| W10 | E8361-20008 | 1 | A26 test port 2 coupler to A30 channel B mixer | |
| W11 | E8364-20171 | 1 | A20 LODA to A27 channel A mixer | |
| W12 | E8364-20172 | 1 | A20 LODA to A28 channel R1 mixer | |
| W13 | E8364-20173 | 1 | A20 LODA to A29 channel R2 mixer | |
| W14 | E8364-20146 | 1 | A20 LODA to W15 (to A30 channel B mixer) | |
| W15 | E8364-20032 | 1 | A30 channel B mixer to W14 (to A20 LODA) | |
| W16 | E8364-20041 | 1 | A19 splitter to A20 LODA | |
| W17 | E8364-20042 | 1 | A19 splitter to A20 LODA | |
| W18 | E8364-20029 | 1 | A18 MA 24 to A19 splitter | |
| W19 | E8364-20145 | 1 | A18 MA 24 to A17 LOMA 12 | |
| W20, W21 | Refer to "Top Cables—All, All Options" on page 6-14. | | | |

Bottom Semi-Rigid Cables, No Options

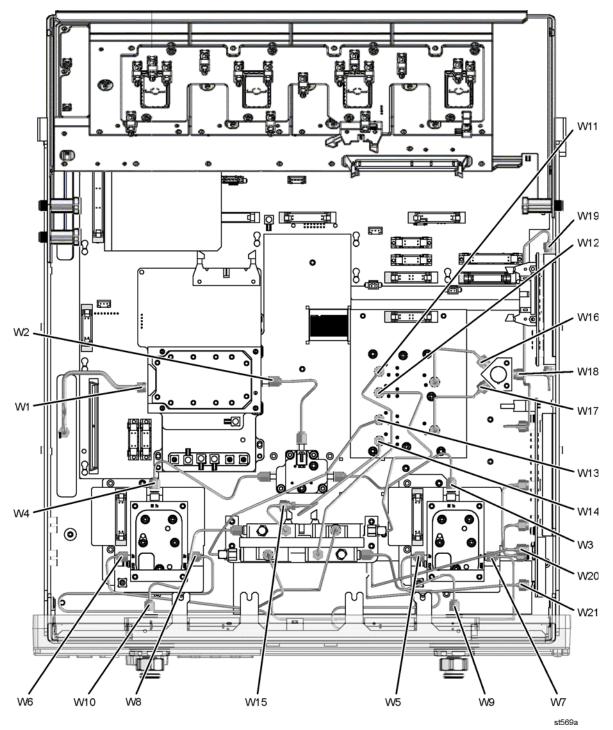


Figure 6-6 Bottom Semi-Rigid Cables, No Options

| Reference Designator | Part Number ^a | Qty | Description |
|--------------------------|--|-----|--|
| A16 | E8364-60138 | 1 | Test set motherboard |
| A17 | 5087-7247 5087-6247 | 1 | LOMA 12 |
| A18 | 5087-7248 5087-6248 | 1 | MA 24 |
| A19 | 5087-7139 | 1 | Splitter |
| A20 | 5087-7129 5087-6129 | 1 | LODA |
| A21 | 5087-7130 5087-6130 | 1 | SOMA 50 |
| A22 | 5087-7238 5087-6238 | 1 | Switch |
| A23 A24 | 5087-7249 | 2 | SOMA 70 |
| A25 A26 | 5087-7225 | 2 | Test port 1 coupler Test port 2 coupler |
| A27 A28 A29 A30 | 5087-7258 5087-6258 | 4 | Channel A first converter (mixer) Channel R1 first converter (mixer) Channel R2 first converter (mixer) Channel B first converter (mixer) |
| A31 A32 A33 A34 | E8364-60134 E8364-69134 | 4 | Channel A receiver module Channel R1 receiver module Channel R2 receiver module Channel B receiver module |
| A35 | E8364-60135 | 1 | Receiver motherboard |
| A41 | Hard disk drive assembly. Refer to "Hard Disk Drive Assembly, All Options" on page 6-58. | | |
| A49 | E8361-60043 | 1 | IF multiplexer board |

Bottom Assemblies, Option 014 and Options 014/080

a. Part numbers in *italic* typeface are for rebuilt exchange assemblies. Refer to "Rebuilt-Exchange Assemblies" on page 6-5.

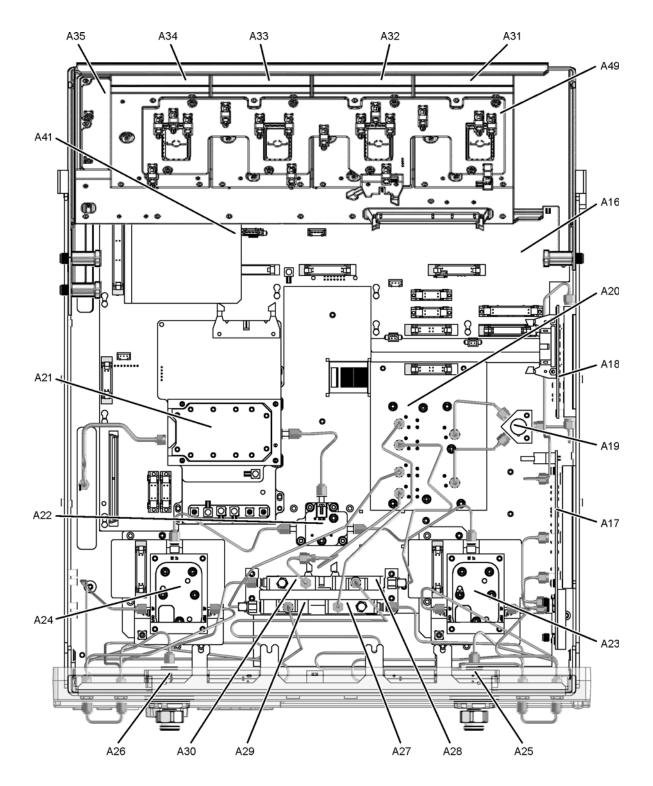


Figure 6-7 Bottom Assemblies, Option 014 and Options 014/080

Bottom Semi-Rigid Cables, Option 014 and Options 014/080

| Reference Designator | Part Number | Qty | Description |
|-------------------------|--|-----|--|
| W1 | E8364-20036 | 1 | A21 SOMA 50 to A12 source 20 assembly |
| W2 | E8361-20002 | 1 | A21 SOMA 50 to A22 switch |
| W3 | E8361-20003 | 1 | A22 switch to A23 SOMA 70 |
| W4 | E8361-20004 | 1 | A22 switch to A24 SOMA 70 |
| W11 | E8364-20171 | 1 | A20 LODA to A27 channel A mixer |
| W12 | E8364-20172 | 1 | A20 LODA to A28 channel R1 mixer |
| W13 | E8364-20173 | 1 | A20 LODA to A29 channel R2 mixer |
| W14 | E8364-20146 | 1 | A20 LODA to W15 (to A30 channel B mixer) |
| W15 | E8364-20032 | 1 | A30 channel B mixer to W14 (to A20 LODA) |
| W16 | E8364-20041 | 1 | A19 splitter to A20 LODA |
| W17 | E8364-20042 | 1 | A19 splitter to A20 LODA |
| W18 | E8364-20029 | 1 | A18 MA 24 to A19 splitter |
| W19 | E8364-20145 | 1 | A18 MA 24 to A17 LOMA 12 |
| W20, W21 | Refer to "Top Cables—All, All Options" on page 6-14. | | |
| W60 | E8361-20023 | 6 | Front-panel jumper |
| W61 | E8361-20021 | 1 | A23 SOMA 70 to PORT 1 SOURCE OUT |
| W62 | E8361-20022 | 1 | A24 SOMA 70 to PORT 2 SOURCE OUT |
| W63 | E8361-20011 | 1 | PORT 1 CPLR THRU to A25 test port 1 coupler |
| W64 | E8361-20012 | 1 | PORT 2 CPLR THRU to A26 test port 2 coupler |
| W65 | E8361-20015 | 1 | A23 SOMA 70 to REFERENCE 1 SOURCE OUT |
| W66 | E8361-20016 | 1 | A24 SOMA 70 to REFERENCE 2 SOURCE OUT |
| W67 | - E8361-20018 | 2 | A25 test port 1 coupler to PORT 1 CPLR ARM |
| W68 | | | A26 test port 2 coupler to PORT 2 CPLR ARM |
| W69 | E8361-20047 | 1 | PORT 1 RCVR A IN to A27 channel A mixer |
| W70 | E8361-20049 | 1 | REFERENCE 1 RCVR R1 IN to A28 channel R1 mixer |
| W71 | E8361-20020 | 1 | REFERENCE 2 RCVR R2 IN to A29 channel R2 mixer |
| W72 | E8361-20048 | 1 | PORT 2 RCVR B IN to A30 channel B mixer |

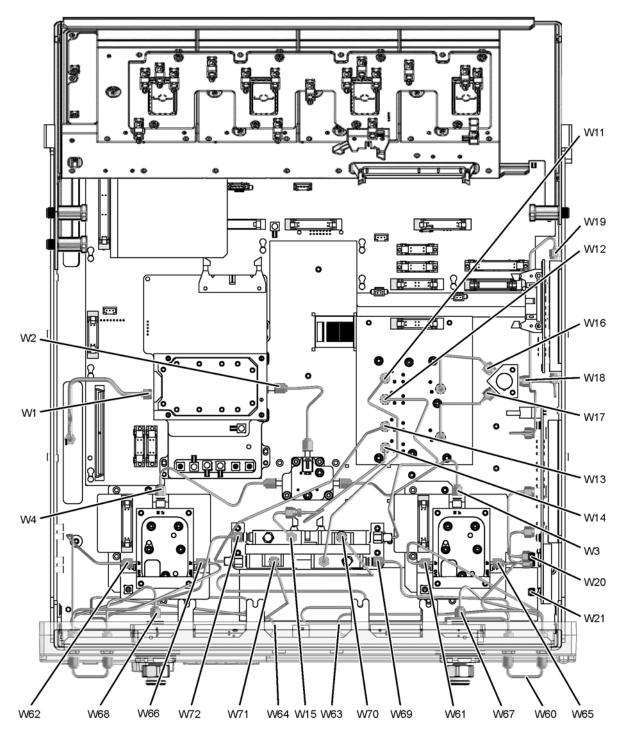


Figure 6-8 Bottom Semi-Rigid Cables, Option 014 and Options 014/080

| Reference Designator | Part Number ^a | Qty | Description |
|--------------------------|--|-----|--|
| A16 | E8364-60138 | 1 | Test set motherboard |
| A17 | 5087-7247 5087-6247 | 1 | LOMA 12 |
| A18 | 5087-7248 5087-6248 | 1 | MA 24 |
| A19 | 5087-7139 | 1 | Splitter |
| A20 | 5087-7129 5087-6129 | 1 | LODA |
| A21 | 5087-7130 5087-6130 | 1 | SOMA 50 |
| A22 | 5087-7238 5087-6238 | 1 | Switch |
| A23 A24 | 5087-7249 | 2 | SOMA 70 |
| A25 A26 | 5087-7225 | 2 | Test port 1 coupler Test port 2 coupler |
| A27 A28 A29 A30 | 5087-7258 5087-6258 | 4 | Channel A first converter (mixer) Channel R1 first converter (mixer) Channel R2 first converter (mixer) Channel B first converter (mixer) |
| A31 A32 A33 A34 | E8364-60134 E8364-69134 | 4 | Channel A receiver module Channel R1 receiver module Channel R2 receiver module Channel B receiver module |
| A35 | E8364-60135 | 1 | Receiver motherboard |
| A36 A37 | 84905-60001 | 2 | Step attenuator (source), 50-dB, port 1 Step attenuator (source), 50-dB, port 2 |
| A38 A39 | 5086-7020 | 2 | Bias tee, port 1 Bias tee, port 2 |
| A41 | Hard disk drive assembly. Refer to "Hard Disk Drive Assembly, All Options" on page 6-58. | | |
| A49 | E8361-60043 | 1 | IF multiplexer board |

Bottom Assemblies, Options 014/UNL

a. Part numbers in *italic* typeface are for rebuilt exchange assemblies. Refer to "Rebuilt-Exchange Assemblies" on page 6-5.

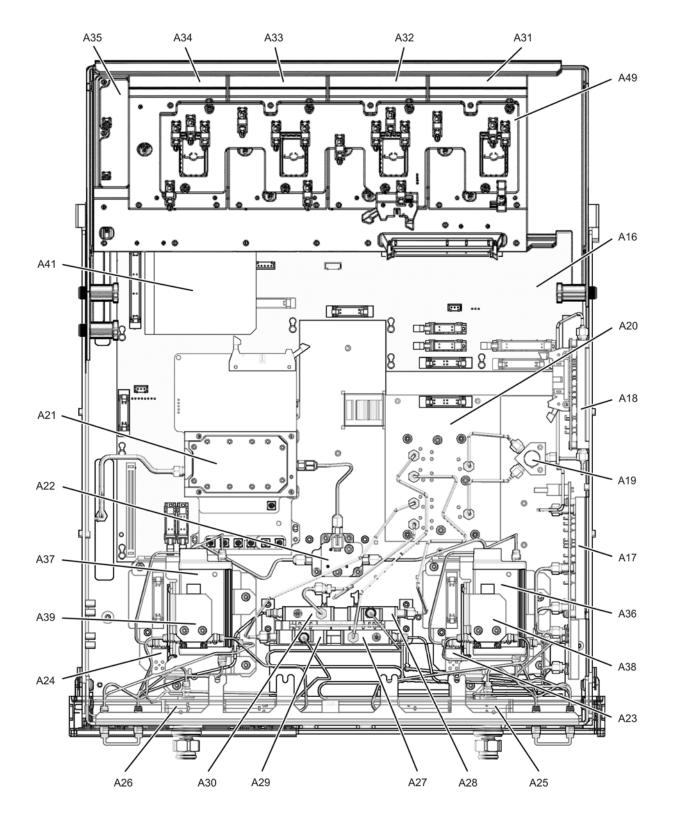


Figure 6-9 Bottom Assemblies, Options 014/UNL

| Reference Designator | Part Number | Qty | Description | |
|-------------------------|--|-----|--|--|
| W1 | E8364-20036 | 1 | A21 SOMA 50 to A12 source 20 assembly | |
| W2 | E8361-20002 | 1 | A21 SOMA 50 to A22 switch | |
| W3 | E8361-20003 | 1 | A22 switch to A23 SOMA 70 | |
| W4 | E8361-20004 | 1 | A22 switch to A24 SOMA 70 | |
| W11 | E8364-20171 | 1 | A20 LODA to A27 channel A mixer | |
| W12 | E8364-20172 | 1 | A20 LODA to A28 channel R1 mixer | |
| W13 | E8364-20173 | 1 | A20 LODA to A29 channel R2 mixer | |
| W14 | E8364-20146 | 1 | A20 LODA to W15 (to A30 channel B mixer) | |
| W15 | E8364-20032 | 1 | A30 channel B mixer to W14 (to A20 LODA) | |
| W16 | E8364-20041 | 1 | A19 splitter to A20 LODA | |
| W17 | E8364-20042 | 1 | A19 splitter to A20 LODA | |
| W18 | E8364-20029 | 1 | A18 MA 24 to A19 splitter | |
| W19 | E8364-20145 | 1 | A18 MA 24 to A17 LOMA 12 | |
| W20, W21 | Refer to "Top Cables—All, All Options" on page 6-14. | | | |
| W51 | E9261 20026 | 2 | A23 SOMA 70 to A36 step attenuator | |
| W52 | - E8361-20036 | 2 | A24 SOMA 70 to A37 step attenuator | |
| W55 | E8361-20033 | 1 | A38 bias tee to A25 test port 1 coupler | |
| W56 | E8361-20027 | 1 | A39 bias tee to A26 test port 2 coupler | |
| W60 | E8361-20023 | 6 | Front-panel jumper | |
| W65 | E8361-20015 | 1 | A23 SOMA 70 to REFERENCE 1 SOURCE OUT | |
| W66 | E8361-20016 | 1 | A24 SOMA 70 to REFERENCE 2 SOURCE OUT | |
| W67 | E02(1,20010 | 2 | A25 test port 1 coupler to PORT 1 CPLR ARM | |
| W68 | - E8361-20018 | 2 | A26 test port 2 coupler to PORT 2 CPLR ARM | |
| W69 | E8361-20047 | 1 | PORT 1 RCVR A IN to A27 channel A mixer | |
| W70 | E8361-20049 | 1 | REFERENCE 1 RCVR R1 IN to A28 channel R1 mixer | |
| W71 | E8361-20020 | 1 | REFERENCE 2 RCVR R2 IN to A29 channel R2 mixer | |
| W72 | E8361-20048 | 1 | PORT 2 RCVR B IN to A30 channel B mixer | |
| W81 | E8361-20035 | 1 | A36 step attenuator to PORT 1 SOURCE OUT | |
| W82 | E8361-20026 | 1 | A37 step attenuator to PORT 2 SOURCE OUT | |
| W83 | E8361-20034 | 1 | PORT 1 CPLR THRU to A38 bias tee | |
| W84 | E8361-20028 | 1 | PORT 2 CPLR THRU to A39 bias tee | |

Bottom Semi-Rigid Cables, Options 014/UNL

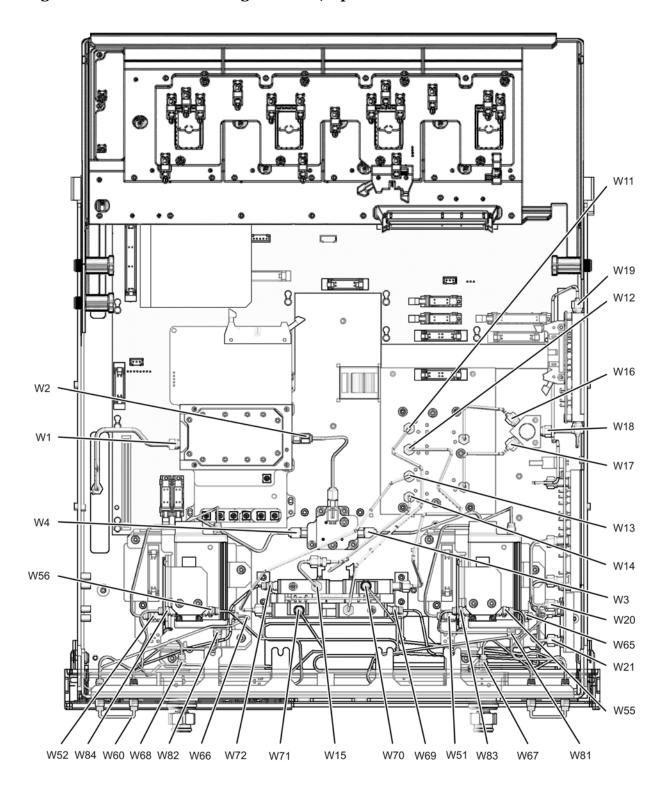


Figure 6-10 Bottom Semi-Rigid Cables, Options 014/UNL

| Reference Designator | Part Number ^a | Qty | Description |
|--------------------------|--|-----|--|
| A16 | E8364-60138 | 1 | Test set motherboard |
| A17 | 5087-7247 5087-6247 | 1 | LOMA 12 |
| A18 | 5087-7248 5087-6248 | 1 | MA 24 |
| A19 | 5087-7139 | 1 | Splitter |
| A20 | 5087-7129 5087-6129 | 1 | LODA |
| A21 | 5087-7130 5087-6130 | 1 | SOMA 50 |
| A22 | 5087-7238 5087-6238 | 1 | Switch |
| A23 A24 | 5087-7249 | 2 | SOMA 70 |
| A25 A26 | 5087-7225 | 2 | Test port 1 coupler Test port 2 coupler |
| A27 A28 A29 A30 | 5087-7258 5087-6258 | 4 | Channel A first converter (mixer) Channel R1 first converter (mixer) Channel R2 first converter (mixer) Channel B first converter (mixer) |
| A31 A32 A33 A34 | E8364-60134 E8364-69134 | 4 | Channel A receiver module Channel R1 receiver module Channel R2 receiver module Channel B receiver module |
| A35 | E8364-60135 | 1 | Receiver motherboard |
| A36 A37 | 84905-60001 | 2 | Step attenuator (source), 50-dB, port 1 Step attenuator (source), 50-dB, port 2 |
| A38 A39 | 5086-7020 | 2 | Bias tee, port 1 Bias tee, port 2 |
| A41 | Hard disk drive assembly. Refer to "Hard Disk Drive Assembly, All Options" on page 6-58. | | |
| A43 A44 | 84905-60001 | 2 | Step attenuator (receiver), 50-dB, channel A Step attenuator (receiver), 50-dB, channel B |
| A49 | E8361-60043 | 1 | IF multiplexer board |

Bottom Assemblies, Options 014/UNL/016

a. Part numbers in *italic* typeface are for rebuilt exchange assemblies. Refer to "Rebuilt-Exchange Assemblies" on page 6-5.

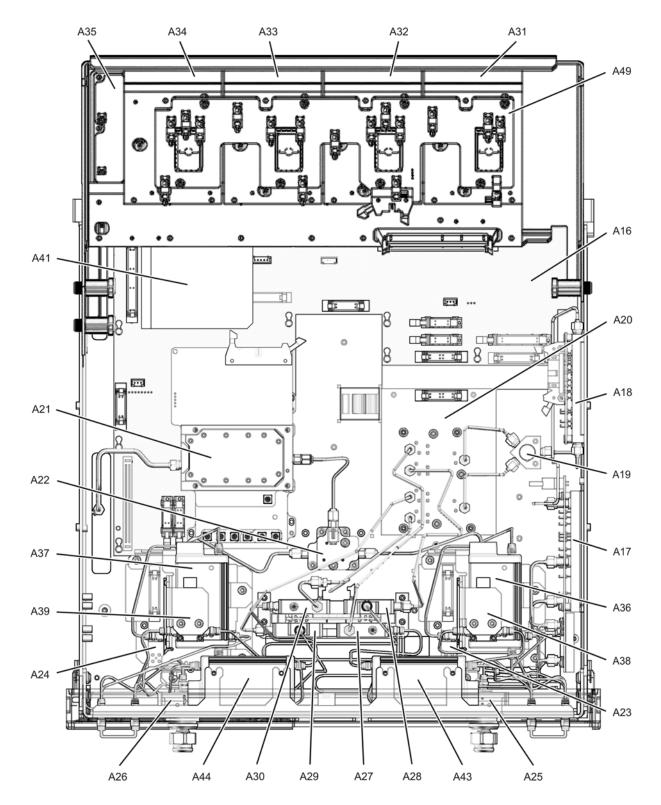


Figure 6-11 Bottom Assemblies, Options 014/UNL/016

| Reference Designator | Part Number | Qty | Description | |
|-------------------------|--|-----|--|--|
| W1 | E8364-20036 | 1 | A21 SOMA 50 to A12 source 20 assembly | |
| W2 | E8361-20002 | 1 | A21 SOMA 50 to A22 switch | |
| W3 | E8361-20003 | 1 | A22 switch to A23 SOMA 70 | |
| W4 | E8361-20004 | 1 | A22 switch to A24 SOMA 70 | |
| W11 | E8364-20171 | 1 | A20 LODA to A27 channel A mixer | |
| W12 | E8364-20172 | 1 | A20 LODA to A28 channel R1 mixer | |
| W13 | E8364-20173 | 1 | A20 LODA to A29 channel R2 mixer | |
| W14 | E8364-20146 | 1 | A20 LODA to W15 (to A30 channel B mixer) | |
| W15 | E8364-20032 | 1 | A30 channel B mixer to W14 (to A20 LODA) | |
| W16 | E8364-20041 | 1 | A19 splitter to A20 LODA | |
| W17 | E8364-20042 | 1 | A19 splitter to A20 LODA | |
| W18 | E8364-20029 | 1 | A18 MA 24 to A19 splitter | |
| W19 | E8364-20145 | 1 | A18 MA 24 to A17 LOMA 12 | |
| W20, W21 | Refer to "Top Cables—All, All Options" on page 6-14. | | | |
| W47 | E8361-20031 | 1 | A43 channel A step attenuator to A27 channel A mixer | |
| W48 | E8361-20025 | 1 | A44 channel B step attenuator to A30 channel B mixer | |
| W49 | E8361-20032 | 1 | PORT 1 RCVR A IN to A43 channel A step attenuator | |
| W50 | E8361-20029 | 1 | PORT 2 RCVR B IN to A44 channel B step attenuator | |
| W51 | | 2 | A23 SOMA 70 to A36 step attenuator | |
| W52 | E8361-20036 | 2 | A24 SOMA 70 to A37 step attenuator | |
| W55 | E8361-20033 | 1 | A38 bias tee to A25 test port 1 coupler | |
| W56 | E8361-20027 | 1 | A39 bias tee to A26 test port 2 coupler | |
| W60 | E8361-20023 | 6 | Front-panel jumper | |
| W65 | E8361-20015 | 1 | A23 SOMA 70 to REFERENCE 1 SOURCE OUT | |
| W66 | E8361-20016 | 1 | A24 SOMA 70 to REFERENCE 2 SOURCE OUT | |
| W67 | E9261 20019 | 2 | A25 test port 1 coupler to PORT 1 CPLR ARM | |
| W68 | - E8361-20018 | 2 | A26 test port 2 coupler to PORT 2 CPLR ARM | |
| W70 | E8361-20049 | 1 | REFERENCE 1 RCVR R1 IN to A28 channel R1 mixer | |
| W71 | E8361-20020 | 1 | REFERENCE 2 RCVR R2 IN to A29 channel R2 mixer | |
| W81 | E8361-20035 | 1 | A36 step attenuator to port 1 SOURCE OUT | |
| W82 | E8361-20026 | 1 | A37 step attenuator to port 2 SOURCE OUT | |
| W83 | E8361-20034 | 1 | Port 1 CPLR THRU to A38 bias tee | |
| W84 | E8361-20028 | 1 | Port 2 CPLR THRU to A39 bias tee | |

Bottom Semi-Rigid Cables, Options 014/UNL/016

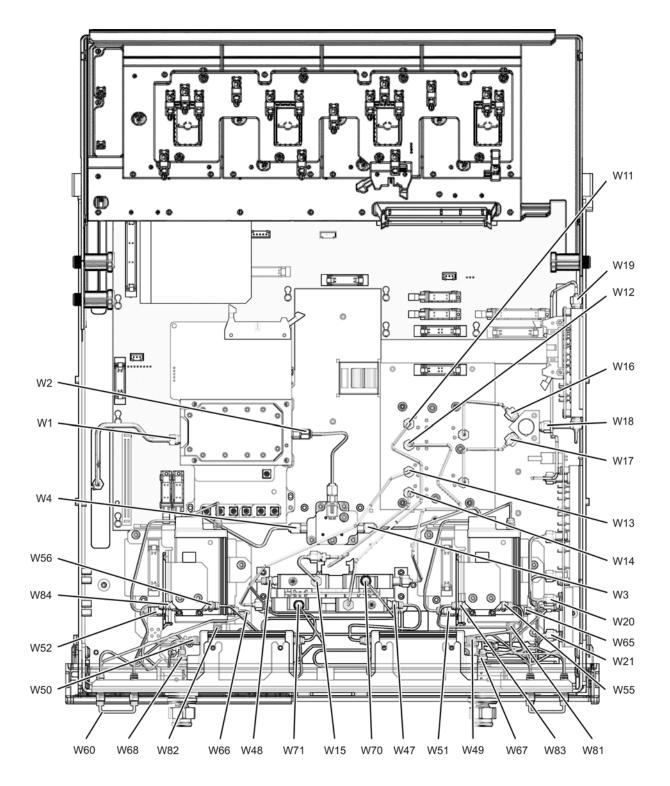


Figure 6-12 Bottom Semi-Rigid Cables, Options 014/UNL/016

| Reference Designator | Part Number ^a | Qty | Description |
|--------------------------|--|-----|--|
| A16 | E8364-60138 | 1 | Test set motherboard |
| A17 | 5087-7247 5087-6247 | 1 | LOMA 12 |
| A18 | 5087-7248 5087-6248 | 1 | MA 24 |
| A19 | 5087-7139 | 1 | Splitter |
| A20 | 5087-7129 5087-6129 | 1 | LODA |
| A21 | 5087-7130 5087-6130 | 1 | SOMA 50 |
| A22 | 5087-7238 5087-6238 | 1 | Switch |
| A23 A24 | 5087-7249 | 2 | SOMA 70 |
| A25 A26 | 5087-7225 | 2 | Test port 1 coupler Test port 2 coupler |
| A27 A28 A29 A30 | 5087-7258 5087-6258 | 4 | Channel A first converter (mixer) Channel R1 first converter (mixer) Channel R2 first converter (mixer) Channel B first converter (mixer) |
| A31 A32 A33 A34 | E8364-60134 E8364-69134 | 4 | Channel A receiver module Channel R1 receiver module Channel R2 receiver module Channel B receiver module |
| A35 | E8364-60135 | 1 | Receiver motherboard |
| A36 A37 | 84905-60001 | 2 | Step attenuator (source), 50-dB, port 1 Step attenuator (source), 50-dB, port 2 |
| A38 A39 | 5086-7020 | 2 | Bias tee, port 1 Bias tee, port 2 |
| A41 | Hard disk drive assembly. Refer to "Hard Disk Drive Assembly, All Options" on page 6-58. | | |
| A43 A44 | 84905-60001 | 2 | Step attenuator (receiver), 50-dB, channel A Step attenuator (receiver), 50-dB, channel B |
| A45 | 5087-7271 | 1 | 70 GHz reference switch |
| A49 | E8361-60043 | 1 | IF multiplexer board |

Bottom Assemblies, Options 014/UNL/080/081

a. Part numbers in *italic* typeface are for rebuilt exchange assemblies. Refer to "Rebuilt-Exchange Assemblies" on page 6-5.

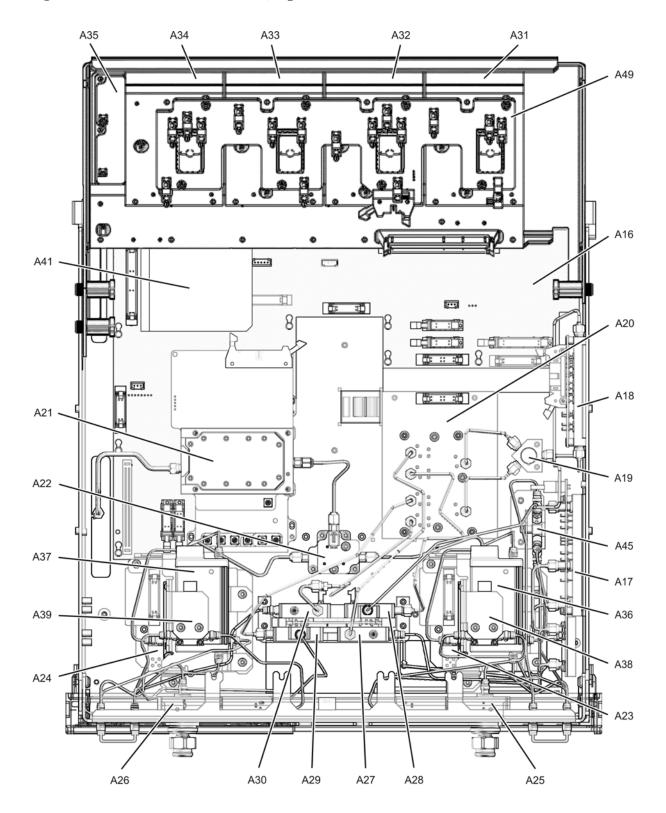


Figure 6-13 Bottom Assemblies, Options 014/UNL/080/081

| Reference Designator | Part Number | Qty | Description |
|-------------------------|------------------|--------|--|
| W1 | E8364-20036 | 1 | A21 SOMA 50 to A12 source 20 assembly |
| W2 | E8361-20002 | 1 | A21 SOMA 50 to A22 switch |
| W3 | E8361-20003 | 1 | A22 switch to A23 SOMA 70 |
| W4 | E8361-20004 | 1 | A22 switch to A24 SOMA 70 |
| W11 | E8364-20171 | 1 | A20 LODA to A27 channel A mixer |
| W12 | E8364-20172 | 1 | A20 LODA to A28 channel R1 mixer |
| W13 | E8364-20173 | 1 | A20 LODA to A29 channel R2 mixer |
| W14 | E8364-20146 | 1 | A20 LODA to W15 (to A30 channel B mixer) |
| W15 | E8364-20032 | 1 | A30 channel B mixer to W14 (to A20 LODA) |
| W16 | E8364-20041 | 1 | A19 splitter to A20 LODA |
| W17 | E8364-20042 | 1 | A19 splitter to A20 LODA |
| W18 | E8364-20029 | 1 | A18 MA 24 to A19 splitter |
| W19 | E8364-20145 | 1 | A18 MA 24 to A17 LOMA 12 |
| W20, W21 | Refer to "Top Ca | ables— | All, All Options" on page 6-14. |
| W51 | E9261 20026 | 2 | A23 SOMA 70 to A36 step attenuator |
| W52 | - E8361-20036 | 2 | A24 SOMA 70 to A37 step attenuator |
| W55 | E8361-20033 | 1 | A38 bias tee to A25 test port 1 coupler |
| W56 | E8361-20027 | 1 | A39 bias tee to A26 test port 2 coupler |
| W60 | E8361-20023 | 6 | Front-panel jumper |
| W66 | E8361-20016 | 1 | A24 SOMA 70 to REFERENCE 2 SOURCE OUT |
| W67 | E8361-20018 | 2 | A25 test port 1 coupler to PORT 1 CPLR ARM |
| W68 | - E8301-20018 | 10 2 | A26 test port 2 coupler to PORT 2 CPLR ARM |
| W69 | E8361-20047 | 1 | PORT 1 RCVR A IN to A27 channel A mixer |
| W71 | E8361-20020 | 1 | REFERENCE 2 RCVR R2 IN to A29 channel R2 mixer |
| W72 | E8361-20048 | 1 | PORT 2 RCVR B IN to A30 channel B mixer |
| W81 | E8361-20035 | 1 | A36 step attenuator to port 1 SOURCE OUT |
| W82 | E8361-20026 | 1 | A37 step attenuator to port 2 SOURCE OUT |
| W83 | E8361-20034 | 1 | Port 1 CPLR THRU to A38 bias tee |
| W84 | E8361-20028 | 1 | Port 2 CPLR THRU to A39 bias tee |
| W96 | E8361-20037 | 1 | A23 SOMA 70 to A45 reference switch |
| W97 | E8361-20038 | 1 | A45 reference switch to REFERENCE 1 SOURCE OUT |
| W98 | E8361-20039 | 1 | REFERENCE 1 RCVR R1 IN to A45 reference switch |
| W99 | E8361-20040 | 1 | A45 reference switch to A28 R1 mixer |

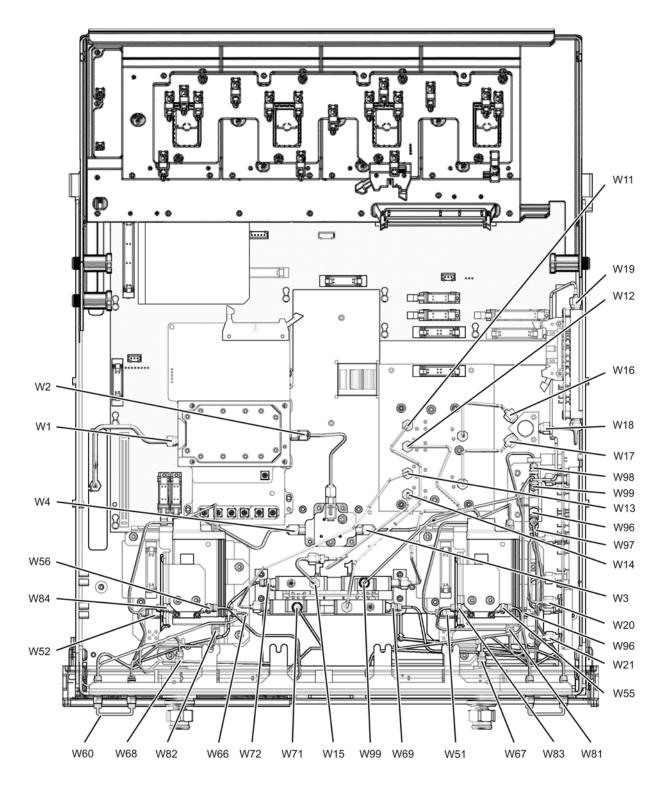


Figure 6-14 Bottom Semi-Rigid Cables, Options 014/UNL/080/081

| Reference Designator | Part Number ^a | Qty | Description |
|--------------------------|----------------------------|---------|--|
| A16 | E8364-60138 | 1 | Test set motherboard |
| A17 | 5087-7247 5087-6247 | 1 | LOMA 12 |
| A18 | 5087-7248 5087-6248 | 1 | MA 24 |
| A19 | 5087-7139 | 1 | Splitter |
| A20 | 5087-7129 5087-6129 | 1 | LODA |
| A21 | 5087-7130 5087-6130 | 1 | SOMA 50 |
| A22 | 5087-7238 5087-6238 | 1 | Switch |
| A23 A24 | 5087-7249 | 2 | SOMA 70 |
| A25 A26 | 5087-7225 | 2 | Test port 1 coupler Test port 2 coupler |
| A27 A28 A29 A30 | 5087-7258 5087-6258 | 4 | Channel A first converter (mixer) Channel R1 first converter (mixer) Channel R2 first converter (mixer) Channel B first converter (mixer) |
| A31 A32 A33 A34 | E8364-60134 E8364-69134 | 4 | Channel A receiver module Channel R1 receiver module Channel R2 receiver module Channel B receiver module |
| A35 | E8364-60135 | 1 | Receiver motherboard |
| A36 A37 | 84905-60001 | 2 | Step attenuator (source), 50-dB, port 1 Step attenuator (source), 50-dB, port 2 |
| A38 A39 | 5086-7020 | 2 | Bias tee, port 1 Bias tee, port 2 |
| A41 | Hard disk drive a | assembl | y. Refer to "Hard Disk Drive Assembly, All Options" on page 6-58. |
| A43 A44 | 84905-60001 | 2 | Step attenuator (receiver), 50-dB, channel A Step attenuator (receiver), 50-dB, channel B |
| A45 | 5087-7271 | 1 | 70 GHz reference switch |
| A49 | E8361-60043 | 1 | IF multiplexer board |

Bottom Assemblies, Options 014/UNL/016/080/081

a. Part numbers in *italic* typeface are for rebuilt exchange assemblies. Refer to "Rebuilt-Exchange Assemblies" on page 6-5.

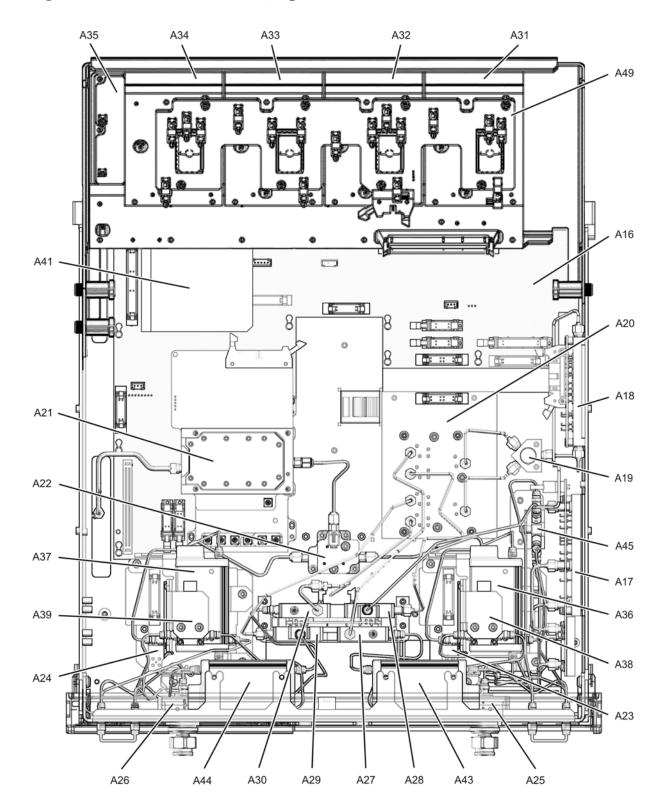


Figure 6-15 Bottom Assemblies, Options 014/UNL/016/080/081

Bottom Semi-Rigid Cables, Options 014/UNL/016/080/081

| Reference Designator | Part Number | Qty | Description |
|-------------------------|-------------------|---------|--|
| W1 | E8364-20036 | 1 | A21 SOMA 50 to A12 source 20 assembly |
| W2 | E8361-20002 | 1 | A21 SOMA 50 to A22 switch |
| W3 | E8361-20003 | 1 | A22 switch to A23 SOMA 70 |
| W4 | E8361-20004 | 1 | A22 switch to A24 SOMA 70 |
| W11 | E8364-20171 | 1 | A20 LODA to A27 channel A mixer |
| W12 | E8364-20172 | 1 | A20 LODA to A28 channel R1 mixer |
| W13 | E8364-20173 | 1 | A20 LODA to A29 channel R2 mixer |
| W14 | E8364-20146 | 1 | A20 LODA to W15 (to A30 channel B mixer) |
| W15 | E8364-20032 | 1 | A30 channel B mixer to W14 (to A20 LODA) |
| W16 | E8364-20041 | 1 | A19 splitter to A20 LODA |
| W17 | E8364-20042 | 1 | A19 splitter to A20 LODA |
| W18 | E8364-20029 | 1 | A18 MA 24 to A19 splitter |
| W19 | E8364-20145 | 1 | A18 MA 24 to A17 LOMA 12 |
| W20, W21 | Refer to "Top Cab | les—All | , All Options" on page 6-14. |
| W47 | E8361-20031 | 1 | A43 channel A step attenuator to A27 channel A mixer |
| W48 | E8361-20025 | 1 | A44 channel B step attenuator to A30 channel B mixer |
| W49 | E8361-20032 | 1 | PORT 1 RCVR A IN to A43 channel A step attenuator |
| W50 | E8361-20029 | 1 | PORT 2 RCVR B IN to A44 channel B step attenuator |
| W51 | E82(1,2002(| 2 | A23 SOMA 70 to A36 step attenuator |
| W52 | - E8361-20036 | 2 | A24 SOMA 70 to A37 step attenuator |
| W55 | E8361-20033 | 1 | A38 bias tee to A25 test port 1 coupler |
| W56 | E8361-20027 | 1 | A39 bias tee to A26 test port 2 coupler |
| W60 | E8361-20023 | 6 | Front-panel jumper |
| W66 | E8361-20016 | 1 | A24 SOMA 70 to REFERENCE 2 SOURCE OUT |
| W67 | E9261 20019 | 2 | A25 test port 1 coupler to PORT 1 CPLR ARM |
| W68 | - E8361-20018 | 2 | A26 test port 2 coupler to PORT 2 CPLR ARM |
| W71 | E8361-20020 | 1 | REFERENCE 2 RCVR R2 IN to A29 channel R2 mixer |
| W81 | E8361-20035 | 1 | A36 step attenuator to port 1 SOURCE OUT |
| W82 | E8361-20026 | 1 | A37 step attenuator to port 2 SOURCE OUT |
| W83 | E8361-20034 | 1 | Port 1 CPLR THRU to A38 bias tee |
| W84 | E8361-20028 | 1 | Port 2 CPLR THRU to A39 bias tee |
| W96 | E8361-20037 | 1 | A23 SOMA 70 to A45 reference switch |
| W97 | E8361-20038 | 1 | A45 reference switch to REFERENCE 1 SOURCE OUT |
| W98 | E8361-20039 | 1 | REFERENCE 1 RCVR R1 IN to A45 reference switch |
| W99 | E8361-20040 | 1 | A45 reference switch to A28 R1 mixer |

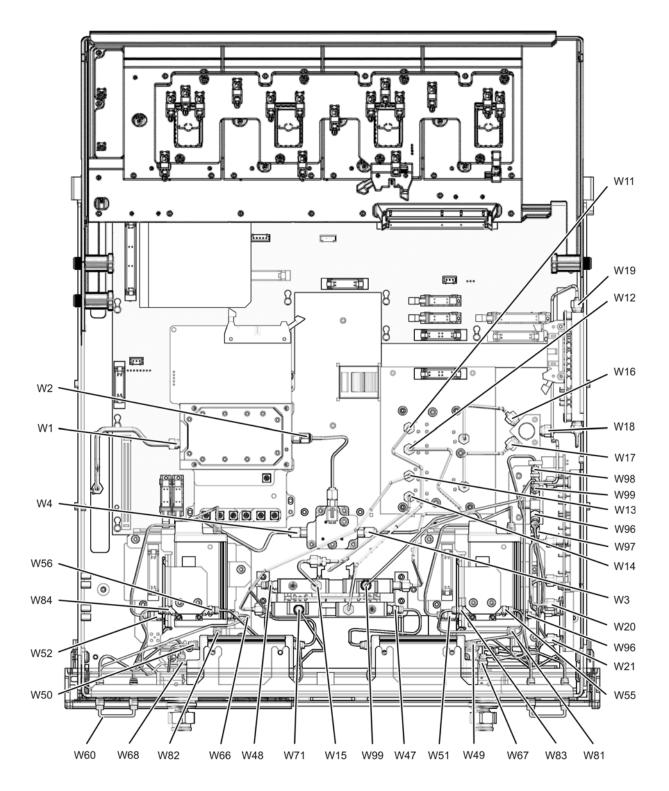


Figure 6-16 Bottom Semi-Rigid Cables, Options 014/UNL/016/080/081

| Reference Designator | Part Number ^a | Qty | Description | |
|--------------------------|--|-----|--|--|
| A16 | E8364-60138 | 1 | Test set motherboard | |
| A17 | 5087-7247 5087-6247 | 1 | LOMA 12 | |
| A18 | 5087-7248 5087-6248 | 1 | MA 24 | |
| A19 | 5087-7139 | 1 | Splitter | |
| A20 | 5087-7129 5087-6129 | 1 | LODA | |
| A21 | 5087-7130 5087-6130 | 1 | SOMA 50 | |
| A22 | 5087-7238 5087-6238 | 1 | Switch | |
| A23 A24 | 5087-7249 | 2 | SOMA 70 | |
| A25 A26 | 5087-7225 | 2 | Test port 1 coupler Test port 2 coupler | |
| A27 A28 A29 A30 | 5087-7258 5087-6258 | 4 | Channel A first converter (mixer) Channel R1 first converter (mixer) Channel R2 first converter (mixer) Channel B first converter (mixer) | |
| A31 A32 A33 A34 | E8364-60134 E8364-69134 | 4 | Channel A receiver module Channel R1 receiver module Channel R2 receiver module Channel B receiver module | |
| A35 | E8364-60135 | 1 | Receiver motherboard | |
| A36 A37 | 84905-60001 | 2 | Step attenuator (source), 50-dB, port 1 Step attenuator (source), 50-dB, port 2 | |
| A38 A39 | 5086-7020 | 2 | Bias tee, port 1 Bias tee, port 2 | |
| A41 | Hard disk drive assembly. Refer to "Hard Disk Drive Assembly, All Options" on page 6-58. | | | |
| A43 A44 | 84905-60001 | 2 | Step attenuator (receiver), 50-dB, channel A Step attenuator (receiver), 50-dB, channel B | |
| A45 | 5087-7271 | 1 | 70 GHz reference switch | |
| A47 A48 | 0955-0148 | 2 | Coupler, RF path Coupler, LO path | |
| A49 | E8361-60043 | 1 | IF multiplexer board | |

Bottom Assemblies, Options 014/UNL/080/081/H11

a. Part numbers in *italic* typeface are for rebuilt exchange assemblies. Refer to "Rebuilt-Exchange Assemblies" on page 6-5.

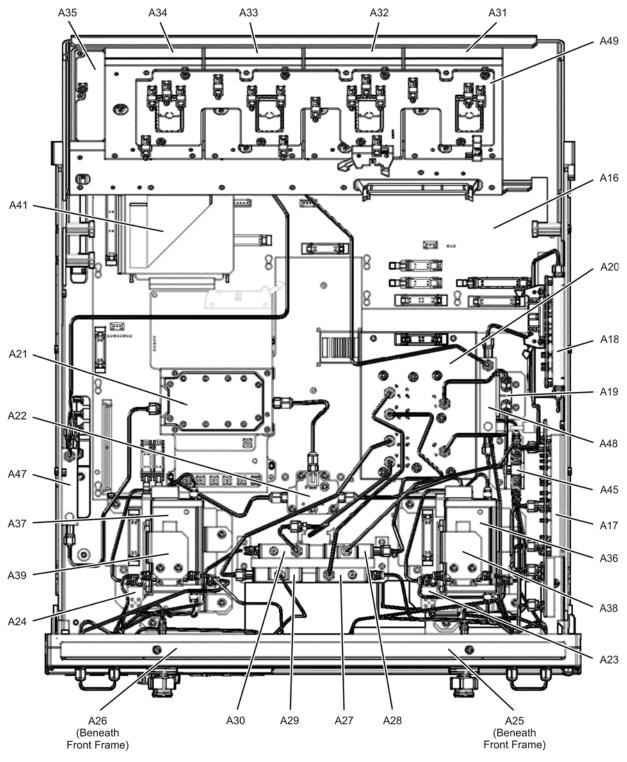


Figure 6-17 Bottom Assemblies, Options 014/UNL/080/081/H11

Bottom Semi-Rigid Cables, Options 014/UNL/080/081/H11

| Reference Designator | Part Number | Qty | Description |
|-------------------------|-------------------|---------|--|
| W2 | E8361-20002 | 1 | A21 SOMA 50 to A22 switch |
| W3 | E8361-20003 | 1 | A22 switch to A23 SOMA 70 |
| W4 | E8361-20004 | 1 | A22 switch to A24 SOMA 70 |
| W11 | E8364-20171 | 1 | A20 LODA to A27 channel A mixer |
| W12 | E8364-20172 | 1 | A20 LODA to A28 channel R1 mixer |
| W13 | E8364-20173 | 1 | A20 LODA to A29 channel R2 mixer |
| W14 | E8364-20146 | 1 | A20 LODA to W15 (to A30 channel B mixer) |
| W15 | E8364-20032 | 1 | A30 channel B mixer to W14 (to A20 LODA) |
| W16 | E8361-20056 | 1 | A19 splitter to A20 LODA |
| W17 | E8361-20057 | 1 | A19 splitter to A20 LODA |
| W19 | E8364-20145 | 1 | A18 MA 24 to A17 LOMA 12 |
| W20, W21 | Refer to "Top Cab | les—All | , All Options" on page 6-14. |
| W51 | E8361-20036 | 2 | A23 SOMA 70 to A36 step attenuator |
| W52 | E8301-20030 | 2 | A24 SOMA 70 to A37 step attenuator |
| W55 | E8361-20033 | 1 | A38 bias tee to A25 test port 1 coupler |
| W56 | E8361-20027 | 1 | A39 bias tee to A26 test port 2 coupler |
| W60 | E8361-20023 | 6 | Front-panel jumper |
| W66 | E8361-20016 | 1 | A24 SOMA 70 to REFERENCE 2 SOURCE OUT |
| W67 | E8361-20018 | 2 | A25 test port 1 coupler to PORT 1 CPLR ARM |
| W68 | 120010 | 2 | A26 test port 2 coupler to PORT 2 CPLR ARM |
| W69 | E8361-20047 | 1 | PORT 1 RCVR A IN to A27 channel A mixer |
| W71 | E8361-20020 | 1 | REFERENCE 2 RCVR R2 IN to A29 channel R2 mixer |
| W72 | E8361-20048 | 1 | PORT 2 RCVR B IN to A30 channel B mixer |
| W81 | E8361-20035 | 1 | A36 step attenuator to port 1 SOURCE OUT |
| W82 | E8361-20026 | 1 | A37 step attenuator to port 2 SOURCE OUT |
| W83 | E8361-20034 | 1 | Port 1 CPLR THRU to A38 bias tee |
| W84 | E8361-20028 | 1 | Port 2 CPLR THRU to A39 bias tee |
| W96 | E8361-20037 | 1 | A23 SOMA 70 to A45 reference switch |
| W97 | E8361-20038 | 1 | A45 reference switch to REFERENCE 1 SOURCE OUT |
| W98 | E8361-20058 | 1 | REFERENCE 1 RCVR R1 IN to A45 reference switch |
| W99 | E8361-20040 | 1 | A45 reference switch to A28 R1 mixer |
| W109 | E8361-20050 | 1 | A12 source to A47 RF coupler |
| W110 | E8361-20053 | 1 | A18 MA24 to A48 LO coupler |
| W111 | E8361-20051 | 1 | A47 coupler to A21 SOMA 50 |
| W112 | E8361-20055 | 1 | A48 LO coupler to A19 splitter |
| W113 | E8361-20052 | 1 | A47 RF coupler to rear panel TEST SET DRIVERS RF |
| W114 | E8361-20054 | 1 | A48 LO coupler to rear panel TEST SET DRIVERS LO |

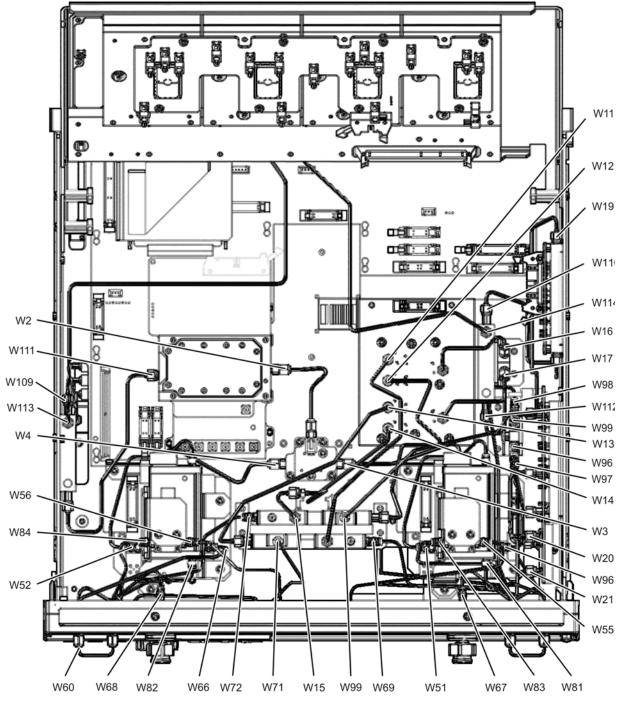


Figure 6-18 Bottom Semi-Rigid Cables, Options 014/UNL/080/081/H11

| Reference Designator | Part Number | Qty | Description |
|-------------------------|-------------|-----|--|
| W23 | E8364-60019 | 1 | A27 channel A mixer to A49 IF multiplexer board |
| W24 | E8364-60020 | 1 | A28 channel R1 mixer to A49 IF multiplexer board |
| W25 | E8364-60021 | 1 | A29 channel R2 mixer to A49 IF multiplexer board |
| W26 | E8364-60022 | 1 | A30 channel B mixer to A49 IF multiplexer board |
| W27 | | | A49 IF multiplexer board to A31 receiver A |
| W28 | 8120-5014 | 4 | A49 IF multiplexer board to A32 receiver R1 |
| W29 | 8120-3014 | 4 | A49 IF multiplexer board to A33 receiver R2 |
| W30 | | | A49 IF multiplexer board to A34 receiver B |
| W31 | E8364-60126 | 1 | A31 receiver A J400 to A6 SPAM board J3 |
| W32 | E8364-60127 | 1 | A32 receiver R1 J400 to A6 SPAM board J4 |
| W33 | E8364-60128 | 1 | A33 receiver R2 J400 to A6 SPAM board J5 |
| W34 | E8364-60129 | 1 | A34 receiver B J400 to A6 SPAM board J6 |
| W35 | E8364-60124 | 1 | A35 receiver motherboard J2 to A10 frequency reference board J4 |
| W36 | E8364-60125 | 1 | A35 receiver motherboard J50 to A11 phase lock board J6 |
| W37 | E8364-60161 | 1 | A49 IF multiplexer board J1 to A16 test set motherboard J15 |
| W38 | E8361-60124 | 1 | A16 test set motherboard J204 (R1) to A23 SOMA 70 |
| W39 | E8361-60123 | 1 | A16 test set motherboard J205 (R2) to A24 SOMA 70 |
| W40 | E8364-60123 | 1 | A16 test set motherboard J206 (SOMA50) to A21 SOMA 50 |
| W95 | E8364-60017 | 1 | A35 receiver motherboard J502 to A13 frequency offset receiver assembly J6 (Option 080) |
| W101 | | | A49 IF multiplexer board J102 to rear panel 8.33 MHz IF IN A (Option H11) |
| W102 | | | A49 IF multiplexer board J202 to rear panel 8.33 MHz IF IN R1 (Option H11) |
| W103 | | | A49 IF multiplexer board J302 to rear panel 8.33 MHz IF IN R2 (Option H11) |
| W104 | 8120-5401 | 8 | A49 IF multiplexer board J402 to rear panel 8.33 MHz IF IN B (Option H11) |
| W105 | | 8 | A49 IF multiplexer board J104 to rear panel PULSE IN A (Option H11) |
| W106 | | | A49 IF multiplexer board J204 to rear panel PULSE IN R1 (Option H11) |
| W107 | | | A49 IF multiplexer board J304 to rear panel PULSE IN R2 (Option H11) |
| W108 | | | A49 IF multiplexer board J404 to rear panel PULSE IN B (Option H11) |

Bottom Flexible RF Cables, All Options

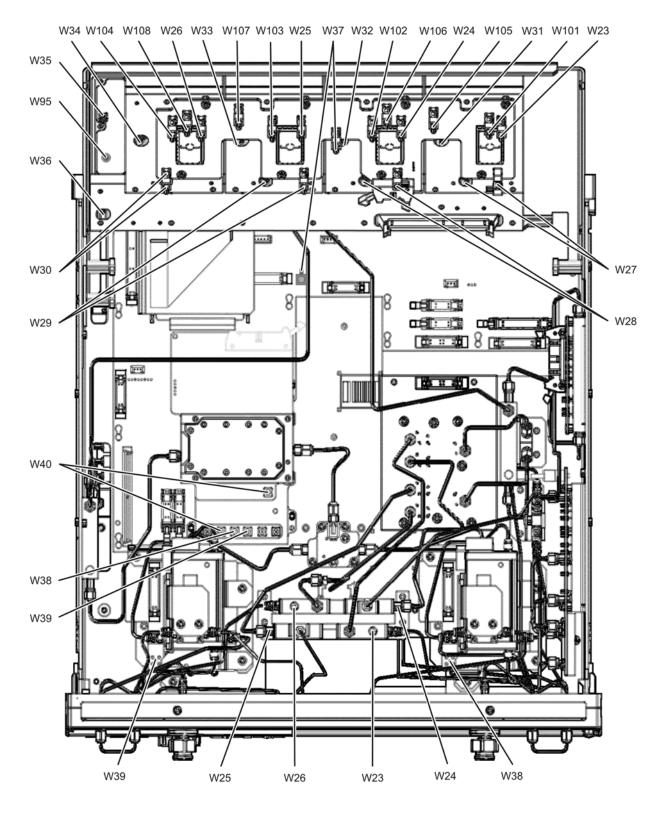


Figure 6-19 Bottom Flexible RF Cables, All Options

Bottom Ribbon and Wrapped-Wire Cables, All Options

| Reference Designator | Type ^a | Part Number | Description |
|-------------------------|-------------------|-------------|--|
| 1 | 40R | 8121-0834 | A16 test set motherboard P701 (MAT HDLR) to rear-panel connector, Handler I/O |
| 2 | 26R | 8121-0818 | A21 SOMA 50 to A16 test set motherboard J4 (SOMA50) |
| 3 | 60R | 8121-0965 | A16 test set motherboard J2 (RCVR) to A35 receiver motherboard and A49 IF multiplexer board |
| 4 | 24R | 8121-0815 | A18 MA 24 to A16 test set motherboard J7 (MA20) |
| 5 | 20R | 8121-0846 | A17 LOMA 12 to A16 test set motherboard J10 (LOMA10) |
| 6 | 16R | 8121-0816 | A20 LODA to A16 test set motherboard J11 (LODA) |
| \bigcirc | 2W | 8121-0990 | A22 switch to A16 test set motherboard J500 |
| 8 | 200 | 8121 1001 | A23 SOMA 70 to A16 test set motherboard J50 (SOMA70_1) |
| 0 | 20R | 8121-1001 | A24 SOMA 70 to A16 test set motherboard J40 (SOMA70_2) |
| 9 | 14R | 8121-0814 | Mixer bias board to A16 test set motherboard J3 (MIXERS) |
| 10 | 4W | 8121-0802 | Front-panel LED board to A16 test set motherboard J502 |
| (1) | 100R | 8121-0118 | A16 test set motherboard J1 to A14 system motherboard J8 |
| (12) | 10R | 8121-0819 | A36 source step attenuator to A16 test set motherboard P510 (P1 SRC ATT) |
| (13) | 10R | 8121-0119 | A37 source step attenuator to A16 test set motherboard P512 (P2 SRC ATT) |
| (14) | 3W | E7340-60075 | A38 bias tee to A16 test set motherboard J22 (P1 BIAS T) |
| <u></u> | | | A39 bias tee to A16 test set motherboard J25 (P2 BIAS T) |
| (15) | 10R | 8121-0819 | A43 receiver step attenuator to A16 test set motherboard P500 (P1 RCVR ATT) |
| | 101 | | A44 receiver step attenuator to A16 test set motherboard P501 (P2 RCVR ATT) |
| (16) | 2W | 8121-0966 | A45 reference switch to A16 test set motherboard J30 (+SW1) |

a. nW = n wires in a wrapped cable; nR = n wires in a ribbon (flat) cable

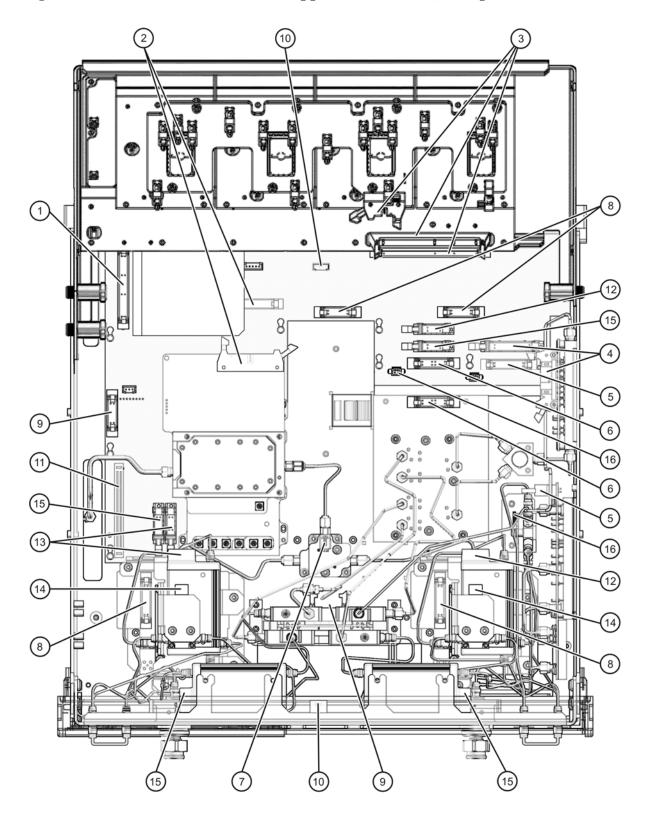


Figure 6-20 Bottom Ribbon and Wrapped-Wire Cables, All Options

| Reference Designator | Part Number | Qty | Description |
|-------------------------|-------------|----------|--|
| B1 | Fans | Refer to | "Internal Hardware and Parts, All Options" on page 6-52. |
| 1 | 5022-6134 | 1 | Cable hold down |
| 2 | E8361-60059 | 1 | USB hub board |
| 3 | E8356-60024 | 1 | Hard disk drive interface board |
| (4) | E8356-00014 | 1 | Bracket (for hard disk drive interface board ③) |
| 5 | 0515-0430 | 2 | Machine screw, M3.0 x 6, pan head (for bracket ④) |
| 6 | E8356-40001 | 1 | Air flow plenum |
| (7) | 5022-6135 | 1 | Cable hold down |

Top Hardware and Parts, All Options

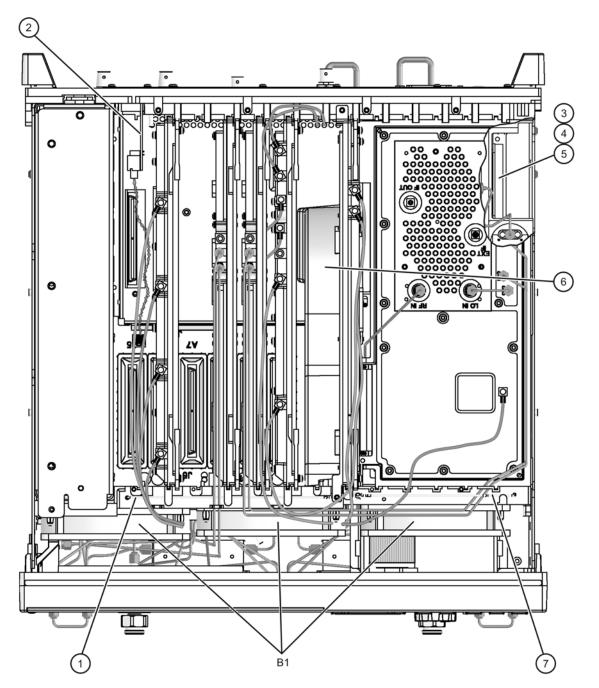


Figure 6-21 Top Hardware and Parts, All Options

| Reference Designator | Part Number | Qty | Description |
|-------------------------|-------------|-----|--|
| (1) | E8361-00002 | 2 | Bracket, A23/A24 SOMA 70s |
| 2 | 0515-0667 | 4 | Machine screw M3.0 x 25 pan head (to attach A23/A24 SOMA 70s to brackets-2 ea) |
| 3 | E8364-20115 | 1 | Bracket, A27–A30 mixers |
| 4 | E8361-60044 | 1 | Mixer bias board |
| (5) | 0515-0430 | 11 | Machine screw M3.0 x 6 pan head (A23/A24 SOMA 70 brackets-3 ea; front-panel LED board-3; A45 reference transfer switch bracket-2) |
| 6 | 0515-0372 | 24 | Machine screw M3.0 x 8 pan head (A35 receiver motherboard-2; A36/A37 source attenuators-2 ea; A38/A39 bias tees-2 ea; A43/A44 receiver attenuators-2 ea; A45 reference transfer switch-2; source attenuator/bias tee brackets-4 ea) |
| (7) | 0515-0374 | 17 | Machine screw M3.0 x 10 pan head (A17 LOMA 12-3; A18 MA 24-4; A20 LODA-2; A22 switch-4; mixer bracket-4) |
| 8 | 0515-0664 | 6 | Machine screw M3.0 x 12 pan head (A19 splitter-2; A16 test set motherboard-4) |
| 9 | 0515-0666 | 29 | Machine screw M3.0 x 18 pan head (A35 receiver motherboard casting-13;A20 LODA-4;A27–A30 mixers-3 ea) |
| 10 | 0515-1349 | 16 | Machine screw M3.0 x 30 pan head (A31–A34 receivers-3 ea; A21 SOMA 50-4) |
| (1) | 08720-60182 | 1 | Front-panel LED board |
| (12) | 5022-1087 | 2 | Test port coupler nut |
| (13) | E8364-00007 | 1 | Hard disk drive shield, stationary bracket |
| 14 | 1400-3014 | 1 | Cable clamp |
| (15) | E8361-00003 | 2 | Bracket, A36/A37 attenuators and A38/A39 bias tees |
| (16) | E8361-00004 | 1 | Bracket, A45 reference transfer switch |
| (17) | 0515-1644 | 8 | Machine screw M3.0 x 12 flat head (A49 IF multiplexer board-8) |
| (18) | 0515-1862 | 4 | Machine screw M3.0 x 27.5 pan head (to attach E8361-20063 lid clamps to A23/A24 SOMA 70s-2 ea) |
| (19) | E8361-20063 | 2 | Lid clamp - SOMA 70s |

Bottom Hardware and Parts, All Options

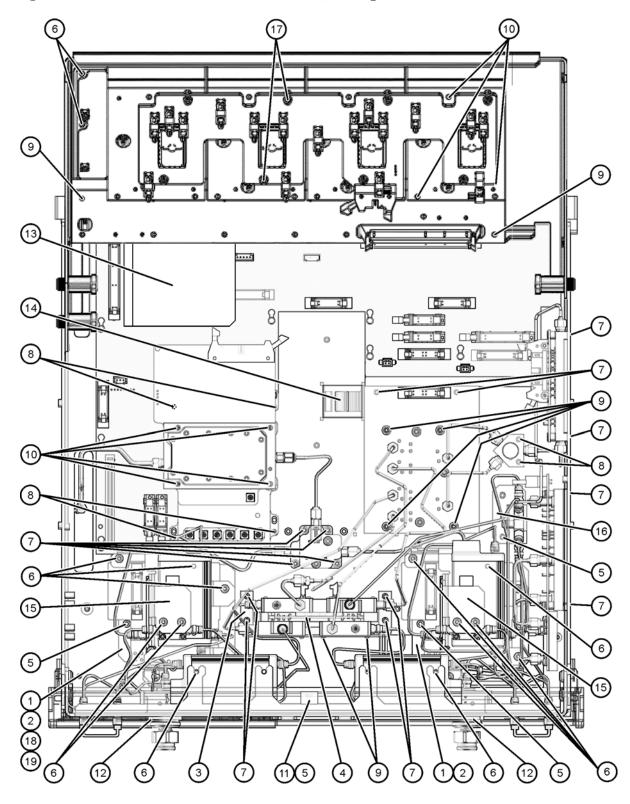


Figure 6-22 Bottom Hardware and Parts, All Options

| Reference Designator | Part Number | Qty | Description |
|-------------------------|-------------|-----|---|
| | 0950-2782 | 1 | Floppy disk drive |
| | 8121-0120 | 1 | Cable |
| A40 | E4406-60014 | 1 | Floppy disk drive board |
| | E4406-40006 | 1 | Floppy disk drive mount |
| | E8356-00007 | 1 | Floppy disk drive enclosure |
| B1 | 3160-1085 | 3 | Fan |
| 1 | E8356-00027 | 1 | Chassis assembly |
| 2 | E8364-00013 | 1 | Test set deck |
| 3 | E8364-00014 | 1 | Test set deck front panel |
| (4) | 5065-4673 | 12 | 1.85 mm (f) bulkhead connectors |
| 5 | 1250-3310 | 12 | Washer (for bulkhead connectors, (4)) |
| 6 | 1250-3311 | 12 | Hex nut (for bulkhead connectors, (4)) |
| Ô | E8356-40004 | 1 | Line switch button |
| 8 | 1460-2632 | 1 | Line switch spring |
| 9 | E4406-60109 | 1 | Midweb assembly (includes three fans, B1) |

Internal Hardware and Parts, All Options

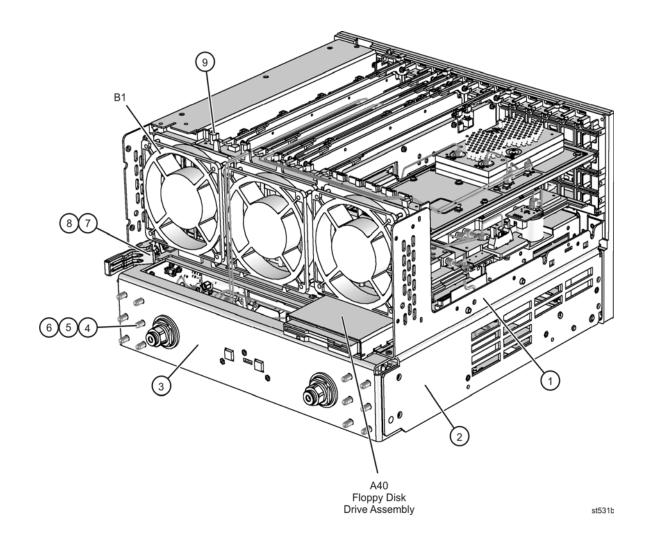
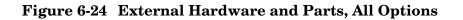
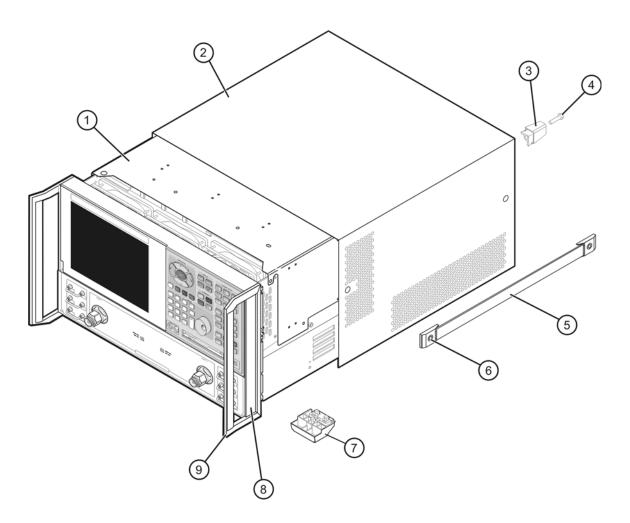


Figure 6-23 Internal Hardware and Parts, All Options

| Reference Designator | Part Number | Qty | Description |
|-------------------------|-------------|-----|---|
| 1 | E8356-00011 | 1 | Inner cover |
| 2 | N5230-00011 | 1 | Outer cover |
| 3 | 5041-9611 | 4 | Rear feet |
| 4 | 0515-1619 | 4 | Machine screw M4.0 x 25, pan head |
| 5 | E4400-60026 | 2 | Strap handle assembly (includes item ⁽⁶⁾) |
| 6 | 0515-0710 | 4 | Machine screw M5.0 x 18, flat head |
| 7 | 5041-9167 | 4 | Bottom feet |
| 8 | 5041-9183 | 2 | With handles—front handle side trim |
| 9 | 5041-9174 | 2 | Without handles—trim strip, filler |
| | 5063-9205 | 2 | Front handle |

External Hardware and Parts, All Options





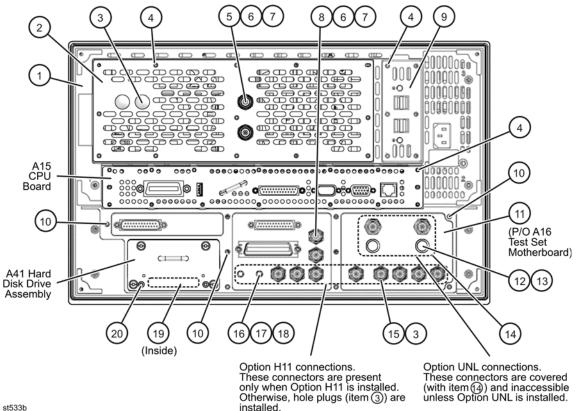
st534a

| Item Number | Part Number | Qty | Description |
|-------------|--|-----|--|
| 1 | E8364-60023 | 1 | Rear frame assembly (includes items (2) – (7)) |
| 2 | E8356-00023 | 1 | Cover plate, large |
| 3 | 6960-0149 | 10 | Hole plug (only 2 installed if Option H11 is installed) |
| 4 | 0515-0372 | 33 | Machine screw, M3.0 x 8, pan head |
| 5 | 8120-5055 | 2 | BNC cable assembly |
| 6 | 2950-0035 | 4 | Hex nut (for BNC cable assemblies (5) and (8)) |
| 0 | 2190-0102 | 4 | Lock washer (for BNC cable assemblies (5) and (8)) |
| 8 | 8120-5027 | 2 | BNC cable assembly |
| 9 | E8356-00037 | 1 | Cover plate, USB hub. Refer to "Top Hardware and Parts, All Options" on page 6-48 or the part number of the USB hub board. |
| 10 | 0515-0374 | 9 | Machine screw, M3.0 x 10, pan head |
| 1) | E8361-00006 | 1 | Test set motherboard rear panel (P/O A16) |
| 12 | 85047-00017 | 2 | Fuse holder (includes wire harness, nut, and washer) ^a |
| (13) | 1400-0012 | 2 | Fuse holder cap |
| 14 | E8364-00018 | 1 | Cover (not shown), for bias connectors and fuse holders (Installed only on analyzers without Option UNL.) |
| (15) | (b) These connectors are part of their respective cables. Refer to "Bottom Flexible RF Cables, All Options" on page 6-44. Hole plugs (item (3)) are installed here if Option H11 is not installed. | | |
| 16 | 6960-0076 | 2 | Hole plug (if Option H11 is not installed) |
| 17 | 1250-1251 | 2 | SMA connector, f-f |
| 18 | 1810-0118 | 2 | SMA coaxial termination, 50 ohm |
| (19 | E8364-60095 | 1 | Hard disk drive stationary board with mating connector. |
| 20 | 0515-1410 | 2 | Machine screw, M3.0 x 20, pan head (to secure item (19) |

Rear Panel Assembly, All Options

a. See page 6-59 for the part number of the fuses.



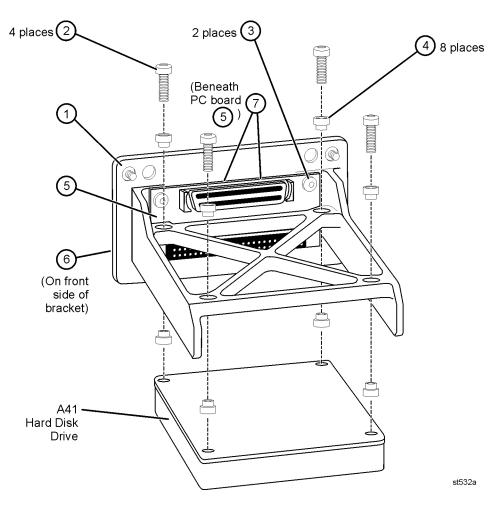


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| Reference Designator | Part Number | Qty | Description |
|-------------------------|-------------|-----|--|
| A41 | E8801-60063 | 1 | Programmed hard disk drive |
| 1 | E8364-20118 | 1 | Hard disk drive bracket |
| 2 | 0515-0664 | 4 | Machine screw, M3.0 x 12, pan head |
| 3 | 0515-0372 | 2 | Machine screw, M3.0 x 8, pan head |
| (4) | 0340-1525 | 8 | Bushing |
| 5 | E8364-60094 | 1 | Hard disk drive board |
| 6 | 1440-0421 | 1 | U-handle, finger grip |
| (7) | 0515-1227 | 2 | Machine screw, M3.0 x 6, flat head (for U-handle, 6) |

Hard Disk Drive Assembly, All Options

Figure 6-26 Hard Disk Drive Assembly, All Options



Miscellaneous Part Numbers

Table 6-3 Part Numbers for Miscellaneous Parts and Accessories

| Description | Model or Part Number | | |
|---|---------------------------------------|--|--|
| Service Tools | | | |
| Extender board, synthesizer/reference | E8356-60021 | | |
| 1/4 inch and 5/16 inch open-end wrench, thin profile | 8710-0510 | | |
| 5/16 inch (8 mm), open-end torque wrench; 0.9 N-m (8 in-lb) | 8710-1765 | | |
| 20 mm open-end torque wrench; 0.9 N-m (8 in-lb) | 8710-1764 | | |
| Spanner wrench | 08513-20014 | | |
| Documentation | | | |
| Installation and Quick Start Guide | E8356-90001 ^a | | |
| Service Guide (this manual) | E8361-90001 ^a | | |
| Protective Caps for Connectors | | | |
| Front panel jumper guard | E8361-00009 | | |
| Protective cap for GPIB connector | 1252-5007 | | |
| Protective cap for Test Set I/O connector | 1252-1935 | | |
| Protective cap for Aux I/O connector | 1252-4691 | | |
| Protective cap for Handler I/O connector | 1253-5320 | | |
| Protective cap for Display (VGA) connector | 1252-0220 | | |
| Protective cap for Serial (RS-232) connector | 1252-3422 | | |
| Protective cap for Parallel (1284-C) connector | 1252-1935 | | |
| Protective cap for test port (Port 1, Port 2) connector | 1401-0247 | | |
| GPIB Cables/GPIB Adapter | | | |
| GPIB cable, 0.5 meter (1.6 feet) | 10833D | | |
| GPIB cable, 1 meter (3.3 feet) | 10833A | | |
| GPIB cable, 2 meter (6.6 feet) | 10833B | | |
| GPIB cable, 4 meter (13.2 feet) | 10833C | | |
| GPIB cable to GPIB cable adapter | 10834A | | |
| Fuses | | | |
| Rear Panel Bias Input Fuse Port 1, Port 2 (0.5 A, 125 V) (Option UNL) | 2110-0046 | | |
| Memory Modules | · · · · · · · · · · · · · · · · · · · | | |
| 128 MB module, 16 M x 64, PC100, 144-pin, SO DIMM | E8356-60089 | | |
| 256 MB module, 32 M x 64, PC100, 144-pin, SO DIMM | 1818-8825 | | |

| Description | Model or Part Number | | | | |
|---|-------------------------|--|--|--|--|
| ESD Supplies | ESD Supplies | | | | |
| Adjustable antistatic wrist strap | 9300-1367 | | | | |
| Antistatic wrist strap grounding cord (5 foot length) | 9300-0980 | | | | |
| Static control table mat and earth ground wire | 9300-0797 | | | | |
| ESD heel strap | 9300-1126 | | | | |
| EMI/RFI Shielding Accessories | | | | | |
| 5 mm ferrite bead for probe power | 9170-2047 | | | | |
| 7 mm ferrite bead for serial cable | 9170-1793 | | | | |
| 9 mm ferrite bead for parallel port | 9170-1702 | | | | |
| Upgrade Kits | | | | | |
| Time domain (Option 010) | E8361AU-010 | | | | |
| Configurable test set (Option 014) | E8361AU-014 | | | | |
| Receiver attenuators (Option 016) | E8361AU-016 | | | | |
| Frequency offset mode (Option 080) | E8361AU-080 | | | | |
| External reference switch (Option 081) | E8361AU-081 | | | | |
| Frequency converter measurement application (Option 083) | E8361AU-083 | | | | |
| Pulse measurement capability (Option H08) | E8361AU-H08 | | | | |
| IF access (Option H11) | E8361AU-H11 | | | | |
| Source attenuators and bias tees (Option UNL) | E8361AU-UNL | | | | |
| Touch-up Paint | | | | | |
| Dove gray (for use on frame around front panel and painted portion of handles) | 6010-1146 | | | | |
| French gray (for use on cover) | 6010-1147 | | | | |
| Parchment white (for use on rack mount flanges, rack support flanges, and front panels) | 6010-1148 | | | | |
| USB Accessories | | | | | |
| Mouse | 1150-7799 | | | | |
| Keyboard (U.S. style) | 1150-7896 | | | | |
| Read/write CD-ROM | N4688A | | | | |

Table 6-3 Part Numbers for Miscellaneous Parts and Accessories (Continued)

| Description | Model or Part Number | | |
|---|-------------------------|--|--|
| Rack Mount Kits and Handle Kits | | | |
| Rack mount kit for instruments with handles (Option 1CP) | 5063-9237 | | |
| Rack mount flange for use with handles (two included in 5063-9237) | 5022-2809 | | |
| Rack mount kit for instruments without handles (Option 1CM) | 5063-9217 | | |
| Rack mount flange for use without handles (two included in 5063-9217) | 5022-2802 | | |
| Front handle kit (two handles and hardware) | 5063-9230 | | |
| Front handle (two included in 5063-9230) | 5063-9205 | | |
| Rack mount rail set | E3663AC | | |

Table 6-3 Part Numbers for Miscellaneous Parts and Accessories (Continued)

a. This item can not be ordered. It can be printed from the Agilent web site. Refer to "Printing Copies of Documentation from the Web" on page iv.

7 Repair and Replacement Procedures

Information in This Chapter

This chapter contains procedures for removing and replacing the major assemblies of your Agilent Technologies PNA series microwave network analyzer.

Chapter Seven at-a-Glance

| Section Title | Summary of Content | Start Page |
|---|--|---|
| Before Starting the Removal and Replacement Procedures | Warnings and cautions pertaining to personal safety and ESD protection. | Page 7-3 |
| | The proper assembly replacement sequence for your analyzer. | |
| Table of Removal and Replacement Procedures | A table of removal and replacement procedures and the corresponding page number where they are located. | Page 7-4 |
| Removal and Replacement Procedures | The actual procedures for removing and replacing the major assemblies in your analyzer. The procedures occur in assembly reference designator numerical order. | See Table 7-1 on page 7-4 for specific procedures. |
| Post-Repair Procedures | A table for the proper tests, verifications, and adjustments to perform on your analyzer after repair. | Page 7-76 |

Before Starting the Removal and Replacement Procedures

Before starting the removal and replacement procedures, review these warnings, cautions, and the assembly replacement sequence.

Personal Safety Warnings

| WARNING | These servicing instructions are for use by qualified personnel only. To avoid electrical shock, do not perform any servicing unless you are qualified to do so. |
|---------|--|
| WARNING | The opening of covers or removal of parts is likely to expose dangerous voltages. Disconnect the analyzer from all voltage sources while it is being opened. |
| WARNING | The power cord is connected to internal capacitors that may remain live for 10 seconds after disconnecting the plug from its power supply assembly. Wait at least 10 seconds, after disconnecting the plug, before removing the covers. |

Electrostatic Discharge (ESD) Protection

| CAUTION | Many of the assemblies in this instrument are very susceptible to damage from electrostatic discharge (ESD). Perform the following procedures only at a static-safe workstation and wear a grounded wrist strap. |
|---------|--|
| | This is important. If not properly protected against, electrostatic discharge can seriously damage your analyzer, resulting in costly repair. |
| | To reduce the chance of electrostatic discharge, follow all of the recommendations outlined in "Electrostatic Discharge Protection" on page 1-6, for all of the procedures in this chapter. |

Assembly Replacement Sequence

The following steps show the sequence that you should follow to replace an assembly in the network analyzer.

- Step 1. Identify the faulty group. Begin with Chapter 4, "Troubleshooting."
- Step 2. Order a replacement assembly. See Chapter 6, "Replaceable Parts."
- **Step 3.** Replace the faulty assembly and determine what adjustments are necessary. Refer to "Post-Repair Procedures" in this chapter.
- Step 4. Perform the necessary adjustments. See Chapter 3, "Tests and Adjustments."
- **Step 5.** Perform the necessary performance tests. See Chapter 3, "Tests and Adjustments."

Removal and Replacement Procedures

| Table 7-1 | List of Procedures |
|-----------|--------------------|
|-----------|--------------------|

| Reference Designator | Assembly Type | Location |
|-------------------------|---|-----------|
| N/A | Covers, outer and inner | Page 7-6 |
| N/A | Receiver deck | Page 7-8 |
| N/A | Midweb and fans | Page 7-72 |
| N/A | Front panel assembly | Page 7-10 |
| N/A | Mixer bias board (part of A27, A28, A29, A30 procedure) | Page 7-48 |
| N/A | USB hub | Page 7-75 |
| A1 | Keypad assembly | |
| A2 | Display assembly | Page 7-12 |
| A3 | Front panel interface board | |
| A4 | Power supply assembly | Page 7-16 |
| A6 | SPAM board | |
| A8 | Fractional-N synthesizer board | D 510 |
| A9 | Fractional-N synthesizer board (Option 080) | Page 7-18 |
| A10 | Frequency reference board | |
| A11 | Phase lock board | Page 7-20 |
| A12 | Source 20 | Page 7-22 |
| A13 | Frequency offset receiver board (Option 080) | Page 7-24 |
| A14 | System motherboard | Page 7-26 |
| A15 | CPU board | Page 7-28 |
| A16 | Test set motherboard | Page 7-30 |
| A17 | LOMA 12 | Page 7-32 |
| A18 | MA 24 | Page 7-34 |
| A19 | Splitter | Page 7-36 |
| A20 | LODA | Page 7-38 |
| A21 | SOMA 50 | Page 7-40 |

| Reference Designator | Assembly Type | Location | |
|-------------------------|---|---------------|--|
| A22 | Switch | Page 7-42 | |
| A23 | SOMA 70 (Port 1) | Page 7-44 | |
| A24 | SOMA 70 (Port 2) | | |
| A25 | Test port 1 coupler | Demo 7.46 | |
| A26 | Test port 2 coupler | Page 7-46 | |
| A27 | Channel A first converter (mixer) | | |
| A28 | Channel R1 first converter (mixer) | D 7 40 | |
| A29 | Channel R2 first converter (mixer) | Page 7-48 | |
| A30 | Channel B first converter (mixer) | | |
| A31 | Channel A receiver module | | |
| A32 | Channel R1 receiver module | D 550 | |
| A33 | Channel R2 receiver module | Page 7-50 | |
| A34 | Channel B receiver module | | |
| A35 | Receiver motherboard | Page 7-52 | |
| A36 | Port 1 50-dB source step attenuator (Option UNL) | D 7 54 | |
| A37 | Port 2 50-dB source step attenuator (Option UNL) | Page 7-54 | |
| A38 | Port 1 bias tee (Option UNL) | D 7 50 | |
| A39 | Port 2 bias tee (Option UNL) | Page 7-56 | |
| A40 | Floppy disk drive | Page 7-58 | |
| A41 | Hard disk drive | Page 7-60 | |
| A43 | Channel A 50-dB receiver step attenuator (Option 016) | D 7.00 | |
| A44 | Channel B 50-dB receiver step attenuator (Option 016) | Page 7-66 | |
| A45 | Channel R1 reference channel transfer switch (Option 081) | Page 7-68 | |
| A47 | RF path coupler (Option H11) | | |
| A48 | LO path coupler (Option H11) | Page 7-70 | |
| A49 | IF multiplexer board (part of A31, A32, A33, A34 procedure) | Page 7-50 | |

Table 7-1 List of Procedures (Continued)

Removing the Covers

Tools Required

- T-10 TORX driver (set to 9 in-lb)
- T-20 TORX driver (set to 21 in-lb)

Removing the Outer Cover

```
CAUTION This procedure is best performed with the analyzer resting on its front handles in the vertical position. Do not place the analyzer on its front panel without the handles. This will damage the front panel assemblies.
```

Refer to Figure 7-1 for this procedure.

- 1. Disconnect the power cord.
- 2. With a T-20 TORX driver, remove the strap handles (item ①) by loosening the screws (item ②) on both ends until the handle is free of the analyzer.
- 3. With a T-20 TORX driver, remove the four rear panel feet (item ③) by removing the center screws (item ④).
- 4. Slide the four bottom feet (item (5)) off the cover.
- 5. Slide the cover off of the frame.

Removing the Inner Cover

Refer to Figure 7-1 for this procedure.

- 1. With a T-10 TORX driver, remove the 11 screws (item ⁽⁶⁾).
- 2. Lift off the cover.

Replacement Procedure

Reverse the order of the removal procedures.

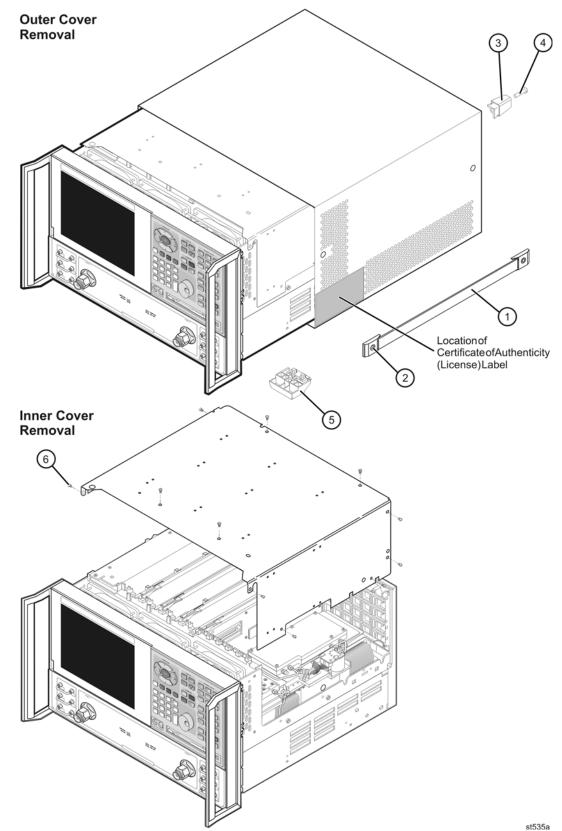


Figure 7-1 Outer and Inner Cover Removal

Raising and Removing the Receiver Deck

Tools Required

• T-10 TORX driver (set to 9 in-lb)

Raising the Receiver Deck

Refer to Figure 7-2 for this procedure.

- 1. Disconnect the power cord.
- 2. Remove the outer cover.
- 3. Place the analyzer bottom-side up on a flat surface.
- 4. With a T-10 TORX driver, remove the four screws (item ①), securing the receiver deck.
- 5. Pull the latch pin (item (2)) toward the center of the analyzer to release receiver deck.
- 6. Lift the receiver deck to partially raise it, then release the latch pin (item 2). Lift the receiver deck to its fully raised position and ensure that the latch pin latches in the raised position.

Lowering the Receiver Deck

Refer to Figure 7-2 for this procedure.

- 1. Pull the latch pin (item (2)) toward the center of the analyzer to release the receiver deck.
- 2. Lift the receiver deck to partially lower it, then release the latch pin (item 2). Lower the receiver deck to its fully lowered position and ensure that the latch pin latches in the lowered position.
- 3. With a T-10 TORX driver, install the four screws (item 1), to secure the receiver deck.

Removing the Receiver Deck

Refer to Figure 7-2 for this procedure.

- 1. Raise the receiver deck as outlined in "Raising the Receiver Deck," above.
- 2. Disconnect all flexible cables and ribbon cables that connect between the receiver deck and the rest of the analyzer. Label the cables and connectors for proper reconnection later.
- 3. Pull the latch pin (item (3)) to release one side of the receiver deck.
- 4. Lift the side of the receiver deck that was just released, above the side of the analyzer, and then lift the entire receiver deck out of the analyzer.

Replacing the Receiver Deck

Refer to Figure 7-2 for this procedure.

1. Reverse the procedure for "Removing the Receiver Deck," above.

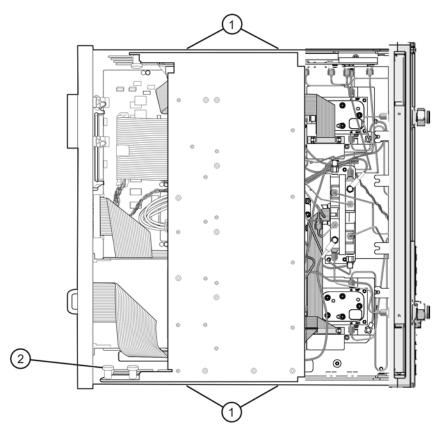
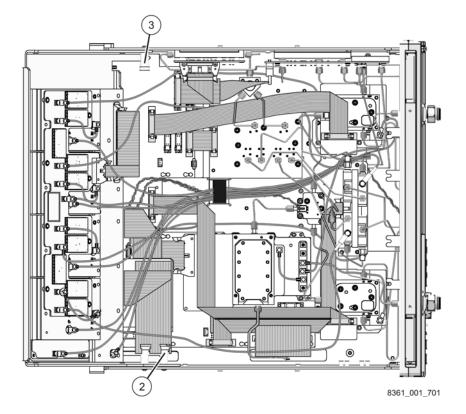


Figure 7-2 Receiver Deck, Raising and Removal



Removing and Replacing the Front Panel Assembly

Tools Required

- T-10 TORX driver (set to 9 in-lb)
- T-20 TORX driver (set to 21 in-lb)
- 5/16 inch open-end torque wrench (set to 10 in-lb)
- ESD grounding wrist strap

Removal Procedure

Refer to Figure 7-3 for this procedure.

- 1. Disconnect the power cord.
- 2. Remove the outer cover. Refer to "Removing the Covers" on page 7-6.
- 3. With a 5/16 inch torque wrench, remove all the semirigid jumpers (item (1)) from the front panel (Option 014 only).
- 4. With a T-10 TORX driver, remove the eight screws (item ⁽²⁾) from the sides of the frame.

| CAUTION | Before removing the front panel from the analyzer, lift and support the front |
|---------|---|
| | of the analyzer frame. |

- 5. Slide the front panel over the test port connectors.
- 6. Disconnect the front panel interface ribbon cable (item ③).

The front panel is now free from the analyzer.

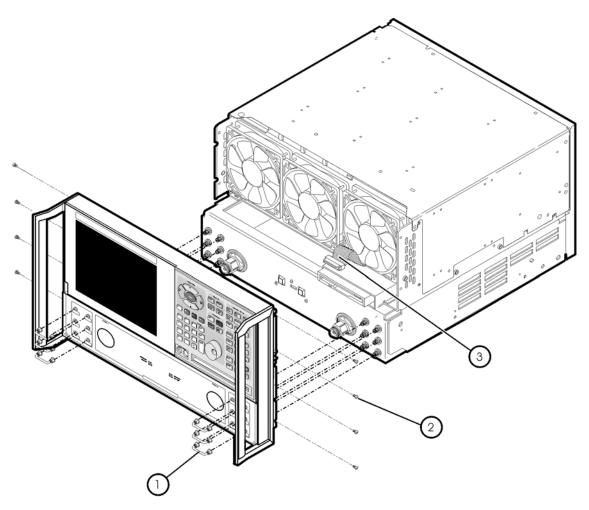
Replacement Procedure

CAUTION When replacing the front panel, align the power switch and the floppy disk drive to their corresponding front panel cutouts.

IMPORTANT When reconnecting semirigid cables, torque the cable connectors to 10 in-lb.

- 1. Reverse the order of the removal procedure.
- 2. Perform the post-repair adjustments, verifications, and performance tests that pertain to this removal procedure. Refer to Table 7-2 on page 7-76.

Figure 7-3 Front Panel Assembly Removal



st536a

Removing and Replacing Front Panel Subassemblies

Tools Required

- T-10 TORX driver (set to 9 in-lb)
- T-20 TORX driver (set to 21 in-lb)
- 5/16 inch open-end torque wrench (set to 10 in-lb)
- ESD grounding wrist strap

Refer to Figure 7-4 for the following procedures.

Pre-removal Procedure

- 1. Disconnect the power cord.
- 2. Remove the front panel assembly. Refer to "Removing and Replacing the Front Panel Assembly" on page 7-10.
- 3. Disconnect the display ribbon cable (item (1)) and the display lamp cable (item (2)) from the A3 front panel interface board.

Removing the A2 Display Assembly

- 1. With a T-10 TORX driver, remove the four retaining screws (item ③) from the display assembly.
- 2. Remove the display assembly from the front panel.

Removing the A3 Front Panel Interface Board

- 1. Remove the round knob (RPG) from the front panel by gently pulling the knob forward.
- 2. With a T-10 TORX driver, remove the seven screws (item 4) from the front panel interface board.
- 3. From the bottom of the frame, lift the A3 front panel interface board up at an angle until the board clears the frame. Disconnect the keypad ribbon cable (item (5)) from the A3 front panel interface board and lift out the board.

Removing the A1 Keypad Assembly

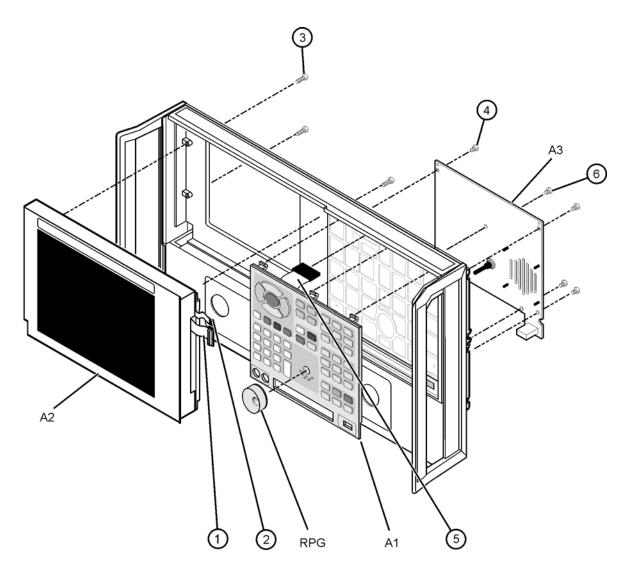
- 1. Remove the A3 front panel interface board as instructed above.
- 2. From the rear of the front panel assembly, remove the center retaining screw (item [®]). Bend the bottom keypad assembly tabs away from the frame and push the A1 keypad assembly out of the frame.

Replacement Procedure

| NOTE When replacing the assemblies, ensure that the ribbon cables are not up the assemblies. | e not under |
|---|-------------|
|---|-------------|

- 1. Reverse the order of the removal procedure.
- 2. Perform the post-repair adjustments, verifications, and performance tests that pertain to this removal procedure. Refer to Table 7-2 on page 7-76.

Figure 7-4 Front Panel Subassemblies Removal



st537a

Removing and Replacing the Display Inverter Board and the Display Lamp

Tools Required

- T-10 TORX driver (set to 9 in-lb)
- T-20 TORX driver (set to 21 in-lb)
- Small jeweler's screwdriver
- 5/16 inch open-end torque wrench (set to 10 in-lb)
- ESD grounding wrist strap

Pre-removal Procedure

- 1. Disconnect the power cord.
- 2. Remove the front panel assembly. Refer to "Removing and Replacing the Front Panel Assembly" on page 7-10.
- 3. Remove the display assembly. Refer to "Removing the A2 Display Assembly" on page 7-12.

Removing the Display Inverter Board

Refer to Figure 7-5 for this procedure.

- 1. Disconnect the ribbon cable (item (1)) and the display lamp cable (item (2)) from the display inverter board.
- 2. Lift the inverter retention tabs (item (3)) with slight pressure and rotate the display inverter board (item (4)).
- 3. Lift the display inverter board (item 4) out of the slot.

Removing the Display Lamp

Refer to Figure 7-5 for this procedure.

- 1. Remove the display lamp cable (item (2)) from the display inverter board (item (4)).
- 2. With a T-10 TORX driver, remove the four screws (item (5)) on the display back panel and then lift the panel off.
- 3. Remove the four display bumpers (item ⁽⁶⁾).
- 4. To gain access to the display lamp, rotate the top of the display outward slightly.

NOTE Stop now if you are only removing the display inverter board. Replace the board and reverse the removal procedure.

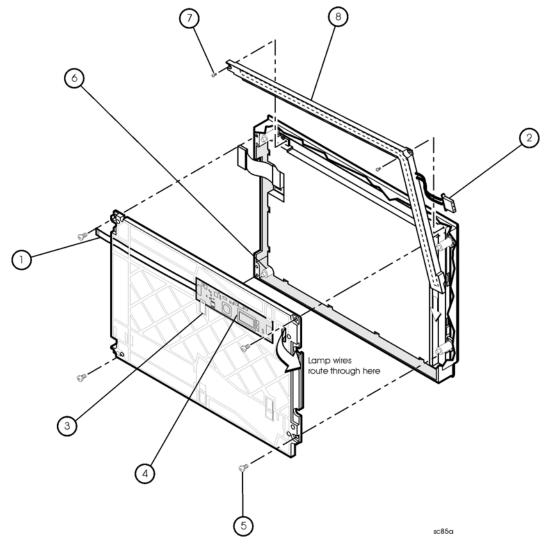
| NOTE | To avoid dust or dirt particles from getting in between the display glass and |
|------|---|
| | the display, do not completely take out the display. |

- 5. Remove the two screws (item ⑦) from the display with the jeweler's screwdriver. Slide the lamp enclosure up to remove it.
- 6. Remove the display lamp (item (8)).

Replacement Procedure

- 1. Reverse the order of the removal procedure.
- 2. Perform the post-repair adjustments, verifications, and performance tests that pertain to this removal procedure. Refer to Table 7-2 on page 7-76.

Figure 7-5 Display Inverter Board and Display Lamp Removal



Removing and Replacing the A4 Power Supply Assembly

Tools Required

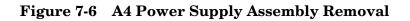
- T-10 TORX driver (set to 9 in-lb)
- T-20 TORX driver (set to 21 in-lb)
- ESD grounding wrist strap

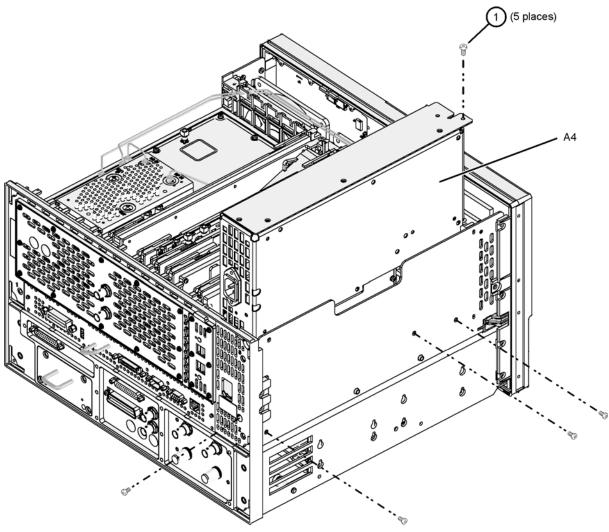
Removal Procedure

Refer to Figure 7-6 for this procedure.

- 1. Disconnect the power cord.
- 2. Remove the outer and inner covers. Refer to "Removing the Covers" on page 7-6.
- 3. With a T-10 TORX driver, remove the five screws (item 1) from the power supply assembly.
- 4. Lift out and remove the A4 power supply assembly.

- 1. Reverse the order of the removal procedure.
- 2. Perform the post-repair adjustments, verifications, and performance tests that pertain to this removal procedure. Refer to Table 7-2 on page 7-76.





st538b

Removing and Replacing the A6, A8, A9, and A10 Boards

Tools Required

- T-10 TORX driver (set to 9 in-lb)
- T-20 TORX driver (set to 21 in-lb)
- ESD grounding wrist strap

Removal Procedure

Refer to Figure 7-7 for this procedure.

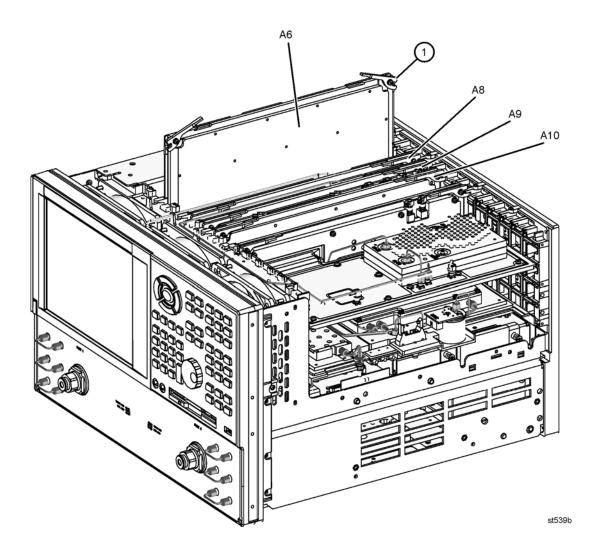
- 1. Disconnect the power cord.
- 2. Remove the outer and inner covers. Refer to "Removing the Covers" on page 7-6.
- 3. With a T-10 TORX driver, remove the two brackets that secure cables to the top of the midweb.
- 4. Identify the board you want to remove and disconnect any cables that are attached to it.
- 5. Lift the two extractors (item 1), located at each end of the board.

| NOTE | Before removing the board completely, check the bottom of the board for any |
|------|---|
| | attached cables. |

6. While holding on to the extractors, slide the board out of the slot and remove it from the analyzer.

- 1. Reverse the order of the removal procedure.
- 2. Perform the post-repair adjustments, verifications, and performance tests that pertain to this removal procedure. Refer to Table 7-2 on page 7-76.





Removing and Replacing the A11 Phase Lock Board

Tools Required

- T-10 TORX driver (set to 9 in-lb)
- T-20 TORX driver (set to 21 in-lb)
- ESD grounding wrist strap

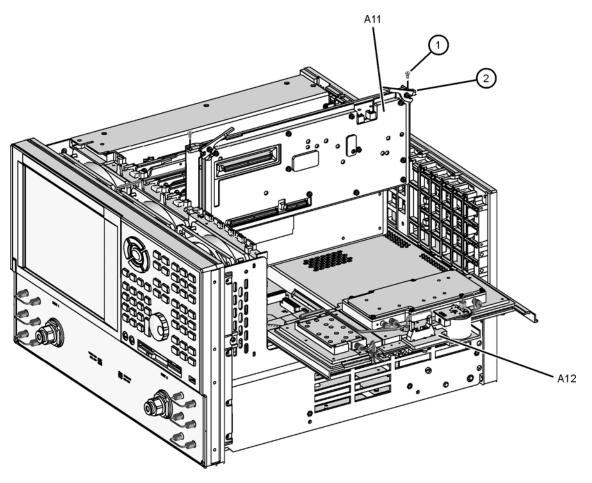
Removal Procedure

Refer to Figure 7-8 for this procedure.

- 1. Disconnect the power cord.
- 2. Remove the outer and inner covers. Refer to "Removing the Covers" on page 7-6.
- 3. With a T-10 TORX driver, remove the two brackets that secure cables to the top of the midweb.
- 4. With a T-10 TORX driver, remove the two screws (item 1) from the top of the A11 phase lock board.
- 5. Remove the A13 frequency offset receiver assembly, if present. Refer to "Removing and Replacing the A13 Frequency Offset Receiver Assembly" on page 7-24.
- 6. Disengage the A12 source 20 from the A11 connector and slide the A12 partially out of the analyzer. Refer to "Removing and Replacing the A12 Source 20" on page 7-22.
- 7. Disconnect any flexible cables that are attached to the A11 phase lock board.
- 8. Lift the two extractors (item 2) located at each end of the board.
- 9. While holding on to the extractors, lift the A11 phase lock board out of the analyzer.

- 1. Reverse the order of the removal procedure.
- 2. Perform the post-repair adjustments, verifications, and performance tests that pertain to this removal procedure. Refer to Table 7-2 on page 7-76.

Figure 7-8 A11 Phase Lock Board Removal



st540b

Removing and Replacing the A12 Source 20

Tools Required

- T-10 TORX driver (set to 9 in-lb)
- T-20 TORX driver (set to 21 in-lb)
- 5/16 inch open-end torque wrench (set to 10 in-lb)
- ESD grounding wrist strap

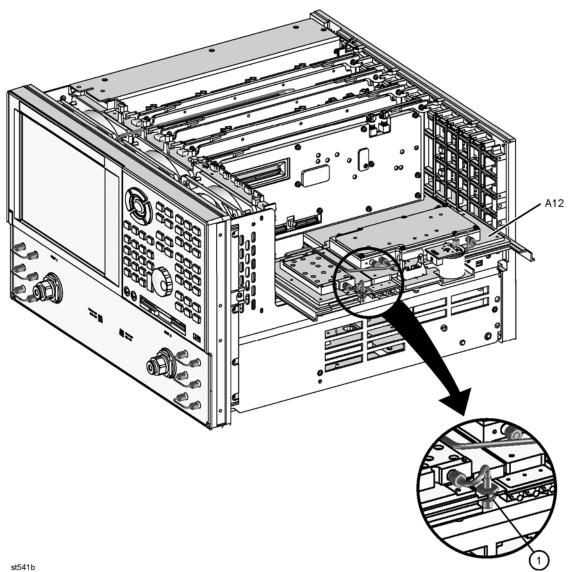
Removal Procedure

Refer to Figure 7-10 for this procedure.

- 1. Disconnect the power cord.
- 2. Remove the outer and inner covers. Refer to "Removing the Covers" on page 7-6.
- 3. Remove the A13 (Option 080) frequency offset receiver assembly, if present. Refer to "Removing and Replacing the A13 Frequency Offset Receiver Assembly" on page 7-24.
- 4. With a 5/16 inch torque wrench, disconnect the semirigid cable (item (1)) from the bottom of the A12 source 20.
- **CAUTION** To avoid damage to the semirigid cable (item ①), pull down on the cable from the bottom of the analyzer to move it away while sliding out the A12 source 20. The cable has some spring to it and the RF pin could be damaged by the A12 source 20.
- 5. Disengage the A12 source 20 from the A11 connector and slide out of the analyzer. Observe the **CAUTION** above.

- 1. Reverse the order of the removal procedure.
- 2. Perform the post-repair adjustments, verifications, and performance tests that pertain to this removal procedure. Refer to Table 7-2 on page 7-76.





Removing and Replacing the A13 Frequency Offset Receiver Assembly

Tools Required

- T-10 TORX driver (set to 9 in-lb)
- T-20 TORX driver (set to 21 in-lb)
- 5/16 inch open-end torque wrench (set to 10 in-lb)
- ESD grounding wrist strap

Removal Procedure

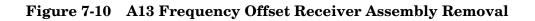
Refer to Figure 7-10 for this procedure.

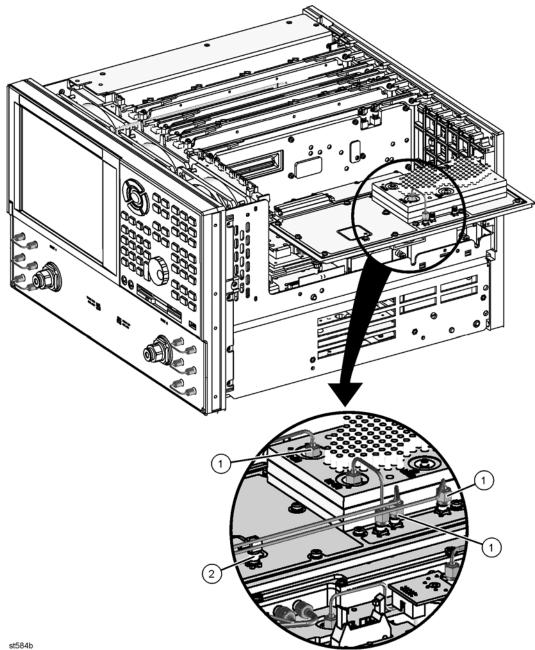
- 1. Disconnect the power cord.
- 2. Remove the outer and inner covers. Refer to "Removing the Covers" on page 7-6.
- 3. With a 5/16 inch torque wrench, disconnect the three semirigid cables (item ①) and flexible cable (item ②) from the top of the A13 frequency offset receiver assembly.

CAUTION Be careful not to damage the center pins of the semirigid cables. Some flexing of the cables is necessary to remove the assembly. Do not over-bend the semirigid cables.

4. Disengage the A13 frequency offset receiver assembly from the A11 connector and slide it out of the analyzer. Observe the **CAUTION** above.

- 1. Reverse the order of the removal procedure.
- 2. Perform the post-repair adjustments, verifications, and performance tests that pertain to this removal procedure. Refer to Table 7-2 on page 7-76.





Removing and Replacing the A14 System Motherboard

Tools Required

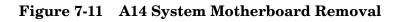
- T-10 TORX driver (set to 9 in-lb)
- T-20 TORX driver (set to 21 in-lb)
- 5/16 inch open-end torque wrench (set to 10 in-lb)
- ESD grounding wrist strap

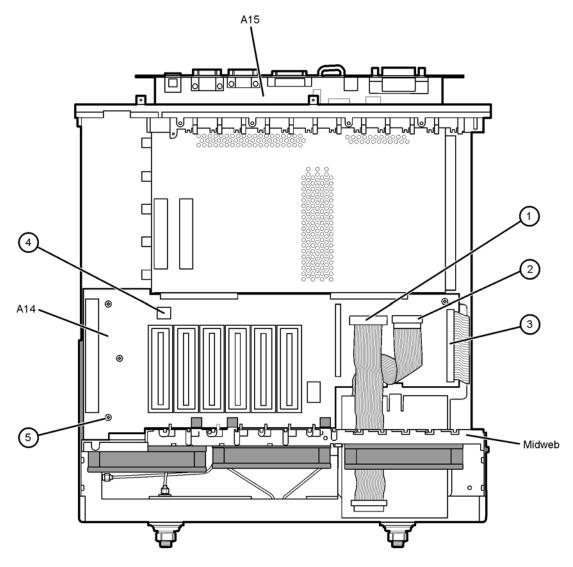
Removal Procedure

Refer to Figure 7-11 for this procedure.

- 1. Disconnect the power cord.
- 2. Remove the outer and inner covers. Refer to "Removing the Covers" on page 7-6.
- 3. Remove the front panel assembly. Refer to "Removing and Replacing the Front Panel Assembly" on page 7-10.
- 4. Remove the A12 source 20. Refer to "Removing and Replacing the A12 Source 20" on page 7-22.
- 5. Remove the A13 (Option 080) frequency offset receiver assembly, if present. Refer to "Removing and Replacing the A13 Frequency Offset Receiver Assembly" on page 7-24.
- 6. Remove the A11 phase lock board. Refer to "Removing and Replacing the A11 Phase Lock Board" on page 7-20.
- 7. Remove the A4 power supply assembly. Refer to "Removing and Replacing the A4 Power Supply Assembly" on page 7-16.
- 8. Remove the card cage boards (A6, A8, and A10). Remove A9 (Option 080), if present. Refer to "Removing and Replacing the A6, A8, A9, and A10 Boards" on page 7-18.
- 9. Remove the A15 CPU board. Refer to "Removing and Replacing the A15 CPU Board" on page 7-28.
- 10. Remove the Midweb. Refer to "Removing and Replacing the Midweb and the B1 Fan" on page 7-72.
- 11. Disconnect the A1 front panel ribbon cable (item ①), the A40 floppy disk drive ribbon cable (item ②), the A16 test set motherboard ribbon cable (item ③), and the USB hub assembly cable (item ④) from the A14 system motherboard.
- 12. Lift the tab at the rear of the A40 floppy disk drive enclosure and remove the rear enclosure cover.
- 13. Remove the four screws (item (5)) that secure the A14 system motherboard.
- 14. Lift the A14 system motherboard out of the analyzer.

- 1. Reverse the order of the removal procedure.
- 2. Perform the post-repair adjustments, verifications, and performance tests that pertain to this removal procedure. Refer to Table 7-2 on page 7-76.





st542b

Removing and Replacing the A15 CPU Board

Tools Required

- T-10 TORX driver (set to 9 in-lb)
- T-20 TORX driver (set to 21 in-lb)
- ESD grounding wrist strap

Removal Procedure

Refer to Figure 7-12 for this procedure.

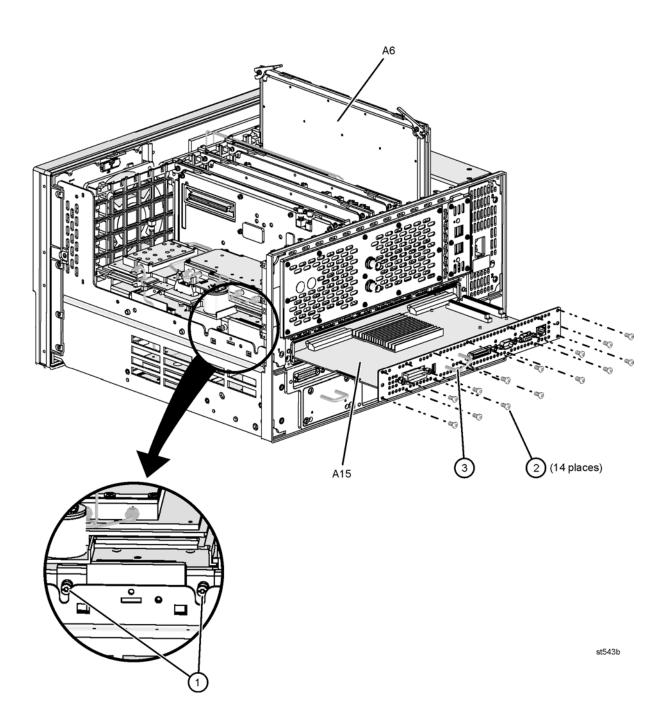
- 1. Disconnect the power cord.
- 2. Remove the outer and inner covers. Refer to "Removing the Covers" on page 7-6.
- 3. Disconnect the hard disk drive assembly (HDDA) ribbon cable and interface board from the A15 CPU board by removing the two screws (item ①).
- 4. Disengage the A6 SPAM board from the A15 CPU board by performing the following steps.
 - a. Lift the two extractors located at each end of the board.
 - b. While holding onto the extractors, lift the board halfway out of the slot.
 - c. Let the extractors drop to their normal position.
 - d. Lower the board into the slot.

The board should now rest above its normal seated position.

- 5. With a T-10 TORX driver, remove the 14 screws (item 2) from the rear panel of the A15 CPU board.
- 6. Gently pull on the finger grip (item (3)) to disengage the A15 CPU board from the analyzer.
- 7. Slide the A15 CPU board out of the analyzer.

- 1. Reverse the order of the removal procedure.
- 2. Adhere the new Certificate of Authenticity (license) label to the outer cover in the location specified in Figure 7-1 on page 7-7.
- 3. Perform the post-repair adjustments, verifications, and performance tests that pertain to this removal procedure. Refer to Table 7-2 on page 7-76.

Figure 7-12 A15 CPU Board Removal



Removing and Replacing the A16 Test Set Motherboard

Tools Required

- T-10 TORX driver (set to 9 in-lb)
- T-20 TORX driver (set to 21 in-lb)
- 5/16 inch open-end torque wrench (set to 10 in-lb)
- ESD grounding wrist strap

Removal Procedure

Refer to Figure 7-13 for this procedure.

- 1. Disconnect the power cord.
- 2. Remove the outer covers. Refer to "Removing the Covers" on page 7-6. Position the analyzer bottom side up and raise the receiver deck as shown. Refer to "Raising and Removing the Receiver Deck" on page 7-8 if necessary.
- 3. Remove the A21 SOMA 50. Refer to "Removing and Replacing the A21 SOMA 50" on page 7-40.
- 4. Remove the A41 hard disk drive. Refer to "Removing and Replacing the A41 Hard Disk Drive (HDD)" on page 7-60.
- 5. Remove the hard disk drive shield (item (8)) by loosening two attachment screws (item (9)), using a T-10 TORX driver. These screws are accessible through holes in the side of the chassis.
- 6. Disconnect the ribbon cables (item 1) from the A16 test set motherboard:
- 7. Disconnect the wrapped-wire cables and flexible RF cables (item ⁽²⁾) from the A16 test set motherboard:
- 8. Release the flexible RF cables from the cable clamp (item ③). Release the receiver deck by pulling the latch pin (item ④), and move the entire receiver deck out of the way, with the cables attached.
- 9. With a T-10 TORX driver, remove the following screws:
 - Nine screws (item (5)) from the rear panel.
 - Four screws (item 6) from the A16 test set motherboard.
- 10. Slide the A16 test set motherboard toward the front of the instrument to release the locking pins (item ⑦), then lift the motherboard and remove it from the analyzer.

- 1. Reverse the order of the removal procedure.
- 2. Perform the post-repair adjustments, verifications, and performance tests that pertain to this removal procedure. Refer to Table 7-2 on page 7-76.

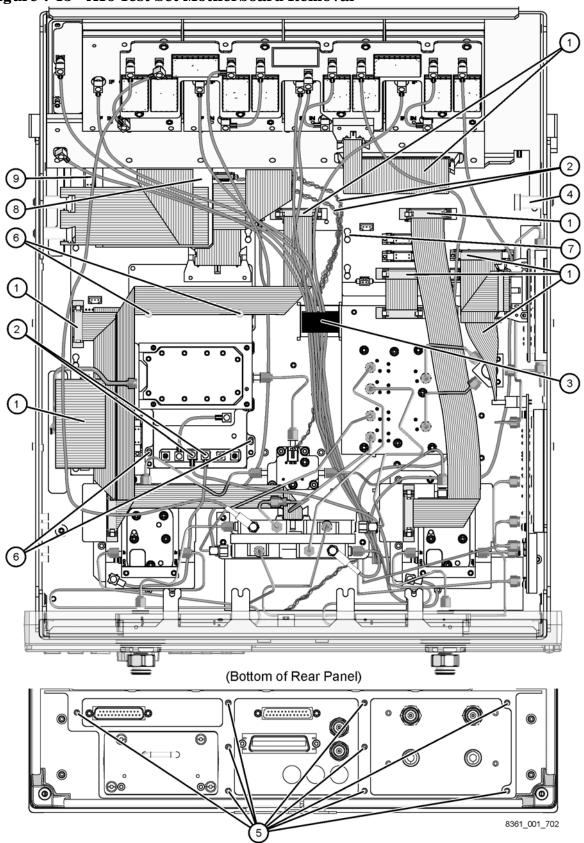


Figure 7-13 A16 Test Set Motherboard Removal

Removing and Replacing the A17 LOMA 12

Tools Required

- T-10 TORX driver (set to 9 in-lb)
- T-20 TORX driver (set to 21 in-lb)
- 5/16 inch open-end torque wrench (set to 10 in-lb)
- ESD grounding wrist strap

Removal Procedure

Refer to Figure 7-14 for this procedure.

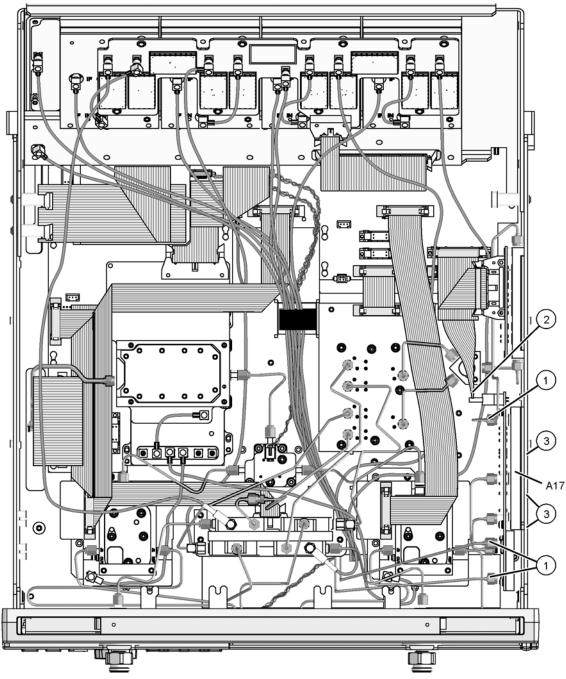
- 1. Disconnect the power cord.
- 2. Remove the outer cover. Refer to "Removing the Covers" on page 7-6. Position the analyzer bottom side up and raise the receiver deck as shown. Refer to "Raising and Removing the Receiver Deck" on page 7-8 if necessary.
- 3. With a 5/16 inch torque wrench, disconnect the three semirigid cables (item 1) from the A17 LOMA 12.
- 4. Disconnect the ribbon cable (item ⁽²⁾) at the A17 LOMA 12.
- 5. With a T-10 TORX driver, remove the three mounting screws (item (3)) from the side of the analyzer.

CAUTION Be careful not to damage the center pins of the semirigid cables. Some flexing of the cables is necessary to remove the assembly. Do not over-bend the semirigid cables.

6. Remove the A17 LOMA 12 from the analyzer. Observe the CAUTION above.

- 1. Reverse the order of the removal procedure.
- 2. Perform the post-repair adjustments, verifications, and performance tests that pertain to this removal procedure. Refer to Table 7-2 on page 7-76.





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Removing and Replacing the A18 MA 24

Tools Required

- T-10 TORX driver (set to 9 in-lb)
- T-20 TORX driver (set to 21 in-lb)
- 5/16 inch open-end torque wrench (set to 10 in-lb)
- ESD grounding wrist strap

Removal Procedure

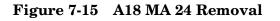
Refer to Figure 7-15 for this procedure.

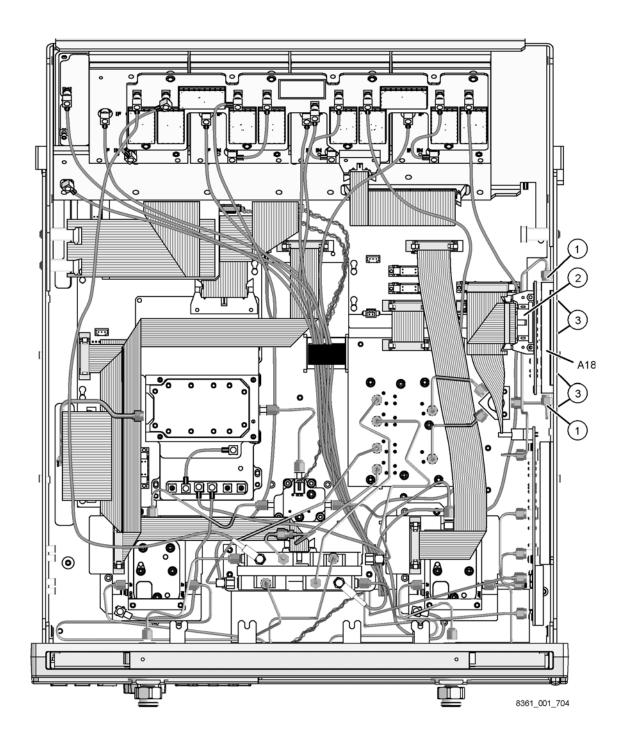
- 1. Disconnect the power cord.
- 2. Remove the outer cover. Refer to "Removing the Covers" on page 7-6. Position the analyzer bottom side up and raise the receiver deck as shown. Refer to "Raising and Removing the Receiver Deck" on page 7-8 if necessary.
- 3. With a 5/16 inch torque wrench, disconnect the two semirigid cables (item ①) from the A18 MA 24. It may be necessary to remove these cables completely to allow the A18 MA 24 to be removed from the analyzer.
- 4. Disconnect the ribbon cable (item ⁽²⁾) at the A18 MA 24.
- 5. With a T-10 TORX driver, remove the four mounting screws (item (3)) from the side of the analyzer.

CAUTION Be careful not to damage the center pins of the semirigid cables. Some flexing of the cables is necessary to remove the assembly. Do not over-bend the semirigid cables.

6. Remove the A18 MA 24 from the analyzer. Observe the CAUTION above.

- 1. Reverse the order of the removal procedure.
- 2. Perform the post-repair adjustments, verifications, and performance tests that pertain to this removal procedure. Refer to Table 7-2 on page 7-76.





Removing and Replacing the A19 Splitter

Tools Required

- T-10 TORX driver (set to 9 in-lb)
- T-20 TORX driver (set to 21 in-lb)
- 5/16 inch open-end torque wrench (set to 10 in-lb)
- ESD grounding wrist strap

Removal Procedure

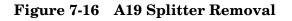
Refer to Figure 7-16 for this procedure.

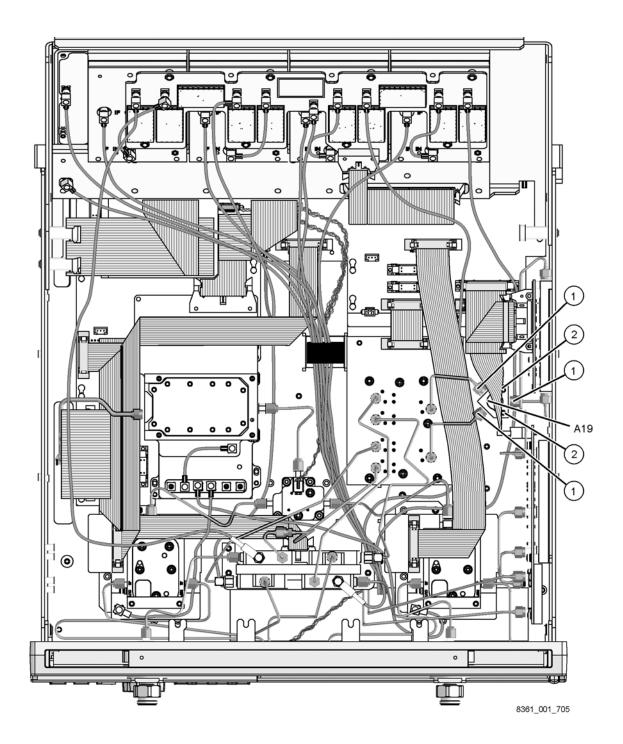
- 1. Disconnect the power cord.
- 2. Remove the outer cover. Refer to "Removing the Covers" on page 7-6. Position the analyzer bottom side up and raise the receiver deck as shown. Refer to "Raising and Removing the Receiver Deck" on page 7-8 if necessary.
- 3. With a 5/16 inch torque wrench, disconnect the three semirigid cables (item 1) from the A19 splitter.
- 4. With a T-10 TORX driver, remove the two mounting screws (item (2)).

CAUTION Be careful not to damage the center pins of the semirigid cables. Some flexing of the cables is necessary to remove the assembly. Do not over-bend the semirigid cables.

5. Remove the A19 splitter from the analyzer. Observe the **CAUTION** above.

- 1. Reverse the order of the removal procedure.
- 2. Perform the post-repair adjustments, verifications, and performance tests that pertain to this removal procedure. Refer to Table 7-2 on page 7-76.





Removing and Replacing the A20 LODA

Tools Required

- T-10 TORX driver (set to 9 in-lb)
- T-20 TORX driver (set to 21 in-lb)
- 5/16 inch open-end torque wrench (set to 10 in-lb)
- ESD grounding wrist strap

Removal Procedure

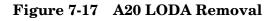
Refer to Figure 7-17 for this procedure.

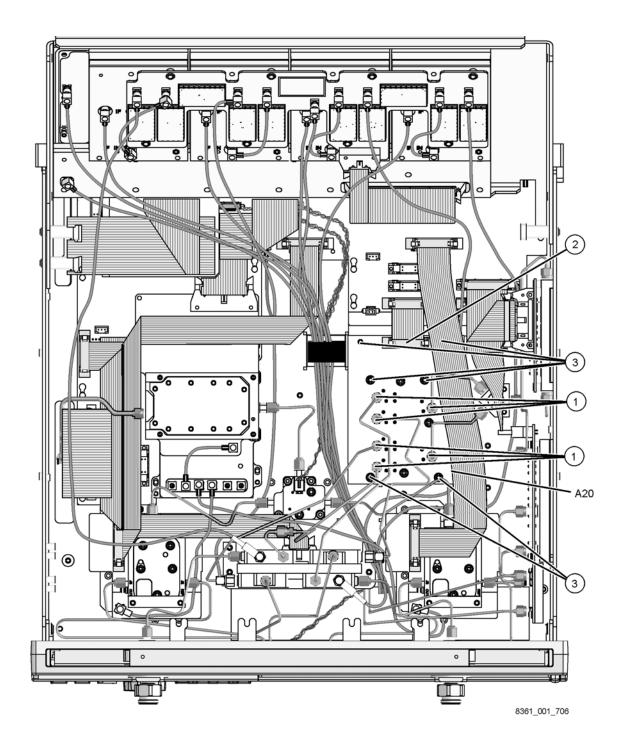
- 1. Disconnect the power cord.
- 2. Remove the outer cover. Refer to "Removing the Covers" on page 7-6. Position the analyzer bottom side up and raise the receiver deck as shown. Refer to "Raising and Removing the Receiver Deck" on page 7-8 if necessary.
- 3. With a 5/16 inch torque wrench, disconnect the six semirigid cables (item (1)) from the A20 LODA.
- 4. Disconnect the ribbon cable (item ⁽²⁾) at the A20 LODA.
- 5. With a T-10 TORX driver, remove the six mounting screws (item ③).

CAUTION Be careful not to damage the center pins of the semirigid cables. Some flexing of the cables is necessary to remove the assembly. Do not over-bend the semirigid cables.

6. Remove the A20 LODA from the analyzer. Observe the CAUTION above.

- 1. Reverse the order of the removal procedure.
- 2. Perform the post-repair adjustments, verifications, and performance tests that pertain to this removal procedure. Refer to Table 7-2 on page 7-76.





Removing and Replacing the A21 SOMA 50

Tools Required

- T-10 TORX driver (set to 9 in-lb)
- T-20 TORX driver (set to 21 in-lb)
- 5/16 inch open-end torque wrench (set to 10 in-lb)
- ESD grounding wrist strap

Removal Procedure

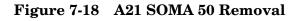
Refer to Figure 7-18 for this procedure.

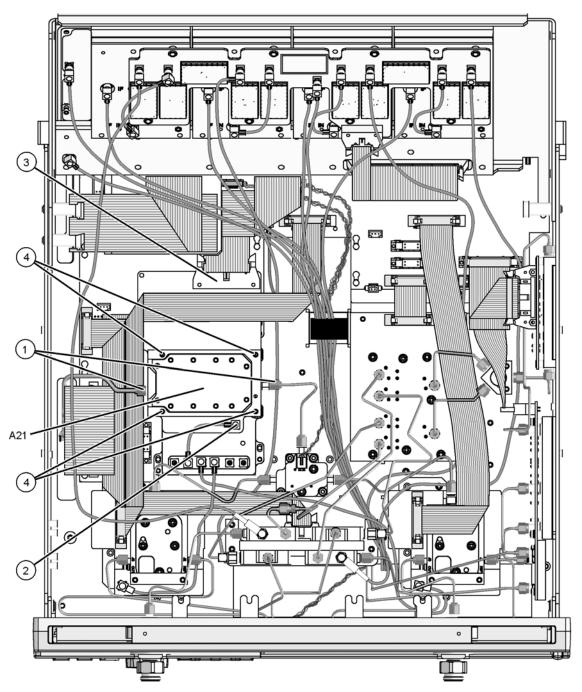
- 1. Disconnect the power cord.
- 2. Remove the outer cover. Refer to "Removing the Covers" on page 7-6. Position the analyzer bottom side up and raise the receiver deck as shown. Refer to "Raising and Removing the Receiver Deck" on page 7-8 if necessary.
- 3. With a 5/16 inch torque wrench, disconnect the two semirigid cables (item 1) from the A21 SOMA 50.
- 4. Disconnect the flexible cable (item ⁽²⁾) from the A21 SOMA 50.
- 5. Disconnect the ribbon cable (item ③) at the A21 SOMA 50.
- 6. With a T-10 TORX driver, remove the four mounting screws (item 4).

CAUTION Be careful not to damage the center pins of the semirigid cables. Some flexing of the cables is necessary to remove the assembly. Do not over-bend the semirigid cables.

7. Remove the A21 SOMA 50 from the analyzer. Observe the CAUTION above.

- 1. Reverse the order of the removal procedure.
- 2. Perform the post-repair adjustments, verifications, and performance tests that pertain to this removal procedure. Refer to Table 7-2 on page 7-76.





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Removing and Replacing the A22 Switch

Tools Required

- T-10 TORX driver (set to 9 in-lb)
- T-20 TORX driver (set to 21 in-lb)
- 5/16 inch open-end torque wrench (set to 10 in-lb)
- ESD grounding wrist strap

Removal Procedure

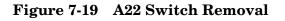
Refer to Figure 7-19 for this procedure.

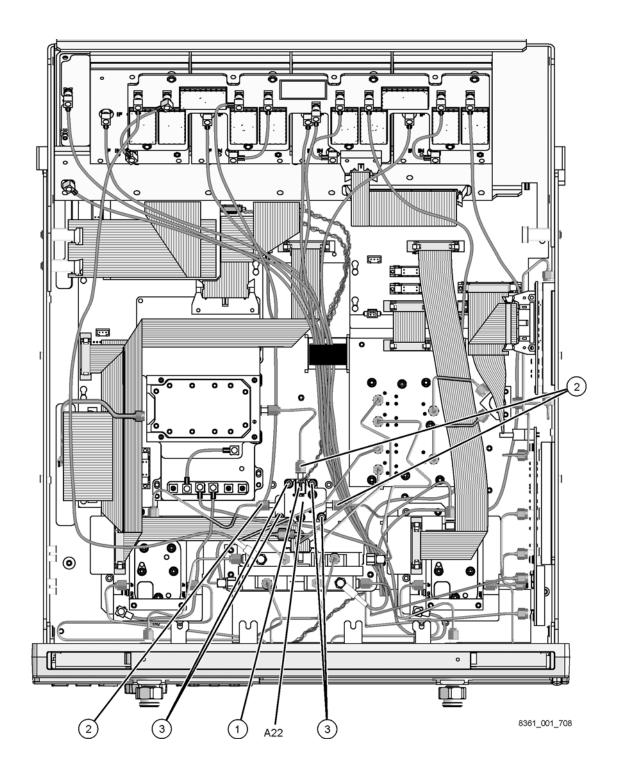
- 1. Disconnect the power cord.
- 2. Remove the outer cover. Refer to "Removing the Covers" on page 7-6. Position the analyzer bottom side up and raise the receiver deck as shown. Refer to "Raising and Removing the Receiver Deck" on page 7-8 if necessary.
- 3. Disconnect the stranded switch control cable (item 1) from the A22 switch.
- 4. With a 5/16 inch torque wrench, disconnect the three semirigid cables (item 2).
- 5. With a T-10 TORX driver, remove the two mounting screws (item (3)).

CAUTION Be careful not to damage the center pins of the semirigid cables. Some flexing of the cables is necessary to remove the assembly. Do not over-bend the semirigid cables.

6. Remove the A22 switch from the analyzer. Observe the **CAUTION** above.

- 1. Reverse the order of the removal procedure.
- 2. Perform the post-repair adjustments, verifications, and performance tests that pertain to this removal procedure. Refer to Table 7-2 on page 7-76.





Removing and Replacing the A23 and A24 SOMA 70s

Tools Required

- T-10 TORX driver (set to 9 in-lb)
- T-20 TORX driver (set to 21 in-lb)
- 5/16 inch open-end torque wrench (set to 10 in-lb)
- ESD grounding wrist strap

Removal Procedure

Refer to Figure 7-20 for this procedure.

- 1. Disconnect the power cord.
- 2. Remove the outer cover. Refer to "Removing the Covers" on page 7-6. Position the analyzer bottom side up as shown. It may be convenient to raise the receiver deck to provide better access. If necessary, refer to "Raising and Removing the Receiver Deck" on page 7-8.
- 3. Identify the SOMA 70 to be removed.
- 4. Disconnect the ribbon cable (item ①) from the appropriate SOMA 70.
- 5. With a 5/16 inch torque wrench, disconnect the three semirigid cables (item 2) from the SOMA 70.
- 6. Remove the flexible cable (item ③) from the SOMA 70.
- 7. With a T-10 TORX driver, remove the four mounting screws (item 4).

CAUTION Be careful not to damage the center pins of the semirigid cables. Some flexing of the cables is necessary to remove the assembly. Do not over-bend the semirigid cables.

8. Remove the SOMA 70 from the analyzer. Observe the CAUTION above.

NOTE If the SOMA 70 lid clamps and screws are not already installed, order items 18 and 19 on page Page 6-50. For ordering information, see "Contacting Agilent" on page 2-11.

- 1. Reverse the order of the removal procedure.
- 2. Perform the post-repair adjustments, verifications, and performance tests that pertain to this removal procedure. Refer to Table 7-2 on page 7-76.

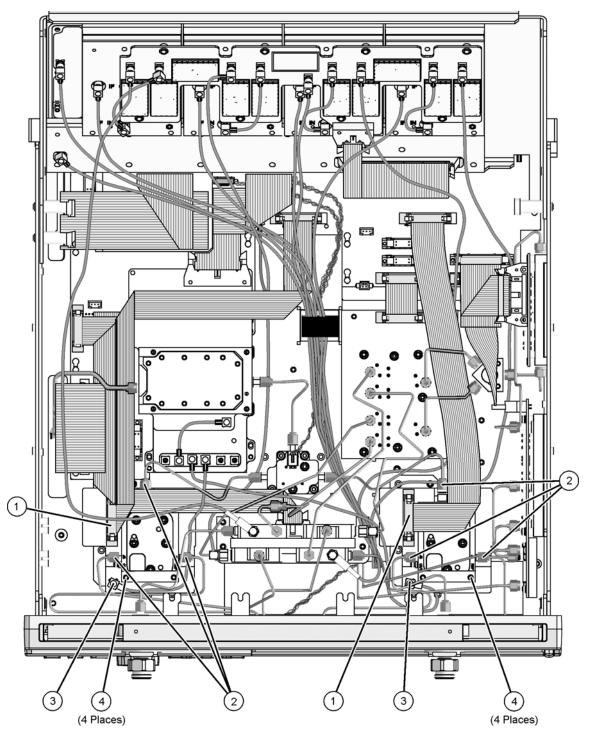


Figure 7-20 A23 and A24 SOMA 70s Removal

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Removing and Replacing the A25 and A26 Test Port Couplers

Tools Required

- T-10 TORX driver (set to 9 in-lb)
- T-20 TORX driver (set to 21 in-lb)
- 5/16 inch open-end torque wrench (set to 10 in-lb)
- 1 inch open-end torque wrench (set to 72 in-lb)
- ESD grounding wrist strap

Removal Procedure

Refer to Figure 7-21 for this procedure.

- 1. Disconnect the power cord.
- 2. Remove the outer cover. Refer to "Removing the Covers" on page 7-6. Position the analyzer bottom side up and raise the receiver deck as shown. Refer to "Raising and Removing the Receiver Deck" on page 7-8 if necessary.
- 3. Identify the test port coupler to be removed.
- 4. With a 5/16 inch torque wrench, disconnect the two semirigid cables (item (1)) from the test port coupler.
- 5. With a 1 inch torque wrench, remove the test port coupler nut (item 2) from the front panel.

CAUTION Be careful not to damage the center pins of the semirigid cables. Some flexing of the cables is necessary to remove the assembly. Do not over-bend the semirigid cables.

6. Remove the test port coupler from the analyzer. Observe the CAUTION above.

- 1. Reverse the order of the removal procedure.
- 2. Perform the post-repair adjustments, verifications, and performance tests that pertain to this removal procedure. Refer to Table 7-2 on page 7-76.

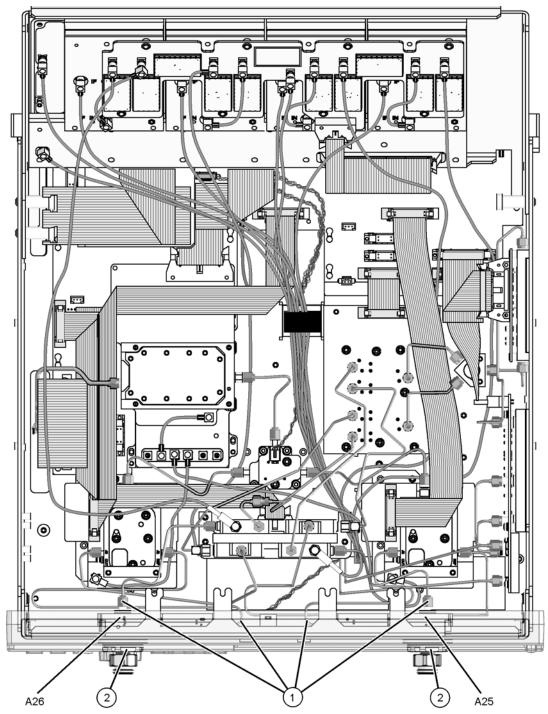


Figure 7-21 A25 and A26 Test Port Couplers Removal

8361_001_710

Removing and Replacing the A27–A30 First Converters (Mixers) and Mixer Bias Board

Tools Required

- T-10 TORX driver (set to 9 in-lb)
- T-20 TORX driver (set to 21 in-lb)
- 5/16 inch open-end torque wrench (set to 10 in-lb)
- ESD grounding wrist strap

Removal Procedure

Refer to Figure 7-22 for this procedure.

- 1. Disconnect the power cord.
- 2. Remove the outer cover. Refer to "Removing the Covers" on page 7-6. Position the analyzer bottom side up and raise the receiver deck as shown. Refer to "Raising and Removing the Receiver Deck" on page 7-8 if necessary.
- 3. With a 5/16 inch torque wrench, disconnect the eight semirigid cables (item (1)) and the four flexible cables (item (2)).

CAUTION Be careful not to damage the center pins of the semirigid cables. Some flexing of the cables is necessary to remove the assembly. Do not over-bend them.

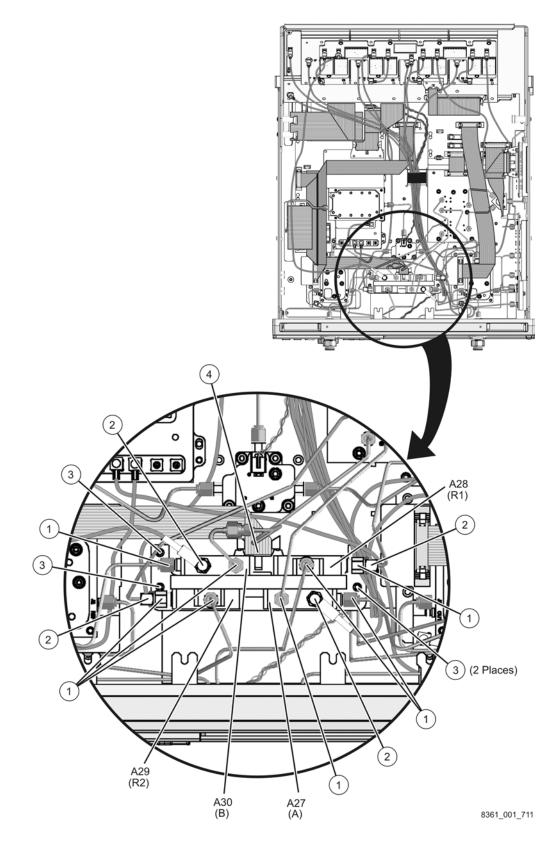
- 4. With a T-10 TORX driver, remove the four mounting screws (item (3)).
- 5. Remove the mixer bracket and disconnect the ribbon cable (item 4).
- 6. If replacing a first converter (mixer):
 - a. Remove the defective mixer from the bracket by removing the attachment screws.
 - b. Install the new mixer onto the bracket using the attachment screws from the mixer that was removed. Be careful to properly align the DC feed-through pins.

If replacing the mixer bias board:

- a. Remove all four mixers from the bracket by removing the attachment screws.
- b. Remove the mixer bias board by removing the attachment screws.
- c. Install the new mixer bias board onto the bracket by *loosely* installing the attachment screws from the old mixer bias board. Do not tighten them at this time.
- d. Reinstall the four mixers using their original attachment screws. Be careful to properly align the DC feed-through pins.
- e. Using a T-10 TORX driver, tighten the mixer bias board attachment screws.

- 1. Reverse the order of the removal procedure.
- 2. Perform the post-repair adjustments, verifications, and performance tests that pertain to this removal procedure. Refer to Table 7-2 on page 7-76.





Removing and Replacing the A31–A34 Receiver Modules and A49 IF Multiplexer Board

Tools Required

- T-10 TORX driver (set to 9 in-lb)
- T-20 TORX driver (set to 21 in-lb)
- 5/16-inch open-end torque wrench (set to 10 in-lb)
- ESD grounding wrist strap

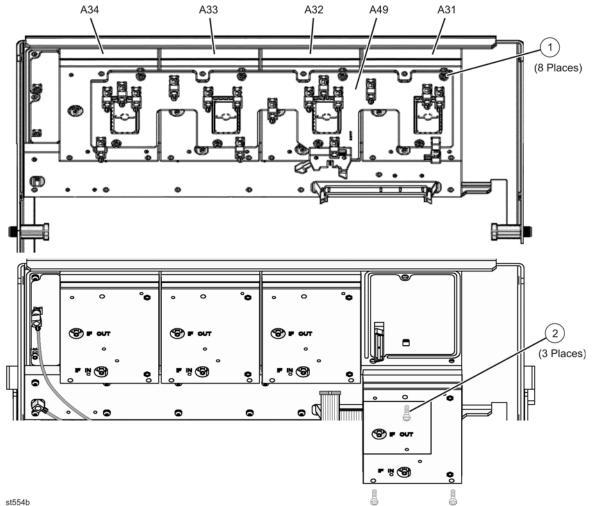
Removal Procedure

Refer to Figure 7-23 for this procedure.

- 1. Disconnect the power cord.
- 2. Remove the outer cover. Refer to "Removing the Covers" on page 7-6. Position the analyzer bottom side up and raise the receiver deck as shown. Refer to "Raising the Receiver Deck" on page 7-8 if necessary.
- 3. Identify the receiver module to be removed. To replace one of the receiver modules, the A49 board must be removed.
- 4. Disconnect the flexible cables from the A49 board and from the receiver module to be replaced.
- 5. Disconnect the ribbon cable from the A49 board.
- 6. With a T-10 TORX driver, remove the eight mounting screws (item ①) from the A49 board. Remove the board from the analyzer.
- 7. With a T-10 TORX driver, remove the three mounting screws (item ⁽²⁾) from the receiver module to be replaced.
- 8. Remove the receiver module from the analyzer.

- **NOTE** Older PNA's were equipped with an A49 LO reject/filter board instead of the A49 IF multiplexer board and therefore had different cable connections. If replacing this A49 LO reject/filter board with the A49 IF multiplexer board, refer to the cable connections on the following page when reconnecting the flexible cables.
- 1. Reverse the order of the removal procedure. Refer to the cable connection table on the following page if necessary.
- 2. Perform the post-repair adjustments, verifications, and performance tests that pertain to this removal procedure. Refer to Table 7-2 on page 7-76.

Removing and Replacing the A31–A34 Receiver Modules and A49 IF Multiplexer Board E8361A



| s | t5 | 5 | 4 | b | |
|---|----|---|---|---|--|
| | | | | | |

| Cable | Part Number | A49 IF Multiplexer Board Cable Connections |
|-------|-------------|--|
| W23 | E8364-60019 | A27 mixer A to A49J101 |
| W24 | E8364-60020 | A28 mixer R1 to A49J201 |
| W25 | E8364-60021 | A29 mixer R2 to A49J301 |
| W26 | E8364-60022 | A30 mixer B to A49J401 |
| W27 | 8120-5014 | A49J103 to A31 receiver A IF IN |
| W28 | 8120-5014 | A49J203 to A32 receiver R1 IF IN |
| W29 | 8120-5014 | A49J303 to A33 receiver R2 IF IN |
| W30 | 8120-5014 | A49J403 to A34 receiver B IF IN |
| W31 | E8364-60126 | A31 receiver A IF OUT to A6 SPAM board J3 |
| W32 | E8364-60127 | A32 receiver R1 IF OUT to A6 SPAM board J4 |
| W33 | E8364-60128 | A33 receiver R2 IF OUT to A6 SPAM board J5 |
| W34 | E8364-60129 | A34 receiver B IF OUT to A6 SPAM board J6 |
| W37 | E8364-60161 | A16J15 to A49J1 |

Removing and Replacing the A35 Receiver Motherboard

Tools Required

- T-10 TORX driver (set to 9 in-lb)
- T-20 TORX driver (set to 21 in-lb)
- 5/16 inch open-end torque wrench (set to 10 in-lb)
- ESD grounding wrist strap

Removal Procedure

Refer to Figure 7-24 for this procedure.

- 1. Disconnect the power cord.
- 2. Remove the outer covers. Refer to "Removing the Covers" on page 7-6. Position the analyzer bottom side up and raise the receiver deck as shown. Refer to "Raising the Receiver Deck" on page 7-8 if necessary.
- 3. Remove the A49 IF multiplexer board and all four receiver modules. Refer to "Removing and Replacing the A31–A34 Receiver Modules and A49 IF Multiplexer Board" on page 7-50.
- 4. Disconnect the flexible cables (item 1) from the receiver motherboard.
- 5. Disconnect the flexible cable (item 2) from the receiver motherboard if present (Option 080 only).
- 6. Disconnect the ribbon cable (item (3)) from the receiver motherboard.
- 7. Remove the receiver deck from the analyzer with the receiver motherboard attached. Refer to "Removing the Receiver Deck" on page 7-8, if necessary. The receiver motherboard and receiver deck are replaced as one unit.

- 1. Reverse the order of the removal procedure.
- 2. Perform the post-repair adjustments, verifications, and performance tests that pertain to this removal procedure. Refer to Table 7-2 on page 7-76.

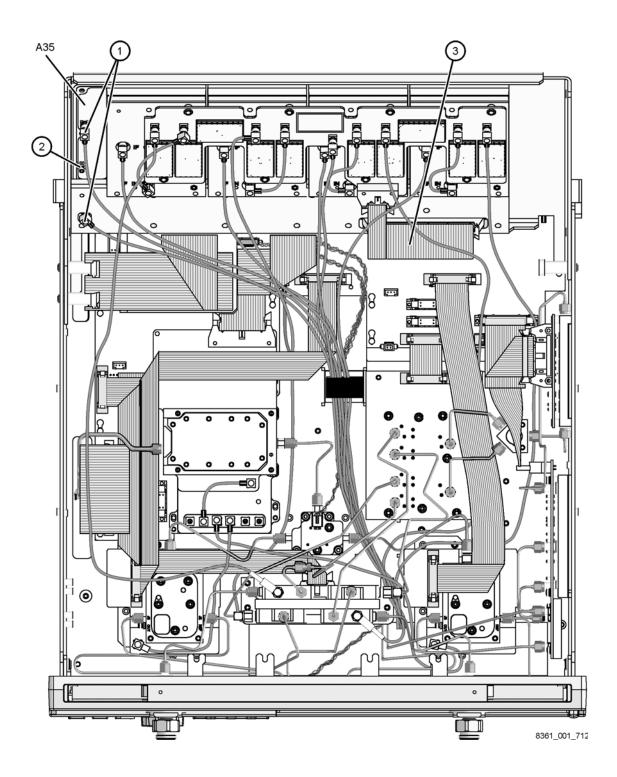


Figure 7-24 A35 Receiver Motherboard Removal

Removing and Replacing the A36 and A37 50-dB Source Step Attenuators (Option UNL)

Tools Required

- T-10 TORX driver (set to 9 in-lb)
- T-20 TORX driver (set to 21 in-lb)
- 5/16-inch open-end torque wrench (set to 10 in-lb)
- ESD grounding wrist strap

Removal Procedure

Refer to Figure 7-25 for this procedure.

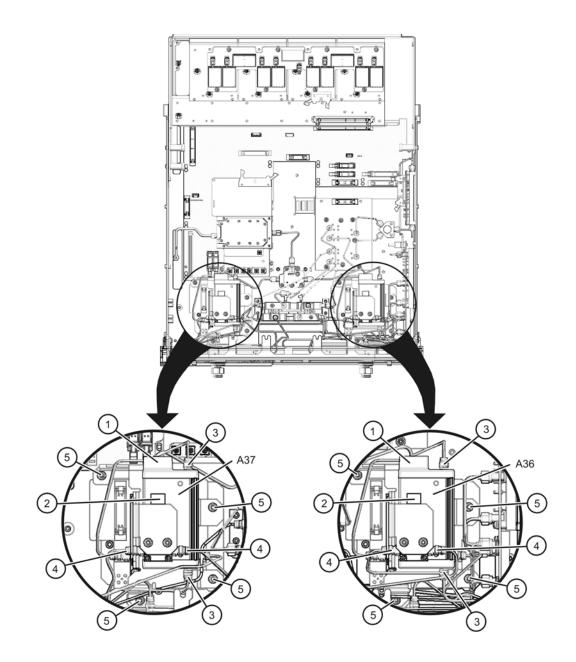
- 1. Disconnect the power cord.
- 2. Remove the outer cover. Refer to "Removing the Covers" on page 7-6. Position the analyzer bottom side up and raise the receiver deck as shown. Refer to "Raising the Receiver Deck" on page 7-8 if necessary.
- 3. Identify the attenuator to be removed. To replace the attenuator, the bracket holding the attenuator and bias tee must be removed.
- 4. Disconnect the ribbon cable (item 1) from the appropriate attenuator.
- 5. Disconnect the control cable (item (2)) from the associated bias tee.
- 6. Disconnect all RF cables from the step attenuator (item ③) and the bias tee (item ④). A 5/16-inch wrench is required for the semi-rigid cables.
- 7. With a T-10 TORX driver, remove the four mounting screws (item (5)) from the bracket holding the attenuator and bias tee.

| CAUTION | Be careful not to damage the center pins of the semirigid cables. Some flexing |
|---------|--|
| | of the cables is necessary to remove the assembly. Do not over-bend the |
| | semirigid cables. |

- 8. Remove the bracket from the analyzer with the attenuator and bias tee attached. Observe the **CAUTION** above.
- 9. With a T-10 TORX driver, remove the mounting screws holding the attenuator and remove the attenuator from the bracket.

- 1. Reverse the order of the removal procedure using the existing cables and hardware.
- 2. Perform the post-repair adjustments, verifications, and performance tests that pertain to this removal procedure. Refer to Table 7-2 on page 7-76.





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Removing and Replacing the A38 and A39 Bias Tees (Option UNL)

Tools Required

- T-8 TORX driver (set to 5 in-lb)
- T-10 TORX driver (set to 9 in-lb)
- T-20 TORX driver (set to 21 in-lb)
- 5/16-inch open-end torque wrench (set to 10 in-lb)
- ESD grounding wrist strap

Removal Procedure

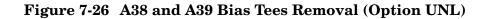
Refer to Figure 7-26 for this procedure.

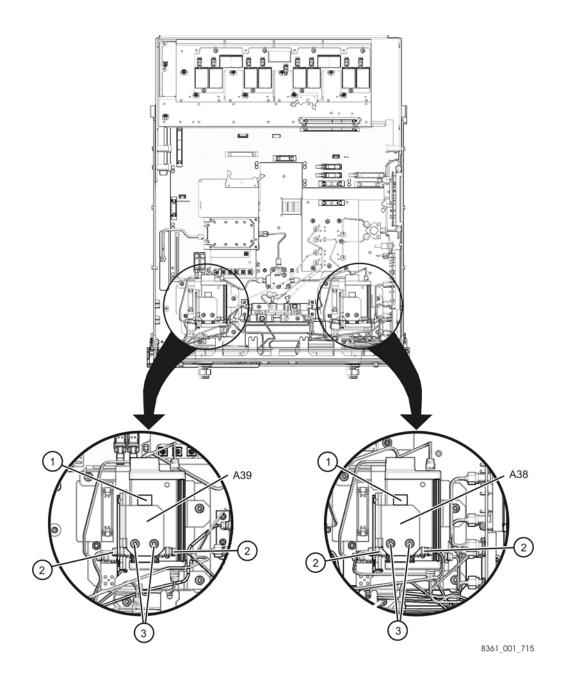
- 1. Disconnect the power cord.
- 2. Remove the outer cover. Refer to "Removing the Covers" on page 7-6. Position the analyzer bottom side up and raise the receiver deck as shown. Refer to "Raising the Receiver Deck" on page 7-8 if necessary.
- 3. Disconnect the control cable (item 1) from the bias tee to be removed.
- 4. Disconnect the RF cables (item (2)) from the bias tee. A 5/16-inch wrench is required for the semi-rigid cables.

- 5. With a T-10 TORX driver, remove the two mounting screws (item ③) holding the bias tee.
- 6. Remove the bias tee from the analyzer.

- 1. Reverse the order of the removal procedure using the existing cables and hardware.
- 2. Perform the post-repair adjustments, verifications, and performance tests that pertain to this removal procedure. Refer to Table 7-2 on page 7-76.

CAUTION Be careful not to damage the center pins of the semirigid cables. Some flexing of the cables is necessary to remove the assembly. Do not over-bend the semirigid cables.





Removing and Replacing the A40 Floppy Disk Drive

Tools Required

- T-10 TORX driver (set to 9 in-lb)
- T-20 TORX driver (set to 21 in-lb)
- 5/16 inch open-end torque wrench (set to 10 in-lb)
- ESD grounding wrist strap

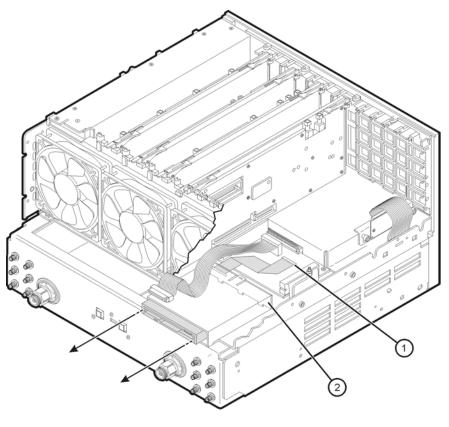
Removal Procedure

Refer to Figure 7-27 and Figure 7-28 for this procedure.

- 1. Disconnect the power cord.
- 2. Remove the outer and inner covers. Refer to "Removing the Covers" on page 7-6.
- 3. Remove the front panel assembly. Refer to "Removing and Replacing the Front Panel Assembly" on page 7-10.
- 4. Remove the A13 (Option 080) frequency offset receiver assembly, if present. Refer to "Removing and Replacing the A13 Frequency Offset Receiver Assembly" on page 7-24.
- 5. Remove the A12 source 20. Refer to "Removing and Replacing the A12 Source 20" on page 7-22.
- 6. Disconnect the ribbon cable (item (1)) from the A14 system motherboard.
- 7. Lift the tab at the rear of the A40 floppy disk drive enclosure and remove the rear enclosure cover (item (2)).
- 8. Slide the A40 floppy disk drive out of the front of the enclosure. The A40 floppy disk drive fits snugly. You may have to push the drive from the back to remove it from the analyzer.

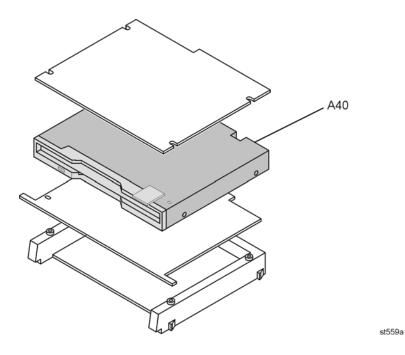
- 1. Reverse the order of the removal procedure using the existing ribbon cable (item 1).
- 2. Perform the post-repair adjustments, verifications, and performance tests that pertain to this removal procedure. Refer to Table 7-2 on page 7-76.





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Figure 7-28 A40 Floppy Disk Drive (Exploded View)



Removing and Replacing the A41 Hard Disk Drive (HDD)

Certain unique files exist on the hard disk drive that are necessary for proper operation of your analyzer. These files must be copied to another location to allow them to be installed onto the new HDD after it has been installed.

If you are replacing the HDD, not just removing the hard disk drive assembly (HDDA) to allow access to other assemblies, the following procedure must be performed first.

If you are not replacing the actual HDD, proceed to "Tools Required," on this page.

Copy Unique Files from the Hard Disk

- 1. Insert a writable floppy disk into the floppy disk drive, or insert a USB flash memory drive into a USB port.
- 2. Open *Windows Explorer*.
- 3. Navigate to C:\Program Files\Agilent\Network Analyzer.
- 4. Copy each of the following files from the hard disk drive to the floppy disk or the USB drive:
 - gen.lic
 - user_calkitfile
 - All files prefixed with mxcalfile_.
 - Any personal user files that you wish to preserve.
- 5. Remove the storage device containing the backup files: either the floppy disk from the analyzer's disk drive, or the USB drive from the USB port.
- 6. Exit *Windows Explorer*.

Tools Required

- T-10 TORX driver (set to 7 in-lb; for hard disk drive replacement)
- T-10 TORX driver (set to 9 in-lb; for all other T-10 applications)
- ESD grounding wrist strap

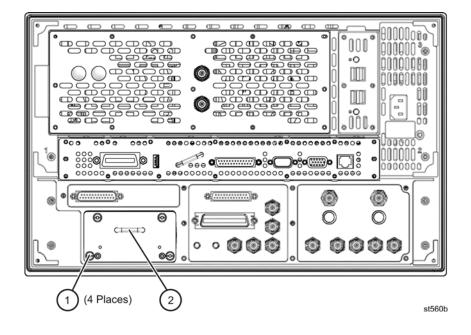
Removal Procedure

1. Disconnect the analyzer power cord.

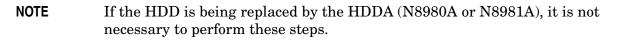
Refer to Figure 7-29. for the remainder of this procedure.

- 2. With a T-10 TORX driver, loosen the four HDDA mounting screws (item 1) on the rear panel.
- 3. Remove the HDDA from the analyzer by pulling on the finger grip (item ⁽²⁾). The HDDA interconnects with a connector inside the analyzer rear panel so moderate force may be necessary to disengage this connector.

Figure 7-29. Hard Disk Drive Assembly Removal



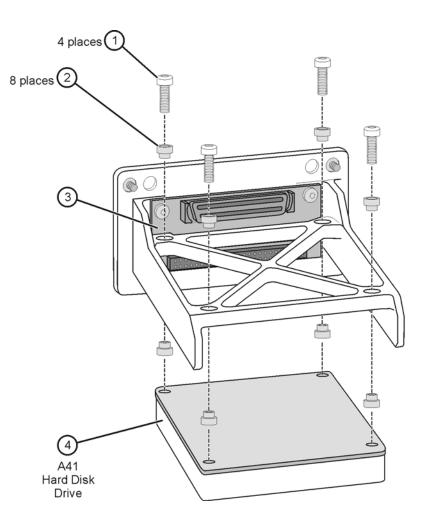
Disassembling the HDDA



Refer to Figure 7-30.

- 1. Remove the HDDA from the analyzer. Refer to "Removal Procedure" on page 7-60.
- 2. With a T-10 TORX driver, remove the four screws (item ①), and the eight bushings (item ②), that mount the HDD (item ④), to the bracket.
- 3. Disconnect the HDD (item 4) from the interface board (item 3).

Figure 7-30 Hard Disk Drive Assembly (Exploded View)



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Reassembly Procedure

| NOTE | If the HDD is being replaced by the HDDA (N8980A or N8981A), it is not |
|------|--|
| | necessary to perform these steps. |

Refer to Figure 7-30 on page 7-62.

- 1. With the disk drive bracket right-side up (it is shown upside down in Figure 7-30), insert four bushings (item ⁽²⁾) into the four holes in the bracket.
- 2. Connect the new HDD (item ④) to the interface board (item ③) by pushing it firmly into the connector on the interface board. Take special care to align the connector pins. Applying power to a misaligned connection can permanently damage the HDD.
- 3. While holding the HDD in place, turn the bracket over and insert the other four bushings (item 2), into the other side of the same four holes specified in step 1.
- 4. Install the four screws (item (1)), finger tight, through the eight bushings (item (2)), to attach the HDD to the bracket.

With a T-10 TORX driver, snug-tighten the four screws in a Z-pattern, and then torque them, in the same pattern, to 7 in-lb.

Update the Bios

```
IMPORTANT Perform this procedure only if replacing an HDD in an analyzer that had a Windows 2000 operating system, but now has a Windows XP operating system.
```

- 1. Insert the BIOS Update Disk, that has been provided, into the floppy disk drive.
- 2. With the HDD removed, turn on power to the analyzer.
- 3. Since there is no HDD installed, the analyzer will automatically boot from the BIOS Update Disk located in the floppy disk drive. The BIOS update process will run automatically. The entire process takes approximately one minute. Make sure that power to the analyzer is not interrupted during this process.
- 4. When the BIOS update process has completed, press and hold the analyzer's power button (approximately five seconds) until the analyzer turns off.
- 5. Remove the BIOS Update Disk from the floppy disk drive.

Reinstalling the HDDA

- 1. Reinstall the HDDA into the analyzer:
 - a. Slide the HDDA into the slot in the rear panel and push it firmly into place to engage the connector. Refer to Figure 7-29. on page 7-61.
 - b. With a T-10 TORX driver, tighten the four HDDA mounting screws (item ①).

Initialize the Windows Operating System

- 1. Connect a mouse and keyboard to the analyzer.
- 2. Turn on power to the analyzer.
- 3. The operating system initialization process will run automatically. Part way through the process, you will be prompted to accept the Windows licensing agreement. The entire process takes approximately six minutes, during which the analyzer will reboot up to three times.
- 4. After the PNA application screen is displayed, there may be a display to remind you to upgrade the firmware. If so, click **OK** to continue.

Set Up the Agilent Administrator Password

After an HDD replacement, it is necessary to set up the Agilent administrator password for the analyzer. If this procedure is being performed by non-Agilent personnel, contact Agilent for a password before beginning this procedure. Refer to "Contacting Agilent" on page 2-11.

The network analyzer must be powered up and operating for this procedure.

- 1. On the Windows Desktop, right-click on My Computer, and then click Manage.
- 2. In the Computer Management window, navigate to System Tools, Local Users and Groups, Users.
- 3. Right-click on **Agilent**, click on **Set Password**, and complete these steps in the window:
 - a. Type the password obtained from Agilent as the **Password**. Refer to "Set Up the Agilent Administrator Password" on page 7-64 for information if you have not yet obtained this password.
 - b. Type the password again in the **Confirm password** block.
 - c. Click **OK**.
- 4. Right-click on **Agilent**, click on **Properties**, and complete these steps in the window:
 - a. Unselect User must change password at next logon (if not already unselected).
 - b. Unselect User cannot change password (if not already unselected).
 - c. Select Password never expires (if not already selected).
 - d. Click **OK**.
- 5. Close the Computer Management window.

Install Backup Files onto the New Hard Disk Drive

The files that were previously saved onto a floppy disk or USB memory drive must now be installed onto the new HDD. The network analyzer must be powered up and operating.

- 1. Insert the storage device containing the backup files: either the floppy disk into the floppy disk drive, or the USB memory drive into a USB port.
- 2. Click on START. (It may be necessary to exit the Network Analyzer application.)

- 3. Point to Programs, Accessories, and then open Windows Explorer.
- 4. Navigate to C:\Program Files\Agilent\Network Analyzer.
- 5. Copy each of the backup files from the floppy disk or USB memory drive to the HDD.
- 6. Navigate to D:\CalFiles\.
- 7. Copy the backup files prefixed with <code>mxcalfile_</code> from the floppy disk or USB memory drive to the HDD.
- 8. After all files have been copied, remove the storage device containing the backup files: either the floppy disk from the analyzer's disk drive, or the USB memory drive from the USB port.
- 9. Exit Windows Explorer.

Post-Repair Procedures

- 1. Adhere the new Certificate of Authenticity (license) label to the outer cover in the location specified in Figure 7-1 on page 7-7.
- 2. Perform the post-repair adjustments, verifications, and performance tests that pertain to this removal procedure. Refer to Table 7-2 on page 7-76.

Removing and Replacing the A43 and A44 50-dB Receiver Step Attenuators (Option 016)

Tools Required

- T-10 TORX driver (set to 9 in-lb)
- T-20 TORX driver (set to 21 in-lb)
- 5/16-inch open-end torque wrench (set to 10 in-lb)
- ESD grounding wrist strap

Removal Procedure

Refer to Figure 7-31 for this procedure.

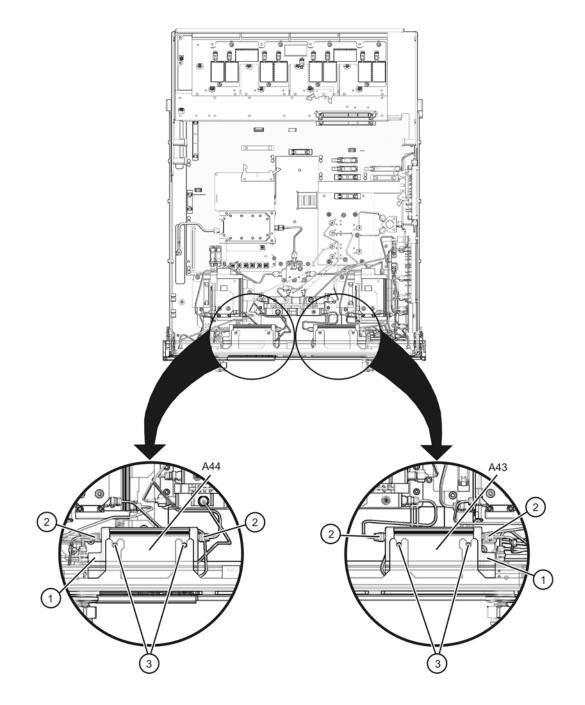
- 1. Disconnect the power cord.
- 2. Remove the outer cover. Refer to "Removing the Covers" on page 7-6. Position the analyzer bottom side up and raise the receiver deck as shown. Refer to "Raising the Receiver Deck" on page 7-8 if necessary.
- 3. Identify the step attenuator to be removed.
- 4. Disconnect the ribbon cable (item (1)) from the appropriate attenuator.
- 5. With a 5/16-inch torque wrench, disconnect the two semirigid cables (item (2)) from the attenuator.
- 6. With a T-10 TORX driver, *loosen* the two mounting screws (item ③).

| CAUTION | Be careful not to damage the center pins of the semirigid cables. Some flexing |
|---------|--|
| | of the cables is necessary to remove the assembly. Do not over-bend the |
| | semirigid cables. |

- 7. Slide the attenuator out of the mounting tabs and remove it from the analyzer. Observe the **CAUTION** above.
- 8. Remove the mounting screws (item ③) from the faulty attenuator and *loosely* install them in the new attenuator.

- 1. Reverse the order of the removal procedure using the existing attenuator ribbon cable.
- 2. Perform the post-repair adjustments, verifications, and performance tests that pertain to this removal procedure. Refer to Table 7-2 on page 7-76.

Figure 7-31 A43 and A44 50-dB Receiver Step Attenuators Removal (Option 016)



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Removing and Replacing the A45 Reference Channel Transfer Switch (Option 081)

Tools Required

- T-10 TORX driver (set to 9 in-lb)
- T-20 TORX driver (set to 21 in-lb)
- 5/16-inch open-end torque wrench (set to 10 in-lb)
- ESD grounding wrist strap

Removal Procedure

Refer to Figure 7-32 for this procedure.

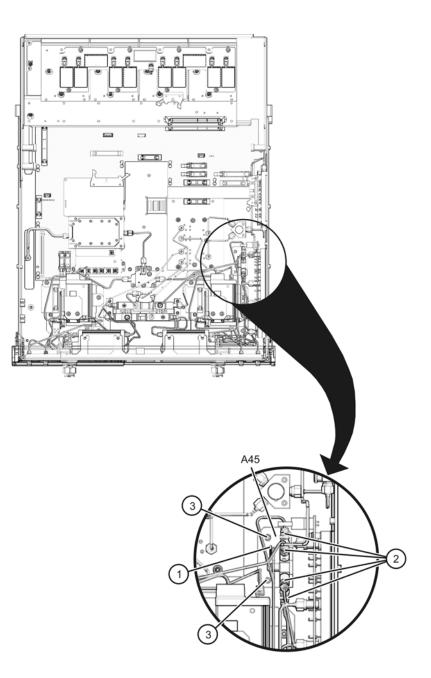
- 1. Disconnect the power cord.
- 2. Remove the outer cover. Refer to "Removing the Covers" on page 7-6. Position the analyzer bottom side up and raise the receiver deck as shown. Refer to "Raising the Receiver Deck" on page 7-8 if necessary.
- 3. Disconnect the stranded control cable (item 1) by pressing the release button in the center of the connector.
- 4. With a 5/16-inch wrench, disconnect the four semirigid cables (item 2) from the A45 reference channel switch.
- 5. With a T-10 TORX driver, remove the mounting screws (item ③) holding the A45 reference switch bracket in the analyzer.

CAUTION Be careful not to damage the center pins of the semirigid cables. Some flexing of the cables is necessary to remove the assembly. Do not over-bend the semirigid cables.

- 6. Remove the bracket, with the A45 reference switch attached, from the analyzer. Observe the **CAUTION** above.
- 7. Remove the A45 reference switch from the bracket by removing the attachment screws.

- 1. Reverse the order of the removal procedure using the existing cables and hardware.
- 2. Perform the post-repair adjustments, verifications, and performance tests that pertain to this removal procedure. Refer to Table 7-2 on page 7-76.

Figure 7-32 A45 Reference Channel Transfer Switch Removal (Option 081)



8361_001_717

Removing and Replacing the A47 and A48 Couplers (Option H11)

Tools Required

- T-10 TORX driver (set to 9 in-lb)
- T-20 TORX driver (set to 21 in-lb)
- 5/16-inch open-end torque wrench (set to 10 in-lb)
- ESD grounding wrist strap

Removal Procedure

Refer to Figure 7-33 for this procedure.

- 1. Disconnect the power cord.
- 2. Remove the outer cover. Refer to "Removing the Covers" on page 7-6. Position the analyzer bottom side up and raise the receiver deck as shown. Refer to "Raising the Receiver Deck" on page 7-8 if necessary.
- 3. Locate the coupler to be removed; the A47 RF path coupler or the A48 LO path coupler. The A47 RF path coupler is secured to the analyzer side frame (test set deck) and the A48 LO path coupler is secured to a bracket which also holds the A19 splitter.
- 4. To remove the A47 RF path coupler:
 - a. With a 5/16-inch wrench, disconnect the three semirigid cables from the coupler.

CAUTION Be careful not to damage the center pins of the semirigid cables. Some flexing of the cables is necessary for removal. Do not over-bend them.

- b. With a T-10 TORX driver, remove the mounting screws holding the coupler.
- 5. To remove the A48 LO path coupler:
 - a. With a 5/16-inch wrench, disconnect the three semirigid cables from the coupler and the three semirigid cables from the A19 splitter.
 - b. With a T-10 TORX driver, remove the mounting screws from the bracket that holds the A48 LO path coupler and the A19 splitter.
- 6. Remove the bracket, with the A48 LO path coupler attached, from the analyzer. Observe the **CAUTION** above.
- 7. Remove the A48 LO path coupler from the bracket by removing the attachment screws.

- 1. Reverse the order of the removal procedure using the existing cables and hardware.
- 2. Perform the post-repair adjustments, verifications, and performance tests that pertain to this removal procedure. Refer to Table 7-2 on page 7-76.

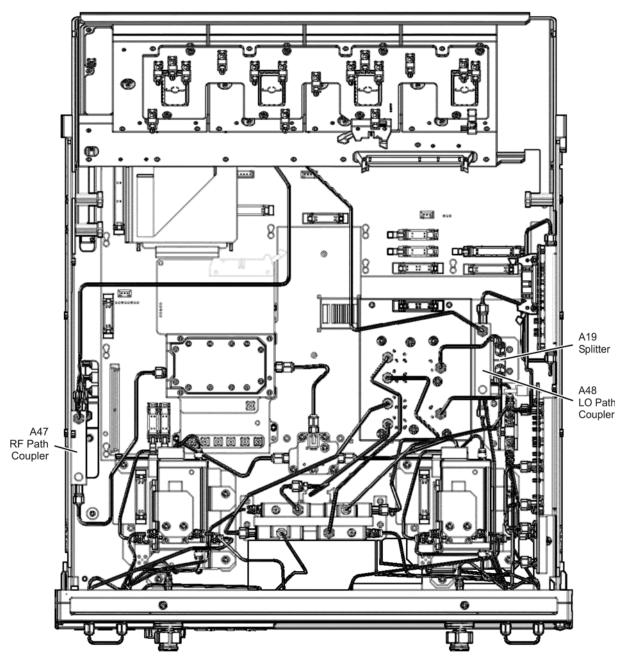


Figure 7-33 A47 and A48 Couplers Removal (Option H11)

8361_001_718

Removing and Replacing the Midweb and the B1 Fan

Tools Required

- T-10 TORX driver (set to 9 in-lb)
- T-20 TORX driver (set to 21 in-lb)
- Pozidriv screw driver
- 5/16 inch open-end torque wrench (set to 10 in-lb)
- ESD grounding wrist strap

Removal Procedure

- 1. Disconnect the power cord.
- 2. Remove the front panel assembly. Refer to "Removing and Replacing the Front Panel Assembly" on page 7-10.
- 3. Remove the outer and inner covers. Refer to "Removing the Covers" on page 7-6.
- 4. On the bottom side of the analyzer, remove the A27–A30 first converters (mixers). This is necessary to gain access to one of the midweb mounting screws. Refer to "Removing and Replacing the A27–A30 First Converters (Mixers) and Mixer Bias Board" on page 7-48.
- 5. Remove the A13 (Option 080) frequency offset receiver assembly, if present. Refer to "Removing and Replacing the A13 Frequency Offset Receiver Assembly" on page 7-24.
- 6. Remove the A12 source 20. Refer to "Removing and Replacing the A12 Source 20" on page 7-22.
- 7. Remove the A11 phase lock board. Refer to "Removing and Replacing the A11 Phase Lock Board" on page 7-20.
- 8. Remove the A4 power supply assembly. Refer to "Removing and Replacing the A4 Power Supply Assembly" on page 7-16.
- 9. Remove the card cage boards (A6, A8, and A10). Remove A9 (Option 080), if present. Refer to "Removing and Replacing the A6, A8, A9, and A10 Boards" on page 7-18.

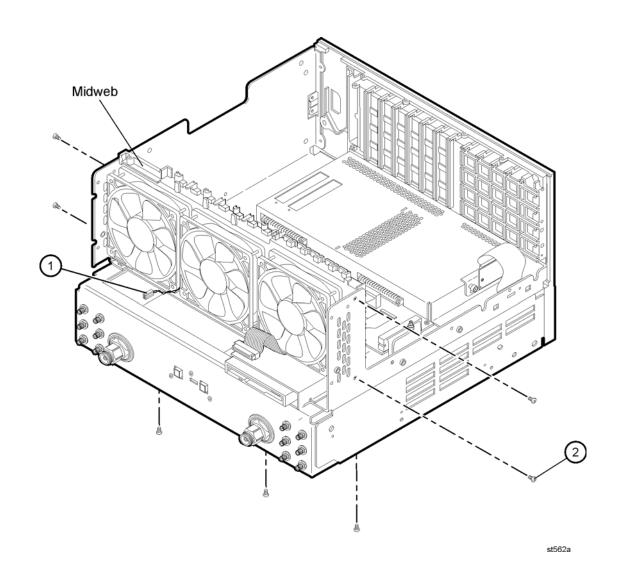
NOTE This procedure has two parts: removing the midweb and removing the fan from the midweb. You must remove the midweb before removing the fan.

Removing the Midweb

Refer to Figure 7-34.

- 1. Disconnect the power cable (item 1) for the three fans from the A14 system motherboard.
- 2. With a T-10 TORX driver, remove the seven midweb mounting screws (item 2). Lift out the midweb.

Figure 7-34 Midweb Removal

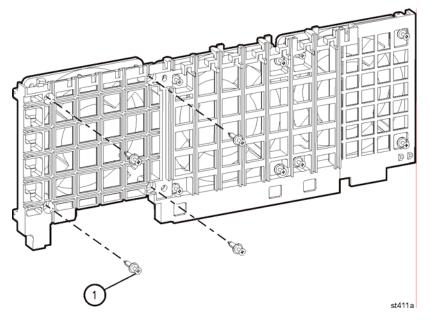


Removing the Fan

Refer to Figure 7-35.

1. To remove the fan, it is necessary to remove the four nylon rivets that attach it to the midweb. To do this, use the Pozidriv screwdriver on the nylon screw (item ①) and a small blade screwdriver to stabilize the rivet. Turn and push the rivet out of the rivet hole. Once the four rivets are out, remove the fan.

Figure 7-35 B1 Fan Removal



- 1. Reverse the order of the removal procedure.
- 2. Perform the post-repair adjustments, verifications, and performance tests that pertain to this removal procedure. Refer to Table 7-2 on page 7-76.

Removing and Replacing the USB Hub

Tools Required

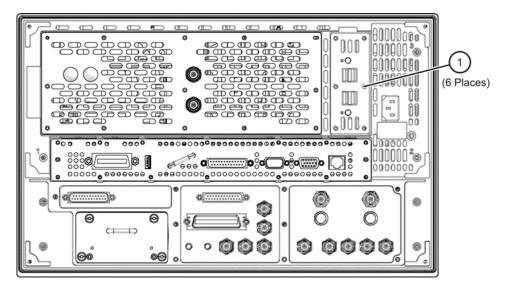
- T-10 TORX driver (set to 9 in-lb)
- ESD grounding wrist strap

Removal Procedure

Refer to Figure 7-36 for this procedure.

- 1. Disconnect the power cord.
- 2. With a T-10 TORX driver, remove the six screws (item ①) from the USB hub cover plate.
- 3. Pull the cover plate away from the analyzer to expose the connecting cable.
- 4. Disconnect the USB hub cable from the USB hub board.
- 5. Remove the USB hub from the analyzer.

Figure 7-36 USB Hub Removal



8361_001_713

- 1. Reverse the order of the removal procedure.
- 2. Perform the post-repair adjustments, verifications, and performance tests that pertain to this removal procedure. Refer to Table 7-2 on page 7-76.

Post-Repair Procedures

After the replacement of an assembly, you must perform the service procedures in the order listed in Table 7-2.

Procedures referenced in this table are located in Chapter 3, "Tests and Adjustments," unless specified otherwise.

| Replaced Assembly | Adjustments and Other Procedures | Verification, Performance, and Other Tests and Procedures |
|--|---|--|
| A1 keypad assembly | No adjustment needed | A1 Front Panel Keypad and RPG Test in Chapter 4 |
| A2 display assembly | No adjustment needed | A2 Display Test in Chapter 4 |
| A3 front panel interface board | No adjustment needed | A1 Front Panel Keypad and RPG Test and A2 Display Test in Chapter 4 |
| A4 power supply assembly | No adjustment needed | None needed |
| | | Noise Floor Test |
| A6 SPAM board | No adjustment needed | Trace Noise Test |
| | | System Crosstalk Test |
| A8 fractional-N | LODerrer Alliester est | Frequency Accuracy Test |
| synthesizer board | LO Power Adjustment | The Operator's Check |
| A9 fractional-N synthesizer board | Offset LO Adjustment | The Operator's Check |
| A10 frequency reference board | 10 MHz Frequency Reference Adjustment Restore option data (Refer to "Repairing and Recovering Option Data" in Appendix B.) | Frequency Accuracy Test |
| A11 phase lock board | No adjustment needed | Frequency Accuracy Test |
| A12 source 20 | 3.8 GHz PMYO Frequency Adjustment Source Calibration Adjustment | Source Power Accuracy Test Source Power Linearity Test |
| | Phase Lock IF Gain Adjustment | Frequency Accuracy Test |
| A13 frequency offset receiver assembly | Offset LO Adjustment | The Operator's Check |
| A14 system motherboard | No adjustment needed | A1 Front Panel Keypad and RPG Test and A2 Display Test in Chapter 4 The Operator's Check |
| A15 CPU board | No adjustment needed | The Operator's Check |

 Table 7-2
 Related Service Procedures

| Replaced Assembly | Adjustments and Other Procedures | Verification, Performance, and Other Tests and Procedures |
|---|--|--|
| A16 test set motherboard | Reinstall the serial number. (Refer to "Installing or Changing a Serial Number" in Appendix B.) | The Operator's Check |
| A16 test set motherboard | Re-enable all hardware options. (Refer to "Enabling or Removing Options" in Appendix B.) | System Crosstalk Test |
| A17 LOMA 12 | LO Power Adjustment | Frequency Accuracy Test The Operator's Check |
| A18 MA 24 | LO Power Adjustment | Frequency Accuracy Test The Operator's Check |
| A19 splitter | LO Power Adjustment | The Operator's Check |
| A20 LODA | LO Power Adjustment | The Operator's Check |
| | Source Calibration | Source Power Accuracy Test |
| A21 SOMA 50 | Adjustment | Source Power Linearity Test |
| | Phase Lock IF Gain Adjustment | Frequency Accuracy Test |
| A22 switch splitter | Source Calibration Adjustment | Source Power Accuracy Test |
| | Phase Lock IF Gain Adjustment | Calibration Coefficient Test |
| A23 and A24 SOMA 70s | Source Calibration Adjustment | Source Power Accuracy Test |
| | Phase Lock IF Gain Adjustment | Calibration Coefficient Test |
| A25 and A26 test port couplers | Source Calibration Adjustment | Source Power Accuracy Test |
| | Phase Lock IF Gain Adjustment | Calibration Coefficient Test |
| A27, A28, A29, and A30 first converters (mixers) | | Receiver Compression Test |
| | Phase Lock IF Gain Adjustment Receiver Calibration Adjustment | Noise Floor Test |
| | | Calibration Coefficient Test |
| | | System Crosstalk Test |
| | | Dynamic Accuracy Test |
| | | Receiver Compression Test |
| AD1 ADD ADD 1 AD4 | Phase Lock IF Gain Adjustment | Noise Floor Test |
| A31, A32, A33, and A34 receiver modules | Receiver Calibration | Calibration Coefficient Test |
| | Adjustment | System Crosstalk Test |
| | | Dynamic Accuracy Test |

| | Table 7-2 | Related Ser | vice Procedu | res (Continued) |
|--|-----------|--------------------|--------------|-----------------|
|--|-----------|--------------------|--------------|-----------------|

| Replaced Assembly | Adjustments and Other Procedures | Verification, Performance, and Other Tests and Procedures |
|--|---|---|
| A35 receiver motherboard | Receiver Calibration Adjustment | The Operator's Check |
| A36 and A37 50-dB source step attenuators | Source Calibration Adjustment Phase Lock IF Gain Adjustment | Source Power Accuracy Test System Crosstalk Test Calibration Coefficient Test |
| A38 and A39 bias tees | Source Calibration Adjustment Phase Lock IF Gain Adjustment | Source Power Accuracy Test Calibration Coefficient Test |
| A40 floppy disk drive | No adjustment needed | Read and write to the drive |
| A41 hard disk drive | Restore previously saved receiver calibration data ^a (or perform Receiver Calibration Adjustment) | Read and write to the drive |
| A43 and A44 50-dB receiver step attenuators | Receiver Calibration Adjustment | The Operator's Check System Crosstalk Test |
| A45 reference channel transfer switch | Source Calibration Adjustment Phase Lock IF Gain Adjustment Receiver Calibration Adjustment | The Operator's Check System Crosstalk Test |
| A47 and A48 couplers | Source Calibration Adjustment Phase Lock IF Gain Adjustment Receiver Calibration Adjustment | The Operator's Check System Crosstalk Test |
| A49 IF multiplexer board | Phase Lock IF Gain Adjustment | The Operator's Check |
| B1 fan | No adjustment needed | Check for fan operation |
| USB hub | No adjustment needed | Check for proper operation |

 Table 7-2
 Related Service Procedures (Continued)

a. If a backup copy of receiver calibration data from the faulty disk drive is available, it can be copied to the new disk drive. If not, new data must be generated by performing the "Receiver Calibration Adjustment."

A Error Terms

Information in This Appendix

Your PNA series network analyzer calculates error terms by measuring well-defined calibration devices over the frequency range of interest and comparing the measured data with an ideal model for the devices. The differences of the compared data represent systematic (repeatable) errors of the analyzer system. The analyzer calculates and stores these differences as error terms. These error terms are then removed from subsequent measurements when error correction is on.

NOTE For details on the various levels and theory of error-correction, refer to the embedded help in the analyzer.

| Section Title | Summary of Content | Start Page |
|---|---|------------|
| Using Error Terms as a Diagnostic Tool | How to use error terms as a preventive maintenance and troubleshooting tool. | Page A-3 |
| Performing Measurement Calibration | Procedure for measurement calibration. Measurement calibration must be performed before you can use error terms as a tool. | Page A-4 |
| Using Flowgraphs to Identify Error Terms | Flowgraphs of the error terms for 1 port and 2 port calibrations. | Page A-4 |
| Accessing Error Terms | How to access error terms either manually or programmatically using the analyzer front panel or SCPI and COM/DCOM commands. | Page A-6 |
| | Values of the error terms of your analyzer. Included are: | |
| Error Term Data | a table of error term values typical response plots typical assembly failures | Page A-8 |

Appendix A at-a-Glance

Using Error Terms as a Diagnostic Tool

By examining error terms, you can monitor system performance for preventive maintenance and troubleshooting purposes.

The magnitude and shape of the error terms are affected by:

- calibration kit devices
- cables
- adapters and accessories
- the assemblies from the signal separation group of the analyzer

Calibration kit devices, cables, and adapters and accessories are the most common cause of error term anomalies. Make sure of the following:

- Connectors must be clean, gaged, and within specification.
- Use proper connection technique during measurement and calibration. For information on connection technique and on cleaning and gaging connectors, refer to "Review the Principles of Connector Care" on page 3-5or to the calibration kit's user's and service guide.

Preventive Maintenance

If you print or plot the error terms at set intervals (weekly, monthly and so forth), you can compare current error terms to these records. A stable system should generate repeatable error terms over long intervals, (for example, six months). Look for the following:

- A long-term trend often reflects drift, connector and cable wear, or gradual degradation, indicating the need for further investigation and preventive maintenance. Yet, the system may still conform to specifications. The cure is often as simple as cleaning and gaging connectors and cables.
- A sudden shift in error terms may indicate the need for troubleshooting.

Troubleshooting

You can use the error terms as a tool to isolate faulty assemblies in the signal separation group of your analyzer. You can compare the current values to preventive maintenance records or to the typical values listed in Table A-1 on page A-9, or data trace plots that start in "Error Term Data" on page A-8.

To find assemblies related to error term failures, refer to plot descriptions in "Error Term Data" on page A-8. Each plot description lists common assemblies related to each error term. Identify the assembly and refer to Chapter 4, "Troubleshooting."

NOTE Always suspect calibration devices, cables, or improper connector maintenance as the primary cause of an error term anomaly.

Performing Measurement Calibration

A calibration must be performed to allow the analyzer to calculate the error terms before they can be used as a tool:

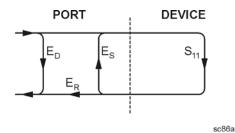
| CAUTION | Perform the following procedure only at a static-safe workstation, and wear a grounded wrist strap. |
|---------|---|
| | This is important. If not properly protected against, electrostatic discharge can seriously damage your analyzer, resulting in costly repair. |
| | To reduce the chance of electrostatic discharge, follow all of the recommendations outlined in "Electrostatic Discharge Protection" on page 1-6, when performing the following calibration. |

- 1. Connect a type-N cable to Port 2.
- 2. Perform a full 2-port calibration, **FULL SOLT 2-Port**. Refer to embedded help in the analyzer if necessary.

Using Flowgraphs to Identify Error Terms

Flowgraphs are a graphical representation of signal flow through the measurement path. The flowgraphs in Figure A-1 and Figure A-2 illustrate the error terms associated with measurement calibration.

Figure A-1 Flowgraph of One-Port Error Terms for Port 1



where:

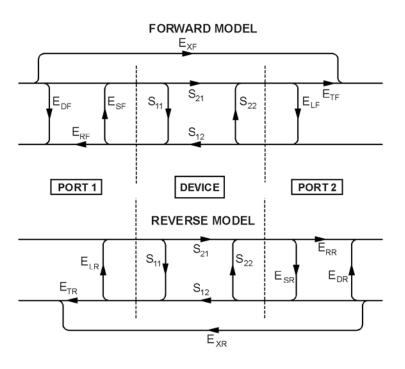
E = Error term

Subscript:

- D = Directivity
- S = Source Match
- R = Reflection Tracking

The error terms are the same for a one port measurement on Port 2 (S_{22}).

Figure A-2 Flowgraph of Two-Port Error Terms



sc87a.cdr

where:

E = error term

1st Subscript:

- D = Directivity
- S = Source Match
- R = Reflection Tracking
- X = Crosstalk (Isolation)
- L = Load Match
- T = Transmission Tracking

2nd Subscript:

- F = forward measurement (Port 1 to Port 2)
- R = reverse measurement (Port 2 to Port 1)

Accessing Error Terms

Error terms can be accessed either manually or programmatically:

Manually

• "Front Panel Access to Error Terms" on page A-6

Programmatically

- "GPIB Access to Error Terms" on page A-7
- "COM/DCOM Access to Error Terms" on page A-7

Manual Access to Error Terms

Front Panel Access to Error Terms

NOTE Ensure the calibration correction is active by making sure that Correction on/OFF has a check-mark in the Calibration menu.

To access the error terms from the front panel, perform the following steps:

1. In the System menu, point to Service, Utilities, and then click Cal Set Viewer.

The **Cal Set Viewer** toolbar appears directly above the trace window.

- 2. In the **Cal Set** list, select the desired cal set.
- 3. Click the **Standards/ETerms** button to toggle between viewing the raw measurement data from the standard or the corrected error term data. Note that the title of the center box in the tool bar will toggle between **Standard** and **Error Term**.
- 4. In the **Standard** or **Error Term** list, select the standard or error term to view. Click the **View** check box.
- 5. Compare the displayed measurement trace to the equivalent data trace plots that start in "Error Term Data" on page A-8, to previously measured data, or to the uncorrected performance specifications listed in Table A-1 on page A-9.
- 6. Print numerical data or print a plot of the measurement results.

Programmatic Access to Error Terms

GPIB Access to Error Terms

You can access error terms by way of GPIB with Standard Commands for Programmable Instruments (SCPI).

For more information on GPIB and SCPI, refer to the embedded help in the analyzer. Type in keyword "errors, systematic" in the index.

COM/DCOM Access to Error Terms

You can access error terms by way of Component Object Model (COM) or Distributed Component Object Model (DCOM) software architecture.

For more information on COM and DCOM, refer to the embedded help in the analyzer. Type in keyword "errors, systematic" in the index.

Error Term Data

The error term descriptions in this section include the following information:

- a table of the error terms
- typical plots of results
- significance of each error term
- guidelines to interpret each error term

The same description applies to both the forward (F) and reverse (R) terms. The plots shown with each description are typical of a working system following a full 2-port calibration as performed in "Performing Measurement Calibration" on page A-4.

IMPORTANT Data are listed here as a convenience only. Detailed instrument specifications are listed in the embedded help in the network analyzer.

If Error Terms Seem Worse than Expected

To verify that the system still conforms to specifications, perform a system verification. Refer to Chapter 3, "Tests and Adjustments".

| er | | Frequency Range | | | | | | | | | | | |
|--|-------------------------------------|-------------------------------------|----------------------------|-------------------------------|----------------------------|----------------------------|------------------------|------------------------|-------------------|-----------------------------|------------------------|-------------------------------------|--|
| Parameter | | 10 MHz to 45 MHz ^b | 45 MHz to 2 GHz | to | to | | GHz to GHz | 30 GHz to 50 GHz | | 0 GHz to 0 GHz | 60 GHz to 67 GHz | 67 GHz to 70 GHz ^b | |
| Directivity | y | >22dB | >24dB | >20 dl | B >16 | dB >1 | 4dB | >13dB | > | >13dB | >10dB | >14dB | |
| ter | | | | | Fre | quency R | ange | | | | | | |
| Parameter | 10 MHz to 45 MHz ^b | 45 MHz to 2 GHz | 2 GHz to 10 GHz | 10 GHz to 20 GHz | 20 GHz to 30 GHz | 30 GHz to 40 GHz | 40 G to 45 G | te |) | 50 GHz to 60 GHz | to | 67 GHz to 70 GHz ^b | |
| Source Match (Std.) (014) (UNL/014) | >7dB >7dB >5dB | >18dB >17dB >15dB | >14dB >12dB >9dB | >12dB >11dB >7.5dB | >8 dB >10dB >8.5 dB | >7.5dB >8.5dB >8dB | >8 >8.5 >8.5 | dB >8.5 | /dB 5dB 3dB | >6dB >6.5dB >7dB | >6dB | >7.5dB >8.5dB >10dB | |
| Load Match (Std.) (014) (UNL/014) | >5.5dB >5.5dB >6dB | >9dB >8.5dB >8.5dB | >9dB >8dB >7dB | >8.5dB >8dB >6dB | >7dB >7.5dB >7.5dB | >6dB >7dB >8dB | >6.5 >7.5 >8 | dB >7.5 | | >5.5 dB >6 dB >7.5 dB | >6dB | >5dB >5dB >13dB | |
| ter | | Frequency Range | | | | | | | | | | | |
| Parameter | 10 MHz to 45 MHz ^b | | | 45 MHz to 20 GHz | 20 GHz to 40 GHz | | 40 GHz to 50 GHz | | | 50 GHz to 67 GHz | | 67 GHz to 70 GHz ^b | |
| Reflection Tracking ^c | 1 | ±1.5d | В | ±1.5dB | ±ź | 2.0dB | ± | 2.0dB | | ±3.0dB | <u>+</u> | 4.5dB | |
| Transmiss Tracking ^{c.} | | ±1.5d | В | ±1.5dB | ±ź | 2.0dB | ± | 2.0dB | | ±3.0dB | ± | 4.5dB | |
| ter | Frequency Range | | | | | | | | | | | | |
| Parameter | 10 MHz to 45 MHz ^b | 45 MHz to 0.5 GHz | 0.5 GHz to 2 GHz | 2 GHz to 10 GHz | 10 GHz to 24 GHz | 24 GHz to 30 GHz | 30 G to 40 G | te |) | 45 GHz to 50 GHz | 50 GHz to 60 GHz | 60 GHz to 70 GHz ^b | |
| Cross talk ^e (Std.) (014) (UNL/014) | -63 dB -63 dB -63 dB | -87dB -87dB -87dB | -110dB -110dB -110dB | -105 dB -105 dB -104 dB | -111dB -111dB -108dB | -106dB -104dB -101dB | -104 -102 -99 | dB -90 | 3dB 5dB 2dB | -100dB -98dB -94dB | -95dB | -94dB -90dB -84dB | |

Table A-1Error Term Data^a

a. The data in this table are uncorrected system performance. The values apply over an environmental temperature range of 23 °C \pm 3 °C, with less than 1 °C deviation from the calibration temperature.

b. All values for 10 MHz to 45 MHz and from 67 GHz to 70 GHz are typical.

c. All reflection tracking and transmission tracking values are typical.

d. Transmission tracking performance is normalized to the insertion loss of the cable used so the indicated performance is independent of the cable used.

e. These are also the typical values for Option 080 analyzers with 0 Hz offset enabled.

Directivity (E_{DF} and E_{DR})

 E_{DF} and E_{DR} are the uncorrected forward and reverse directivity error terms of the system. The directivity error of the test port is determined by measuring the S_{11} and S_{22} reflection of the calibration kit load. The load has a much better return loss specification than does the uncorrected test port. Therefore, any power detected from this measurement is assumed to be from directivity error.

The measurements most affected by directivity errors are measurements of low reflection devices.

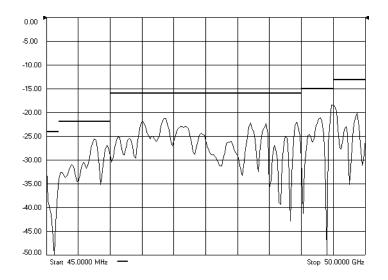
Typical Cause of Failure

The *calibration kit load* is the most common cause of directivity specification failure.

If the load has been gaged and its performance independently verified, suspect the analyzer *test port coupler*.

To troubleshoot, refer to "Checking the Signal Separation Group" on page 4-47.

Figure A-3 Typical E_{DF}/E_{DR} Without Cables



Source Match (E_{SF} and E_{SR})

 E_{SF} and E_{SR} are the forward and reverse uncorrected source match terms of the driven port. They are obtained by measuring the reflection $(S_{11},\,S_{22})$ of an open, and a short that are connected directly to the ports. Source match is a measure of the match of the coupler, as well as the match between all components from the source to the output port.

The measurements most affected by source match errors are reflection and transmission measurements of highly reflective DUTs.

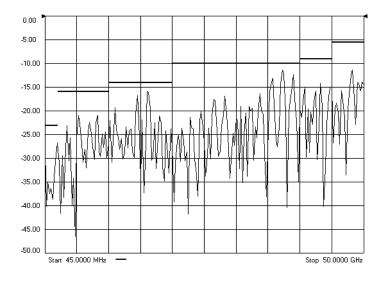
Typical Cause of Failure

The *calibration kit open or short* is the most common cause of source match specification failure.

If the open or short performance has been independently verified, then suspect the analyzer *switch splitter, step attenuator, or coupler*.

To troubleshoot, refer to "Checking the Signal Separation Group" on page 4-47.

Figure A-4 Typical E_{SF}/E_{SR} Without Cables



Load Match (E_{LF} and E_{LR})

Load match is a measure of the impedance match of the test port that terminates the output of a 2-port device. The match of test port cables is included in this response. Load match error terms are characterized by measuring the S_{11} and S_{22} responses of a "thru" configuration during the calibration procedure.

The measurements most affected by load match errors are all transmission measurements, and reflection measurements of a low insertion loss two-port device, such as an airline.

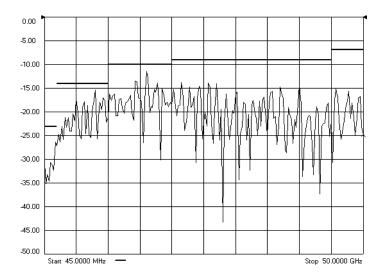
Typical Cause of Failure

The *calibration kit load or a bad "thru" cable* is the most common cause of load match specification failure.

If the load and cable performance are independently verified, then suspect the analyzer *test port coupler, step attenuator, or the test receiver* at the bad port.

To troubleshoot, refer to "Checking the Receiver Group" on page 4-51 or to "Checking the Signal Separation Group" on page 4-47.

Figure A-5 Typical E_{LF}/E_{LR}



Reflection Tracking $(E_{RF} \text{ and } E_{RR})$

Reflection tracking is the difference between the frequency response of the reference path (R1 or R2path) and the frequency response of the reflection test path (A or B input path). These error terms are characterized by measuring the reflection (S₁₁, S₂₂) of the open and the short during the measurement calibration.

All reflection measurements are affected by the reflection tracking errors.

Typical Cause of Failure

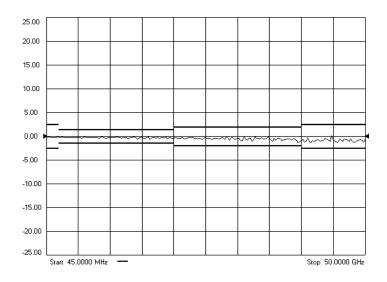
The *calibration kit open or short* is the most common cause of reflection tracking specification failure.

If the open or short performance has been independently verified, suspect the following:

- If both E_{RF} and E_{RR} fail
 - suspect the analyzer *switch splitter*
- If one of the track term specification fails
 - suspect the *coupler*, *step attenuator*, *or the test receiver* of the failed port

To troubleshoot, refer to "Checking the Receiver Group" on page 4-51 or to "Checking the Signal Separation Group" on page 4-47.

Figure A-6 Typical E_{RF}/E_{RR}



Transmission Tracking (E_{TF} and E_{TR})

Transmission tracking is the difference between the frequency response of the reference path (including the R input) and the frequency response of the transmission test path (including the A or B input) while measuring transmission. The response of the test port cables is included. These terms are characterized by measuring the transmission (S_{21} , S_{12}) of the "thru" configuration during the measurement calibration.

All transmission measurements are affected by transmission tracking errors.

Typical Cause of Failure

The *test port cable* is the most common cause of transmission tracking specification failure.

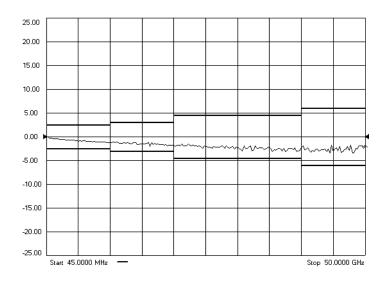
If the test port cable performance has been independently verified, suspect the following:

- If both E_{TF} and E_{TR} fail
 - suspect the analyzer *switch splitter*
- If one of the track term specification fails

— suspect the *coupler*, *step attenuator*, *or the test receiver* of the failed port

To troubleshoot, refer to "Checking the Receiver Group" on page 4-51 or to "Checking the Signal Separation Group" on page 4-47.

Figure A-7 Typical E_{TF}/E_{TR}



Isolation (E_{XF} and E_{XR})

Isolation, or crosstalk, is the uncorrected forward and reverse isolation error terms that represent leakage between the test ports and the signal paths. The isolation error terms are characterized by measuring transmission (S_{21}, S_{12}) with loads attached to both ports during the measurement calibration.isolation errors affect transmission measurements primarily where the measured signal level is very low.

The measurements most affected by isolation error terms are DUTs with large insertion loss. Since these terms are low in magnitude, they are usually noisy (not very repeatable).

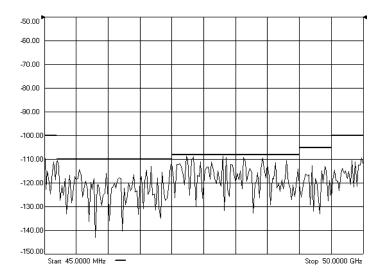
Typical Cause of Failure

A *loose cable connection or leakage between components* in the test set are the most likely cause of isolation problems.

After verifying the cable and its connections, suspect the analyzer *switch splitter*, *step attenuator*, *coupler*, *or receivers*, *and associated cabling*.

To troubleshoot, refer to "Checking the Receiver Group" on page 4-51 or to "Checking the Signal Separation Group" on page 4-47.

Figure A-8 Typical E_{XF}/E_{XR} with 10 Hz Bandwidth



B Option Enable Utility

Information in This Appendix

NOTE For more in-depth information on option enable, refer to the embedded help in the analyzer.

Appendix B at-a-Glance

| Section Title | Summary of Content | Start Page |
|--|---|------------|
| Accessing the Option Enable Utility | How to access the option enable utility within the analyzer's menu system. | Page B-3 |
| Enabling or Removing OptionsHow to add or remove options from the analyzer's option list. | | Page B-4 |
| Repairing and Recovering Option Data | How to recover lost option data. | Page B-5 |
| Installing or Changing a Serial Number | How to install a new serial number for the analyzer or change the existing serial number. | Page B-6 |

Accessing the Option Enable Utility

To start the option enable utility:

- On the System menu, point to Service, and then click Option Enable.
- The dialog box illustrated in Figure B-1 is displayed.
- **NOTE** Some applications require a keyword that is provided by Agilent. If you do not have the required keyword, contact Agilent for assistance. Refer to "Contacting Agilent" on page 2-11.

Figure B-1 Option Enable Dialog Box

| 📽 Option Enable |
|--|
| <u>Change Serial</u> <u>R</u> epair <u>A</u> bout <u>H</u> elp |
| Model: E8361A Serial: US40210005 Agilent |
| Host ID: 36A78F1B Installed Options: 010, 080 |
| Select Desired Option |
| Option Type - Permanent Imporary |
| dd-Mmm-yyyy Enter Date |

Option Entitlement Certificate

If you have received an "Option Entitlement Certificate", follow the instructions on the certificate, under "HOW TO USE THIS CERTIFICATE:", to obtain license key(s) for the option(s) listed on the certificate. See the important note below.

NOTE When upgrading from one model number to another, a new option entitlement certificate will be issued. When this certificate is redeemed for a license key, the automated system will ask for the instrument's Host ID. Be sure to use the new Host ID that is associated with the new model number. Using the current Host ID will cause a license to be generated that will not work with the instrument. To determine the new Host ID, use the utility at the below listed web site with the new model number.

http://na.tm.agilent.com/pna/upgrades.html

Enabling or Removing Options

There are two types of options:

• Hardware: Hardware options involve adding additional hardware to the analyzer. After the proper hardware has been installed in the analyzer, the option can be enabled using the option enable utility.

It is necessary to re-enable all hardware options if the A16 test set motherboard is replaced.

• Software: Software options add features or functionality to the analyzer without the need for additional hardware. These options are enabled using a special keyword. They are enabled using the option enable utility.

It is necessary to backup the software options if the A10 frequency reference board is replaced.

To enable or remove an option:

- 1. Start the option enable utility. Refer to "Accessing the Option Enable Utility" on page B-3.
- 2. Click the arrow in the **Select Desired Option** box. A list of available options, similar to the list below, will appear.
 - 010 Time Domain
 - UNL Bias Tees w/Atten
 - 014 Configurable Test Set
 - 016 Receiver Attenuators
 - 080 Frequency Offset Mode
 - 081 Reference Transfer Switch
 - 083 Mixer Measurement Appl
 - ??? Enter Unlisted Option
- 3. Click on the option that you wish to either enable or remove, and then click **Enable** or **Remove**, whichever is appropriate.
- 4. If the desired option is not available in the list, select **Enter Unlisted Option**. A dialog box appears that will allow you to enter the option number. Enter the option number and follow the instructions on the display.

Repairing and Recovering Option Data

License, option, and model number data are stored in an EEPROM on the A10 frequency reference board and written into the gen.lic file on the hard disk drive. If the data stored in either of these items is lost, it can be recovered from the other item.

If the data on both the hard disk drive and the frequency reference board is lost, it can not be recovered. Contact Agilent for assistance. Refer to "Contacting Agilent" on page 2-11.

Recovery of Data After Repair

- If the A10 frequency reference board is replaced, use the **Repair** selection to recover data that has been lost as a result of the repair:
 - 1. Select Repair from the Option Enable menu bar (see Figure B-1).
 - 2. Click the Freq Ref board has been replaced check box.
 - 3. Click Begin Repair. The data is written from the gen.lic file into the EEPROM.
- If the hard disk drive is replaced, a new gen.lic file is automatically created when the Network Analyzer application starts, by retrieving the data from the EEPROM.

Recovery of Data if Option or Model Numbers are Incorrect

If the analyzer option or model numbers are not listed correctly on the analyzer display, in either the Option Enable Dialog Box or the About Network Analyzer display, you should regenerate the options license file, gen.lic:

- 1. Exit the Network Analyzer application.
- 2. Remove (or rename) the existing gen.lic file:
 - a. Open Windows Explorer and navigate to C:\Program Files\Agilent\Network Analyzer.
 - b. Delete (or rename) gen.lic.
- 3. Exit the Windows Explorer application.
- 4. Open the Network Analyzer application. The application will generate a new gen.lic file when it starts.
- 5. Check the option listing:
 - a. On the System menu, point to Service, and then click Option Enable, or
 - b. On the Help menu, click About Network Analyzer.
- 6. If the options are still not listed correctly, contact Agilent for assistance. Refer to "Contacting Agilent" on page 2-11.

Installing or Changing a Serial Number

It is necessary to reinstall the instrument serial number if the A16 test set motherboard is replaced.

| IMPORTANT | Use extreme care when entering the serial number, as only one attempt is |
|-----------|--|
| | allowed. |

- 1. To change a serial number, select **Change Serial** from the **Option Enable** menu bar (see Figure B-1 on page B-3). The current serial number is displayed. If no serial number has previously been entered, the word "NONE" will be displayed.
- 2. Type the new serial number into the space provided, click Serial.
- **NOTE** To change an incorrect serial number, a clear-code password is required. Contact Agilent to obtain the clear-code. Refer to "Contacting Agilent" on page 2-11.

C Firmware Upgrades

Information in This Appendix

This appendix provides instructions for installing firmware upgrades in your PNA series microwave network analyzer.

Appendix C at-a-Glance

| Section Title | Summary of Content | Start Page | |
|---|--|------------|--|
| Downloading from the Internet | How to download firmware upgrades from the Internet. | Page C-2 | |
| Downloading Using Option 099, Firmware Upgrade | How to download firmware upgrades from a CD-ROM. | Page C-3 | |

How to Check the Current Firmware Version

- 1. With the Network Analyzer application running, click Help, About Network Analyzer. A dialog box showing the current installed Application Code Version is displayed.
- 2. To determine if a firmware update is available, proceed to "Downloading from the Internet."

Downloading from the Internet

If your network analyzer is connected to the Internet, there are two methods available for checking the availability of, and downloading, new firmware:

- Download directly from: http://www.agilent.com/find/pna. (Select your analyzer's model number in this website to view available upgrades.)
- On the **System** menu, point to **Service**, and then click **AgileUpdate**. **AgileUpdate** compares the firmware revision currently installed in your network analyzer to the latest version available and assists you in downloading and installing the most recent version. This is available only on analyzers with firmware revision A.01.20 and higher.

Downloading Using Option 099, Firmware Upgrade

Option 099 provides a firmware upgrade kit containing a CD-ROM that contains firmware upgrades for your network analyzer. Refer to "Option 099, Firmware Upgrade" on page 2-4 for additional information.

Two procedures are provided for updating the analyzer firmware using the upgrade kit:

- Downloading from a USB CD Drive Connected to the Analyzer
- Downloading from a Shared CD Drive Over the LAN

Installation Requirements

- The network analyzer must be in proper working condition prior to installing this option. Any necessary repairs must be made before proceeding with this installation.
- This installation does not require removal of the analyzer's protective outer covers.
- The analyzer must be powered up and operating to perform this installation.

Downloading from a USB CD Drive Connected to the Analyzer

- A mouse and a keyboard must be connected to the network analyzer.
- A CD drive must be connected to the network analyzer. This procedure has been verified using the CD drive specified in "USB Accessories" on page 6-60. It has not been verified using other USB CD drives.

Installation Procedure

- 1. Exit all applications; the analyzer display should show the PC desktop icons.
- 2. Insert the upgrade CD into your analyzer's CD drive.
- 3. Click My Computer, and then click your analyzer's CD drive.
- 4. On the CD drive menu, click on the program file listed to begin the installation.
- 5. Follow the instructions as they appear. Select your network analyzer's hard disk drive as the destination for the files being installed.

Downloading from a Shared CD Drive Over the LAN

- If your PC and your network analyzer are both connected to the same LAN, proceed to "Downloading Over the LAN."
- If your PC and your network analyzer are NOT connected to a LAN, you can connect them using a crossover cable. A crossover cable can be purchased or can be constructed from a standard LAN cable. Refer to "Constructing a Crossover Cable" on page 4-26 for details.

Downloading Over the LAN

This procedure assumes that the network analyzer and the computer are both connected to the same LAN or are connected using a crossover cable.

From your PC:

- 1. Insert the upgrade CD in your PC's CD drive.
- 2. Right click on Network Neighborhood, and then click Properties. Record the Computer Name here: ______. Click Cancel.
- Double-click My Computer. Click on your PC's CD drive. On the File menu, click Sharing. Under the Sharing tab, click Share as. Type a Share Name and record it here: ______. Do not use the default letter that is displayed. Click Cancel to close the dialog box.

From your network analyzer:

- 4. On the PC desktop, click My Computer, click Tools, and then click Map Network Drive.
- 5. The network analyzer will choose the next available drive letter. Record this drive letter here: ______.
- 6. In the Map Network Drive window, click the Folder box (this is the Path box on the PC) and type the path of your PC's CD drive in the form \\computername\sharename. You recorded the computername in step 2 and the sharename in step 3.
- **NOTE** If you are logged onto the analyzer using the same logon as for your PC, it is not necessary to select "Connect using a different user name". If, however, you are not logged onto your analyzer using the same logon or you prefer to connect under a different user name, click this hyperlink and type the user name and password. If the user name is in a different domain, use the format: domain\username.
- 7. To automatically connect to the shared drive each time you log on, check **Reconnect at logon**.
- 8. Click Finish.
- 9. Your PC's CD drive should now be visible on the display as the drive letter you recorded in step 5 with the share name you assigned in step 3.
- 10. A window listing the contents of the CD installed in your PC's CD drive is displayed.
- 11. On the CD drive menu, click on the program file listed to begin the installation.
- 12. Follow the instructions as they appear. Select your network analyzer's hard disk drive as the destination for the files being installed.

D Operating System Recovery

Recovering from Hard Disk Drive Problems

If you suspect that you have a hard disk drive problem, go to the "Hard Drive Recovery" link on the Agilent PNA Series: Service & Support Home Page on the Internet.

The URL for the Agilent PNA Series: Service & Support Home Page is:

http://na.tm.agilent.com/pna/

The URL for the Hard Drive Recovery page is: http://na.tm.agilent.com/pna/hdrecovery.html

Numerics

1284-C port rear panel connector, 5-33 troubleshooting, 4-22
50-dB receiver step attenuators, See attenuators, step
50-dB source step attenuators, See attenuators, step
8.33 MHz IF IN connectors operation, 5-26

Α

A channel attenuator removal and replacement, 7-66troubleshooting, 4-30 typical power output, 4-47 A receiver module troubleshooting, 4-52 A trace troubleshooting, 4-30, 4-32, 4 - 33A1 keypad assembly illustrated, 6-11 operation, 5-31 part number, 6-10 removal and replacement illustrated, 7-13 procedure, 7-12 test, 4-17, 4-19 test values, 4-18 troubleshooting, 4-17 A10 frequency reference board illustrated, 6-13 operation, 5-9 part number, 6-12 removal and replacement, 7-18 illustrated, 7-19 test nodes, 4-36 troubleshooting, 4-42, 4-43, 4 - 53A11 phase lock board illustrated, 6-13 operation, 5-10 part number, 6-12 removal and replacement, 7-20 illustrated, 7-21 test nodes, 4-36 troubleshooting, 4-36 A12 source 20 illustrated, 6-13 operation, 5-10 part numbers, 6-12 removal and replacement, 7-22 illustrated, 7-23 test nodes, 4-35

troubleshooting, 4-41 bands 3-26, frequency offset mode, 4-55 A13 frequency offset receiver board illustrated, 6-13 operation, 5-24part numbers, 6-12 removal and replacement, 7-24 illustrated, 7-25 troubleshooting band 0, 4-56 A14 system motherboard illustrated, 6-13 operation, 5-31, 5-33, 5-34 part number, 6-12 removal and replacement, 7-26 illustrated, 7-27 troubleshooting, 4-10, 4-12 voltage checks, 4-8 A15 CPU board illustrated, 6-13 operation, 5-32 part numbers, 6-12 removal and replacement, 7-28 illustrated, 7-29 troubleshooting, 4-10, 4-13, 4 - 21A16 test set motherboard illustrated, 6-17, 6-21 operation, 5-12part number, 6-16, 6-20 removal and replacement, 7-30 illustrated, 7-31 test nodes, 4-37, 4-38, 4-39 troubleshooting, 4-37, 4-38, 4-39, 4-51, 4-52 A17 LOMA 12 illustrated, 6-17, 6-21 operation, 5-9 part number, 6-16, 6-20 removal and replacement illustrated, 7-33 procedure, 7-32 troubleshooting, 4-44 A18 MA 24 illustrated, 6-17, 6-21 operation, 5-9 part number, 6-16, 6-20 removal and replacement illustrated, 7-35 procedure, 7-34 troubleshooting, 4-45 A19 splitter illustrated, 6-17, 6-21 operation, 5-9 part number, 6-16, 6-20 removal and replacement

illustrated, 7-37 procedure, 7-36 A2 display assembly illustrated, 6-11 operation, 5-31 part number, 6-10 removal and replacement illustrated, 7-13 procedure, 7-12 troubleshooting, 4-13, 4-17 A20 LODA illustrated, 6-17, 6-21 operation, 5-9 part number, 6-16, 6-20 removal and replacement illustrated, 7-39 procedure, 7-38 troubleshooting, 4-45 A21 SOMA 50 illustrated, 6-17, 6-21 operation, 5-11 part number, 6-16, 6-20 removal and replacement illustrated, 7-41 procedure, 7-40 troubleshooting, 4-42 A22 switch illustrated, 6-17, 6-21 operation, 5-17 part number, 6-16, 6-20 removal and replacement illustrated, 7-43 procedure, 7-42 troubleshooting, 4-48, 4-49 A23 SOMA 70 illustrated, 6-17, 6-21 operation, 5-17 part number, 6-16, 6-20 removal and replacement illustrated, 7-45 procedure, 7-44 troubleshooting, 4-42, 4-48, 4 - 49A24 SOMA 70 illustrated, 6-17, 6-21 operation, 5-17 part number, 6-16, 6-20 removal and replacement illustrated, 7-45 procedure, 7-44 troubleshooting, 4-42, 4-48, 4 - 49A25 test port 1 coupler illustrated, 6-17, 6-21 operation, 5-17 part number, 6-16, 6-20 removal and replacement illustrated, 7-47

procedure, 7-46 troubleshooting, 4-48, 4-49 A26 test port 2 coupler illustrated, 6-17, 6-21 operation, 5-17 part number, 6-16, 6-20 removal and replacement illustrated, 7-47 procedure, 7-46 troubleshooting, 4-48, 4-49 A27 channel A first converter illustrated, 6-17, 6-21 part number, 6-16, 6-20 removal and replacement illustrated, 7-49 procedure, 7-48 troubleshooting, 4-51 A28 channel R1 first converter illustrated, 6-17, 6-21 part number, 6-16, 6-20 removal and replacement illustrated, 7-49 procedure, 7-48 troubleshooting, 4-51 A29 channel R2 first converter illustrated, 6-17, 6-21 part number, 6-16, 6-20 removal and replacement illustrated, 7-49 procedure, 7-48 troubleshooting, 4-51 A3 front panel interface board illustrated, 6-11 operation, 5-31 part number, 6-10 removal and replacement illustrated, 7-13 procedure, 7-12 troubleshooting, 4-13, 4-17 A30 channel B first converter illustrated, 6-17, 6-21 part number, 6-16, 6-20 removal and replacement illustrated, 7-49 procedure, 7-48 troubleshooting, 4-51 A31 channel A receiver module illustrated, 6-17, 6-21 operation, 5-21 part number, 6-16, 6-20 removal and replacement illustrated, 7-51 procedure, 7-50 troubleshooting, 4-52 A32 channel R1 receiver module illustrated, 6-17, 6-21 operation, 5-21 part number, 6-16, 6-20

removal and replacement illustrated, 7-51 procedure, 7-50 troubleshooting, 4-52 A33 channel R2 receiver module illustrated, 6-17, 6-21 operation. 5-21part number, 6-16, 6-20 removal and replacement illustrated, 7-51 procedure, 7-50 troubleshooting, 4-52 A34 channel B receiver module illustrated, 6-17, 6-21 operation, 5-21 part number, 6-16, 6-20 removal and replacement illustrated, 7-51 procedure, 7-50 troubleshooting, 4-52 A35 receiver motherboard illustrated, 6-17, 6-21 operation, 5-23 part number, 6-16, 6-20 removal and replacement illustrated, 7-53 procedure, 7-52 troubleshooting, 4-52 A36 port 1 step attenuator illustrated, 6-25 operation, 5-17 part number, 6-24 removal and replacement illustrated, 7-55 procedure, 7-54 troubleshooting, 4-48, 4-49 A37 port 2 step attenuator illustrated, 6-25 operation, 5-17 part number, 6-24 removal and replacement illustrated. 7-55 procedure, 7-54 troubleshooting, 4-48, 4-49 A38 port 1 bias tee illustrated, 6-25 operation, 5-17 part number, 6-24 removal and replacement illustrated, 7-57 procedure, 7-56 troubleshooting, 4-50 A39 port 2 bias tee illustrated, 6-25 operation, 5-17 part number, 6-24 removal and replacement illustrated, 7-57

procedure, 7-56 troubleshooting, 4-50 A4 power supply assembly illustrated, 6-13 operation, 5-34 part number, 6-12 removal and replacement, 7-16 illustrated, 7-17 troubleshooting, 4-7 A40 floppy disk drive illustrated, 6-53 operation, 5-33 part numbers, 6-52 removal and replacement illustrated, 7-59 procedure, 7-58 A41 hard disk drive illustrated, 6-58 location of, 6-56, 6-57 operation, 5-33 part numbers, 6-58 removal and replacement illustrated, 7-61 procedure, 7-60 A43 channel A step attenuator illustrated, 6-29 operation, 5-17 part number, 6-28 removal and replacement illustrated, 7-67 procedure, 7-66 A44 channel B step attenuator illustrated, 6-29 operation, 5-17 part number, 6-28 removal and replacement illustrated, 7-67 procedure, 7-66 A45 reference transfer switch illustrated. 6-33 operation, 5-24part number, 6-32 removal and replacement illustrated, 7-69 procedure, 7-68 troubleshooting, 4-56 A47 RF path coupler illustrated, 6-41 operation, 5-26 part number, 6-40 removal and replacement illustrated, 7-71 procedure, 7-70 A48 LO path coupler illustrated, 6-41 operation, 5-26 part number, 6-40 removal and replacement

Index

illustrated, 7-71 procedure, 7-70 A49 IF multiplexer board illustrated, 6-17 operation, 5-21, 5-26 part number, 6-16 removal and replacement illustrated, 7-51 procedure, 7-50 troubleshooting, 4-52 A6 SPAM board illustrated, 6-13 operation analog, 5-23 digital, 5-32 part number, 6-12 removal and replacement, 7-18 illustrated, 7-19 troubleshooting, 4-52 A8 fractional-N synthesizer board illustrated, 6-13 operation, 5-8 part number, 6-12 removal and replacement, 7-18 illustrated, 7-19 test nodes, 4-37 troubleshooting band 2, 4-44 bands 0 and 1, 4-43 bands 3-26, 4-44 A9 fractional-N synthesizer board illustrated, 6-13 operation, 5-24 part number, 6-12 removal and replacement, 7-18 illustrated, 7-19 test nodes, 4-39 troubleshooting band 2, 4-54 bands 0 and 1, 4-54 bands 3-26, 4-55 accessories analyzer, 2-6 CD-RW drive, 2-6 in operator's check, 3-10 in test port cable checks, 3-12 USB part numbers, 6-60 USB hub, 2-6 accuracy dynamic accuracy test, 3-36 frequency test, 3-31 adapters required for servicing, 2-8 adding options. B-4 adjustments frequency

at 10 MHz, 3-44 at 3.8 MHz, 3-45 LO offset, 3-48 LO power, 3-46 phase lock IF gain, 3-52 receiver calibration, 3-53 source calibration, 3-50 system, 3-1, 3-43, B-1, C-1 getting ready. 3-4 administrator password Agilent, 7-64 Agilent administrator password, 7-64 contacting, 2-11 support, 2-10 all traces troubleshooting, 4-32 analyzer accessories, 2-6 block diagram configurable test set, Option 014, 5-19 digital control group, 5-30 digital processor group, 5-30 frequency offset group, 5-25 IF access group, 5-28 receiver group, 5-22 signal separation group, 5-16 source group, 5-7 covers illustrated, 6-55 part numbers, 6-54 removal and replacement, 7-6 display lamp replacement illustrated, 7-15 replacement procedure, 7-14 external replaceable parts illustrated, 6-55 part numbers, 6-54 feet illustrated, 6-55 part numbers, 6-54 frequency range and max ouput power, 5-4 frequency reference board assembly, 5-9 front panel interconnects, 5-31 functional groups, 5-3 digital control, 5-5 digital processing, 5-5 frequency offset group, 5-4, 5 - 5power supply, 5-5 receiver group, 5-4 signal separation, 5-4 synthesized source, 5-4 internal replaceable parts illustrated, 6-53

part numbers, 6-52 miscellaneous replaceable parts part numbers, 6-59 mounting in equipment rack, 2-5operation A47 RF path coupler, 5-26 A48 LO path coupler, 5-26 A49 IF multiplexer board, 5 - 26bias tees, 5-17 configurable test set, Option 014. 5-18 CPU board, 5-32 data acquisition subgroup, 5 - 32digital control group, 5-29 digital processor group, 5-29 display assembly, 5-31 floppy disk drive, 5-33 fractional-N synthesizer board, 5-8, 5-9, 5-24 fractional-N synthesizer board assembly, 5-9 frequency offset group, 5-24 frequency offset receiver board, 5-24 front panel interface board, 5 - 31front panel subgroup, 5-31 hard disk drive, 5-33 IF access group, 5-26 IF multiplexer board, 5-21 keypad assembly, 5-31 LODA, 5-9 main RAM, 5-32 phase lock board assembly, 5 - 10processing subgroup, 5-32 receiver group, 5-21 receiver modules, 5-21 receiver motherboard, 5-23 receiver step attenuators, 5-17 reference transfer switch, 5-24 signal separation group, 5-16 SOMA 50, 5-11 SOMA 70, 5-17 source 20 assembly, 5-10 source group, 5-6 source step attenuators, 5-17 SPAM board-analog, 5-23 SPAM board-digital, 5-32 splitter assembly, 5-9 switch, 5-17 test port couplers, 5-17 test set motherboard, 5-12 USB hub, 5-33

options, 2-3 rear panel interconnects, 5-10, 5-12, 5-26, 5-33 rear panel replaceable parts illustrated, 6-57 part numbers, 6-56 strap handle illustrated, 6-55 part number, 6-54 system block diagram, 5-3 system operation theory of, 5-3 upgrades, 2-6 warmup time, 3-4 ANSI/NCSL Z540-1-1994 verification, 3-8 ANSI/NCSL Z540-1-1994 non-type verification, 3-9 assemblies location of part numbers, 6-8 rebuilt-exchange procedure, 6-5 rebuilt-exchange program, 6-5 replacement cautions about, 7-3 list of procedures. 7-4 sequence, 6-4, 7-3 warnings about, 7-3 attenuator bracket illustrated, 6-51 part number, 6-50 attenuators required for servicing, 2-8 attenuators, step receiver illustrated, 6-29 operation, 5-17 part number, 6-28 source illustrated, 6-25 operation, 5-17 part number, 6-24 **AUX I/O connector** pin assignments, 5-15 rear panel, 5-12

В

B channel attenuator removal and replacement, 7-66 troubleshooting, 4-30 typical power output, 4-48 B receiver module troubleshooting, 4-52 B trace

troubleshooting, 4-30, 4-33 B1 fan removal and replacement, 7-72 band modes source group configurations, 5-6 operation, 5-6 troubleshooting band 2, 4-44 band 2, frequency offset mode, 4 - 54bands 0 and 1, 4-43 bands 0 and 1, frequency offset mode, 4-54 bands 3-26, 4-44 bands 3-26, frequency offset mode, 4-55 battery disposal, 1-8 before applying power, 1-3 bias tee illustrated, 6-25 part number, 6-24 bias tee bracket illustrated, 6-51 part number, 6-50 bias tee, port 1 operation, 5-17 removal and replacement illustrated. 7-57 procedure, 7-56 troubleshooting, 4-50 bias tee, port 2 operation, 5-17 removal and replacement illustrated, 7-57 procedure, 7-56 troubleshooting, 4-50 block diagram configurable test set. Option 014, 5-19 digital control group, 5-30 digital processor group, 5-30 frequency offset group, 5-25 IF access group, 5-28 receiver group, 5-22 signal separation group, 5-16 source group, 5-7 bottom assembly, all options hardware part numbers, 6-50 replaceable cables, flexible illustrated. 6-45 part numbers, 6-44 replaceable cables, ribbon illustrated, 6-47 part numbers, 6-46 replaceable cables, wrapped-wire

illustrated, 6-47 part numbers, 6-46 bottom assembly, no options replaceable cables, semi-rigid illustrated, 6-19 part numbers, 6-18 replaceable parts illustrated, 6-17 part numbers, 6-16 bottom assembly, Option 014 replaceable cables, semi-rigid illustrated, 6-23 part numbers, 6-22 replaceable parts illustrated, 6-21 part numbers, 6-20 bottom assembly, Options 014/080 replaceable cables, semi-rigid illustrated, 6-23 part numbers, 6-22 replaceable parts illustrated. 6-21 part numbers, 6-20 bottom assembly, **Options 014/UNL** replaceable cables, semi-rigid illustrated, 6-27 part numbers, 6-26 replaceable parts illustrated, 6-25 part numbers, 6-24 bottom assembly, Options 014/UNL/016 replaceable cables, semi-rigid illustrated, 6-31 part numbers, 6-30 replaceable parts illustrated. 6-29 part numbers, 6-28 bottom assembly, **Options 014/UNL/016/080/081** replaceable cables, semi-rigid illustrated, 6-39 part numbers, 6-38 replaceable parts illustrated, 6-37 part numbers, 6-36 bottom assembly, Options 014/UNL/080/081 replaceable cables, semi-rigid illustrated, 6-35, 6-43 part numbers, 6-34, 6-42 replaceable parts illustrated, 6-33 part numbers, 6-32 bottom assembly. all options hardware illustrated, 6-51 bracket

Index

attenuator illustrated, 6-51 part number, 6-50 bias tee illustrated, 6-51 part number, 6-50 **broadband failure**, 4-40

C

cable substitution, 3-22 test port checks, 3-10, 3-12, 3-13, 3-14, 3-15, 3-17 connector repeatability failure, 3-18 insertion loss failure, 3-14 magnitude and phase stability failure, 3-16 return loss failure, 3-13 cables, flexible in bottom assembly, all options illustrated, 6-45 part numbers, 6-44 in top assembly, all options illustrated. 6-15 part numbers, 6-14 cables, GPIB part numbers, 6-59 cables, required for servicing, 2-8 cables, ribbon in bottom assembly illustrated, 6-47 part numbers, 6-46 in top assembly, all options illustrated, 6-15 part numbers, 6-14 cables, semi-rigid in bottom assembly, no options illustrated, 6-19 part numbers, 6-18 in bottom assembly, Option 014 illustrated, 6-23 part numbers, 6-22 in bottom assembly, Options 014/UNL part numbers, 6-26 in bottom assembly, Options 014/UNL/016/080/081 illustrated, 6-39 part numbers, 6-38 in bottom assembly, Options 014/080 illustrated, 6-23 part numbers, 6-22 in bottom assembly, **Options 014/UNL**

illustrated, 6-27 in bottom assembly, Options 014/UNL/016 illustrated, 6-31 part numbers, 6-30 in bottom assembly, Options 014/UNL/080/081 part numbers, 6-34, 6-42 in bottom assembly, standard illustrated, 6-35, 6-43 in top assembly, all options illustrated, 6-15 part numbers. 6-14 cables, wrapped-wire in bottom assembly, all options illustrated, 6-47 part numbers, 6-46 in top assembly, all options illustrated, 6-15 part numbers, 6-14 calibration certificate of, 3-7 coefficients test, 3-34 commercial, Option R-50C-001, 2 - 10kits, 2-8, 3-7 substitution, 3-22 measurement, A-4 options available, 2-10 receiver, 3-53 source, 3-50standards compliant, Option R-50C-002, 2-10 care of connectors, 3-5 caution, 1-3 CD-RW drive, 2-6 ČE mark, 1-7 certificate of calibration, 3-7 changing a serial number, B-6 channel A troubleshooting, 4-30, 4-47 typical power output, 4-47 channel A receiver module troubleshooting, 4-52 channel B troubleshooting, 4-30, 4-47 typical power output, 4-48 channel B receiver module troubleshooting, 4-52 channel R1 troubleshooting, 4-30 channel R1 receiver module troubleshooting, 4-52 channel R2 troubleshooting, 4-30 channel R2 receiver module troubleshooting, 4-52 checks

cable connector repeatability, failure of. 3-18 insertion loss, failure of, 3-14 magnitude and phase stability, failure of, 3-16 return loss, failure of, 3-13 test port cables, 3-10, 3-12 operator's. 3-10 accessories used in, 3-10 dialog box, 3-11 failure of, 3-11 performing, 3-10 Port 1, 3-10 Port 2, 3-10 preliminary, 3-10 system, 3-1, B-1, C-1 getting ready, 3-4 test port cable accessories used in, 3-12connector repeatability, 3-17 insertion loss, 3-14 magnitude and phase stability, 3-15 performing, 3-12 return loss, 3-13 COM, A-7 commercial calibration, **Option R-50C-001**, 2-10 compression test, receiver, 3-32 configurable test set, Option 014, block diagram, 5-19 operation, 5-18 configuration high dynamic range, 5-20 diagram, 5-20 Option 014, 5-19 connector care principles of, 3-5 quick reference, 3-5 protective end caps part numbers, 6-59 repeatability check failure of, 3-18 of test port cables, 3-17 connector repeatability check test port cables, 3-17 connectors care of. 3-5 front panel, 5-31 Probe Power, 5-31 USB, 5-31 rear panel, 5-10, 5-12, 5-33 1284-C, 5-33 8.33 MHz IF IN, 5-26

AUX I/O, 5-12, 5-15 Display, 5-33 EXT 10 MHz REF IN, 5-10 EXT 10 MHz REF OUT, 5-10 GPIB, 5-33 HANDLER I/O, 5-12, 5-14 PARALLEL, 5-33 PULSE IN, 5-26 RS-232, 5-33 SERIAL, 5-33 TEST SET DRIVERS, 5-26 TEST SET I/O, 5-12, 5-13 **TRIG IN**, 5-12 TRIG OUT, 5-12 USB, 5-33 VGA, 5-33 contacting Agilent, 2-11 controllers troubleshooting with, 4-23 coupler LŌ path operation, 5-26 nut illustrated, 6-51 part number, 6-50 port 1 illustrated, 6-17, 6-21 part number, 6-16, 6-20 troubleshooting, 4-49 port 2 illustrated, 6-17, 6-21 part number, 6-16, 6-20 troubleshooting, 4-49 RF path operation, 5-26 coupler, LO path illustrated, 6-41 part number, 6-40 removal and replacement illustrated, 7-71 procedure, 7-70 coupler, RF path illustrated, 6-41 part number, 6-40 removal and replacement illustrated, 7-71 procedure, 7-70 cover, removing, 1-4 covers, analyzer illustrated, 6-55 part numbers, 6-54 removal and replacement illustrated, 7-7 procedure, 7-6 CPU board illustrated, 6-13 operation, 5-32 part numbers, 6-12

removal and replacement illustrated, 7-29 procedure, 7-28 troubleshooting, 4-13, 4-21 cross talk system test, 3-35 test port test, 3-35 cross-over cable, LAN, 4-26 CSA mark, 1-7

D

dangerous voltage, 1-4 data acquisition operation, 5-32 data acquisition and processing subgroup, 5-29 data storage floppy disk, 5-33 hard disk, 5-33 IDE, 5-33 data, option recovering, B-5 repairing, B-5 DCOM, A-7 description functional digital control group, 5-5 digital processing group, 5-5 frequency offset group, 5-5 frequency offset group, 5-4 power supply group, 5-5 receiver group, 5-4 signal separation group, 5-4 synthesized source group, 5-4 device connections system verification, 3-24 digital control group block diagram, 5-30 functional description of, 5-5 operation, 5-29 digital processing and control functional group, 5-3 digital processing group block diagram, 5-30 functional description of, 5-5 operation, 5-29 directivity cause of failure, A-10 definition of, A-10 measurements affected by, A-10 disabling options, B-4 display assembly illustrated, 6-11 operation, 5-31 parts list, 6-10 removal and replacement illustrated, 7-13

procedure, 7-12 troubleshooting, 4-13, 4-17 display inverter removal and replacement illustrated, 7-15 procedure, 7-14 display lamp removal and replacement illustrated, 7-15 procedure, 7-14 **Display port** rear panel connector, 5-33 display test running, 4-19 documentation part numbers, 6-59 printing copies, -iv standard, -iv dynamic range, high configuration, 5-20

Е

earth ground, 1-3 electrostatic discharge, See ESD **EMI/RFI** supplies part numbers, 6-60 enabling options, B-4 environment, operating specifications, 3-4 verification, 3-4 equipment rack horizontal spacing, 2-5 mounting analyzer in, 2-5 equipment, service test required, 2-7 error terms access to, A-6 via COM/DCOM commands, A-7 via front panel. A-6 via SCPI commands (using GPIB), A-7 cause of failure to, A-3 descriptions, A-8 directivity, A-10 flowgraph of one port, A-4 flowgraph of two port, A-5 identifying using flowgraphs, A-4 isolation, A-15 load match, A-12 magnitude affected by, A-3 monitoring over time, A-3 reflection tracking, A-13 shape affected by, A-3

source match, A-11 transmission tracking, A-14 typical data, A-8 using as diagnostic tool, A-3 using to aid troubleshooting, A-3 worse than typical values, A-8 ESD protection, 1-6, 3-4, 4-3, 7-3, A-4 supplies part numbers, 6-60 exchange module procedure, 6-5 rebuilt assemblies program, 6-5 EXT 10 MHz REF IN connector rear panel, 5-10 **EXT 10 MHz REF OUT connector** rear panel, 5-10 extender board measurement points, 4-8 voltages, 4-8 external analyzer replaceable parts illustrated, 6-55 part numbers, 6-54 external monitor, 4-13

\mathbf{F}

failure broadband, 4-40 of connector repeatability check, 3 - 18of insertion loss check, 3-14 of magnitude and phase stability check, 3-16 of operator's check, 3-11 of return loss check, 3-13 of system verification, 3-25 flowchart, 3-25 single vs. broadband, 4-40 fan removal and replacement, 7-72 troubleshooting, 4-12 feet analyzer illustrated, 6-55 part numbers, 6-54 firmware upgrade downloading from the internet, C-2 installing using Option 099, C-3 Option 099, 2-4 first converter channel A illustrated, 6-17, 6-21

part number, 6-16, 6-20 removal and replacement illustrated, 7-49 removal and replacement procedure, 7-48 troubleshooting, 4-51 channel B illustrated, 6-17, 6-21 part number, 6-16, 6-20 removal and replacement illustrated, 7-49 removal and replacement procedure, 7-48 troubleshooting, 4-51 channel R1 illustrated, 6-17, 6-21 part number, 6-16, 6-20 removal and replacement illustrated, 7-49 removal and replacement procedure, 7-48 troubleshooting, 4-51 channel R2 illustrated, 6-17, 6-21 part number, 6-16, 6-20 removal and replacement illustrated, 7-49 removal and replacement procedure, 7-48 troubleshooting, 4-51 floppy disk drive data storage, 5-33 illustrated, 6-53 operation, 5-33 part number, 6-52 removal and replacement illustrated, 7-59 procedure, 7-58 flowgraph of one port error terms, A-4 of two port error terms, A-5 using to identify error terms, A-4 Fourier transform, 2-3 fractional-N synthesizer board illustrated, 6-13 operation, 5-8, 5-24 part number, 6-12 removal and replacement illustrated, 7-19 procedure, 7-18 test nodes, 4-37, 4-39 troubleshooting band 0 and 1, frequency offset mode, 4-54 band 2, 4-44 band 2, frequency offset mode, 4 - 54

bands 0 and 1, 4-43 bands 3-26, 4-44 bands 3-26, frequency offset mode, 4-55 frequency accuracy test, 3-31 frequency adjustment at 10 MHz, 3-44 at 3.8 MHz, 3-45 frequency converter measurement application Option 083, 2-4 frequency offset functional description of. 5-5 frequency offset group block diagram, 5-25 defined, 4-32 operation, 5-24 frequency offset mode functional description of, 5-4 Option 080, 2-4 frequency offset receiver assembly illustrated, 6-13 part numbers, 6-12 removal and replacement illustrated, 7-25 procedure, 7-24 troubleshooting band 0. 4-56 frequency range and max output power, 5-4 frequency reference board illustrated, 6-13 operation, 5-9 part number, 6-12 removal and replacement illustrated, 7-19 procedure, 7-18 test nodes, 4-36 troubleshooting, 4-42, 4-43, 4-53front panel connectors Probe Power, 5-31 USB, 5-31 interconnects, 5-31 knob part number, 6-10 test, 4-19 troubleshooting, 4-17 LED board illustrated, 6-51 part number, 6-50 operation, 5-31 speaker, 5-31 subgroup, 5-29 USĒ troubleshooting, 4-17, 4-21

Index

front panel assembly removal and replacement illustrated, 7-11 procedure, 7-10 replaceable parts illustrated, 6-11 part numbers, 6-10 front panel interface board illustrated, 6-11 operation, 5-31 part number, 6-10 removal and replacement illustrated, 7-13 procedure, 7-12 troubleshooting, 4-13, 4-17 front panel knob test, 4-17 front panel subassemblies removal and replacement illustrated, 7-13 procedures, 7-12 functional groups, 5-3 fuses, 6-59

G

general safety considerations, 1-3 GPIB, A-7 cables part numbers, 6-59 port rear panel connector, 5-33 running test software, 4-23 troubleshooting, 4-23 systems check, 4-23 ground, safety earth, 1-3 groups functional, 5-3

Н

handle damaged, 1-3 kits part numbers, 6-61 HANDLER I/O connector pin assignments, 5-14 rear panel, 5-12 handles with rack mount, 2-5 hard disk drive copying files from, 7-60 data storage, 5-33 illustrated, 6-58 installing backup files onto, 7-64 location of, 6-56, 6-57 operation, 5-33 part number, 6-58

removal and replacement illustrated, 7-61 procedure, 7-60 replaceable parts illustrated, 6-58 part numbers, 6-58 unique files located on, 7-60 hardware in bottom assembly illustrated, 6-51 part numbers, 6-50 in external analyzer illustrated, 6-55 part numbers, 6-54 in hard disk drive assembly illustrated, 6-58 part numbers, 6-58 in internal analyzer illustrated, 6-53 part numbers, 6-52 in rear panel assembly illustrated, 6-57 part numbers, 6-56 in top assembly illustrated, 6-49 part numbers, 6-48 location of part numbers, 6-8 options, 2-3, B-4 upgrades, 2-6 high dynamic range configuration, 5-2 diagram, 5-20 hub. USB removal and replacement illustrated, 7-75 procedure, 7-75

I

IDE data storage, 5-33 IF access group block diagram, 5-28 operation, 5-26 IF access, Option H11 operation verification, 3-28 IF access, Option H11, 2-5 IF gain adjustment for phase lock, 3-52 **IF IN connectors** operation, 5-26 IF multiplexer board illustrated, 6-17 operation, 5-21, 5-26 part number, 6-16 removal and replacement illustrated, 7-51 procedure, 7-50

troubleshooting, 4-52 insertion loss check failure of, 3-14 test port cables, 3-14 installing a serial number, B-6 instruction documentation symbol, 1-7 instrument markings, 1-7 instrument specifications, 3-6 interconnects AUX I/O pin assignments, 5-15 front panel, 5-31 Probe Power, 5-31 USB, 5-31 HANDLER I/O pin assignments, 5-14 rear panel, 5-10, 5-12, 5-33 1284-C, 5-33 AUX I/O, 5-12 Display, 5-33 EXT 10 MHz REF IN, 5-10 EXT 10 MHz REF OUT, 5-10 GPIB, 5-3 HANDLER I/O, 5-12 LAN, 5-33 PARALLEL, 5-33 RS-232, 5-33 SERIAL, 5-33 **TEST SET I/O, 5-12 TRIG IN**, 5-12 **TRIG OUT. 5-12** USB, 5-33 VGA, 5-33 TEST SET I/O pin assignments, 5-13 internal analyzer replaceable hardware illustrated, 6-53 part numbers, 6-52 replaceable parts illustrated, 6-53 part numbers, 6-52 IP address, LAN, 4-24 ISM1-A mark, 1-7 isolation cause of failure, A-15 definition of. A-15 measurements affected by, A-15

K

keypad assembly illustrated, 6-11 operation, 5-31 part number, 6-10 removal and replacement

illustrated, 7-13 procedure, 7-12 test, 4-17, 4-19 troubleshooting, 4-17 kits calibration, 2-8, 3-7 handle part numbers, 6-61 rack mount part numbers, 6-61 upgrade part numbers, 6-60 verification, 2-8, 3-7 knob front panel part number, 6-10 test, 4-17, 4-19 troubleshooting, 4-17

\mathbf{L}

LAN connector rear panel, 5-33 cross-over cable, 4-26 IP address, 4-24 ping command, 4-24 ping to and from, 4-24 subnet mask, 4-24 testing between analyzers, 4-26 troubleshooting, 4-24 LCD display troubleshooting, 4-13 LED board, front panel illustrated, 6-51 part number, 6-50 linearity source power test, 3-30 test port output power test, 3-30 lithium battery disposal, 1-8 LO offset adjustment, 3-48 LO path coupler illustrated, 6-41 part number, 6-40 removal and replacement illustrated, 7-71 procedure, 7-70 LO path coupler, A48 operation, 5-26 LO power adjustment, 3-46 load match cause of failure, A-12 definition of, A-12 measurements affected by, A-12, A-14

locating assembly part numbers, 6-8 hardware part numbers, 6-8 miscellaneous part numbers, 6-8, 6-9 replaceable part numbers by reference designator, 6-6 by type of part, 6-8 LODA illustrated, 6-17, 6-21 operation, 5-9 part number, 6-16, 6-20 removal and replacement illustrated, 7-39 procedure, 7-38 troubleshooting, 4-45 **LOMA 12** illustrated, 6-17, 6-21 operation, 5-9 part number, 6-16, 6-20 removal and replacement illustrated, 7-33 procedure, 7-32 troubleshooting, 4-44

М

MA 24 illustrated, 6-17, 6-21 operation, 5-9 part number, 6-16, 6-20 removal and replacement illustrated, 7-35 procedure, 7-34 troubleshooting, 4-45 machine screws in bottom assemblies illustrated, 6-51 part numbers, 6-50 in external analyzer illustrated, 6-55 part numbers, 6-54 in hard disk drive assembly illustrated, 6-58 part numbers, 6-58 in rear panel assembly illustrated, 6-57 part numbers, 6-56 magnitude check failure of, 3-16 test port cables, 3-15 maintenance cleaning, 2-3 preventive effect on error terms, A-3 manuals, printing copies, -iv max output power and frequency range, 5-4

measurement calibration. A-4 traceability, 3-21 path, 3-21 uncertainty, 3-20 measurement system troubleshooting, 4-28 measuring high-dynamic range devices, 2-3 high-power devices, 2-3memory modules part numbers, 6-59 midweb removal and replacement, 7-72 illustrated, 7-73 midweb fans troubleshooting, 4-12 miscellaneous parts location of part numbers, 6-8, 6-9 required for servicing, 2-9 miscellaneous replaceable parts part numbers, 6-59 mixer bias board illustrated, 6-51 part number, 6-50 mixer bracket illustrated, 6-51 part number, 6-50 module exchange procedure, 6-5 monitor, external, 4-13 motherboard, receiver illustrated, 6-17, 6-21 part number, 6-16, 6-20 troubleshooting, 4-52 motherboard, system illustrated, 6-13 operation, 5-31 part number, 6-12 removal and replacement illustrated, 7-27 procedure, 7-26 troubleshooting, 4-12 motherboard, test set illustrated, 6-17, 6-21 part number, 6-16, 6-20 multiplexer board illustrated, 6-17 part number, 6-16 multiplexer board, IF troubleshooting, 4-52

Ν

network analyzer, *See analyzer* noise floor, test, 3-33 noise, trace noise test, 3-31 Non-ANSI/NCSL Z540-1-1994 verification, 3-9 nut test port coupler illustrated, 6-51 part number, 6-50

0

OCXO (oven-controlled crystal oscillator) frequency adjustment, 3-44 theory of operation, 5-9 operating environment specifications, 3-4verification, 3-4 operating system recovery, D-1 operation bias tees, 5-17 configurable test set, Option 014, 5-18 CPU board, 5-32 data acquisition, 5-32digital control, 5-29 digital processor, 5-29 display assembly, 5-31 floppy disk drive, 5-33 fractional-N synthesizer board, 5-8, 5-24frequency offset group, 5-24 frequency offset receiver board, 5 - 24frequency reference board, 5-9 front panel, 5-31 front panel interface board, 5-31 hard disk drive, 5-33 IF access group, 5-26 IF multiplexer board, 5-21, 5-26 keypad assembly, 5-31 LO path coupler, 5-26 LODA, 5-9 LOMA 12, 5-9 MA 24, 5-9 main RAM, 5-32 phase lock board, 5-10 power supply, 5-34 processing subgroup, 5-32 receiver group, 5-21 receiver modules, 5-21 receiver motherboard, 5-23 reference transfer switch, 5-24 RF path coupler, 5-26 signal separation group, 5-16 SOMA 50, 5-11 SOMA 70, 5-17 source, 5-6 source assembly, 5-10

source group, band modes, 5-6 SPAM board-analog, 5-23 SPAM board-digital, 5-32 splitter assembly, 5-9 step attenuators receiver, 5-17 source, 5-17 switch, 5-17 system motherboard, 5-31 test port couplers, 5-17 test set motherboard, 5-12 transfer switch, 5-24 USB hub. 5-33 operator's check, 3-10 accessories used in, 3-10dialog box, 3-11 failure of, 3-11 performing, 3-10 Port 1, 3-10 Port 2, 3-10 option analyzer, 2-3 calibration, 2-10 data recovering, B-5 repairing, B-5 enable utility accessing, B-3 dialog box, B-3 enabling and removing, B-4 hardware, B-4 service and support, 2-10 software, B-4 Option 010, time domain, 2-3 Option 014, configurable test set, block diagram, 5-19 normal configuration, 5-19 operation, 5-18 **Option 016, receiver attenuators,** 2-4operation, 5-17 **Option 080, frequency offset** mode, 2-Option 081, transfer switch, 2-4 **Option 083, frequency converter** measurement application, 2-4Option 099, firmware upgrade, **Option 1CM, rack mount without** handles, 2-5 **Option 1CP, rack mount with** handles, 2-**Option H08, pulse measurement** capability, 2-4 Option H11, IF access, 2-5 operation, 5-26 operation verification, 3-28

Option UNL, source attenuators, 2-5operation, 5-17 Option R-50C-001 commercial calibration, 2-10 Option R-50C-002 standards compliant calibration, 2-10 ordering information options and upgrades, 2-3 replaceable parts, 6-3 output power, source accuracy test, 3-29 linearity, 3-30 maximum test, 3-30 output power, test port accuracy test, 3-29 linearity, 3-30 maximum test, 3-30

Р

pads required for servicing, 2-8 paint touch-up part numbers, 6-60 PARALLEL port rear panel connector, 5-33 troubleshooting, 4-22 part numbers accessories USB, 6-60 cables GPIB. 6-59 cables, all in top assembly, all options, 6-14 cables, flexible in bottom assembly, all options, 6-44 cables, ribbon in bottom assembly, all options, 6-46 cables, semi-rigid in bottom assembly, no options, 6-18 in bottom assembly, Option 014. 6-22 in bottom assembly, Options 014/080, 6-22 in bottom assembly, Options 014/UNL, 6-26 in bottom assembly, Options 014/UNL/016/080/081, 6-38

in bottom assembly, Options 014/UNL/080/081, 6-34, 6-42 in bottom assembly, Options 014/UNL/016, 6-30 cables, wrapped-wire in bottom assembly, 6-46 documentation, 6-59 hardware in bottom assembly, 6-50 in external analyzer, 6-54 in hard disk drive, 6-58 in internal analyzer, 6-52 in rear panel assembly, 6-56 in top assembly, 6-48 kits handle, 6-61 rack mount, 6-61 locating by reference designator, 6-6 by type of part, 6-8 for assemblies, 6-8 for hardware, 6-8 for miscellaneous parts, 6-8, 6-9 paint touch-up, 6-60 protective end caps for connectors, 6-59 replaceable parts analyzer covers, 6-54 analyzer feet, 6-54 analyzer strap handle, 6-54 in bottom assembly, all options, 6-50 in bottom assembly, no options, 6-16 in bottom assembly, Option 014, 6-20 in bottom assembly, Options 014/080, 6-20 in bottom assembly, Options 014/UNL, 6-24 in bottom assembly, Options 014/UNL/016, 6-28 in bottom assembly, Options 014/UNL/016/080/081, 6-36 in bottom assembly, Options 014/UNL/080/081. 6-32 in external analyzer, 6-54 in front panel assembly, 6-10 in hard disk drive assembly, 6 - 58in internal analyzer, 6-52 in rear panel assembly, 6-56

in top assembly, all options, 6-12, 6-48 miscellaneous analyzer, 6-59 supplies EMI/RFI, 6-60 ESD, 6-60 memory modules, 6-59 tools service, 6-59 upgrade kits, 6-60 parts in bottom assembly illustrated, 6-51 part numbers, 6-50 in bottom assembly, no options illustrated, 6-17 part numbers, 6-16 in bottom assembly, Option 014 illustrated, 6-21 part numbers, 6-20 in bottom assembly, Options 014/080 illustrated, 6-21 part numbers, 6-20 in bottom assembly, Options 014/UNL/016/080/081 illustrated, 6-37 part numbers, 6-36 in bottom assembly, **Options 014/UNL** illustrated, 6-25 part numbers, 6-24 in bottom assembly, Options 014/UNL/016 illustrated, 6-29 part numbers, 6-28 in bottom assembly, Options 014/UNL/080/081 illustrated, 6-33 part numbers, 6-32 in external analyzer illustrated, 6-55 part numbers, 6-54 in front panel assembly illustrated, 6-11 part numbers, 6-10 in hard disk drive assembly illustrated, 6-58 part numbers. 6-58 in internal analyzer illustrated, 6-53 part numbers, 6-52 in rear panel assembly illustrated, 6-57 part numbers, 6-56 in top assembly, all options illustrated, 6-13, 6-49

part numbers, 6-12, 6-48 locating by reference designator, 6-6 by type of part, 6-8 miscellaneous part numbers, 6-59 required for servicing, 2-9 replaceable listing of. 6-6 ordering information, 6-3 parts, hardware in bottom assembly illustrated, 6-51 part numbers, 6-50 in external analyzer, all options illustrated, 6-55 part numbers, 6-54 in hard disk drive assembly, all options illustrated, 6-58 part numbers, 6-58 in internal analyzer, all options illustrated, 6-53 part numbers, 6-52 in rear panel assembly, all options illustrated, 6-57 part numbers, 6-56 in top assembly, all options illustrated, 6-49 part numbers, 6-48 password Agilent administrator, 7-64 performance tests, 3-29calibration coefficients, 3-34 description of, 3-7 dynamic accuracy, 3-36 frequency accuracy, 3-31 noise floor, 3-33 power meter accuracy, 3-38 receiver compression, 3-32 source maximum power output, 3-30 source power accuracy, 3-29 source power linearity, 3-30 system crosstalk, 3-35 test port crosstalk, 3-35 test port output maximum power, 3-30 test port output power accuracy, 3-29 test port output power linearity, 3-30 trace noise, 3-31 verification ANSI/NCSL Z540-1-1994, 3-8

non-ANSI/NCSLZ540-1-1994, 3-9 phase lock IF gain adjustment, 3-52 phase lock board illustrated, 6-13 operation, 5-10 part number, 6-12 removal and replacement illustrated, 7-21 procedure, 7-20 test nodes, 4-36 troubleshooting, 4-36 phase stability check failure of, 3-16 test port cables, 3-15 pin assignments connectors AUX I/O, 5-15 HANDLER I/O, 5-14 **TEST SET I/O, 5-13** ping command, LAN, 4-24 from network, 4-25 to analyzer, 4-24 pixel damaged, 4-19 definition, 4-19 **PMYO** (permanent-magnet YIG oscillator) frequency adjustment, 3-45 theory of operation, 5-10 Port 1 attenuator removal and replacement, 7-54check, 3-10 typical power output, 4-47 Port 2 attenuator removal and replacement, 7-54check, 3-10 typical power output, 4-48 post-repair procedures, 7-76 power meter accuracy test, 3-38 power supply check, 4-7 functional description of, 5-5 functional group, 5-3 if all voltages are missing, 4-10 operation, 5-34 voltage checks, 4-8 power supply assembly illustrated, 6-13 part number, 6-12 removal and replacement illustrated, 7-17 procedure, 7-16

troubleshooting, 4-7 power, source accuracy test, 3-29 linearity test, 3-30 power, source output maximum test, $\overline{3}$ -30 power, test port output accuracy test, 3-29 linearity test, 3-30 maximum test, 3-30 pre-repair procedures, 7-3 caution about, 7-3 warnings about, 7-3 preventive maintenance effect on error terms, A-3 printing copies of documentation, -iv probe power connector, 5-31 measurement points, 4-7 troubleshooting, 4-17 processing subgroup operation, 5protection against EMI/RFI, 6-60 against ESD, 1-6, 3-4, 4-3, 7-3, A-4 protective end caps for connectors part numbers, 6-59 **PULSE IN connectors** operation, 5-26 pulse measurement capability, **Option H08**, **2-4**

R

R1 channel troubleshooting, 4-30 **R1** receiver module troubleshooting, 4-52 R1 trace troubleshooting, 4-30, 4-32, 4 - 33R2 channel troubleshooting, 4-30 R2 receiver module troubleshooting, 4-52 R2 trace troubleshooting, 4-30, 4-33 rack mount kits part numbers, 6-61 with handles, Option 1CP, 2-5 without handles, Option 1CM, 2-5raising the receiver deck illustrated, 7-9 procedure, 7-8 RAM, main

operation, 5-32 rear panel connectors 1284-C, 5-33 8.33 MHz IF IN, 5-26 AUX I/O, 5-12 Display, 5-33 EXT 10 MHz REF IN, 5-10 GPIB, 5-33 HANDLER I/O, 5-12 LAN, 5-33 PARALLEL, 5-33 PULSE IN, 5-26 RS-232, 5-33 SERIAL, 5-33 TEST SET DRIVERS, 5-26 **TEST SET I/O**, 5-12 TRIG IN, 5-12 TRIG OUT, 5-12 USB, 5-33 VGA, 5-33 interconnects, 5-10, 5-12, 5-33 replaceable parts illustrated, 6-57 part numbers, 6-56 troubleshooting, 4-21 rebuilt-exchange assemblies program, 6-5 receiver accuracy dynamic accuracy test, 3-36 calibration, 3-53 compression test, 3-32 dynamic accuracy test, 3-36 frequency offset troubleshooting band 0, 4-56 functional description of, 5-4 functional group, 5-3 linearity dynamic accuracy test, 3-36 output troubleshooting, 4-52receiver attenuators, Option 016, illustrated, 6-29 operation, 5-17 removal and replacement illustrated. 7-67 procedure, 7-66 receiver attenuatos, Option 016 part number, 6-28 receiver deck raising and removing illustrated, 7-9 procedure, 7-8 receiver display running the test, 4-30

receiver group block diagram, 5-22 defined, 4-31 operation, 5-21 troubleshooting, 4-51 receiver module channel A illustrated, 6-17, 6-21 operation, 5-21 part number, 6-16, 6-20 removal and replacement illustrated, 7-51 removal and replacement procedure, 7-50 channel B illustrated, 6-17, 6-21 operation, 5-21 part number, 6-16, 6-20 removal and replacement illustrated, 7-51 removal and replacement procedure, 7-50 channel R1 illustrated, 6-17, 6-21 operation, 5-21 part number, 6-16, 6-20 removal and replacement illustrated, 7-51 removal and replacement procedure, 7-50 channel R2 illustrated, 6-17, 6-21 operation, 5-21 part number, 6-16, 6-20 removal and replacement illustrated, 7-51 removal and replacement procedure, 7-50 receiver motherboard illustrated, 6-17, 6-21 operation, 5-23 part number, 6-16, 6-20 removal and replacement illustrated, 7-53 procedure, 7-52 troubleshooting, 4-52 recovery option data, B-5 recovery, operating system, D-1 reference channel R1, See R1 channel reference channel R2, See R2 channel reference transfer switch. Option 081 illustrated, 6-33 operation, 5-24part number, 6-32

removal and replacement illustrated, 7-69 procedure, 7-68 reflection tracking cause of failure, A-13 definition of, A-13 measurements affected by, A-13 removing assemblies, See specific assembly. options, B-4 parts, See specific part. removing the cover, 1-4 repair post-repair procedures, 7-76 pre-repair procedures, 7-3 procedures caution about, 7-3 warnings about, 7-3 repairing option data, B-5 replaceable cables, flexible in bottom assembly, all options illustrated, 6-45 part numbers, 6-44 in top assembly, all options illustrated, 6-15 part numbers, 6-14 replaceable cables, ribbon in bottom assembly illustrated, 6-47 part numbers, 6-46 in top assembly, all options illustrated. 6-15 part numbers, 6-14 replaceable cables, semi-rigid in bottom assembly, no options illustrated, 6-19 part numbers, 6-18 in bottom assembly, Option 014 illustrated, 6-23 part numbers, 6-22 in bottom assembly, Options 014/080illustrated, 6-23 part numbers, 6-22 in bottom assembly, Options 014/UNL illustrated, 6-27 part numbers, 6-26 in bottom assembly, Options 014/UNL/016/080/081 part numbers, 6-38 in bottom assembly, Options 014/UNL/080/081 illustrated, 6-35, 6-43 in bottom assembly, Options 014/UNL/016

illustrated, 6-31 part numbers, 6-30 in bottom assembly, Options 014/UNL/080/081 illustrated, 6-39 part numbers, 6-34, 6-42 in top assembly, all options illustrated, 6-15 part numbers, 6-14 replaceable cables, wrapped-wire in bottom assembly illustrated, 6-47 part numbers, 6-46 in top assembly, all options illustrated, 6-15 part numbers, 6-14 replaceable hardware in bottom assembly illustrated, 6-51 part numbers, 6-50 in external analyzer illustrated, 6-55 part numbers, 6-54 in hard disk drive assembly illustrated, 6-58 part numbers, 6-58 in internal analyzer illustrated, 6-53 part numbers, 6-52 in rear panel assembly illustrated, 6-57 part numbers, 6-56 in top assembly illustrated, 6-49 replaceable parts hardware, in bottom assembly illustrated, 6-51 part numbers, 6-50 in bottom assembly, no options illustrated, 6-17 part numbers, 6-16 in bottom assembly, Option 014 illustrated, 6-21 part numbers, 6-20 in bottom assembly, Options 014/080 illustrated, 6-21 part numbers, 6-20 in bottom assembly, **Options 014/UNL** illustrated, 6-25 part numbers, 6-24 in bottom assembly, Options 014/UNL/016 illustrated. 6-29 part numbers, 6-28

in bottom assembly, Options 014/UNL/016/080/0 81 illustrated, 6-37 part numbers, 6-36 in bottom assembly, Options 014/UNL/080/081 illustrated, 6-33 part numbers, 6-32 in external analyzer illustrated, 6-55 part numbers, 6-54 in front panel assembly illustrated, 6-11 part numbers, 6-10 in hard disk drive assembly illustrated, 6-58 part numbers, 6-58 in internal analyzer illustrated, 6-53 part numbers, 6-52 in rear panel assembly illustrated, 6-57 part numbers, 6-56 in top assembly, all options, 6-12 illustrated, 6-13, 6-49 part numbers, 6-48 listing of, 6-6 locating by reference designator, 6-6 by type of part, 6-8 miscellaneous analyzer part numbers, 6-59 ordering information, 6-3 replacement A1 keypad assembly illustrated, 7-13 procedure, 7-12 A10 frequency reference board illustrated, 7-19 procedure, 7-18 A11 phase lock board illustrated, 7-21 procedure, 7-20 A12 source 20 illustrated, 7-23 procedure, 7-22 A13 frequency offset receiver board illustrated, 7-25 procedure, 7-24 A14 motherboard illustrated, 7-27 procedure, 7-26 A15 CPU board illustrated, 7-29 procedure, 7-28

A16 test set motherboard illustrated, 7-31 procedure, 7-30 A17 LOMA 12 illustrated, 7-33 procedure, 7-32 A18 MA 24 illustrated, 7-35 procedure, 7-34 A19 splitter illustrated, 7-37 procedure, 7-36 A2 display assembly illustrated, 7-13 procedure, 7-12 A20 LODA illustrated, 7-39 procedure, 7-38 A21 SOMA 50 illustrated, 7-41 procedure, 7-40 A22 switch illustrated, 7-43 procedure, 7-42 A23 SOMA 70 illustrated, 7-45 procedure, 7-44 A24 SOMA 70 illustrated, 7-45 procedure, 7-44 A25 test port 1 coupler illustrated, 7-47 procedure, 7-46 A26 test port 2 coupler illustrated, 7-47 procedure, 7-46 A27 channel A first converter illustrated, 7-49 procedure, 7-48 A28 channel R1 first converter illustrated, 7-49 procedure, 7-48 A29 channel R2 first converter illustrated, 7-49 procedure, 7-48 A3 front panel interface board illustrated, 7-13 procedure, 7-12 A30 channel B first converter illustrated, 7-49 procedure, 7-48 A31 channel A receiver module illustrated, 7-51 procedure, 7-50 A32 channel R1 receiver module illustrated, 7-51 procedure, 7-50

A33 channel R2 receiver module illustrated, 7-51 procedure, 7-50 A34 channel B receiver module illustrated, 7-51 procedure, 7-50 A35 receiver motherboard illustrated, 7-53 procedure, 7-52 A36 port 1 50-dB step attenuator illustrated, 7-55 procedure, 7-54 A37 port 2 50-dB step attenuator illustrated, 7-55 procedure, 7-54 A38 port 1 bias tee illustrated, 7-57 procedure, 7-56 A39 port 2 bias tee illustrated, 7-57 procedure, 7-56 A4 power supply assembly illustrated, 7-17 procedure, 7-16 A40 floppy disk drive illustrated, 7-59 procedure, 7-58 A41 hard disk drive illustrated, 7-61 procedure, 7-60 A43 channel A 50-dB step attenuator illustrated, 7-67 procedure, 7-66 A44 channel B 50-dB step attenuator illustrated, 7-67 procedure, 7-66 A45 reference transfer switch illustrated, 7-69 procedure, 7-68 A47 RF path coupler illustrated, 7-71 procedure, 7-70 A48 LO path coupler illustrated, 7-71 procedure, 7-70 A49 IF multiplexer board illustrated. 7-51 procedure, 7-50 A6 SPAM board illustrated, 7-19 procedure, 7-18 A8 fractional-N synthesizer board

illustrated, 7-19 procedure, 7-18 A9 fractional-N synthesizer board illustrated, 7-19 procedure, 7-18 analyzer covers illustrated, 7-7 procedure, 7-6 assembly cautions about, 7-3 list of procedures, 7-4 sequence, 6-4, 7-3 warnings about, 7-3 display inverter illustrated, 7-15 procedure, 7-14 display lamp illustrated, 7-15 procedure, 7-14 fan, 7-72 front panel assembly illustrated, 7-11 procedure, 7-10 front panel subassemblies illustrated, 7-13 procedures, 7-12 IF multiplexer board illustrated, 7-51 procedure, 7-50 midweb illustrated, 7-73 procedure, 7-72 raising the receiver deck illustrated, 7-9 procedure, 7-8 USB hub illustrated, 7-75 procedure, 7-75 replacement sequence, 4-3 return loss check failure of, 3-13 test port cables, 3-13 **RF** path coupler illustrated, 6-41 part number, 6-40 removal and replacement illustrated, 7-71 procedure, 7-70 RF path coupler, A47 operation, 5-26 **RFI/EMI** supplies part numbers, 6-60 rotary pulse generator (RPG) part number, 6-10 test, 4-17, 4-19 troubleshooting, 4-17

RS-232 port rear panel connector, 5-33 troubleshooting, 4-22

\mathbf{S}

safetv considerations, 1-3 earth ground, 1-3 symbols, 1-3 SCPI. A-7 screws for bottom assemblies illustrated, 6-51 part numbers, 6-50 in external analyzer illustrated, 6-55 part numbers, 6-54 in hard disk drive assembly illustrated, 6-58 part numbers, 6-58 in rear panel assembly illustrated, 6-57 part numbers, 6-56 serial bus test, 4-34 dialog box, 4-35 performing, 4-34 serial number changing, B-6 installing, B-6 SERIAL port rear panel connector, 5-33 troubleshooting, 4-22 service contacting Agilent, 2-11 EMI/RFI parts part numbers, 6-60 memory modules part numbers, 6-59 miscellaneous parts required, 2-9 options, 2-10 procedures caution about, 7-3 post-repair, 7-76 pre-repair, 7-3 warnings about, 7-3 static safety parts part numbers, 6-60 required, 2-9 test equipment required, 2-7 tools part numbers, 6-59 required, 2-9 warnings, 1-4 warranty

standard, 2-10 three-year return to Agilent, 2-10 shipment for service or repair, 2-11signal separation functional description of, 5-4 functional group, 5-3 signal separation group block diagram, 5-16 defined, 4-31 operation, 5-16 troubleshooting, 4-47 single band failure, 4-40 software options, B-4 **SOMA 50** illustrated, 6-17, 6-21 operation, 5-11 part number, 6-16, 6-20 removal and replacement illustrated, 7-41 procedure, 7-40 troubleshooting, 4-42 **SOMA 70** illustrated, 6-17, 6-21 operation, 5-17 part number, 6-16, 6-20 Port 1 removal and replacement illustrated, 7-45 removal and replacement procedure, 7-44 Port 2 removal and replacement illustrated, 7-45 removal and replacement procedure, 7-44 troubleshooting, 4-42, 4-49 source calibration, 3-50 functional group, 5-3 maximum output power test, 3-30 power accuracy test, 3-29 power linearity test, 3-30 troubleshooting, 4-41 source 20 illustrated, 6-13 operation, 5-6, 5-10 part numbers, 6-12 removal and replacement illustrated, 7-23 procedure, 7-22 test nodes, 4-35 troubleshooting bands 3-26, frequency offset mode, 4-55

source attenuators, Option UNL, 2-5operation, 5-17 removal and replacement illustrated, 7-55 procedure, 7-54 source group block diagram, 5-7 defined, 4-31 troubleshooting, 4-34 source match cause of failure, A-11 definition of, A-11 measurements affected by, A-11 source step attenuators, Option UNL illustrated, 6-25 part number, 6-24 SPAM board illustrated, 6-13 operation analog, 5-23 digital, 5-32 part number, 6-12 removal and replacement illustrated, 7-19 procedure, 7-18 troubleshooting, 4-52 speaker front panel, 5-31 troubleshooting, 4-17 specifications instrument, 3-6 stabilization, warm up time, 3-4 system, 3-6 splitter illustrated, 6-17, 6-21 operation, 5-9 part number, 6-16, 6-20 removal and replacement illustrated, 7-37 procedure, 7-36 stabilization warm up time, 3-4 standards compliant calibration. **Option R-50C-002**, **2-10** static safety parts required for servicing, 2-9 step attenuator, receiver illustrated, 6-29 operation, 5-17 part number, 6-28 removal and replacement illustrated, 7-67 procedure, 7-66 step attenuator, source illustrated, 6-25 operation, 5-17 part number, 6-24

port 1 troubleshooting, 4-49 port 2 troubleshooting, 4-49 removal and replacement illustrated, 7-55 procedure, 7-54 storage data IDE, 5-33 strap handle analyzer illustrated, 6-55 part number, 6-54 subgroup data acquisition and processing, 5-29front panel, 5-29 subnet mask, LAN, 4-24 substitution cable, 3-22 calibration kits, 3-22 verification kits, 3-22 supplies EMI/RFI part numbers, 6-60 ESD part numbers, 6-60 memory modules part numbers, 6-59 support contacting Agilent, 2-11 options, 2-10 organization, 2-10 switch illustrated, 6-17, 6-21 operation, 5-17 part number, 6-16, 6-20 removal and replacement illustrated, 7-43 procedure, 7-42 troubleshooting, 4-49 switch, reference transfer illustrated, 6-33 part number, 6-32 removal and replacement illustrated, 7-69 procedure, 7-68 synthesized source functional description of, 5-4 system adjustments, 3-1, 3-43, B-1, C-1 frequency at 10 MHz, 3-44 frequency at 3.8 MHz, 3-45 getting ready, 3-4 LO offset, 3-48 LO power, 3-46 phase lock IF gain, 3-52 receiver calibration, 3-53

source calibration, 3-50checks, 3-1, B-1, C-1 getting ready, 3-4 cross talk test, 3-35 operating recovery, D-1 specifications, 3-6 verification, 3-1, 3-7, 3-19, B-1, C-1 device connections, 3-24 dialog box, 3-23 example of results, 3-26, 3-27 failure flowchart, 3-25 failure of, 3-25 getting ready, 3-4 interpreting results, 3-26 performing, 3-22 procedure, 3-23 test setup, 3-23 what it verifies, 3-19 system motherboard illustrated, 6-13 operation, 5-31 part number, 6-12 removal and replacement illustrated, 7-27 procedure, 7-26 troubleshooting, 4-12

Т

test calibration coefficients, 3-34 dynamic accuracy, 3-36 frequency accuracy, 3-31 noise floor, 3-33 performance frequency accuracy, 3-31 source maximum power output, 3-30 source power accuracy, 3-29 test port maximum power output, 3-30 test port output power accuracy, 3-29 power meter accuracy, 3-38 receiver compression, 3-32 source power linearity, 3-30 system crosstalk, 3-35 test port crosstalk, 3-35 test port output power linearity, 3 - 30trace noise, 3-31 test equipment required for service, 2-7 required for servicing, 2-7 test nodes on A12 source 20, 4-35

test port cable checks connector repeatability failure, 3-18 coupler nut illustrated, 6-51 part number. 6-50 cross talk test, 3-35 dynamic accuracy test, 3-36 maximum output power test, 3-30 noise floor test, 3-33 output power accuracy test, 3-29 output power linearity test, 3-30 test port 1 coupler illustrated, 6-17, 6-21 operation, 5-17 part number, 6-16, 6-20 removal and replacement illustrated, 7-47 procedure, 7-46 troubleshooting, 4-49 test port 2 coupler illustrated, 6-17, 6-21 operation, 5-17 part number, 6-16, 6-20 removal and replacement illustrated, 7-47 procedure, 7-46 troubleshooting, 4-49 test port cable checks, **3-10** accessories used in, 3-12connector repeatability, 3-17 insertion loss, 3-14 insertion loss failure, 3-14 magnitude and phase stability, 3-15 magnitude and phase stability failure, 3-16 performing, 3-12 return loss, 3-13 return loss failure, 3-13 **TEST SET DRIVERS connectors** operation, 5-26 TEST SET I/O connector pin assignments, 5-13 rear panel, 5-12 test set motherboard illustrated, 6-17, 6-21 operation, 5-12 part number, 6-16, 6-20 removal and replacement illustrated, 7-31 procedure, 7-30 test nodes, 4-37, 4-38, 4-39

troubleshooting, 4-37, 4-38, 4 - 39test setup system verification, 3-23 tests adjustments, 3-43 frequency offset group, 4-53 performance, 3-7, 3-29 serial bus, 4-34 dialog box, 4-35 performing, 4-34 source group, 4-40 tests nodes on A10 frequency reference, 4 - 36on A11 phase lock board, 4-36 on A16 test set motherboard. 4-37, 4-38, 4-39 on A8 fractional-N synthesizer board, 4-37 on A9 fractional-N synthesizer board. 4-39 time domain, Option 010, 2-3 tools required for servicing, 2-9 service, part numbers, 6-59 top assembly, all option replaceable parts illustrated, 6-49 top assembly, all options replaceable cables, all illustrated, 6-15 part numbers, 6-14 replaceable parts illustrated, 6-13 part numbers, 6-12, 6-48 touch-up paint part numbers, 6-60 trace troubleshooting all traces, 4-32 troubleshooting all, 4-30 trace A troubleshooting, 4-30, 4-32, 4 - 33trace B troubleshooting, 4-30, 4-33 trace noise test, 3-31 trace R1 troubleshooting, 4-30, 4-32, 4 - 33trace R2 troubleshooting, 4-30, 4-33 trace, all troubleshooting, 4-32 traceability measurement, 3-21

path, 3-21 transfer switch, Option 081, 2-4 illustrated, 6-3 operation, 5-24 part number, 6-32 removal and replacement illustrated, 7-69 procedure, 7-68 transmission tracking cause of failure, A-14 definition of, A-14 **TRIG IN connector** rear panel, 5-12 TRIG OUT connector rear panel, 5-12 troubleshooting 1284-C port, 4-22 A1 front panel keypad, 4-17 A10 frequency reference board, 4-42, 4-43, 4-53 A11 phase lock board, 4-36 A12 source 20, 4-40, 4-41 bands 3-26, frequency offset mode, 4-55 A13 frequency offset receiver band 0, 4-56 A14 motherboard, 4-12 A15 CPU board, 4-13, 4-21 A16 test set motherboard board, 4-37, 4-38, 4-39 A17 LOMA 12, 4-44 A18 MA 24, 4-45 A2 display assembly, 4-13, 4-17 A20 LODA, 4-45 A21 SOMA 50, 4-42 A22 switch, 4-49 A23 SOMA 70, 4-42, 4-49 A24 SOMA 70, 4-42, 4-49 A25 test port 1 coupler, 4-49 A26 test port 2 coupler, 4-49 A27 channel A first converter, 4 - 51A28 channel R1 first converter, 4-51A29 channel R2 first converter, 4 - 51A3 front panel interface board, 4-13, 4-17 A30 channel B first converter, 4 - 51A31 channel A receiver module, 4 - 52A32 channel R1 receiver module, 4-52A33 channel R2 receiver module, 4-52A34 channel B receiver module, 4-52

A35 receiver motherboard, 4-52 A36 port 1 step attenuator, 4-49 A37 port 2 step attenuator, 4-49 A38 port 1 bias tee, 4-50 A39 port 2 bias tee, 4-50 A4 power supply assembly, 4-7 A45 reference transfer switch, 4-56 A6 SPAM board, 4-52 A8 fractional-N synthesizer board band 2, 4-44 bands 0 and 1, 4-43 bands 3–26, 4-44 A9 fractional-N synthesizer board band 2, 4-54 bands 0 and 1. 4-54 bands 3–25, 4-55 all traces, 4-32 band 2, 4-44 band 2, frequency offset mode, 4-54 bands 0 and 1, 4-43 bands 0 and 1 for A9, 4-54 bands 3–26, 4-44 bands 3-26, frequency offset mode, 4-55 channel A, 4-30, 4-47 channel B, 4-30, 4-47 channel R1, 4-30 channel R2, 4-30 check the basics, 4-4 error term failure suspect devices, A-3 fans, 4-12 front panel, 4-17 front panel knob, 4-17 front-panel USB, 4-17 GPIB port, 4-23 LAN, 4-24 LCD display, 4-13 measurement system, 4-28 frequency offset group, 4-53 receiver group, 4-51 running the receiver display, 4 - 30signal separation group, 4-47 source group, 4-34, 4-40 traces A, B, R1, R2, 4-30 where to begin, 4-31 order of removal of boards, 4-10 PARALLEL port, 4-22 ping command, 4-24 power output of channel A, 4-47 power output of channel B, 4-47 power up, 4-6

power supply check, 4-7 probe power, 4-17 rear panel, 4-21 rear-panel USB, 4-21 receiver output, 4-52 RPG, 4-17 RS-232 port, 4-22 SERIAL port, 4-22 source 20, 4-40 source group single vs. broadband, 4-40 speaker, 4-17 trace A, 4-30 trace B, 4-30 trace R1, 4-30 trace R2, 4-30 typical power output Port 1, 4-47 Port 2, 4-48 using controllers to system troubleshoot, 4-23 using error terms, A-3 using the extender board, 4-8 VGA port, 4-22 where to begin, 4-4

U

uncertainty measurement, 3-20 upgrade configurable test set, Option 014, 2-3 firmware downloading from the internet, C-2 installing using Option 099, C-3 firmware, Option 099, 2-4 frequency converter measurement application Option 083, 2-4 frequency offset mode Option 080, 2-4 how to order, 2-3 IF access, Option H11, 2-5 pulse measurement capability, Option H08, 2-4 receiver attenuators Option 016, 2-4 source attenuators, Option UNL, 2-5 time domain, Option 010, 2-3 transfer switch Option 081, 2-4 upgrade kits part numbers, 6-60 upgrades

analyzer, 2-6 USB accessories CD-RW drive, 2-6 hub, 2-6 part numbers, 6-60 front panel troubleshooting, 4-17 port front panel connector, 5-31 rear panel connector, 5-33 rear panel troubleshooting, 4-21 USB hub operation, 5-33 removal and replacement, 7-75 illustrated, 7-75 utility option enable accessing, B-3 dialog box, B-3

V

VCO (voltage-controlled oscillator) defined, 5-6 ventilation requirements, 1-3 verification ANSI/NCSL Z540-1-1994, 3-8 kits, 2-8, 3-7 substitution, 3-22 non-ANSI/NCSL Z540-1-1994, 3-9 of operating environment, 3-4 of operating specifications, 3-4 of Option H11, IF access, 3-28 system, 3-1, 3-7, 3-19, B-1, C-1 device connections, 3-24 dialog box, 3-23 example of results, 3-26, 3-27 failure flowchart, 3-25 failure of, 3-25 getting ready, 3-4 interpreting results, 3-26 performing, 3-22 procedure, 3-23 test setup, 3-23 what it verifies, 3-19 VGA monitor, 4-13 VGA port rear panel connector, 5-33 troubleshooting, 4-22

W

warm up analyzer, 3-4

warning, 1-3 warnings for servicing, 1-4 warranty service one-year return to Agilent, 2-10 standard, 2-10 Windows, 2-7

Y

YIG (yttrium-iron-garnet) defined, 5-6 YIG oscillator PMYO frequency adjustment, 3-45 YTO (YIG-tuned oscillator) defined, 5-10 theory of operation, 5-10